













#### AM3359, AM3358, AM3357, AM3356, AM3354, AM3352, AM3351

SPRS717I - OCTOBER 2011 - REVISED DECEMBER 2015

# AM335x Sitara™ Processors

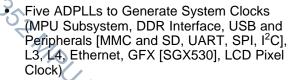
#### 1 Device Overview

#### 1.1 Features

- Up to 1-GHz Sitara<sup>™</sup> ARM<sup>®</sup> Cortex<sup>®</sup>-A8 32-Bit RISC Processor
  - NEON™ SIMD Coprocessor
  - 32KB of L1 Instruction and 32KB of Data Cache With Single-Error Detection (Parity)
  - 256KB of L2 Cache With Error Correcting Code (ECC)
  - 176KB of On-Chip Boot ROM
  - 64KB of Dedicated RAM
  - Emulation and Debug JTAG
  - Interrupt Controller (up to 128 Interrupt Requests)
- On-Chip Memory (Shared L3 RAM)
  - 64KB of General-Purpose On-Chip Memory Controller (OCMC) RAM
  - Accessible to All Masters
  - Supports Retention for Fast Wakeup
- External Memory Interfaces (EMIF)
  - mDDR(LPDDR), DDR2, DDR3, DDR3L Controller:
    - mDDR: 200-MHz Clock (400-MHz Data Rate)
    - DDR2: 266-MHz Clock (532-MHz Data Rate)
    - DDR3: 400-MHz Clock (800-MHz Data Rate)
    - DDR3L: 400-MHz Clock (800-MHz Data Rate)
    - 16-Bit Data Bus
    - 1GB of Total Addressable Space
    - Supports One x16 or Two x8 Memory Device Configurations
  - General-Purpose Memory Controller (GPMC)
    - Flexible 8-Bit and 16-Bit Asynchronous Memory Interface With up to Seven Chip Selects (NAND, NOR, Muxed-NOR, SRAM)
    - Uses BCH Code to Support 4-, 8-, or 16-Bit ECC
    - Uses Hamming Code to Support 1-Bit ECC
  - Error Locator Module (ELM)
    - Used in Conjunction With the GPMC to Locate Addresses of Data Errors from Syndrome Polynomials Generated Using a BCH Algorithm
    - Supports 4-, 8-, and 16-Bit per 512-Byte Block Error Location Based on BCH Algorithms
- Programmable Real-Time Unit Subsystem and Industrial Communication Subsystem (PRU-ICSS)

- Supports Protocols such as EtherCAT<sup>®</sup>, PROFIBUS, PROFINET, EtherNet/IP™, and More
- Two Programmable Real-Time Units (PRUs)
  - 32-Bit Load/Store RISC Processor Capable of Running at 200 MHz
  - 8KB of Instruction RAM With Single-Error Detection (Parity)
  - 8KB of Data RAM With Single-Error Detection (Parity)
  - Single-Cycle 32-Bit Multiplier With 64-Bit Accumulator
  - Enhanced GPIO Module Provides Shift-In/Out Support and Parallel Latch on External Signal
- 12KB of Shared RAM With Single-Error Detection (Parity)
- Three 120-Byte Register Banks Accessible by Each PRU
- Interrupt Controller (INTC) for Handling System Input Events
- Local Interconnect Bus for Connecting Internal and External Masters to the Resources Inside the PRU-ICSS
- Peripherals Inside the PRU-ICSS:
  - One UART Port With Flow Control Pins, Supports up to 12 Mbps
  - One Enhanced Capture (eCAP) Module
  - Two MII Ethernet Ports that Support Industrial Ethernet, such as EtherCAT
  - One MDIO Port
- Power, Reset, and Clock Management (PRCM) Module
  - Controls the Entry and Exit of Stand-By and Deep-Sleep Modes
  - Responsible for Sleep Sequencing, Power Domain Switch-Off Sequencing, Wake-Up Sequencing, and Power Domain Switch-On Sequencing
  - Clocks
    - Integrated 15- to 35-MHz High-Frequency Oscillator Used to Generate a Reference Clock for Various System and Peripheral Clocks
    - Supports Individual Clock Enable and Disable Control for Subsystems and Peripherals to Facilitate Reduced Power Consumption





#### Power

- Two Nonswitchable Power Domains (Real-Time Clock [RTC], Wake-Up Logic [WAKEUP])
- Three Switchable Power Domains (MPU Subsystem [MPU], SGX530 [GFX], Peripherals and Infrastructure [PER])
- Implements SmartReflex<sup>™</sup> Class 2B for Core Voltage Scaling Based On Die Temperature, Process Variation, and Performance (Adaptive Voltage Scaling [AVS])
- Dynamic Voltage Frequency Scaling (DVFS)
- Real-Time Clock (RTC)
  - Real-Time Date (Day-Month-Year-Day of Week) and Time (Hours-Minutes-Seconds) Information
  - Internal 32.768-kHz Oscillator, RTC Logic and 1.1-V Internal LDO
  - ☐ Independent Power-on-Reset (RTC\_PWRONRSTn) Input
  - Dedicated Input Pin (EXT\_WAKEUP) for **External Wake Events**
  - Programmable Alarm Can be Used to Generate Internal Interrupts to the PRCM (for Wakeup) or Cortex-A8 (for Event Notification)
  - Programmable Alarm Can be Used With External Output (PMIC POWER EN) to Enable the Power Management IC to Restore Non-RTC **Power Domains**
- Peripherals
  - Up to Two USB 2.0 High-Speed OTG Ports With Integrated PHY
  - Up to Two Industrial Gigabit Ethernet MACs (10, 100, 1000 Mbps)
    - Integrated Switch
    - Each MAC Supports MII, RMII, RGMII, and **MDIO** Interfaces
    - Ethernet MACs and Switch Can Operate Independent of Other Functions
    - IEEE 1588v2 Precision Time Protocol (PTP)
  - Up to Two Controller-Area Network (CAN) Ports
    - Supports CAN Version 2 Parts A and B Up to Two Multichannel Audio Serial Ports (McASPs)
    - Pransmit and Receive Clocks up to 50 MHz
    - Up to Four Serial Data Pins per McASP Port With Independent TX and RX Clocks
    - Supports Time Division Multiplexing (TDM), Inter-IC Sound (I2S), and Similar Formats

- Supports Digital Audio Interface Transmission (SPDIF, IEC60958-1, and AES-3 Formats)
- FIFO Buffers for Transmit and Receive (256 Bytes)
- Up to Six UARTs//
  - All UARTs Support IrDA and CIR Modes
  - All UARTs Support RTS and CTS Flow Control
  - UART1 Supports Full Modem Control
- Up to Two Master and Slave McSPI Serial Interfaces
  - Up to Two Chip Selects
  - Up to 48 MHz
- Up to Three MMC, SD, SDIO Ports
  - 1-, 4- and 8-Bit MMC, SD, SDIO Modes
  - MMCSD0 has Dedicated Power Rail for 1.8-V or 3.3-V Operation
  - Up to 48-MHz Data Transfer Rate
  - Supports Card Detect and Write Protect
  - Complies With MMC4.3, SD, SDIO 2.0 **Specifications**
- Up to Three I<sup>2</sup>C Master and Slave Interfaces
  - Standard Mode (up to 100 kHz)
  - Fast Mode (up to 400 kHz)
- Up to Four Banks of General-Purpose I/O (GPIO) Pins
  - 32 GPIO Pins per Bank (Multiplexed With Other Functional Pins)
  - GPIO Pins Can be Used as Interrupt Inputs (up to Two Interrupt Inputs per Bank)
- Up to Three External DMA Event Inputs that can Also be Used as Interrupt Inputs
- Eight 32-Bit General-Purpose Timers
  - DMTIMER1 is a 1-ms Timer Used for Operating System (OS) Ticks
  - DMTIMER4-DMTIMER7 are Pinned Out
- One Watchdog Timer
- SGX530 3D Graphics Engine
  - Tile-Based Architecture Delivering up to 20 Million Polygons per Second
  - Universal Scalable Shader Engine (USSE) is a Multithreaded Engine Incorporating Pixel and Vertex Shader Functionality
  - Advanced Shader Feature Set in Excess of Microsoft VS3.0, PS3.0, and OGL2.0
  - Industry Standard API Support of Direct3D Mobile, OGL-ES 1.1 and 2.0, OpenVG 1.0, and OpenMax
  - Fine-Grained Task Switching, Load Balancing, and Power Management
  - Advanced Geometry DMA-Driven Operation for Minimum CPU Interaction

- Programmable High-Quality Image Anti-Aliasing
- Fully Virtualized Memory Addressing for OS Operation in a Unified Memory Architecture
- LCD Controller
  - Up to 24-Bit Data Output; 8 Bits per Pixel (RGB)
  - Resolution up to 2048 × 2048 (With Maximum 126-MHz Pixel Clock)
  - Integrated LCD Interface Display Driver (LIDD) Controller
  - Integrated Raster Controller
  - Integrated DMA Engine to Pull Data from the External Frame Buffer Without Burdening the Processor via Interrupts or a Firmware Timer
  - 512-Word Deep Internal FIFO
  - Supported Display Types:
    - Character Displays Uses LIDD Controller to Program these Displays
    - Passive Matrix LCD Displays Uses LCD Raster Display Controller to Provide Timing and Data for Constant Graphics Refresh to a Passive Display
    - Active Matrix LCD Displays Uses External Frame Buffer Space and the Internal DMA Engine to Drive Streaming Data to the Panel
- 12-Bit Successive Approximation Register (SAR) ADC
  - 200K Samples per Second
  - Input can be Selected from any of the Eight Analog Inputs Multiplexed Through an 8:1 Analog Switch
  - Can be Configured to Operate as a 4-Wire, 5-Wire, or 8-Wire Resistive Touch Screen Controller (TSC) Interface
- Up to Three 32-Bit eCAP Modules
  - Configurable as Three Capture Inputs or Three Auxiliary PWM Outputs
- Up to Three Enhanced High-Resolution PWM Modules (eHRPWMs)
  - Dedicated 16-Bit Time-Base Counter With Time and Frequency Controls
- POPS, AMBOSE MADU MUR Configurable as Six Single-Ended, Six Dual-Edge Symmetric, or Three Dual-Edge Asymmetric Outputs

- Up to Three 32-Bit Enhanced Quadrature Encoder Pulse (eQEP) Modules
- Device Identification
  - Contains Electrical Fuse Farm (FuseFarm) of Which Some Bits are Factory Programmable
    - Production ID
    - Device Part Number (Unique JTAG ID)
    - Device Revision (Readable by Host ARM)
- Debug Interface Support
  - JTAG and cJTAG for ARM (Cortex-A8 and PRCM), PRU-ICSS Debug
  - Supports Device Boundary Scan
  - Supports IEEE 1500
- DMA
  - On-Chip Enhanced DMA Controller (EDMA) has Three Third-Party Transfer Controllers (TPTCs) and One Third-Party Channel Controller (TPCC), Which Supports up to 64 Programmable Logical Channels and Eight QDMA Channels. EDMA is Used for:
    - Transfers to and from On-Chip Memories
    - Transfers to and from External Storage (EMIF, GPMC, Slave Peripherals)
- Inter-Processor Communication (IPC)
  - Integrates Hardware-Based Mailbox for IPC and Spinlock for Process Synchronization Between Cortex-A8, PRCM, and PRU-ICSS
    - Mailbox Registers that Generate Interrupts
      - Four Initiators (Cortex-A8, PRCM, PRU0, PRU1)
    - Spinlock has 128 Software-Assigned Lock Registers
- Security
  - Crypto Hardware Accelerators (AES, SHA, RNG)
- Boot Modes
  - Boot Mode is Selected Through Boot Configuration Pins Latched on the Rising Edge of the PWRONRSTn Reset Input Pin
- Packages:
  - 298-Pin S-PBGA-N298 Via Channel Package (ZCE Suffix), 0.65-mm Ball Pitch
- 23. AMBO MAL MUR 324-Pin S-PBGA-N324 Package (ZCZ Suffix), 0.80-mm Ball Pitch

#### 1.2 Applications

- Gaming Peripherals
- Home and Industrial Automation
- Consumer Medical Appliances
- Printers
- Smart Toll Systems

- Connected Vending Machines
- Weighing Scales
- Educational Consoles
- · Advanced Toys

#### 1.3 Description

The AM335x microprocessors, based on the ARM Cortex-A8 processor, are enhanced with image, graphics processing, peripherals and industrial interface options such as EtherCAT and PROFIBUS. The devices support high-level operating systems (HLOS). Linux<sup>®</sup> and Android<sup>™</sup> are available free of charge from TI

The AM335x microprocessor contain the subsystems shown in Figure 1-1 and a brief description of each follows:

The microprocessor unit (MPU) subsystem is based on the ARM Cortex-A8 processor and the PowerVR SGX<sup>™</sup> Graphics Accelerator subsystem provides 3D graphics acceleration to support display and gaming effects.

The PRU-ICSS is separate from the ARM core, allowing independent operation and clocking for greater efficiency and flexibility. The PRU-ICSS enables additional peripheral interfaces and real-time protocols such as EtherCAT, PROFINET, EtherNet/IP, PROFIBUS, Ethernet Powerlink, Sercos, and others. Additionally, the programmable nature of the PRU-ICSS, along with its access to pins, events and all system-on-chip (SoC) resources, provides flexibility in implementing fast, real-time responses, specialized data handling operations, custom peripheral interfaces, and in offloading tasks from the other processor cores of SoC.

Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE
AM3359ZCZ	NFBGA (324)	15.0 mm × 15.0 mm
AM3358ZCZ	NFBGA (324)	15.0 mm × 15.0 mm
AM3357ZCZ	NFBGA (324)	15.0 mm × 15.0 mm
AM3356ZCZ, AM3356ZCE	NFBGA (324), NFBGA (298)	15.0 mm × 15.0 mm, 13.0 mm × 13.0 mm
AM3354ZCZ, AM3354ZCE	NFBGA (324), NFBGA (298)	15.0 mm × 15.0 mm, 13.0 mm × 13.0 mm
AM3352ZCZ, AM3352ZCE	NFBGA (324), NFBGA (298)	15.0 mm × 15.0 mm, 13.0 mm × 13.0 mm
AM3351ZCE	NFBGA (298)	13.0 mm × 13.0 mm

(1) For more information, see Section 9, Mechanical Packaging and Orderable Information.

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Device Overview

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#### 1.4 Functional Block Diagram

Figure 1-1 shows the AM335x microprocessor functional block diagram.

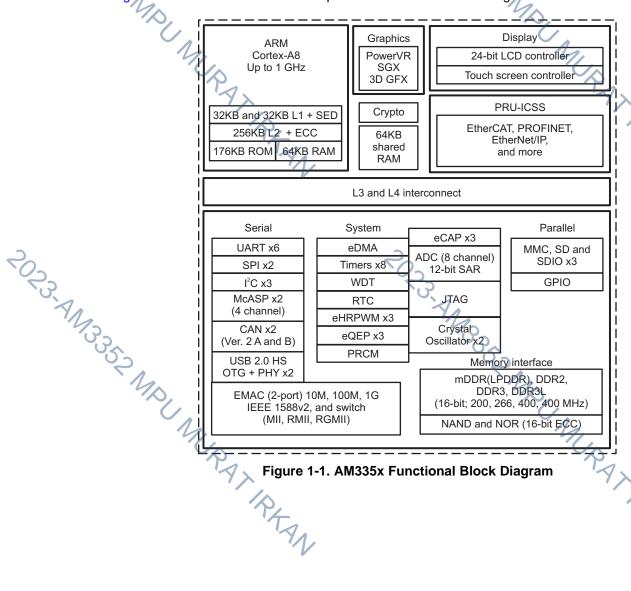


Figure 1-1. AM335x Functional Block Diagram

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2 **Revision History** 

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision H (May 2015) to Revision I	· 4/2,	Page
<ul> <li>Added Part Number AM3351ZCE to Device Info</li> <li>Added column for AM3351 device, changed AM devices in Table 3-1</li> <li>Changed silicon revision 2.1 to 2.x in Footnotes</li> <li>Changed link to Footnote (25) to apply to all pins</li> <li>Corrected callout numbers to correspond with Srigure 7-69</li> <li>Added AM3351 Device to Figure 8-1</li> <li>Added Section 8.3, Receiving Notification of Doc</li> </ul>	.1. PKA feature is not available on this device	on for all  4-1
M3352 MALMURAN PARA	PORS. AMSSSS MADU MURATILE	it of the same of

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#### **Device Comparison** 3

Table 3-1 shows the features supported across different AM335x devices.

# Table 3-1. Device Features Comparison

FUNCTION AM3351 AM3352 AM3354 AM3356 AM3357 AM3358 AM3359											
						_					
Frequency <sup>(1)</sup>	Yes 300 MHz 600 MHz	Yes 300 MHz 600 MHz 800 MHz 1000 MHz	Yes 600 MHz 800 MHz 1000 MHz	Yes 300 MHz 600 MHz 800 MHz	Yes 300 MHz 600 MHz 800 MHz	Yes 600 MHz 800 MHz 1000 MHz	Yes 600 MHz 800 MHz				
MIPS <sup>(2)</sup>	600 1200	600 1200 1600 2000	1200 1600 2000	600 1200 1600	600 1200 1600	1200 1600 2000	1200 1600				
On-chip L1 cache	64 KB	64 KB	64 KB	64 KB	64 KB	64 KB	64 KB				
On-chip L2 cache	256 KB	256 KB	256 KB	256 KB	256 KB	256 KB	256 KB				
Graphics accelerator (SGX530)	_	_	3D	_	_	3D	3D				
Hardware acceleration	Crypto accelerator	Crypto accelerator	Crypto accelerator	Crypto accelerator	Crypto accelerator	Crypto accelerator	Crypto accelerator				
Programmable real-time unit subsystem and industrial communication subsystem (PRU-ICSS)	_	_	<u>-</u> Q	Features including basic Industrial protocols; ZCE: Limited PRU I/Os pinned out	Features including all Industrial protocols	Features including basic Industrial protocols	Features including all Industrial protocols				
On-chip memory	128 KB	128 KB	128 KB	128 KB	128 KB	128 KB	128 KB				
Display options	LCD	LCD	LCD	LCD	LCD	LCD	LCD				
General-purpose memory	1 16-bit (GPMC, NAND flash, NOR flash, SRAM)	116-bit (GPMC, NAND flash, NOR flash, SRAM)	1 16-bit (GPMC, NAND flash, NOR flash, SRAM)	1 16-bit (GPMC, NAND flash, NOR flash, SRAM)							
DRAM <sup>(3)</sup>	1 16-bit (LPDDR-400, DDR2-532, DDR3-800)	1 16-bit (LPDDR-400, DDR2-532, DDR3-800)	1 16-bit (LPDDR-400, DDR2-532, DDR3-800)	1 16-bit (LPDDR-400, DDR2-532, DDR3-800)	1 16-bit (LPDDR-400, DDR2-532, DDR3-800)	1 16-bit (LPDDR-400, DDR2-532, DDR3-800)	1 16-bit (LPDDR-400, DDR2-532, DDR3-800)				
Universal serial bus (USB)	ZCE: 1 port	ZCE: 1 port ZCZ: 2 ports	ZCE: 1 port ZCZ: 2 ports	ZCE: 1 port ZCZ: 2 ports	No ZCE Available ZCZ: 2 ports	No ZCE Available ZCZ: 2 ports	No ZCE Available ZCZ: 2 ports				
Ethernet media access controller (EMAC) with 2-port switch	10/100/1000 ZCE: 1 port	10/100/1000 ZCE: 1 port ZCZ: 2 ports	10/100/1000 ZCE: 1 port ZCZ: 2 ports	10/100/1000 ZCE: 1 port ZCZ: 2 ports	10/100/1000 No ZCE Available ZCZ: 2 ports	10/100/1000 No ZCE Available ZCZ: 2 ports	10/100/1000 No ZCE Available ZCZ: 2 ports				
Multimedia card (MMC)	3	3	3	3	3	3	3				
Controller-area network (CAN)	_	2	2	2	2	2	2				
Universal asynchronous receiver and transmitter (UART)	6	6	6	6	6	6	6				
Analog-to-digital converter (ADC)	8-ch 12-bit	8-ch 12-bit	8-ch 12-bit	8-ch 12-bit	8-ch 12-bit	8-ch 12-bit	8-ch 12-bit				
Enhanced high-resolution PWM modules (eHRPWM)	3	3	3	3	3	3	3				
Enhanced capture modules (eCAP)	3	3	3	33	3	3	3				
Enhanced quadrature encoder pulse (eQEP)	3	3	3	3 0	3	3	3				
Real-time clock (RTC)	1	1	1	1	1/1	1	1				
Inter-integrated circuit (I <sup>2</sup> C)	3	3	3	3	3	3	3				

Device Comparison

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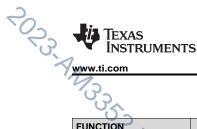


Table 3-1. Device Features Comparison (continued)

AM3351	AM3351 AM3352		AM3356	AM3357	AM3358	AM3359
2	2	2	2	1/0 <sup>2</sup>	2	2
2	2	2	2	2/	2	2
64-Ch	64-Ch	64-Ch	64-Ch	64-Ch	64-Ch	64-Ch
1.8 V, 3.3 V	1.8 V, 3.3 V	1.8 V, 3.3 V	1.8 V, 3.3 V	1.8 V, 3.3 V	1.8 V, 3.3 V	1.8 V, 3.3 V
0 to 90°C	-40 to 125°C <sup>(4)</sup> -40 to 105°C -40 to 90°C 0 to 90°C	-40 to 105°C -40 to 90°C 0 to 90°C	-40 to 105°C -40 to 90°C 0 to 90°C	-40 to 105°C -40 to 90°C	-40 to 105°C -40 to 90°C 0 to 90°C	-40 to 105°C -40 to 90°C
	2 2 64-Ch 1.8 V, 3.3 V	2 2 2 2 64-Ch 64-Ch 1.8 V, 3.3 V 1.8 V, 3.3 V 0 to 90°C -40 to 125°C(4) -40 to 105°C -40 to 90°C	2 2 2 2 2 2 2 64-Ch 64-Ch 64-Ch 1.8 V, 3.3 V 1.8 V, 3.3 V 1.8 V, 3.3 V 0 to 90°C -40 to 125°C -40 to 105°C -40 to 90°C -40 to 90°C 0 to 90°C	2 2 2 2 2 2 2 2 64-Ch 64-Ch 64-Ch 64-Ch 1.8 V, 3.3 V 1.8 V, 3.3 V 1.8 V, 3.3 V 0 to 90°C -40 to 125°C -40 to 105°C -40 to 90°C -40 to 90°C -40 to 90°C 0 to 90°C  -40 to 90°C 0 to 90°C 0 to 90°C	2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2

- (1) Frequencies listed correspond to silicon revision 2.x. Earlier silicon revisions support 275 MHz, 500 MHz, 600 MHz, and 720 MHz.
- (2) MIPS listed correspond to silicon revision 2 x. Earlier silicon revisions support 560, 1000, 1200, and 1440.
- (3) DRAM speeds listed are data rates.
- (4) Industrial extended temperature only supported for 300-MHz and 600-MHz frequencies.

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POPS AMSSE MAUNUA

Device Comparison

#### Terminal Configuration and Functions 4

#### Pin Diagrams 4.1

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#### **NOTE**

The terms 'ball', 'pin', and 'terminal' are used interchangeably throughout the document. An attempt is made to use 'ball' only when referring to the physical package.

#### 4.1.1 ZCE Package Pin Maps (Top View)

The pin maps that follow show the pin assignments on the ZCE package in three sections (left, middle, and right).

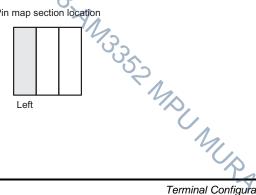
PORS. AMBSSS MANUMERAN PRANT

POPS AMSSE MAN MURE 201



### ZCE Pin Map [Section Left - Top View]

		140	В	С	D	E E	F
	19	vss	I2C0_SCL	UART1_TXD	UART1_RTSn	UARTO_RXD	UART0_CTSn
	18	SPI0_SCLK	SPI0_D0	I2C0_SDA	UART1_RXD	ECAPO_IN_PWM0_OUT	UART0_RTSn
	17	SPI0_CS0	SPI0_D1	EXTINTn	xxxx	UART1_CTSn	UART0_TXD
	16	WARMRSTn	SPI0_CS1	xxxx	xxxx	xxxx	VDDS
	15	VSS         I2C0_SCL         UART1_TXD         UART1_RTSn         OAR           SPI0_SCLK         SPI0_D0         I2C0_SDA         UART1_RXD         ECAP0_IN           SPI0_CS0         SPI0_D1         EXTINTI         XXXX         UART1_RXD         UART1_RXD           WARMRSTI         SPI0_CS1         XXXXX         XXXXX         XXXXX         XXXXX         XXXXX         XXXXX         XXXXX         XXXXX         PWR0           TDO         TCK         TMS         EMU1         X         XXXX         PWR0         PWR0         TM         TM         TM         TM         TM         TM         XXXX         PWR0         TM         TM	PWRONRSTn	XXXX			
	19	xxxx	VDDSHV6				
2	13	18 SPR_SCLK SPR_DD	VSS				
7023	12	AIN7	AIN5	VDDS_SRAM_MPU_BB	VDDS	VDDSHV6	VSS
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	7,11	AIN1	AIN3	XXXX	XXXX	VDDSHV6	VDD_CORE
	10	AIN6	CAP_VDD_SRAM_CORE	VDDS_SRAM_CORE_BG	vse	VSS	xxxx
	9	VREFP	VREFN	xxxx	xxxx P	VSS	VDD_CORE
	8	AIN2	AIN0	AIN4	VSSA_ADC	VSS	VSS
	7	RTC_KALDO_ENn	RTC_PWRONRSTn	PMIC_POWER_EN	VDDA_ADC	V\$8	VSS
	7 R	RTC_XTALIN	RESERVED	VDDS_RTC	CAP_VDD_RTC	xxxx 🔻	VSS
	5	RTC_XTALOUT	FP VREFN XXXX XXXX VSS  2 AINO AIN4 VSSA_ADC VSS  DO_ENN RTC_PWRONRSTN PMIC_POWER_EN VDDA_ADC VSS  TALIN RESERVED VDDS_RTC CAP_VDD_RTC XXXX  ALOUT EXT_WAKEUP VDDS_PLL_DDR XXXX DDR_A  WEN DDR_BA2 XXXX XXXX XXXX  BAO DDR_A3 DDR_A8 XXXX DDR_A1	DDR_A4	xxxx		
	4	DDR_WEn	DDR_BA2	xxxx	xxxx	xxxx	DDR_A12
	3	DDR_BA0	DDR_A3	DDR_A8	XXXX	DDR_A15	DDR_A0
	2	DDR_A5	DDR_A9	DDR_CK	DDR_A7	DDR_A10	DDR_RASn
205	1	VSS	DDR_A6	DDR_CKn	DDR_A2	DDR_BA1	DDR_CASn
	7,			Pin map sect	tion location		
		Don Man		Left	10000	7/s,	
		1,				My	
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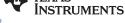




#### ZCE Pin Map [Section Middle - Top View]

2023,	SPR	S717I – OCTOBER 2011-			2, AM3351		TEXAS INSTRUMENT
	1				n Middle - Top Vi	ew]	
		10%	н	J	К	10. L	М
	19	MMCO_CLR	MMC0_DAT3	MII1_COL	MII1_RX_ER	MII1_RX_DV	MII1_RX_CLK
	18	MMC0_DAT0	MMC0_DAT2	MII1_CRS	RMII1_REF_CLK	MII1_TXD0	MII1_TXD1
	17	MMC0_CMD	MMC0_DAT1	xxxx	MII1_TX_EN	INSTRUMENT  WWW.ti.cc  III. RX_ER  MIII. RX_DV  MIII. TXD1  MIII. TXD3  DD_CORE  XXXX  VDDSHV5  XXXX  VSS  VDDSHV5  XXXX  VSS  VDD_CORE  VSS  VDD_CORE  VSS  VDD_CORE  VSS  VSS  VSS  VSS  VSS  VSS  VSS  V	
	16	USB0_DRVVBUS	VDDS_PLL_MPU	AM3354, AM3352, AM3351    NSTRUT   WW    Pin Map [Section Middle - Top View]   J	VDDS		
	15	VDDSHV4	VDDSHV4	vss	VDD_CORE	VSS	VDDSHV5
	14	xxxx	VDDSHV4	VSS	xxxx	VSS	VDDSHV5
2	13	xxxx	VDD_CORE	VDD_CORE	xxxx	VDD_CORE	VDD_CORE
702	12	VSS	VDD_CORE	VDD_CORE	yss vss	VDD_CORE	VDD_CORE
	7,11	VDD_CORE	VSS	VSS	yss	VSS	VSS
	10	xxxx	VSS	xxxx	xxxx	xxxx	VSS
	9	VDD/CORE	VSS	VSS	vss	VSS	VSS
	8	VSS	VDD_CORE	VDD_CORE	VSS	VDD_CORE	VDD_CORE
	7	7 XXXX VDD_CORE		VDD_CORE	xxxx	VDD_CORE	VDD_CORE
	6	xxxx	VDDS_DDR	VSS	xxxx	vss 7	VDDS_DDR
	5	VDDS_DDR	VDDS_DDR	VSS	VDDS_DDR	VSS	VDDS_DDR
	4	DDR_A11	DDR_VREF	xxxx	VDDS_DDR	xxxx	DDR_D11
	3	DDR_CKE	DDR_A14	xxxx	DDR_DQM1	xxxx	DDR_D10
	2	DDR_RESETn	DDR_CSn0	DDR_A1	DDR_D8	DDR_DQSn1	DDR_D12
200	19 18 17 16 15 14 13 12 11 10 9 8 7 6 5 4 3	DDR_ODT	DDR_A13	DDR_VTP	DDR_D9	DDR_DQS1	DDR_D13
	Ang.	DDR_RESETN  DDR_ODT  Terminal Configure			tion location  dle	May My	
	12	Terminal Configur	ation and Functions	Submit Documen	Co	opyright © 2011–2015, Te	exas Instruments Incorpora







#### ZCE Pin Map [Section Right - Top View]

' <del>T</del> ,	ww.ti.com				SPKS/1/I-0	CTOBER 2011-REVI	SED DECEMBER 201
			ZCE Pin Map	[Section Right	() <sub>2</sub>		
	1/0.	Р	R	Т	M	v	w
19	9 MII1_TX_CLK	MII1_RXD1	MDC	USB0_VBUS	USB0_DP	USB0_ID	VSS
18	8 MII1_TXD2	MII1_RXD0	VDDA3P3V_USB0	USB0_CE	USB0_DM	GPMC_BEn1	GPMC_WPn
17	7 MII1_RXD3	MDIO	VDDA1P8V_USB0	xxxx	GPMC_CSn3	GPMC_AD15	GPMC_AD14
16	6 MII1_RXD2	VSSA_USB	xxxx	xxxx	xxxx	GPMC_CLK	GPMC_AD9
15	5 VDDSHV5	xxxx	GPMC_WAIT0	xxxx	GPMC_CSn2	GPMC_AD8	GPMC_AD7
14	4 XXXX	VSS	xxxx	VDDS	GPMC_AD6	GPMC_CSn1	GPMC_AD5
13	3 XXXX	VSS	VDDSHV1	GPMC_AD13	GPMC_AD12	GPMC_AD4	GPMC_AD3
TO 12	2 VSS	VSS	VDDSHV1	GPMC_AD10	GPMC_AD11	GPMC_AD2	XTALOUT
AN	1 VDD_CORE	VDD_CORE	VDDSHV1	xxxx 🔨	xxxx	vss_osc	XTALIN
10	o S xxxx	xxxx	VSS	VSS	VDDS_OSC	GPMC_ADVn_ALE	GPMC_AD0
9	VDD_CORE	VDD_CORE	VDDSHV1	xxxx	XXXX	GPMC_AD1	GPMC_OEn_REn
8	s vss	VSS	VDDSHV1	VDDS_PLL_CORE_LCD	GPMC_WEn	GPMC_BEn0_CLE	GPMC_CSn0
7	XXXX	vss	VDDSHV6	LCD_HSYNC	LCD_VSYNC	LCD_DATA15	LCD_AC_BIAS_EN
6	XXXX	VDDSHV6	xxxx	VDDS	LCD_DATA13	LCD_DATA12	LCD_DATA14
5	VDDS_DDR	xxxx	VPP	xxxx	LCD_DATA10	LCD_DATA11	LCD_PCLK
4	DDR_D0	DDR_D1	A xxxx	xxxx	xxxx	LCD_DATA8	LED_DATA9
3		DDR_D4	DDR_D7	xxxx	LCD_DATA7	LCD_DATA6	LCD_DATA5
2	DDR_D14	DDR_D2	DDR_DQSn0	DDR_D6	LCD_DATA1	LCD_DATA3	LCD_DATA4
PO 1	DDR_D15	DDR_D3	DDR_DQS0	PDR_D5	LCD_DATA0	LCD_DATA2	VSS
73.71	DDR_D14  DDR_D15  DDR_D15		Piı	n map section location	Termi		
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# 4.1.2 ZCZ Package Pin Maps (Top View)

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REAL The pin maps that follow show the pin assignments on the ZCZ package in three sections (left, middle, EMERA PARTAN and right).

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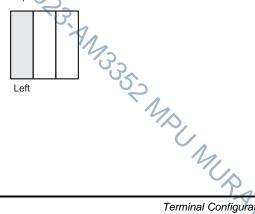
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T-2017

POPS, AMBUMURAY IRAM



# ZCZ Pin Map [Section Left - Top View]

		140	В	С	D /	E E	F
	18	vss C	EXTINTn	ECAP0_IN_PWM0_OUT	UART1_CTSn	UART0_CTSn	MMC0_DAT2
	17	SPI0_SCLK	SPI0_D0	I2C0_SDA	UART1_RTSn	UARTO_RTSn	MMC0_DAT3
	16	SPI0_CS0	SPI0_D1	I2C0_SCL	UART1_RXD	UARTO_TXD	USB0_DRVVBUS
18	UART0_RXD	USBT_DRVVBUS					
	18	VDDSHV6					
		VDD_MPU					
17 SPI0_SCLK SPI0_D0 IZCO_SDA UART1_RTS0 UART0_RTS0 MMC 16 SPI0_CS0 SPI0_D1 IZCO_SCL UART1_RXD UART0_TXD USB0_ 15 XDMA_EVENT_INTRO PWRONRS0 SPI0_CS1 UART1_TXD UART0_TXD USST_ 14 MCASP0_ARLLXX EMU1 EMU0 XDMA_EVENT_INTR1 VDDS VDI 13 MCASP0_ACLKX MCASP0_FSX MCASP0_FSR MCASP0_AXR1 VDDSHV6 VDI 14 TCK MCASP0_ACLKR MCASP0_ACLKR MCASP0_AXR0 VDDSHV6 VDI 15 TOW MRMRST0 TRST0 CAP_VBB_MPU VDDS_SBAM_MPU_BB VDDSHV6 VDI 16 WARMRST0 TRST0 CAP_VBB_MPU VDDS_SBAM_MPU_BB VDDSHV6 VDI 17 AINS AINS AINS AINS AINS VDDA_ADC VSSA_ADC VSSA_ADC VSSA_ADC VSSA_ADC VDDS_SRAM_CORE_BG VDDS_DR	VDD_MPU						
7023	11	TDO	TDI	TMS	CAP_VDD_SRAM_MPU	VDDSHV6	VDD_MPU
70,	7 10	WARMRSTn	TRSTn	CAP_VBB_MPU	VDDS_SRAM_MPU_BB	VDDSHV6	VDD_MPU
	9	VREFN	VREFP	AIN7	CAP_VDD_SRAM_CORE	VDDS_SRAM_CORE_BG	VDDS
	8	AIN6	AIN5	AIN4	VDDA_ADC	VSSA_ADC	VSS
	7	AIN3	AIN2	AIN1	VDDS_RTC	VDDS_PLL_DDR	VDD_CORE
	6	RTC_XTALIN	AINO	PMIC_POWER_EN	CAP_VDD_RTC	VDDS	VDD_CORE
	5	VSS_RTC	RTC_PWRONRSTn	EXT_WAKEUP	DDR_A6	VDDS_DDR	VDDS_DDR
	6	DDR_A2	DDR_A10				
	3	RESERVED	DDR_BA2	DDR_A3	DDR_A15	DDR_A12	DDR_A0
	2	VDD_MPU_MON	DDR_WEn	DDR_A4	DDR_CK	DDR_A7	DDR_A11
	1	VSS	DDR_A5	DDR_A9	DDR_CKn	DDR_BA1	DDR_CASn
POPSIX	M	BS NAUN			<u> </u>	Mac Mars	
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#### ZCZ Pin Map [Section Middle - Top View]

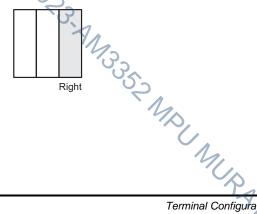
2023	SPR	S717I - OCTOBER 2011-	<b>M3357, AM3356,</b> <i>A</i> -REVISED DECEMBER 2		2, AM3351	•	TEXAS INSTRUMENT www.ti.co
	1		ZCZ	Pin Map [Section	n Middle - Top Vie	ew]	
		19/2	н	J	к		М
	18	MMC0_CMD	RMII1_REF_CLK	MII1_TXD3	MII1_TX_CLK	MII1_RX_CLK	MDC
	17	MMC0_CLK	MII1_CRS	MII1_RX_DV	MII1_TXD0	MII1_RXD3	MDIO
	16	MMC0_DAT0	Mf1_COL	MII1_TX_EN	MII1_TXD1	MII1_RXD2	MII1_RXD0
	15	MMC0_DAT1	VDDS_PLL_MPU	MII1_RX_ER	MII1_TXD2	MII1_RXD1	USB0_CE
	14	VDDSHV6	VDDSHV4	VDDSHV4	VDDSHV5	VDDSHV5	VSSA_USB
	13	VDD_MPU	VDD_MPU	VDD_MPU	VDDS	VSS	VDD_CORE
2	12	VSS	VSS	VDD_CORE	VDD_CORE	VSS	VSS
7023,	11	VSS	VDD_CORE	vss	vss	VSS	VDD_CORE
7	7 10	VDD_CORE	VSS	VSS	yss	VSS	VSS
	9	vss	VSS	VSS	v98)	VDD_CORE	VSS
	8	Ass	VSS	VSS	Map   Section Middle - Top View	VSS	
	7	VDD_CORE	VSS	VSS	VSS	VDD_CORE	VSS
	6	VDD_CORE	Vss	VSS	VDD_CORE	VDD_CORE	VSS
	5	VDDS_DDR	VDDS_DDR	VDDS_DDR	VDDS_DDR	VDDS_DDR	VPP
	4	DDR_RASn	DDR_A14	DDR_VREF	DDR_D12	DDR_D14	DDR_D1
	3	DDR_CKE	DDR_A13	DDR_VTP	DDR_D11	DDR_D13	DDR_D0
	2	DDR_RESETn	DDR_CSn0	DDR_DQM1	DDR_D10	DDR_DQSn1	DDR_DQM0
	1	DDR_ODT	DDR_A1	DDR_D8	DDR_D9	DDR_DQS1	DDR_D15
2023,	Ang.	Terminal Configura				May May	
	16	Terminal Configur	ation and Functions	Submit Documer	00	pyright © 2011–2015, Te.	xas Instruments Incorporat





# ZCZ Pin Map [Section Right - Top View]

		1470	Р	R	т	75. U	V	
	18	USB0_DM	USB1_CE	USB1_DM	USB1_VBUS	GPMC_BEn1	VSS	
	17	USB0_DP	USB1_ID	USB1_DP	GPMC_WAIT0	GPMC_WPn	GPMC_A11	
	17 16 15 14 13 12 11 10 9 8 7 6 5 4 3 2	VDDA1P8V_USB0	USB0_ID	VDDA1P8V_USB1	GPMC_A10	GPMC_A9	GPMC_A8	
	15	USB0_DN	GPMC_A5					
	14	VSSA_USB	USB1_DN	GPMC_A1				
	13	VDD_CORE						
2	12	VDD_CORE						
702	11	VSS	VDDSHV2	VDDS_OSC	GPMC_AD10	XTALOUT	VSS_OSC	
7	10	VSS	VDDSHV2	VDDS_PLL_CORE_LCD	GPMC_AD9	GPMC_AD8	XTALIN	
	7	VDD_CORE	VDDS	GPMC_AD6	GPMC_AD7	GPMC_CSn1	GPMC_CSn2	
	8	VDD_CORE	VDDSHV1	GPMC_AD2	GPMC_AD3	GPMC_AD4	GPMC_AD5	
	7	VSS	VDDSHV1	GPMC_ADVn_ALE	GPMC_OEn_REn	GPMC_AD0	GPMC_AD1	
	6	VDDS	VDDSHV6	LCD_AC_BIAS_EN	GPMC_BEn0_CLE	GPMC_WEn	GPMC_CSn0	
	5	VDDSHV6	VDDSHV6	LCD_HSYNC	LCD_DATA15	LCD_VSYNC	LCD_PCLK	
	4	DDR_D5	E VDDSHV1 GPMC_AD2 GPMC_AD3 GPMC_AD4 GPMC_AD5  VDDSHV1 GPMC_ADVn_ALE GPMC_OEn_REN GPMC_AD0 GPMC_AD1  VDDSHV6 LCD_AC_BIAS_EN GPMC_BEN0_CLE GPMC_WEN GPMC_CSn0  S VDDSHV6 LCD_HSYNC LCD_DATA15 LCD_VSYNC LCD_PCLK  DDR_DT LCD_DATA3 LCD_DATA7 LCD_DATA11 LCD_DATA14  DDR_D6 LCD_DATA2 LCD_DATA6 LCD_DATA10 LCD_DATA13  DDR_DQSn0 LCD_DATA1 LCD_DATA5 LCD_DATA9 LCD_DATA12	LCD_DATA14				
	7 VSS VDDSHV1 GP 6 VDDS VDDSHV6 LCI 5 VDDSHV6 VDDSHV6 I 4 DDR_D5 DDR_D1 3 DDR_D4 DDR_D6 2 DDR_D3 DDR_DQSn0	LCD_DATA2	LCD_DATA6	LCD_DATA10	LCD_DATA13			
	2	DDR_D3	DDR_DQSn0	LCD_DATA1	LCD_DATA5	LCD_DATA9	LCD_DATA12	
	1	DDR_D2	DDR_DQS0	LCD_DATA0	LCD_DATA4	LCD_DATA8	VSS	
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<u>.</u>	Соруі	right © 2011–2015, Texa:	s Instruments Incorporate			Terminal Configuration	on and Functions	



#### 4.2 Pin Attributes

The AM335x Sitara Processors Technical Reference Manual (SPRUH73) and this document may reference internal signal names when discussing peripheral input and output signals because many of the AM335x package terminals can be multiplexed to one of several peripheral signals. The following table has a Pin Name column that lists all device terminal names and a Signal Name column that lists all internal signal names multiplexed to each terminal which provides a cross reference of internal signal names to terminal names. This table also identifies other important terminal characteristics.

- 1. BALL NUMBER: Package ball numbers associated with each signals.
- 2. **PIN NAME:** The name of the package pin or terminal. Note: The table does not take into account subsystem terminal multiplexing options
- 3. SIGNAL NAME: The signal name for that pin in the mode being used.
- 4. **MODE:** Multiplexing mode number.
  - (a) Mode 0 is the primary mode; this means that when mode 0 is set, the function mapped on the terminal corresponds to the name of the terminal. There is always a function mapped on the primary mode. Notice that primary mode is not necessarily the default mode.

Note: The default mode is the mode at the release of the reset; also see the RESET REL. MODE column.

- (b) Modes 1 to 7 are possible modes for alternate functions. On each terminal, some modes are effectively used for alternate functions, while some modes are not used and do not correspond to a functional configuration.
- 5. TYPE: Signal direction
  - I = Input
    - O = Output
  - I/O = Input and Output
  - D = Open drain
  - DS = Differential
  - A = Analog
  - PWR = Power
  - GND = Ground

**Note**: In the safe mode, the buffer is configured in high-impedance.

- 6. BALL RESET STATE: State of the terminal while the active low PWRONRSTn terminal is low.
  - 0: The buffer drives V<sub>OL</sub> (pulldown or pullup resistor not activated)
    - 0(PD): The buffer drives  $V_{\text{OL}}$  with an active pulldown resistor
  - 1: The buffer drives V<sub>OH</sub> (pulldown or pullup resistor not activated) 1(PU): The buffer drives V<sub>OH</sub> with an active pullup resistor
  - Z: High-impedance
  - L: High-impedance with an active pulldown resistor
  - H: High-impedance with an active pullup resistor
- 7. BALL RESET REL. STATE: State of the terminal after the active low PWRONRSTn terminal transitions from low to high.
  - 0: The buffer drives V<sub>OL</sub> (pulldown or pullup resistor not activated) 0(PD): The buffer drives V<sub>OL</sub> with an active pulldown resistor
  - 1: The buffer drives V<sub>OH</sub> (pulldown or pullup resistor not activated) 1(PU): The buffer drives VOH with an active pullup resistor
  - Z: High-impedance.
  - L: High-impedance with an active pulldown resistor
  - H: High-impedance with an active pullup resistor
- 8. RESET REL. MODE: The mode is automatically configured after the active low PWRONRSTn terminal transitions from low to high.
- 9. **POWER:** The voltage supply that powers the terminal's IO buffers.



HYS: Indicates if the input buffer is with hysteresis.

PAR

- 11. BUFFER STRENGTH: Drive strength of the associated output buffer.
- 12. PULLUP OR PULLDOWN TYPE: Denotes the presence of an internal pullup or pulldown resistor. Pullup and pulldown resistors can be enabled or disabled via software.
- 13. **IO CELL:** IO cell information.

Note: Configuring two terminals to the same input signal is not supported as it can yield unexpected results. This can be easily prevented with the proper software configuration.

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PORS. AMBSSS MANUAL MURAN IRAM

POPS AMSSE MAD MUR



# Table 4-1. Pin Attributes (ZCE and ZCZ Packages)

O							アつ						
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]		ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
B8	B6	AINO	AIN0	0	A (22)	Z	Z	0	VDDA_ADC / VDDA_ADC	NA	25	NA	Analog
A11	C7	AIN1	AIN1	0	A (21)	Z	Z	0	VDDA_ADC / VDDA_ADC	NA	25	NA	Analog
A8	B7	AIN2	AIN2	0	A (21)	Z	Z	0	VDDA_ADC / VDDA_ADC	NA	25	NA	Analog
B11	A7	AIN3	AIN3	0	A (20)	Z	Z	0	VDDA_ADC / VDDA_ADC	NA	25	NA	Analog
C8	C8	AIN4	AIN4	0	A <sup>(20)</sup>	Z	Z	0	VDDA_ADC VDDA_ADC	NA	25	NA	Analog
B12	B8	AIN5	AIN5	0	A	Z	Z	0	VDDA_ADC / VDDA_ADC	NA	NA	NA	Analog
A10	A8	AIN6	AIN6	0	A	Z	Z	0	VDDA_ADC / VDDA_ADC	NA	NA	NA	Analog
A12	C9	AIN7	AIN7	0	A	Z	Z	0	VDDA_ADC / VDDA_ADC	NA	NA	NA	Analog
C13	C10	CAP_VBB_MPU	CAP_VBB_MPU	NA	Α						111		
D6	D6	CAP_VDD_RTC	CAP_VDD_RTC	NA	Α						Y	1	
B10	D9	CAP VDD SRAM CORE	CAP VDD SRAM CORE	NA	Α						*/	//	
D13	D11	CAP VDD SRAM MPU	CAP VDD SRAM MPU	NA	Α							-	
F3	F3	DDR_A0	ddr_a0	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
J2	H1	DDR_A1	ddr_a1	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
D1	E4	DDR_A2	ddr_a2	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
B3	C3	DDR_A3	ddr_a3	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
E5	C2	DDR_A4	ddr_a4	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
A2	B1	DDR_A5	ddr_a5	0	0	H	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
B1	D5	DDR_A6	ddr_a6	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
D2	E2	DDR_A7	ddr_a7	0	0	н	13	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
C3	D4	DDR_A8	ddr_a8	0	0	Н	1 6	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
B2	C1	DDR_A9	ddr_a9	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
E2	F4	DDR_A10	ddr_a10	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
G4	F2	DDR_A11	ddr_a11	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
		1/1.							1/1.				

		Table 4-1.1 III Attilb	, ,				, , , , , ,					
ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
E3	DDR_A12	ddr_a12	0	0	Н	1 7	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
H3	DDR_A13	ddr_a13	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
H4	DDR_A14	ddr_a14	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
D3	DDR_A15	ddr_a15	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
C4	DDR_BA0	ddr_ba0	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
E1	DDR_BA1	ddr_ba1	0	0	Н	1	0	VDDS_DDR VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
B3	DDR_BA2	ddr_ba2	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
F1	DDR_CASn	ddr_casn	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
D2	DDR_CK	ddr_ck	0	0	L	0	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
G3	DDR_CKE	ddr_cke	0	0	L	0	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
D1	DDR_CKn	ddr_nck	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
H2	DDR_CSn0	ddr_csn0	0	0	н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
МЗ	DDR_D0	ddr_d0	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
M4	DDR_D1	ddr_d1	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
N1	DDR_D2	ddr_d2	0	1/0	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
N2	DDR_D3	ddr_d3	0	VO.	)	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
N3	DDR_D4	ddr_d4	0	I/O	4,	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
N4	DDR_D5	ddr_d5	0	I/O	L 1/	Z O	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
P3	DDR_D6	ddr_d6	0	I/O		z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
P4 2	DDR_D7	ddr_d7	0	I/O	L	z Q	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
J1	DDR_D8	ddr_d8	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
K1	DDR_D9	ddr_d9	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
K2	DDR_D10	ddr_d10	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
	HOWBER [1] E3 H3 H4 D3 C4 E1 B3 F1 D2 G3 D1 H2 M3 M4 N1 N2 N3 N4 P3 J1 K1	NUMBER [1]   PIN NAME [2]     E3	DR_A12   DR_A13   DR_A14   DR_A15   DR_BA0   DR_BA1   DR_BA1   DR_BA1   DR_BA1   DR_CASh   DR_CKE   DR_CKE   DR_CKN   DR_CSh0   ddr_csh0   ddr_csh0   ddr_csh0   ddr_csh0   ddr_cke   DR_CKh   ddr_cke   DR_CKh   ddr_cke   DR_CKh   ddr_cke   DR_CKh   ddr_d0   ddr_d1   ddr_d1   ddr_d1   ddr_d1   ddr_d1   ddr_d1   ddr_d1   ddr_d2   ddr_d2   ddr_d2   ddr_d2   ddr_d3   ddr_d3   ddr_d4   ddr_d4   ddr_d5   DR_D6   ddr_d6   DR_D7   ddr_d7   J1   DDR_D8   ddr_d8   ddr_d8   ddr_d8   ddr_d8   ddr_d8   ddr_d9   ddr_d9   ddr_d9   ddr_d9   ddr_d9   ddr_d7   J1   DDR_D8   ddr_d8   ddr_d8   ddr_d8   ddr_d9   ddr_d9   ddr_d9   ddr_d9   ddr_d9   ddr_d9   ddr_d9   ddr_d9   ddr_d8   ddr_d8   ddr_d8   ddr_d8   ddr_d8   ddr_d8   ddr_d9   ddr_d9	PIN NAME   2    SIGNAL NAME   3    MODE   4	Note   Pin Name   Pi	DR_A12   DR_A13   DR_A13   DR_A14   DR_A15   DR_CK   DR_CK	Total   Pin Name   P	PIN NAME [2]   SIGNAL NAME [3]   MODE [4]   TYPE BALL RESET REL SYATE   RESET RESET   RESET REL SYATE   RESET RESET   RESET REL SYATE   RESET REL SYATE   RESET RESET   RESET RESE		Type   SIGNAL NAME [2]   SIGNAL NAME [3]   MODE [4]   Type   BALL RESET   REST REL   MODE [8]   MODE [8]   MODE [8]   STATE   STATE	202 BALL   PN NAME     SIGNAL NAME   SIGNAL	



7.			Table 4-1. Pin Attr	•				, (001111111	,				
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	VO CELL [13]
Л4	КЗ	DDR_D11	ddr_d11	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
<b>Л</b> 2	K4	DDR_D12	ddr_d12	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
И1	L3	DDR_D13	ddr_d13	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
<b>N</b> 2	L4	DDR_D14	ddr_d14	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
<b>N</b> 1	M1	DDR_D15	ddr_d15	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
<b>1</b> 3	M2	DDR_DQM0	ddr_dqm0	0	0	Н	1	0	VDDS_DDR VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
<b>K</b> 3	J2	DDR_DQM1	ddr_dgm1	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
R1	P1	DDR_DQS0	ddr_dqs0	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
.1	L1	DDR_DQS1	ddr_dqs1	0	I/O	L	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
R2	P2	DDR_DQSn0	ddr_dqsn0	0	I/O	Н	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL/ HSTL
.2	L2	DDR_DQSn1	ddr_dqsn1	0	I/O	Н	Z	0	VDDS_DDR / VDDS_DDR	Yes	8	PU/PD	LVCMOS/SSTL HSTL
<b>9</b> 1	G1	DDR_ODT	ddr_odt	0	0	L	0	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
-2	G4	DDR_RASn	ddr_rasn	0	0	Н	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
G2	G2	DDR_RESETn	ddr_resetn		0	L	0	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
14	J4	DDR_VREF	ddr_vref	0	A (18)	NA	NA	NA	VDDS_DDR / VDDS_DDR	NA	NA	NA	Analog
11	J3	DDR_VTP	ddr_vtp	0	(19)	NA	NA	NA	VDDS_DDR / VDDS_DDR	NA	NA	NA	Analog
47/	B2	DDR_WEn	ddr_wen	0	0	T	1	0	VDDS_DDR / VDDS_DDR	NA	8	PU/PD	LVCMOS/SSTL/ HSTL
18	C18	ECAP0_IN_PWM0_OUT	eCAP0_in_PWM0_out	0	I/O	Z	L	7	VDDSHV6 /	Yes	4	PU/PD	LVCMOS
<b>'</b> U'	7		uart3_txd	1	0	<b>1</b>	7		VDDSHV6				
	U^		spi1_cs1	2	I/O		UZ						
	0		pr1_ecap0_ecap_capin_apwm_o	3	I/O		05						
	2		spi1_sclk	4	I/O		~	<u> </u>					
			mmc0_sdwp	5	I			1/2					
	4		xdma_event_intr2	6	I								
		1	gpio0_7	7	I/O	1		19					
\15	C14	EMU0	EMU0	0	I/O	Н	Н	0	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
		1/2.	gpio3_7	7	I/O				VDDSHV6				

ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE	RESET REL. MODE [8]		HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
D14	B14	EMU1	EMU1	0	I/O	Н	Н	0	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
	`/		gpio3_8	7	I/O		`/	7_	VDDSHV6				
C17	B18	EXTINTO	nNMI	0	I	Z	Н	0	VDDSHV6 / VDDSHV6	Yes	NA	PU/PD	LVCMOS
B5	C5	EXT_WAKEUP	EXT_WAKEUP	0	I	L	Z	0	VDDS_RTC / VDDS_RTC	Yes	NA	NA	LVCMOS
NA	R13	GPMC_A0	gpmc_a0	0	0	L	L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
		-//,	gmii2_txen	1	0								
			rgmii2_tctl	2	0								
		1	rmii2_txen	3	0				1	1			
			gpmc_a16	4	0					<b>y</b> >			
			pr1_mii_mt1_clk	5	I								
			ehrpwm1_tripzone_input	6	I								
			gpio1_16	7	I/O						7		
NA	V14	GPMC_A1	gpmc_a1	0	0	L	L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_rxdv	1	I							A	
			rgmii2_rctl	2	I						//		
			mmc2_dat0	3	I/O								
			gpmc_a17	4	0								
			pr1_mii1_txd3	5	0								
			ehrpwm0_synco	6	0								
			gpio1_17	7	I/O								
NA	U14	GPMC_A2	gpmc_a2	0	0	L	L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_txd3	1	0								
			rgmii2_td3	2	0								
			mmc2_dat1	3	I/O								
			gpmc_a18	4	0								
YA			pr1_mii1_txd2	5	0	4/							
1/1			ehrpwm1A	6	0	1/1							
	)		gpio1_18	7	I/O		<b>D</b>						
NA	T14	GPMC_A3	gpmc_a3	0	0	L	12	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
`	55		gmii2_txd2	1	0		75						
	7		rgmii2_td2	2	0		7						
		7	mmc2_dat2	3	I/O			7_					
	1		gpmc_a19	4	0								
			pr1_mii1_txd1	5	0								
			ehrpwm1B	6	0								
			gpio1_19	7	I/O				1				



# Table 4-1. Pin Attributes (ZCE and ZCZ Packages) (continued)

ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
NA	R14	GPMC_A4	gpmc_a4	0	0	L	7	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
	`/		gmii2_txd1	1	0		`/	1					
			rgmii2_td1	2	0								
			rmii2_txd1	3	0								
			gpmc_a20	4	0								
		112	pr1_mii1_txd0	5	0				1/2				
			eQEP1A_in	6	I			,	4				
			gpio1_20	7	I/O								
NA	V15	GPMC_A5	gpmc_a5	0	0	L	L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_txd0	1	0					ク、			
			rgmii2_td0	2	0								
			rmii2_txd0	3	0						/_		
			gpmc_a21	4	0						M.		
			pr1_mii1_rxd3	5	I						1/		
			eQEP1B_in	6	I								
			gpio1_21	7	I/O						7,	1,	
NA	U15	GPMC_A6	gpmc_a6	0	0	L	L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_txclk	1	I								
			rgmii2_tclk	2	0								
			mmc2_dat4	3	I/O								
			gpmc_a22	4	0								
			pr1_mii1_rxd2	5	I								
			eQEP1_index	6	I/O								
			gpio1_22	7	1/0								10
NA	T15	GPMC_A7	gpmc_a7	0	0	Ļ	L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_rxclk	1	ľÚ								
<b>\( \)</b>			rgmii2_rclk	2	I	<b>\( \)</b>							
1/1_			mmc2_dat5	3	I/O	1//_							
1/-			gpmc_a23	4	0	1							
, O	้ว		pr1_mii1_rxd1	5	I	, C							
(	50		eQEP1_strobe	6	I/O		U.A.						
	0		gpio1_23	7	I/O		U )						

Terminal Configuration and Functions

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ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET REL. STATE [6](25)	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]		PULLUP /DOWN TYPE [12]	I/O CELL [13]
NA	V16	GPMC_A8	gpmc_a8	0	0	7	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
		7	gmii2_rxd3	1	I		7_					
	- 4		rgmii2_rd3	2	I							
			mmc2_dat6	3	I/O							
			gpmc_a24	4	0							
			pr1_mii1_rxd0	5	I			1				
			mcasp0_aclkx	6	I/O			4				
		· C/^	gpio1_24	7	I/O							
NA	U16	GPMC_A9 (10)	gpmc_a9	0	0	L L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_rxd2	1	I				ク、			
			rgmii2_rd2	2	I							
			mmc2_dat7 / rmii2_crs_dv	3	I/O					/_		
			gpmc_a25	4	0					P.		
			pr1_mii_mr1_clk	5	I					1/4		
			mcasp0_fsx	6	I/O							
			gpio1_25	7	I/O					Y,	1.	
NA	T16	GPMC_A10	gpmc_a10	0	0	L L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_rxd1	1	I							
			rgmii2_rd1	2	I							
			rmii2_rxd1	3	I							
			gpmc_a26	4	0							
			pr1_mii1_rxdv	5	I							
			mcasp0_axr0	6	I/O							رکہ
			gpio1_26	7	1/0							10
NA	V17	GPMC_A11	gpmc_a11	0	0	L L	7	NA / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_rxd0	1	ľ							
<b>1</b>			rgmii2_rd0	2	I							
1/1			rmii2_rxd0	3	I	1//						
1/-			gpmc_a27	4	0	1/5						
'U	2		pr1_mii1_rxer	5	I	1000						
	0.4		mcasp0_axr1	6	I/O	0.4						
	0		gpio1_27	7	I/O	05						
W10	U7	GPMC_AD0	gpmc_ad0	0	I/O	L L	7)	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
		1	mmc1_dat0	1	I/O		11.	VDDSHV1				
		<b>10</b> .	gpio1_0	7	I/O	1						
V9	V7	GPMC_AD1	gpmc_ad1	0	I/O	L L	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			mmc1_dat1	1	I/O	1		VDDSHV1				
		// _	gpio1_1		I/O	-						



ZCE BALL NUMBER [1		PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]		ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
V12	R8	GPMC_AD2	gpmc_ad2	0	I/O	L	L 7	7	VDDSHV1 / VDDSHV1	Yes	6	PU/PD	LVCMOS
			mmc1_dat2	1	I/O			1.	VEEDONY				
	•		gpio1_2	7	I/O		(						
W13	Т8	GPMC_AD3	gpmc_ad3	0	I/O	L	L	7	VDDSHV1 / VDDSHV1	Yes	6	PU/PD	LVCMOS
			mmc1_dat3	1	I/O				VBBGHVI				
			gpio1_3	7	I/O								
V13	U8	GPMC_AD4	gpmc_ad4	0	I/O	L	L	7	VDDSHV1 / VDDSHV1	Yes	6	PU/PD	LVCMOS
			mmc1_dat4	1	I/O				VDDSHVI				
		1	gpio1_4	7	I/O				7				
W14	V8	GPMC_AD5	gpmc_ad5	0	I/O	L	L	7	VDDSHV1 / VDDSHV1	Yes	6	PU/PD	LVCMOS
			mmc1_dat5	1	I/O				VDD2HV1				
			gpio1_5	7	I/O								
U14	R9	GPMC_AD6	gpmc_ad6	0	I/O	L	L	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			mmc1_dat6	1	I/O				VDDSHV1		1/		
			gpio1_6	7	I/O							7	
W15	Т9	GPMC_AD7	gpmc_ad7	0	I/O	L	L	7	VDDSHV1 / VDDSHV1	Yes	6	PU/PD	LVCMOS
			mmc1_dat7	1	I/O				VDDSHV1				
			gpio1_7	7	I/O								
V15	U10	GPMC_AD8	gpmc_ad8	0	I/O	L	L	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			lcd_data23	1	0				VDDSHV2				
			mmc1_dat0	2	I/O								
			mmc2_dat4	3	I/O								
			ehrpwm2A	4	0								2
			pr1_mii_mt0_clk	5	1-								10
			gpio0_22	7	1/0								7
W16	T10	GPMC_AD9	gpmc_ad9	0	I/O	Ĺ	L	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
<b>1</b>			lcd_data22	1	0	<b>1</b>			VDDSHV2				
1/1_			mmc1_dat1	2	I/O	1//_							
1	3		mmc2_dat5	3	I/O	1							
·C	Z		ehrpwm2B	4	0	T C							
M	0.4		pr1_mii0_col	5	I	1	U.A						
	0		gpio0_23	7	I/O	1	0						

ZCE BALL NUMBER [1	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
T12	T11	GPMC_AD10	gpmc_ad10	0	I/O	L	ر کی ا	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
		7	lcd_data21	1	0			1	VDDSHV2				
	1		mmc1_dat2	2	I/O								
			mmc2_dat6	3	I/O								
		<b>(</b> / )	ehrpwm2_tripzone_input	4	I								
			pr1_mii0_txen	5	0				1				
			gpio0_26	7	I/O			Ţ	41				
J12	U12	GPMC_AD11	gpmc_ad11	0	I/O	L	L	7	VDDSHV1/ VDDSHV2	Yes	6	PU/PD	LVCMOS
			lcd_data20	1	0				VDDSHV2				
			mmc1_dat3	2	I/O					ノ、			
			mmc2_dat7	3	I/O					//			
			ehrpwm0_synco	4	0					•	/_		
			pr1_mii0_txd3	5	0						(A)		
			gpio0_27	7	I/O								
J13	T12	GPMC_AD12	gpmc_ad12	0	I/O	L	L	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			Icd_data19	1	0				VDDSHV2		7	1,	
			mmc1_dat4	2	I/O						•		
			mmc2_dat0	3	I/O								
			eQEP2A_in	4	I								
			pr1_mii0_txd2	5	0								
			pr1_pru0_pru_r30_14	6	0								
			gpio1_12	7	I/O								
Г13	R12	GPMC_AD13	gpmc_ad13	0	I/O	L	L	7	VDDSHV1 / VDDSHV2	Yes	6	PU/PD	LVCMOS
			lcd_data18	1	0				VDDSHV2				10
			mmc1_dat5	2	1/0								7
			mmc2_dat1	3	I/O								
<b>4</b> .			eQEP2B_in	4	I	<b>\( \)</b>							
1/1/2			pr1_mii0_txd1	5	0	1/1/2							
	3		pr1_pru0_pru_r30_15	6	0								
	N <sub>2</sub>		gpio1_13	7	I/O	C							
W17	V13	GPMC_AD14	gpmc_ad14	0	I/O	L	5	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
	9		lcd_data17	1	0		9		VDDSHV2				
		7	mmc1_dat6	2	I/O			1					
		1/2	mmc2_dat2	3	I/O			11/					
		<b>10</b> ,	eQEP2_index	4	I/O			10,					
			pr1_mii0_txd0	5	0								
			pr1_pru0_pru_r31_14	6	ı				1				
		1/1.	gpio1_14	7	I/O			•	11.				



	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]		ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	VO CELL [13]
V17	U13	GPMC_AD15	gpmc_ad15	0	I/O	L	L	7	VDDSHV1 / VDDSHV2	Yes	6	PU/PD	LVCMOS
			lcd_data16	1	0			1	VDDSITVZ				
	4		mmc1_dat7	2	I/O		4						
			mmc2_dat3	3	I/O								
			eQEP2_strobe	4	I/O								
		1/2	pr1_ecap0_ecap_capin_apwm_o	5	I/O			,	110				
			pr1_pru0_pru_r31_15	6	I				91				
			gpio1_15	7	I/O								
V10	R7	GPMC_ADVn_ALE	gpmc_advn_ale	0	0	Н	Н	7	VDDSHV1/ VDDSHV1	Yes	6	PU/PD	LVCMOS
			timer4	2	I/O				VDDSHV1	abla			
			gpio2_2	7	I/O								
V8	T6	GPMC_BEn0_CLE	gpmc_be0n_cle	0	0	Н	Н	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			timer5	2	I/O				VDDSHV1		(A)		
			gpio2_5	7	I/O						1/		
V18	U18	GPMC_BEn1	gpmc_be1n	0	0	Н	Н	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			gmii2_col	1	I				VDDSHV3		7,	1,	
			gpmc_csn6	2	0						·		
			mmc2_dat3	3	I/O								
			gpmc_dir	4	0								
			pr1_mii1_rxlink	5	I								
			mcasp0_aclkr	6	I/O								
			gpio1_28	7	I/O								
V16	V12	GPMC_CLK	gpmc_clk	0	1/0	L	L	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			lcd_memory_clk	1	0				VDDSHV2				10
			gpmc_wait1	2									7
			mmc2_clk	3	I/O								
<b>A</b> .			pr1_mii1_crs	4	I	<b>\( \)</b>							
1//_			pr1_mdio_mdclk	5	0								
-			mcasp0_fsr	6	I/O		<b>b</b>						
· O	3		gpio2_1	7	I/O	·C							
W8	V6	GPMC_CSn0	gpmc_csn0	0	0	Н	H	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
	2		gpio1_29	7	I/O		2		VDDSHV1				

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			145.5 4 111 111 / (((1))				DAIL DESET	,			BUFFFD	PULLUP	
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	/DOWN TYPE [12]	I/O CELL [13]
V14	U9	GPMC_CSn1	gpmc_csn1	0	0	Н	Н	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
		7	gpmc_clk	1	I/O			7_	VDDSHV1				
			mmc1_clk	2	I/O								
			pr1_edio_data_in6	3	ı								
			pr1_edio_data_out6	4	0								
			pr1_pru1_pru_r30_12	5	0				1				
			pr1_pru1_pru_r31_12	6	I								
		. (/^	gpio1_30	7	I/O								
U15	V9	GPMC_CSn2	gpmc_csn2	0	0	Н	Н	7	VDDSHV1/	Yes	6	PU/PD	LVCMOS
			gpmc_be1n	1	0				VDDSHV1	ク、			
			mmc1_cmd	2	I/O								
			pr1_edio_data_in7	3	ı						/_		
			pr1_edio_data_out7	4	0						D.		
			pr1_pru1_pru_r30_13	5	0								
			pr1_pru1_pru_r31_13	6	I								
			gpio1_31	7	I/O						Y,	1.	
U17	T13	GPMC_CSn3 (6)	gpmc_csn3	0	0	Н	Н	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			gpmc_a3	1	0				VDDSHV2				
			rmii2_crs_dv	2	I								
			mmc2_cmd	3	I/O								
			pr1_mii0_crs	4	I								
			pr1_mdio_data	5	I/O								
			EMU4	6	I/O								2
			gpio2_0	7	1/0								10
W9	T7	GPMC_OEn_REn	gpmc_oen_ren	0	0	Н	Н	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			timer7	2	I/O				VDDSHV1				
			gpio2_3	7	I/O	<b>1</b>							
R15	T17	GPMC_WAIT0	gpmc_wait0	0	I	H ///	Н	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
1/-			gmii2_crs	1	I				VDDSHV3				
'U	<b>S</b>		gpmc_csn4	2	0	, C	(3)						
	50		rmii2_crs_dv	3	I		04						
	0		mmc1_sdcd	4	I		0						
		n e	pr1_mii1_col	5	I			1					
		1	uart4_rxd	6	I			11					
		<b>10</b> ,	gpio0_30	7	I/O			10.					
U8	U6	GPMC_WEn	gpmc_wen	0	0	Н	Н	7	VDDSHV1 /	Yes	6	PU/PD	LVCMOS
			timer6	2	I/O				VDDSHV1				
		1/1.	gpio2_4	7	I/O				1.				
	l .		1		1	1	1	I .		1	1	1	1

	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]		BALL RESET STATE [6] <sup>(25)</sup>	(	RESET REL. MODE [8]	ZCZ POWER [9]		BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
W18	U17	GPMC_WPn	gpmc_wpn	0	0	Н	H	7	VDDSHV1 / VDDSHV3	Yes	6	PU/PD	LVCMOS
			gmii2_rxerr	1	I			1.					
	•		gpmc_csn5	2	0			10.					
		7,	rmii2_rxerr	3									
			mmc2_sdcd	4	1								
		1/1.	pr1_mii1_txen	5	0				1/2.				
		-//,	uart4_txd	6	0								
	0.17	1000 OD4	gpio0_31	7	I/O	_		7	V D D Q U V D Q	.,		511/55	
C18	C17	I2C0_SDA	I2C0_SDA	0	I/OD	Z	Н	7	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
		,	timer4	1	I/O					<b>y</b> >			
			uart2_ctsn	2	I/O								
			eCAP2_in_PWM2_out gpio3_5	3	1/0								
B19	C16	I2C0_SCL	12C0_SCL	0	I/OD	Z	Н	7	VDDSHV6 /	Yes	174	PU/PD	LVCMOS
ыя	C16	12C0_3CL	timer7	1	1/0		П	,	VDDSHV67	162	" "	PO/PD	LVCIVIOS
			uart2 rtsn	2	0						Y	1	
			eCAP1_in_PWM1_out	3	1/0						**		
			gpio3_6	7	I/O								
W7	R6	LCD_AC_BIAS_EN	lcd_ac_bias_en	0	0	Z	L	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
			gpmc_a11	1	0				VDDSHV6				
			pr1_mii1_crs	2	ı								
			pr1_edio_data_in5	3	ı								
			pr1_edio_data_out5	4	0								رہ
			pr1_pru1_pru_r30_11	5	0								1
			pr1_pru1_pru_r31_11	6									
			gpio2_25	7	I/O								
U17 .	R1	LCD_DATA0 (5)	lcd_data0	0	I/O	Z	Z	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
1/1			gpmc_a0	1	0	1//_			VDDSHV6				
1			pr1_mii_mt0_clk	2	ı								
, O			ehrpwm2A	3	0	, C							
	U.V.		pr1_pru1_pru_r30_0	5	0		U.A						
	2		pr1_pru1_pru_r31_0	6	I		2						
		7	gpio2_6	7	I/O			1					

ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]		SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
U2	R2	LCD_DATA1 (5)	lcd_data1	0	I/O	Z	Z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
	`/	7	gpmc_a1	1	0			1	VDDSHV6				
	4		pr1_mii0_txen	2	0								
			ehrpwm2B	3	0								
			pr1_pru1_pru_r30_1	5	0								
			pr1_pru1_pru_r31_1	6	I				1				
			gpio2_7	7	I/O			·	41				
V1	R3	LCD_DATA2 (5)	lcd_data2	0	I/O	Z	Z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
		<b>1</b>	gpmc_a2	1	0				VDDSHV6				
			pr1_mii0_txd3	2	0					ノ、			
			ehrpwm2_tripzone_input	3	I					//			
			pr1_pru1_pru_r30_2	5	0						/_		
			pr1_pru1_pru_r31_2	6	I						W.		
			gpio2_8	7	I/O						1/		
V2	R4	LCD_DATA3 (5)	lcd_data3	0	I/O	Z	Z	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
			gpmc_a3	1	0				VDDSHV6		Y	1.	
			pr1_mii0_txd2	2	0								
			ehrpwm0_synco	3	0								
			pr1_pru1_pru_r30_3	5	0								
			pr1_pru1_pru_r31_3	6	I								
			gpio2_9	7	I/O								
W2	T1	LCD_DATA4 (5)	lcd_data4	0	I/O	Z	Z	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
			gpmc_a4	1 2	0				VDDSHV6				رحہ
			pr1_mii0_txd1	2	0								
			eQEP2A_in	3									
)			pr1_pru1_pru_r30_4	5	o (	7							
1			pr1_pru1_pru_r31_4	6	ı								
1/1			gpio2_10	7	I/O	1//							
W3	T2	LCD_DATA5 (5)	lcd_data5	0	I/O	Z	Z	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
'U	1		gpmc_a5	1	0	10	75		VDDSHV6				
	5		pr1_mii0_txd0	2	0		UA						
	US		eQEP2B_in	3	i		Un						
	~		pr1_pru1_pru_r30_5	5	0	1		A					
			pr1_pru1_pru_r31_5	6	1	1		11.					
	4		gpio2_11	7	I/O	1	•						



# Table 4-1. Pin Attributes (ZCE and ZCZ Packages) (continued)

ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]		SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
V3	T3	LCD_DATA6 (5)	lcd_data6	0	I/O	Z	Z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
			gpmc_a6	1	0		` /	7	VDD2HV6				
	4		pr1_edio_data_in6	2	I								
			eQEP2_index	3	I/O								
			pr1_edio_data_out6	4	0								
		1/2	pr1_pru1_pru_r30_6	5	0				11-				
			pr1_pru1_pru_r31_6	6	I			,	4				
		. (/^	gpio2_12	7	I/O								
U3	T4	LCD_DATA7 (5)	lcd_data7	0	I/O	Z	Z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
			gpmc_a7	1	0				VDDSHV6	ク、			
			pr1_edio_data_in7	2	I					//			
			eQEP2_strobe	3	I/O						/_		
			pr1_edio_data_out7	4	0						D.		
			pr1_pru1_pru_r30_7	5	0						1/		
			pr1_pru1_pru_r31_7	6	I								
			gpio2_13	7	I/O						7,	1,	
V4	U1	LCD_DATA8 (5)	lcd_data8	0	I/O	Z	Z	7		Yes	6	PU/PD	LVCMOS
			gpmc_a12	1	0				VDDSHV6				
			ehrpwm1_tripzone_input	2	I								
			mcasp0_aclkx	3	I/O								
			uart5_txd	4	0								
			pr1_mii0_rxd3	5	I								
			uart2_ctsn	6									
			gpio2_14	7	1/0								10
W4	U2	LCD_DATA9 (5)	lcd_data9	0	1/0	Z	Z	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
			gpmc_a13	1	o U				VDDSHV6				
<b>7</b> .			ehrpwm0_synco	2	0	<b>\( \)</b>							
1//_			mcasp0_fsx	3	I/O	1//_							
1/-			uart5_rxd	4	I		<b>b</b>						
, O	່ວ		pr1_mii0_rxd2	5	I	, C							
ANS	ブへ		uart2_rtsn	6	О		U.A.						
	0		gpio2_15	7	I/O		0						

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# Table 4-1. Pin Attributes (ZCE and ZCZ Packages) (continued)

	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]		BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]		BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	
U5	J5 U3	LCD_DATA10 (5)	lcd_data10	0	I/O	Z	z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
			gpmc_a14	1	0			1.					
	•		ehrpwm1A	2	0								
		7	mcasp0_axr0	3	I/O			' 9/					
			pr1_mii0_rxd1	5	I								
		1/2	uart3_ctsn	6	I				110				
		4//	gpio2_16	7	I/O				4//				
V5	U4	LCD_DATA11 (5)	lcd_data11	0	I/O		Z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
			gpmc_a15	1	0				VDDSHVO	_	P		
		•	ehrpwm1B	2	0					<b>Y</b> >			
			mcasp0_ahclkr	3	I/O					//			
			mcasp0_axr2	4	I/O								
			pr1_mii0_rxd0	5	I								
			uart3_rtsn	6	0								
			gpio2_17	7	I/O								
V6	V2	LCD_DATA12 <sup>(5)</sup>	lcd_data12	0	I/O	Z	Z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
			gpmc_a16	1	0				VDDSTIVO				
			eQEP1A_in	2	I								
			mcasp0_aclkr	3	I/O								
			mcasp0_axr2	4	I/O								
			pr1_mii0_rxlink	5	I								
			uart4_ctsn	6	I								
			gpio0_8	7	I/O								2
U6	V3	LCD_DATA13 (5)	lcd_data13	0	I/O	Z	Z	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
			gpmc_a17	1	0				VDDSHV6				7
			eQEP1B_in	2	i' U								
<b>V</b> .			mcasp0_fsr	3	I/O	<b>4</b> .							
1/1/2			mcasp0_axr3	4	I/O								
	5		pr1_mii0_rxer	5	I		5						
			uart4_rtsn	6	0								
	5		gpio0_9	7	I/O		54						

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Terminal Configuration and Functions



# Table 4-1. Pin Attributes (ZCE and ZCZ Packages) (continued)

112				1			5	-	1				
ZCE BALL ZCZ NUMBER [1] NUM	BALL BER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
W6 V4	LCD_D/	ATA14 <sup>(5)</sup>	lcd_data14	0	I/O	Z	Z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
	1/2		gpmc_a18	1	0			1	VDD2HV6				
	4//		eQEP1_index	2	I/O								
			mcasp0_axr1	3	I/O								
			uart5_rxd	4	I								
			pr1_mii_mr0_clk	5	I				11-				
			uart5_ctsn	6	I								
		· C/A	gpio0_10	7	I/O				. (//				
V7 T5	LCD_DA	ATA15 <sup>(5)</sup>	lcd_data15	0	I/O	Z	Z	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
			gpmc_a19	1	0				VDDSHV6	ク、			
			eQEP1_strobe	2	I/O					//			
			mcasp0_ahclkx	3	I/O								
			mcasp0_axr3	4	I/O								
			pr1_mii0_rxdv	5	I						1/		
			uart5_rtsn	6	0							7	
			gpio0_11	7	I/O						Y,	1.	
T7 R5	LCD_HS	LCD_HSYNC (7)	lcd_hsync	0	0	Z	L	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
			gpmc_a9	1	0								
			gpmc_a2	2	0								
			pr1_edio_data_in3	3	I								
			pr1_edio_data_out3	4	0								
			pr1_pru1_pru_r30_9	5	0								
			pr1_pru1_pru_r31_9	6	_								2
			gpio2_23	7	1/0								10
W5 V5	LCD_PC	CLK	lcd_pclk	0	0	Z	L	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
			gpmc_a10	1	o 🔾				VDDSHV6				
			pr1_mii0_crs	2	I	1							
1//			pr1_edio_data_in4	3	ı	1//							
7N332			pr1_edio_data_out4	4	0	1//							
TO D			pr1_pru1_pru_r30_10	5	0	T C							
U,			pr1_pru1_pru_r31_10	6	ı		U.A						
O	20		gpio2_24	7	I/O		0						
-			I.	1	1	1			1		1	1	1

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ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
U7	7 U5	LCD_VSYNC (7)	lcd_vsync	0	0	Z	ر ک	7	VDDSHV6 / VDDSHV6	Yes	6	PU/PD	LVCMOS
			gpmc_a8	1	0		. /		ADD2UA9				
			gpmc_a1	2	0								
			pr1_edio_data_in2	3	I								
			pr1_edio_data_out2	4	0								
		1/2	pr1_pru1_pru_r30_8	5	0				11-				
			pr1_pru1_pru_r31_8	6	I				41				
		. (//	gpio2_22	7	I/O								
NA	B13	MCASP0_FSX	mcasp0_fsx	0	I/O	L	L	7	NA / VDDSHV6	Yes	6	PU/PD	LVCMOS
			ehrpwm0B	1	0					✓,			
			spi1_d0	3	I/O								
			mmc1_sdcd	4	I						/_		
			pr1_pru0_pru_r30_1	5	0						<b>1</b>		
			pr1_pru0_pru_r31_1	6	ı						1/4		
			gpio3_15	7	I/O								
NA	B12	MCASP0_ACLKR	mcasp0_aclkr	0	I/O	L	L	7	NA / VDDSHV6	Yes	6	PU/PD	LVCMOS
			eQEP0A_in	1	ı						•		
			mcasp0_axr2	2	I/O								
			mcasp1_aclkx	3	I/O								
			mmc0_sdwp	4	ı								
			pr1_pru0_pru_r30_4	5	0								
			pr1_pru0_pru_r31_4	6	ı								
			gpio3_18	7	I/O								2
NA	C12	MCASP0_AHCLKR	mcasp0_ahclkr	0	1/0	L	L	7	NA / VDDSHV6	Yes	6	PU/PD	LVCMOS
		_	ehrpwm0_synci	1									
)			mcasp0_axr2	2	I/O	7							
<b>1</b>			spi1_cs0	3	I/O	1							
1/1			eCAP2_in_PWM2_out	4	I/O	1// _							
1/			pr1_pru0_pru_r30_3	5	0	1 1/							
'U	່ ລ		pr1_pru0_pru_r31_3	6	ı	T C	75						
	50		gpio3_17	7	I/O		UN						



			Table 4-1. Pin Attrib	ates (20	, L ai	14 2021	ckages	(00111111	aca,				
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
NA	A14	MCASP0_AHCLKX	mcasp0_ahclkx	0	I/O	L		7	NA / VDDSHV6	Yes	6	PU/PD	LVCMOS
	`/	7	eQEP0_strobe	1	I/O			7					
	. 4		mcasp0_axr3	2	I/O								
			mcasp1_axr1	3	I/O								
			EMU4	4	I/O								
			pr1_pru0_pru_r30_7	5	0				1				
			pr1_pru0_pru_r31_7	6	I			· ·	41				
		· (/^	gpio3_21	7	I/O								
NA	A13	MCASP0_ACLKX	mcasp0_aclkx	0	I/O	L	L L	7	NA / VDDSHV6	Yes	6	PU/PD	LVCMOS
			ehrpwm0A	1	0					ノ、			
			spi1_sclk	3	I/O					//			
			mmc0_sdcd	4	I						/_		
			pr1_pru0_pru_r30_0	5	0						D.		
			pr1_pru0_pru_r31_0	6	I								
			gpio3_14	7	I/O								
NA	C13	MCASP0_FSR	mcasp0_fsr	0	I/O	L	L	7	NA / VDDSHV6	Yes	6	PU/PD	LVCMOS
			eQEP0B_in	1	I						•		
			mcasp0_axr3	2	I/O								
			mcasp1_fsx	3	I/O								
			EMU2	4	I/O								
			pr1_pru0_pru_r30_5	5	0								
			pr1_pru0_pru_r31_5	6	I								
			gpio3_19	7	I/O								ر کے
NA	D12	MCASP0_AXR0	mcasp0_axr0	0	I/O	L L	L	7	NA / VDDSHV6	Yes	6	PU/PD	LVCMOS
			ehrpwm0_tripzone_input	1	J-								7
			spi1_d1	3	I/O								·
1			mmc2_sdcd	4	I	<b>A</b> .							
1//			pr1_pru0_pru_r30_2	5	О	1/1							
1/			pr1_pru0_pru_r31_2	6	ı	1/							
'U	13		gpio3_16	7	I/O	T 'U	<b>a</b>						
NA	D13	MCASP0_AXR1	mcasp0_axr1	0	I/O	L	20	7	NA / VDDSHV6	Yes	6	PU/PD	LVCMOS
	Un		eQEP0_index	1	I/O	1	0						
		7	mcasp1_axr0	3	I/O	1		1					
			EMU3	4	I/O	1		11					
		<b>10.</b>	pr1_pru0_pru_r30_6	5	0	1	•						
			pr1_pru0_pru_r31_6	6	ı	1							
			gpio3_20	7	I/O	1							
	1	· // ^	12	1	1	1		1	// _		1	1	

ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
R19	M18	MDC	mdio_clk	0	0	Н	1	7	VDDSHV5 / VDDSHV5	Yes	6	PU/PD	LVCMOS
	` /		timer5	1	I/O			7	VDD2HV5				
	- 4		uart5_txd	2	0								
			uart3_rtsn	3	0								
			mmc0_sdwp	4	I								
		1/2	mmc1_clk	5	I/O				11-				
			mmc2_clk	6	I/O				91				
			gpio0_1	7	I/O								
P17	M17	MDIO	mdio_data	0	I/O	Н	Н	7	VDDSHV5/	Yes	6	PU/PD	LVCMOS
			timer6	1	I/O				VDDSHV5	ノ、			
			uart5_rxd	2	I								
			uart3_ctsn	3	I					•	/_		
			mmc0_sdcd	4	I						(A)		
			mmc1_cmd	5	I/O								
			mmc2_cmd	6	I/O								
			gpio0_0	7	I/O						7	1,	
L19	J17	MII1_RX_DV	gmii1_rxdv	0	I	L	L	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
			lcd_memory_clk	1	0				VDDSHV5				
			rgmii1_rctl	2	I								
			uart5_txd	3	0								
			mcasp1_aclkx	4	I/O								
			mmc2_dat0	5	I/O								
			mcasp0_aclkr	6	I/O								
			gpio3_4	7	1/0								10
K17	J16	MII1_TX_EN	gmii1_txen	0	0	Ļ	L	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
			rmii1_txen	1	o O				VDDSHV5				
<b>1</b>			rgmii1_tctl	2	0	<b>1</b>							
1/1_			timer4	3	I/O	1//_							
1/-			mcasp1_axr0	4	I/O	1							
, O	<b>S</b>		eQEP0_index	5	I/O	, C							
	ブへ -		mmc2_cmd	6	I/O		U.A.						
	2		gpio3_3	7	I/O		2						



### Table 4-1. Pin Attributes (ZCE and ZCZ Packages) (continued)

7, 2				,			5 3 7		,				
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
K19 J	15	MII1_RX_ER	gmii1_rxerr	0	I	L	L 7	7	VDDSHV5 / VDDSHV5	Yes	6	PU/PD	LVCMOS
		7_	rmii1_rxerr	1	I			7	VDDSHV5				
	4		spi1_d1	2	I/O								
			I2C1_SCL	3	I/OD								
			mcasp1_fsx	4	I/O								
			uart5_rtsn	5	0				11-				
			uart2_txd	6	0								
		'(//	gpio3_2	7	I/O				. (//				
M19 L	.18	MII1_RX_CLK	gmii1_rxclk	0	I	L	L	7	VDDSHV5 / VDDSHV5	Yes	6	PU/PD	LVCMOS
		4.	uart2_txd	1	0				VDDSHV5	ノ、			
			rgmii1_rclk	2	I					//			
			mmc0_dat6	3	I/O						/_		
			mmc1_dat1	4	I/O						<b>1</b>		
			uart1_dsrn	5	I						1/		
			mcasp0_fsx	6	I/O								
			gpio3_10	7	I/O						Y,	1.	
N19 K	(18	MII1_TX_CLK	gmii1_txclk	0	I	L	L	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
			uart2_rxd	1	I				VDDSHV5				
			rgmii1_tclk	2	0								
			mmc0_dat7	3	I/O								
			mmc1_dat0	4	I/O								
			uart1_dcdn	5	I								
			mcasp0_aclkx	6	I/O								
			gpio3_9	7	I/O								10
J19 H	116	MII1_COL	gmii1_col	0	1	Ļ	L	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
			rmii2_refclk	1	I/O				VDDSHV5				
<b>A</b> .			spi1_sclk	2	I/O	<b>\( \)</b>							
1/1			uart5_rxd	3	I	1//_							
1/3			mcasp1_axr2	4	I/O	1	5						
· O	<b>C</b>		mmc2_dat3	5	I/O	, C							
C			mcasp0_axr2	6	I/O		U.A.						
	2		gpio3_0	7	I/O		0						
					1	1			1	1	1	1	1

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ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
J18	H17	MII1_CRS	gmii1_crs	0	I	L	1	7	VDDSHV5 / VDDSHV5	Yes	6	PU/PD	LVCMOS
	/		rmii1_crs_dv	1	I		/	1,	VDD9HV5				
	4		spi1_d0	2	I/O								
			I2C1_SDA	3	I/OD								
			mcasp1_aclkx	4	I/O								
		1/2	uart5_ctsn	5	I				11				
			uart2_rxd	6	I			,	41				
		·	gpio3_1	7	I/O								
P18	M16	MII1_RXD0	gmii1_rxd0	0	I	L	L	7	VDDSHV5 / VDDSHV5	Yes	6	PU/PD	LVCMOS
			rmii1_rxd0	1	ı				VDDSHV5	ノ、			
			rgmii1_rd0	2	ı					//			
			mcasp1_ahclkx	3	I/O						/_		
			mcasp1_ahclkr	4	I/O						<b>1</b>		
			mcasp1_aclkr	5	I/O								
			mcasp0_axr3	6	I/O								
			gpio2_21	7	I/O						Y	1.	
P19	L15	MII1_RXD1	gmii1_rxd1	0	ı	L	L	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
			rmii1_rxd1	1	I				VDDSHV5				
			rgmii1_rd1	2	ı								
			mcasp1_axr3	3	I/O								
			mcasp1_fsr	4	I/O								
			eQEP0_strobe	5	I/O								
			mmc2_clk	6	I/O								ر کے
			gpio2_20	7	1/0								10
N16	L16	MII1_RXD2	gmii1_rxd2	0	P,	L	L	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
			uart3_txd	1	o O				VDDSHV5				
1			rgmii1_rd2	2	ı								
1/1			mmc0_dat4	3	I/O	1// .							
1/-			mmc1_dat3	4	I/O	1							
'U'	<b>1</b>		uart1_rin	5	ı	1	75						
	5		mcasp0_axr1	6	I/O	1	UN						
	0		gpio2_19	7	I/O		Un						



### Table 4-1. Pin Attributes (ZCE and ZCZ Packages) (continued)

ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
N17	L17	MII1_RXD3	gmii1_rxd3	0	I	L	ر ک	7	VDDSHV5 / VDDSHV5	Yes	6	PU/PD	LVCMOS
			uart3_rxd	1	I		`/	1,	VDD2HV5				
	4		rgmii1_rd3	2	I								
			mmc0_dat5	3	I/O								
			mmc1_dat2	4	I/O								
		1/2	uart1_dtrn	5	0				11-				
			mcasp0_axr0	6	I/O			· ·	41				
		. (//	gpio2_18	7	I/O								
L18	K17	MII1_TXD0	gmii1_txd0	0	0	L	L	7	VDDSHV5 / VDDSHV5	Yes	6	PU/PD	LVCMOS
			rmi1_txd0	1	0				VDDSHV5	ノ、			
			rgmii1_td0	2	0								
			mcasp1_axr2	3	I/O						/_		
			mcasp1_aclkr	4	I/O					•	M.		
			eQEP0B_in	5	I						1/		
			mmc1_clk	6	I/O								
			gpio0_28	7	I/O						7,	1,	
M18	K16	MII1_TXD1	gmii1_txd1	0	0	L	L	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
			rmii1_txd1	1	0				VDDSHV5				
			rgmii1_td1	2	0								
			mcasp1_fsr	3	I/O								
			mcasp1_axr1	4	I/O								
			eQEP0A_in	5	I								
			mmc1_cmd	6	1/0								
			gpio0_21	7	1/0								10
N18	K15	MII1_TXD2	gmii1_txd2	0	0	Ļ	L	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
			dcan0_rx	1	ľ				VDDSHV5				
<b>4</b> .			rgmii1_td2	2	0	<b>\( \)</b>							
1//_			uart4_txd	3	0	1//_							
1/-	5		mcasp1_axr0	4	I/O		5						
, O	(a)		mmc2_dat2	5	I/O	·C							
	5		mcasp0_ahclkx	6	I/O		5						
	2		gpio0_17	7	I/O		2						

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	ZCZ BALL NUMBER [1]		SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
<i>I</i> 17	J18	MII1_TXD3	gmii1_txd3	0	0	L	L 7	7	VDDSHV5 / VDDSHV5	Yes	6	PU/PD	LVCMOS
			dcan0_tx	1	0			1.					
	•		rgmii1_td3	2	0								
		1	uart4_rxd	3	I			' /					
			mcasp1_fsx	4	I/O								
		1/2	mmc2_dat1	5	I/O								
		9//	mcasp0_fsr	6	I/O				7//				
			gpio0_16	7	I/O								
G17	G18	MMC0_CMD	mmc0_cmd	0	I/O	Н	Н	7	VDDSHV4 / VDDSHV4	Yes	6	PU/PD	LVCMOS
		•	gpmc_a25	1	0				VDD3HV4	<b>/</b> \			
			uart3_rtsn	2	0					'/			
			uart2_txd	3	0					Ť			
			dcan1_rx	4	I						(A)		
			pr1_pru0_pru_r30_13	5	0						1		
			pr1_pru0_pru_r31_13	6	I								
			gpio2_31	7	I/O						7,	1,	
G19	G17	MMC0_CLK	mmc0_clk	0	I/O	Н	Н	7	VDDSHV4 / VDDSHV4	Yes	6	PU/PD	LVCMOS
			gpmc_a24	1	0				VDDSHV4				
			uart3_ctsn	2	I								
			uart2_rxd	3	I								
			dcan1_tx	4	0								
			pr1_pru0_pru_r30_12	5	0								
			pr1_pru0_pru_r31_12	6	_								
			gpio2_30	7	1/0								10
G18	G16	MMC0_DAT0	mmc0_dat0	0	1/0	Н	Н	7	VDDSHV4 /	Yes	6	PU/PD	LVCMOS
			gpmc_a23	1	0				VDDSHV4				
1			uart5_rtsn	2	0	1							
1/1			uart3_txd	3	0	1// _							
1/-			uart1_rin	4	I	1							
TO.	<b>(</b> 2)		pr1_pru0_pru_r30_11	5	0	TU	75						
			pr1_pru0_pru_r31_11	6	I		U.S.						
	0 2		gpio2_29	7	I/O	1	0						

ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]		HYS [10]		PULLUP /DOWN TYPE [12]	I/O CELL [13]
H17	G15	MMC0_DAT1	mmc0_dat1	0	I/O	Н	Н	7	VDDSHV4 /	Yes	6	PU/PD	LVCMOS
		7	gpmc_a22	1	0			1	VDDSHV4				
		<b>7</b> ^	uart5_ctsn	2	ı								
		<i>'</i> \\',	uart3_rxd	3	ı			·/O/					
			uart1_dtrn	4	0								
			pr1_pru0_pru_r30_10	5	0				1				
		'171	pr1_pru0_pru_r31_10	6	I			•	4				
		· (/^	gpio2_28	7	I/O								
H18	F18	MMC0_DAT2	mmc0_dat2	0	I/O	Н	Н	7	VDDSHV4/	Yes	6	PU/PD	LVCMOS
			gpmc_a21	1	0				VDDSHV4	ク、			
			uart4_rtsn	2	0								
			timer6	3	I/O						/_		
			uart1_dsrn	4	I						(A)		
			pr1_pru0_pru_r30_9	5	0						1		
			pr1_pru0_pru_r31_9	6	I								
			gpio2_27	7	I/O						7,	1,	
H19	F17	MMC0_DAT3	mmc0_dat3	0	I/O	Н	Н	7	VDDSHV4 / VDDSHV4	Yes	6	PU/PD	LVCMOS
			gpmc_a20	1	0				VDD5HV4				
			uart4_ctsn	2	I								
			timer5	3	I/O								
			uart1_dcdn	4	I								
			pr1_pru0_pru_r30_8	5	0								
			pr1_pru0_pru_r31_8	6	_								
			gpio2_26	7	I/O								, 0
C7	C6	PMIC_POWER_EN	PMIC_POWER_EN	0	0	5	1	0	VDDS_RTC / VDDS_RTC	NA	6	NA	LVCMOS
E15	B15	PWRONRSTn	porz	0		Z	Z	0	VDDSHV6 / VDDSHV6 (12)	Yes	NA	NA	LVCMOS
B6	A3	RESERVED (3)	testout	0	0	NA	NA	NA	VDDSHV6 / VDDSHV6	NA	NA	NA	Analog
K18	H18	RMII1_REF_CLK	rmii1_refclk	0	I/O	L C	<b>1</b>	7	VDDSHV5 /	Yes	6	PU/PD	LVCMOS
	50		xdma_event_intr2	1	ı		UA		VDDSHV5				
	05		spi1_cs0	2	I/O		05						
		•	uart5_txd	3	0			1					
		1	mcasp1_axr3	4	I/O			1					
	•	<b>10</b> .	mmc0_pow	5	0		1	10.					
			mcasp1_ahclkx	6	I/O								
			gpio0_29	7	I/O				<b>A</b>				
A7	B4	RTC_KALDO_ENn	ENZ_KALDO_1P8V	0	I	Z	Z	0	VDDS_RTC / VDDS_RTC	NA	NA	NA	Analog

ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	VO CELL [13]
B7	B5	RTC_PWRONRSTn	RTC_PORz	0	I	Z	z	0	VDDS_RTC / VDDS_RTC	Yes	NA	NA	LVCMOS
A6	A6	RTC_XTALIN	OSC1_IN	0	I	Н	Н	0	VDDS_RTC / VDDS_RTC	Yes	NA	PU <sup>(1)</sup>	LVCMOS
A5	A4	RTC_XTALOUT	OSC1_OUT	0	0	Z <sup>(23)</sup>	Z <sup>(23)</sup>	0	VDDS_RTC / VDDS_RTC	NA	NA <sup>(15)</sup>	NA	LVCMOS
A18	A17	SPI0_SCLK	spi0_sclk	0	I/O	Z	Н	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
		'//	uart2_rxd	1	I				VDDSHV6				
		'(//	I2C2_SDA	2	I/OD				· (/^				
		<b>*</b>	ehrpwm0A	3	0				~\p				
			pr1_uart0_cts_n	4	I					ノ、			
			pr1_edio_sof	5	0					//			
			EMU2	6	I/O						/_		
			gpio0_2	7	I/O						<b>1</b>		
A17	A16	SPI0_CS0	spi0_cs0	0	I/O	Z	Н	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
			mmc2_sdwp	1	I				VDDSHV6				
			I2C1_SCL	2	I/OD						Y	1.	
			ehrpwm0_synci	3	I								
			pr1_uart0_txd	4	0								
			pr1_edio_data_in1	5	I								
			pr1_edio_data_out1	6	0								
			gpio0_5	7	I/O								
B16	C15	SPI0_CS1	spi0_cs1	0	I/O	Z	Н	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
			uart3_rxd	1	_				VDDSHV6				2
			eCAP1_in_PWM1_out	2	1/0								10
			mmc0_pow	3	0								7
			xdma_event_intr2	4									
			mmc0_sdcd	5	I	1							
1//			EMU4	6	I/O	1/1							
1/-			gpio0_6	7	I/O	1/							
B18	B17	SPI0_D0	spi0_d0	0	I/O	z Ü	H	7	VDDSHV6 /	Yes	6	PU/PD	LVCMOS
	20		uart2_txd	1	0		04		VDDSHV6				
	0		I2C2_SCL	2	I/OD		0						
		7	ehrpwm0B	3	0			1					
		1	pr1_uart0_rts_n	4	0			11					
		<b>10</b> ,	pr1_edio_latch_in	5	l			40,					
			EMU3	6	I/O								
			gpio0_3	7	I/O				1				



ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]			BALL RESET REL. STATE		ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
B17	B16	SPI0_D1	spi0_d1	0	I/O	Z	H	7	VDDSHV6 /	Yes	6		LVCMOS
		7	mmc1_sdwp	1	ı			1	VDDSHV6				
		7	I2C1_SDA	2	I/OD			1/1					
		<b>'</b> \\	ehrpwm0_tripzone_input	3	ı			10,					
			pr1_uart0_rxd	4	ı								
			pr1_edio_data_in0	5	I				1				
		1//	pr1_edio_data_out0	6	0			•	4,				
		'(//	gpio0_4	7	I/O				·(/^				
B14	A12	тск	тск	0	I	Н	Н	0	VDDSHV6 / VDDSHV6	Yes	NA	PU/PD	LVCMOS
B13	B11	TDI	TDI	0	I	Н	Н	0	VDDSHV6 / VDDSHV6	Yes	NA	PU/PD	LVCMOS
A14	A11	TDO	TDO	0	0	Н	Н	0	VDDSHV6 / VDDSHV6	NA	40	PU/PD	LVCMOS
C14	C11	TMS	TMS	0	I	Н	Н	0	VDDSHV6 / VDDSHV6	Yes	NA	PU/PD	LVCMOS
A13	B10	TRSTn	nTRST	0	I	L	L	0	VDDSHV6 / VDDSHV6	Yes	NA	PU/PD	LVCMOS
F17	E16	UART0_TXD	uart0_txd	0	0	Z	Н	7	VDDSHV6 /	Yes	4	PU/PD	LVCMOS
			spi1_cs1	1	I/O				VDDSHV6				
			dcan0_rx	2	ı								
			I2C2_SCL	3	I/OD								
			eCAP1_in_PWM1_out	4	I/O								
			pr1_pru1_pru_r30_15	5	0								
			pr1_pru1_pru_r31_15	6	7								
			gpio1_11	7	I/O								.0
F19	E18	UART0_CTSn	uart0_ctsn	0	I	Z	Н	7	VDDSHV6 /	Yes	4	PU/PD	LVCMOS
			uart4_rxd	1	i O				VDDSHV6				
<b>V</b>			dcan1_tx	2	0	<b>1</b>							
1/1/2			I2C1_SDA	3	I/OD	1///	•						
7.:			spi1_d0	4	I/O		5						
Q	C		timer7	5	I/O		[3]						
ANS	45		pr1_edc_sync0_out	6	0	1	95						
	2		gpio1_8	7	I/O		2						

		I	Table 4-1. Pin Attrib	utes (20	ı∟ aı	IU ZGZ I	ackages	(COIILIII	ueu)		1		1
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
E19	E15	UART0_RXD	uart0_rxd	0	ı	Z	Н	7	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
		7	spi1_cs0	1	I/O		` /	7	VDDSHV6				
	. 4		dcan0_tx	2	0								
			I2C2_SDA	3	I/OD								
			eCAP2_in_PWM2_out	4	I/O								
			pr1_pru1_pru_r30_14	5	0				11-				
		1	pr1_pru1_pru_r31_14	6	I								
		'(//	gpio1_10	7	I/O				. (//				
F18	E17	UART0_RTSn	uart0_rtsn	0	0	Z	Н	7	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
			uart4_txd	1	0				VDDSHV6	ノ、			
			dcan1_rx	2	I								
			I2C1_SCL	3	I/OD						/_		
			spi1_d1	4	I/O						<b>1</b>		
			spi1_cs0	5	I/O						1/		
			pr1_edc_sync1_out	6	0							7	
			gpio1_9	7	I/O						7	1.	
C19	D15	UART1_TXD	uart1_txd	0	0	Z	Н	7	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
			mmc2_sdwp	1	I				VDDSHV6				
			dcan1_rx	2	I								
			I2C1_SCL	3	I/OD								
			pr1_uart0_txd	5	0								
			pr1_pru0_pru_r31_16	6	I								
			gpio0_15	7	I/O								
D18	D16	UART1_RXD	uart1_rxd	0	/_	Z	Н	7	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
			mmc1_sdwp	1					VDDSHV6				
			dcan1_tx	2	o 🔾								
1			I2C1_SDA	3	I/OD	<b>1</b>							
1/1			pr1_uart0_rxd	5	I	1//_							
-			pr1_pru1_pru_r31_16	6	I								
, O	<b>S</b>		gpio0_14	7	I/O	, C							
D19	D17	UART1_RTSn	uart1_rtsn	0	0	Z	H	7	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
	9		timer5	1	I/O		0		VDDSHV6				
		7	dcan0_rx	2	ı	1		1					
		1	I2C2_SCL	3	I/OD	1		11					
		<b>10</b> ,	spi1_cs1	4	I/O	1		10.					
			pr1_uart0_rts_n	5	0	1							
			pr1_edc_latch1_in	6	ı	1			1				
		1/1.	gpio0_13	7	I/O	1			11.				
	1		1	-1	1	1	1				1	-1	1

			Table 4-1. Fill Atti						, ,				
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	VO CELL [13]
E17	D18	UART1_CTSn	uart1_ctsn	0	I	Z	Н	7	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
		7	timer6	1	I/O			1	VDDSHV6				
			dcan0_tx	2	0								
		·~,	I2C2_SDA	3	I/OD			·//					
			spi1_cs0	4	I/O								
			pr1_uart0_cts_n	5	I				1				
		1//	pr1_edc_latch0_in	6	I			,	4,				
		(//	gpio0_12	7	I/O				(/^				
T18	M15	USB0_CE	USB0_CE	0	A	Z	Z	0	VDDA*_USB0 / VDDA*_USB0 (26)	NA	NA	NA	Analog
T19	P15	USB0_VBUS	USB0_VBUS	0	A	Z	Z	0	VDDA*_USB0 / VDDA*_USB0 (26)	NA	NA	NA	Analog
U18	N18	USB0_DM	USB0_DM	0	A	Z	Z	0 (13)	VDDA*_USB0 / VDDA*_USB0 (26)	Yes (16)	8 (16)	NA	Analog
G16	F16	USB0_DRVVBUS	USB0_DRVVBUS	0	0	L	0(PD)	0	VDDSHV6 /	Yes	4	PU/PD	LVCMOS
			gpio0_18	7	I/O				VDDSHV6		**		
V19	P16	USB0_ID	USB0_ID	0	A	Z	Z	0	VDDA*_USB0 / VDDA*_USB0	NA	NA	NA	Analog
U19	N17	USB0_DP	USB0_DP	0	A	Z	Z	0 (13)	VDDA*_USB0 / VDDA*_USB0 (26)	Yes (16)	8 (16)	NA	Analog
NA	P18	USB1_CE	USB1_CE	0	A	Z	Z	0	NA / VDDA*_USB1	NA	NA	NA	Analog
NA	P17	USB1_ID	USB1_ID	0	A	Z	Z	0	NA / VDDA*_USB1	NA	NA	NA	Analog
NA	T18	USB1_VBUS	USB1_VBUS	0	А	2	Z	0	NA / VDDA*_USB1	NA	NA	NA	Analog
NA C	R17	USB1_DP	USB1_DP	0	A	z	3	0 (14)	NA / VDDA*_USB1	Yes (17)	8 (17)	NA	Analog
NA	F15	USB1_DRVVBUS	USB1_DRVVBUS	0	0	L	0(PD)	0	NA / VDDSHV6	Yes	4	PU/PD	LVCMOS
	2		gpio3_13	7	I/O		2						
NA	R18	USB1_DM	USB1_DM	0	A	Z	Z	0 (14)	NA / VDDA*_USB1	Yes (17)	8 (17)	NA	Analog
R17	N16	VDDA1P8V_USB0	VDDA1P8V_USB0	NA	PWR								
NA	R16	VDDA1P8V_USB1	VDDA1P8V_USB1	NA	PWR								
R18	N15	VDDA3P3V_USB0	VDDA3P3V_USB0	NA	PWR				11-				
NA	R15	VDDA3P3V_USB1	VDDA3P3V_USB1	NA	PWR	1	1		<i>U</i> 1,	1	1	1	1



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				<u> </u>			(			B.15	B. II	
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET REL. STATE [6] <sup>(25)</sup>	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]	BUFFER STRENGTH (mA) [11]	PULLUP /DOWN TYPE [12]	I/O CELL [13]
D7	D8	VDDA_ADC	VDDA_ADC	NA	PWR	7						
D12, F16, M16, T6, T14	E6, E14, F9, K13, N6, P9, P14	VDDS	VDDS	NA	PWR		1/20					
R8, R9, R11, R12, R13	P7, P8	VDDSHV1	VDDSHV1	NA	PWR							
NA	P10, P11	VDDSHV2	VDDSHV2	NA	PWR			1				
NA	P12, P13	VDDSHV3	VDDSHV3	NA	PWR			4,				
G15, H14, H15	H14, J14	VDDSHV4	VDDSHV4	NA	PWR			(V)				
M14, M15, N15	K14, L14	VDDSHV5	VDDSHV5	NA	PWR			1	7			
E11, E12, E13, F14, P6, R7	E10, E11, E12, E13, F14, G14, N5, P5, P6	VDDSHV6	VDDSHV6	NA	PWR					(A).		
G5, H5, H6, K4, K5, M5, M6, N5	E5, F5, G5, H5, J5, K5, L5	VDDS_DDR	VDDS_DDR	NA	PWR					'Ta		
U10	R11	VDDS_OSC	VDDS_OSC	NA	PWR					1/	7/	
T8	R10	VDDS_PLL_CORE_LCD	VDDS_PLL_CORE_LCD	NA	PWR							
C5	E7	VDDS_PLL_DDR	VDDS_PLL_DDR	NA	PWR							
H16	H15	VDDS_PLL_MPU	VDDS_PLL_MPU	NA	PWR							
C6	D7	VDDS_RTC	VDDS_RTC	NA	PWR							
C10	E9	VDDS_SRAM_CORE_BG	VDDS_SRAM_CORE_BG	NA	PWR							
C12	D10	VDDS_SRAM_MPU_BB	VDDS_SRAM_MPU_BB	NA 📉	PWR							2
G11, H7, H8, H12, H13, J7, J8, J12, J13, K15, K16, L7, L8, L12, L13, M7, M8, M12,	G7, G10, H11, J12, K6, K8, K12, L6, L7, L8, L9, M11, M13,	VDD_CORE	VDD_CORE	NA	PWR	A						70
NA	F10, F11, F12, F13, G13, H13, J13	VDD_MPU	VDD_MPU (30)	NA	PWR	100						
NA	A2	VDD_MPU_MON	VDD_MPU_MON (31)	NA	A	2						
R5	M5	VPP	VPP	NA	PWR		1					
B9		VREFN	VREFN	0	AP	z z	0	VDDA_ADC		NA		Analog
A9	B9	VREFP	VREFP	0	AP	z z	0	VDDA_ADC / VDDA_ADC	NA	NA	NA	Analog



			Table 4-1. Pili Attribu	(	- u.		do.lagoo,	(00::::::	aou,				
ZCE BALL NUMBER [1]	ZCZ BALL NUMBER [1]	PIN NAME [2]	SIGNAL NAME [3]	MODE [4]	TYPE [5]	BALL RESET STATE [6] <sup>(25)</sup>	BALL RESET REL. STATE [7]	RESET REL. MODE [8]	ZCE POWER / ZCZ POWER [9]	HYS [10]		PULLUP /DOWN TYPE [12]	I/O CELL [13]
F8, F12, F13, G8, G12, H9, H10, H11, J5, J6, J9, J11, J14, J15, K8, K9, K11, K12, L5, L6, L9, L11, L14, L15, M9, M10, M11, N8,	H12, J6, J7,	VSS // // // // // // // // // // // // /	vss	NA	GND			MSC.	Mes		(my page)		
P12, P13, P14, R10, T10, W1, W19		VSSA_ADC	VSSA_ADO	NA	GND				14	9>			
P16	M14, N14	VSSA_ADC VSSA_USB	VSSA_USB	NA	GND								
V11	V11	VSS_OSC	VSS_OSC (28)	NA	A						172		
NA	A5	VSS_RTC	VSS_RTC <sup>(29)</sup>	NA	A						TA		
A16	A10	WARMRSTn	nRESETIN_OUT	0	I/OD (8)	0	0(PU) (11)	0	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
C15	A15	XDMA_EVENT_INTR0	xdma_event_intr0	0	I	Z	(4)	(9)	VDDSHV6 /	Yes	4	PU/PD	LVCMOS
			timer4	2	I/O				VDDSHV6				
			clkout1	3	0								
			spi1_cs1	4	I/O								
			pr1_pru1_pru_r31_16	5	l								
			EMU2	6	I/O								2
			gpio0_19	7	1/0								10
B15	D14	XDMA_EVENT_INTR1	xdma_event_intr1	0	D.	Z	L	7	VDDSHV6 / VDDSHV6	Yes	4	PU/PD	LVCMOS
			tclkin	2	C	7			VDDONVO				
1			clkout2	3	0	1							
1/1			timer7	4	I/O	1/1							
1/-			pr1_pru0_pru_r31_16	5	I	1/							
TO.			EMU3	6	I/O	TU	(S						
	U.	\	gpio0_20	7	I/O	_	UN	_				(2)	
W11	V10	XTALIN	OSC0_IN	0	I	Z	5	0	VDDS_OSC / VDDS_OSC	Yes	NA	PD <sup>(2)</sup>	LVCMOS
W12	U11	XTALOUT	OSC0_OUT	0	0	(24)	(24)		VDDS_OSC / VDDS_OSC	NA	NA <sup>(15)</sup>	NA	LVCMOS

- (1) An internal 10 kohm pullup is turned on when the oscillator is diasabled. The oscillator is disabled by default after power is applied.
- (2) An internal 15 kohm pulldown is turned on when the oscillator is disabled. The oscillator is enabled by default after power is applied.
- (3) Do not connect anything to this terminal.
- (4) If sysboot[5] is low on the rising edge of PWRONRSTn, this terminal has an internal pulldown turned on after reset is released. If sysboot[5] is high on the rising edge or PWRONRSTn, this terminal will initially be driven low after reset is released then it begins to toggle at the same frequency of the XTALIN terminal.
- (5) LCD\_DATA[15:0] terminals are respectively SYSBOOT[15:0] inputs, latched on the rising edge of PWRONRSTn.
- (6) Mode1 and Mode2 signal assignments for this terminal are only available with silicon revision 2.0 or newer devices.
- (7) Mode2 signal assignment for this terminal is only available with silicon revision 2.0 or newer devices.
- (8) Refer to the External Warm Reset section of the AM335x Technical Reference Manual for more information related to the operation of this terminal.
- (9) Reset Release Mode = 7 if sysboot[5] is low. Mode = 3 if sysboot[5] is high.
- (10) Silicon revision 1.0 devices only provide the MMC2\_DAT7 signal when Mode3 is selected. Silicon revision 2.0 and newer devices implement another level of pin multiplexing which provides the original MMC2\_DAT7 signal or RMII2\_CRS\_DV signal when Mode3 is selected. This new level of pin multiplexing is selected with bit zero of the SMA2 register. For more details refer to Section 1.2 of the AM335x Technical Reference Manual.
- (11) The 0(PU) indicates that this terminal is initially low based on the description in the AM335x Technical Reference Manual. However, it is also has a weak internal pullup applied.
- (12) The input voltage thresholds for this input are not a function of VDDSHV6. Please refer to the DC Electrical Characteristics section for details related to electrical parameters associated with this input terminal.
- (13) The internal USB PHY can be configured to multiplex the UART2\_TX or UART2\_RX signals to this terminal. For more details refer to USB GPIO Details section of the AM335x Technical Reference Manual.
- (14) The internal USB PHY can be configured to multiplex the UART3\_TX or UART3\_RX signals to this terminal. For more details refer to USB GPIO Details section of the AM335x Technical Reference Manual.
- (15) This output should only be used to source the recommended crystal circuit.
- (16) This parameter only applies when this USB PHY terminal is operating in UART2 mode.
- (17) This parameter only applies when this USB PHY terminal is operating in UART3 mode.
- (18) This terminal is a analog input used to set the switching threshold of the DDR input buffers to (VDDS DDR / 2).
- (19) This terminal is a analog passive signal that connects to an external 49.9 ohm 1%, 20mW reference resistor which is used to calibrate the DDR input/output buffers.
- (20) This terminal is analog input that may also be configured as an open-drain output.
- (21) This terminal is analog input that may also be configured as an open-source or open-drain output.
- (22) This terminal is analog input that may also be configured as an open-source output.
- (23) This terminal is high-Z when the oscillator is disabled. This terminal is driven high if RTC\_XTALIN is less than VIL, driven low if RTC\_XTALIN is greater than VIH, and driven to a unknown value if RTC\_XTALIN is between VIL and VIH when the oscillator is enabled. The oscillator is disabled by default after power is applied.
- (24) This terminal is high-Z when the oscillator is disabled. This terminal is driven high if XTALIN is less than VIL, driven low if XTALIN is greater than VIH, and driven to a unknown value if XTALIN is between VIL and VIH when the oscillator is enabled. The oscillator is enabled by default after power is applied.
- (25) For all pins with content in the Ball Reset State column of this table, the terminal is not defined until all the supplies are ramped.
- (26) This terminal requires two power supplies, VDDA3p3v\_USB0 and VDDA1p8v\_USB0. The "\*" character in the power supply name is a wild card that represents "3p3v" and "1p8v".
- (27) This terminal requires two power supplies, VDDA3p3v USB1 and VDDA1p8v USB1. The "\*" character in the power supply name is a wild card that represents "3p3v" and "1p8v".
- (28) Refer to Section 6.2.2 for additional details about VSS OSC.
- (29) Refer to Section 6.2.2 for additional details about VSS RTC.
- (30) This power rail is connected to VDD\_CORE in the ZCE package.
- (31) This terminal provides a Kelvin connection to VDD\_MPU. It can be connected to the power supply feedback input to provide remote sensing which compensates for voltage drop in the

né connected to th. PCB power distribution network and package. When the Kelvin connection is not used it should be connected to the same power source as VDD\_MPU.

PROMINGOS MARIANTE MARIANTE PAR FURT Terminal Configuration and Functions

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### 4.3 Signal Descriptions

The AM335x device contains many peripheral interfaces. In order to reduce package size and lower overall system cost while maintaining maximum functionality, many of the AM335x terminals can multiplex up to eight signal functions. Although there are many combinations of pin multiplexing that are possible, only a certain number of sets, called IO Sets, are valid due to timing limitations. These valid IO Sets were carefully chosen to provide many possible application scenarios for the user.

Texas Instruments has developed a Windows-based application called Pin Mux Utility that helps a system designer select the appropriate pin-multiplexing configuration for their AM335x-based product design. The Pin Mux Utility provides a way to select valid IO Sets of specific peripheral interfaces to ensure the pin-multiplexing configuration selected for a design only uses valid IO Sets supported by the AM335x device.

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SPRS717I – OCTOBER 2011 – REVISED DECEMBER 2015  (1) SIGNAL NAME: The signal name (2) DESCRIPTION: Description of the signal (3) TYPE: Ball type for this specific function:  - I = Input - O = Output - I/O = Input/Output - D = Open drain - DS = Differential - A = Analog  (4) BALL: Package ball location  ADC Signals Description	AM3359, AM3358, AM3357, AM	13356, AM3354, AM3352, AM3351		•	INSTRUMENTS		
(1) SIGNAL NAME: The signal name (2) DESCRIPTION: Description of the signal (3) TYPE: Ball type for this specific function:  - I = Input - O = Output - I/O = Input/Output - D = Open drain - DS = Differential - A = Analog (4) BALL: Package ball location  ADC Signals Description	SPRS717I – OCTOBER 2011 – REVISED DEC	EMBER 2015			www.ti.com		
(1) SIGNAL NAME: The signal name (2) DESCRIPTION: Description of the signal (3) TYPE: Ball type for this specific function:  - I = Input - O = Output - I/O = Input/Output - D = Open drain - DS = Differential - A = Analog (4) BALL: Package ball location  ADC Signals Description	7,2	12					
(2) DESCRIPTION: Description of the signal  (3) TYPE: Ball type for this specific function:  - I = Input - O = Output - I/O = Input/Output - D = Open drain - DS = Differential - A = Analog  (4) BALL: Package ball location  ADC Signals Description	(1) SIGNAL NAME: The signal name						
(3) TYPE: Ball type for this specific function:  - I = Input - O = Output - I/O = Input/Output - D = Open drain - DS = Differential - A = Analog  (4) BALL: Package ball location  ADC Signals Description	(2) <b>DESCRIPTION</b> : Description of the signal						
- I = Input - O = Output - I/O = Input/Output - I/O = Input/Output - D = Open drain - DS = Differential - A = Analog  (4) BALL: Package ball location  ADC Signals Description	(3) TYPE: Ball type for this specific fun	ction:	1				
- O = Output - I/O = Input/Output - D = Open drain - DS = Differential - A = Analog  (4) BALL: Package ball location  ADC Signals Description			10,				
- I/O = Input/Output - D = Open drain - DS = Differential - A = Analog  (4) BALL: Package ball location  ADC Signals Description							
- DS = Differential - A = Analog  (4) BALL: Package ball location  ADC Signals Description				4,			
- A = Analog  (4) BALL: Package ball location  ADC Signals Description	<ul><li>DS = Differential</li></ul>			'O <sub>A</sub>			
(4) BALL: Package ball location  ADC Signals Description				7			
ADC Signals Description	(4) BALL: Package ball location			7			
7.20 digitale 2000 lipitel.		ADC Signals Description			<b>S</b>		
TYPE TOT DALL OF THE TOT DALL OF		<b>F</b>			<del>_</del>		
SIGNAL NAME [1] DESCRIPTION [2] TYPE [3] ZCE BALL [4] ZCZ BALL [4]	SIGNAL NAME [1]	DESCRIPTION [2]		ZCE BALL [4]	ZCZ BALL [4]		
AINO Analog Input/Output A B8 B6	AIN0	Analog Input/Output	Α	B8	B6		
AIN1 Analog Input/Output A A11 C7	AIN1	Analog Input/Output	Α	A11	C7		
AIN2 Analog Input/Output A A8 B7	AIN2	Analog Input/Output	Α	A8	B7		
AIN3 Analog Input/Output A B11 A7	AIN3	Analog Input/Output	Α	B11	A7		
AIN4 Analog Input/Output A C8 C8	AIN4	Analog Input/Output	Α	C8	C8		
AIN5 Analog Input A B12 B8	AIN5	Analog Input	Α	B12	B8		
AIN6 Analog Input A A10 A8	AIN6	Analog Input	Α	A10	A8		
AIN7 Analog Input A A12 C9	AIN7	Analog Input	Α	A12	C9		
VREFN     Analog Negative Reference Input     AP     B9     A9	VREFN	Analog Negative Reference Input	AP	B9	A9		
VREFP Analog Positive Reference Input AP A9 B9	VREFP	Analog Positive Reference Input	AP	A9	B9		

**Debug Subsystem Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
EMU0	MISC EMULATION PIN	1/0	A15	C14
EMU1	MISC EMULATION PIN	I/O	D14	B14
EMU2	MISC EMULATION PIN	I/O	A18, C15	A15, A17, C13
EMU3	MISC EMULATION PIN	I/O	B15, B18	B17, D13, D14
EMU4	MISC EMULATION PIN	I/O	B16, U17	A14, C15, T13
nTRST	JTAG TEST RESET (ACTIVE LOW)	I	A13	B10
TCK	JTAG TEST CLOCK	I	B14	A12
TDI	JTAG TEST DATA INPUT	I	B13	B1Y
TDO	JTAG TEST DATA OUTPUT	0	A14	A11
TMS	JTAG TEST MODE SELECT	I	C14	C11

**LCD Controller Signals Description** 

200 Controllor Cignate Decemption					
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
lcd_ac_bias_en	LCD AC bias enable chip select	0	W7	R6	
lcd_data0	LCD data bus	I/O	U1	R1	
Jcd_data1	LCD data bus	I/O	U2	R2	
lcd_data10	LCD data bus	I/O	U5	U3	
lcd_data11	LCD data bus	I/O	V5	U4	
lcd_data12	LCD data bus	I/O	V6	V2	
lcd_data13	LCD data bus	1/0	U6	V3	
lcd_data14	LCD data bus	I/O	W6	V4	
lcd_data15	LCD data bus	1/0	V7	T5	
lcd_data16	LCD data bus	0	V17	U13	
Icd_data17	LCD data bus	0	W17	V13	

Terminal Configuration and Functions

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### LCD Controller Signals Description (continued)

Col. data   Col.		0.3	. 0 -			
Icd_data18         LCD data bus         O         T13         R12           Icd_data19         LCD data bus         O         U13         T12           Icd_data2         LCD data bus         I/O         V/I         R3           Icd_data20         LCD data bus         O         U12         U12           Icd_data21         LCD data bus         O         T12         T11           Icd_data22         LCD data bus         O         W16         T10           Icd_data23         ICD data bus         I/O         V2         R4           Icd_data3         ICD data bus         I/O         V2         R4           Icd_data4         LCD data bus         I/O         W3         T2           Icd_data5         LCD data bus         I/O         V3         T3           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		SIGNAL NAME [1]	DESCRIPTION [2]	[3]	ZCE BALL [4]	ZCZ BALL [4]
Icd_data2         LCD data bus         I/O         V1         R3           Icd_data20         LCD data bus         O         U12         U12           Icd_data21         LCD data bus         O         T12         T11           Icd_data22         LCD data bus         O         W16         T10           Icd_data23         LCD data bus         O         V15         U10           Icd_data3         LCD data bus         I/O         V2         R4           Icd_data4         LCD data bus         I/O         W2         T1           Icd_data5         LCD data bus         I/O         W3         T2           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data18	LCD data bus	0/0	T13	R12
Icd_data20         LCD data bus         O         U12         U12           Icd_data21         LCD data bus         O         T12         T11           Icd_data22         LCD data bus         O         W16         T10           Icd_data23         LCD data bus         O         V15         U10           Icd_data3         LCD data bus         I/O         V2         R4           Icd_data4         LCD data bus         I/O         W2         T1           Icd_data5         LCD data bus         I/O         W3         T2           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data19	LCD data bus	0	U13	T12
Icd_data21         LCD data bus         O         T12         T11           Icd_data22         LCD data bus         O         W16         T10           Icd_data23         LCD data bus         O         V15         U10           Icd_data3         LCD data bus         I/O         V2         R4           Icd_data4         LCD data bus         I/O         W2         T1           Icd_data5         LCD data bus         I/O         W3         T2           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         U3         T4           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data2	LCD data bus	I/O	VI	R3
Icd_data22         LCD data bus         O         W16         T10           Icd_data23         LCD data bus         O         V15         U10           Icd_data3         LCD data bus         I/O         V2         R4           Icd_data4         LCD data bus         I/O         W2         T1           Icd_data5         LCD data bus         I/O         W3         T2           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         U3         T4           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data20	LCD data bus	0	U12	U12
Icd_data23         LCD data bus         O         V15         U10           Icd_data3         LCD data bus         I/O         V2         R4           Icd_data4         LCD data bus         I/O         W2         T1           Icd_data5         LCD data bus         I/O         W3         T2           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         U3         T4           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data21	LCD data bus	0	T12	T11
Icd_data3         LCD data bus         I/O         V2         R4           Icd_data4         LCD data bus         I/O         W2         T1           Icd_data5         LCD data bus         I/O         W3         T2           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         U3         T4           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data22	LCD data bus	0	W16	T10
Icd_data4         LCD data bus         I/O         W2         T1           Icd_data5         LCD data bus         I/O         W3         T2           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         U3         T4           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data23	LCD data bus	0	V15	U10
Icd_data5         LCD data bus         I/O         W3         T2           Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         U3         T4           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data3	LCD data bus	I/O	V2	R4
Icd_data6         LCD data bus         I/O         V3         T3           Icd_data7         LCD data bus         I/O         U3         T4           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data4	LCD data bus	I/O	W2	T1//
Icd_data7         LCD data bus         I/O         U3         T4           Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data5	LCD data bus	I/O	W3	T2
Icd_data8         LCD data bus         I/O         V4         U1           Icd_data9         LCD data bus         I/O         W4         U2		lcd_data6	LCD data bus	I/O	V3	T3
lcd_data9 LCD data bus I/O W4 U2		lcd_data7	LCD data bus	I/O	U3	T4
Icd_data9		lcd_data8	LCD data bus	I/O	V4	U1
Icd_hsync		lcd_data9	LCD data bus	I/O	W4	U2
Icd_memory_clk	502	lcd_hsync	LCD Horizontal Sync	0	T7	R5
led_pclk	772	lcd_memory_clk	LCD MCLK	0	L19, V16	J17, V12
Cod vsync LCD Vertical Sync O U7 U5		lcd_pclk	LCD pixel clock	0	W5	V5
MATIREM WATER AND MIRATIREM	4	lcd_vsync	LCD Vertical Sync	0	U7	U5
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Terminal Configuration and Functions

## **External Memory Interfaces**

External Memory Interfaces/DDR Signals Description					
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
ddr_a0	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	F3//	F3	
ddr_a1	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	J2	H1	
ddr_a10	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	E2	F4	
ddr_a11	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	G4	£2	
ddr_a12	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	F4	E3//	
ddr_a13	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	H1	Н3	
ddr_a14	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	H3	H4	
ddr_a15	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	E3	D3	
ddr_a2	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	D1	E4	
ddr_a3	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	B3	C3	
ddr_a4	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	E5	C2	
ddr_a5	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	2/2	A2	B1	
ddr_a6	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	B1	D5	
ddr_a7	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	D2/	E2	
ddr_a8	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	C3 77	D4	
ddr_a9	DDR SDRAM ROW/COLUMN ADDRESS OUTPUT	0	B2 //	C1	
ddr_ba0	DDR SDRAM BANK ADDRESS OUTPUT	0	A3	C4	
ddr_ba1	DDR SDRAM BANK ADDRESS OUTPUT	0	E1	E1/	
ddr_ba2	DDR SDRAM BANK ADDRESS OUTPUT	0	B4	B3	
ddr_casn	DDR SDRAM COLUMN ADDRESS STROBE OUTPUT (ACTIVE LOW)	0	F1	F1	
ddr_ck	DDR SDRAM CLOCK OUTPUT (Differential+)	0	C2	D2	
ddr_cke	DDR SDRAM CLOCK ENABLE OUTPUT	0	G3	G3	
ddr_csn0	DDR SDRAM CHIP SELECT OUTPUT	0	H2	H2	
ddr_d0	DDR SDRAM DATA INPUT/OUTPUT	I/O	N4	M3	
ddr_d1	DDR SDRAM DATA INPUT/OUTPUT	I/O	P4	M4	
ddr_d10	DDR SDRAM DATA INPUT/OUTPUT/	I/O	M3	K2	
ddr_d11	DDR SDRAM DATA INPUT/OUTPUT	I/O	M4	K3	
ddr_d12	DDR SDRAM DATA INPUT/OUTPUT	I/O	M2	K4	
ddr_d13	DDR SDRAM DATA INPUT/OUTPUT	1/0	M1	L3	
ddr_d14	DDR SDRAM DATA INPUT/OUTPUT	VO	N2	L4	
ddr_d15	DDR SDRAM DATA INPUT/OUTPUT	1/0	N1	M1	
ddr_d2	DDR SDRAM DATA INPUT/OUTPUT	1/0	P/2	N1	
ddr_d3	DDR SDRAM DATA INPUT/OUTPUT	I/O	P3/	N2	
ddr_d4	DDR SDRAM DATA INPUT/OUTPUT	I/O	P3	N3	
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External Memory Interfaces/DDR Signals Description (continued)

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
ddr_d5	DDR SDRAM DATA INPUT/OUTPUT	I/O	T1	N4
ddr_d6	DDR SDRAM DATA INPUT/OUTPUT	1/0	Τ2	P3
ddr_d7	DDR SDRAM DATA INPUT/OUTPUT	I/O	R3	P4
ddr_d8	DDR SDRAM DATA INPUT/OUTPUT	I/O	K2	J1
ddr_d9	DDR SDRAM DATA INPUT/OUTPUT	I/O	K1 🗸	K1
ddr_dqm0	DDR WRITE ENABLE / DATA MASK FOR DATA[7:0]	0	N3	M2
ddr_dqm1	DDR WRITE ENABLE / DATA MASK FOR DATA[15:8]	0	К3	12
ddr_dqs0	DDR DATA STROBE FOR DATA[7:0] (Differential+)	I/O	R1	P1
ddr_dqs1	DDR DATA STROBE FOR DATA[15:8] (Differential+)	I/O	L1	L1
ddr_dqsn0	DDR DATA STROBE FOR DATA[7:0] (Differential-)	I/O	R2	P2
ddr_dqsn1	DDR DATA STROBE FOR DATA[15:8] (Differential-)	I/O	L2	L2
ddr_nck	DDR SDRAM CLOCK OUTPUT (Differential-)	0	C1	D1
ddr_odt	ODT OUTPUT	0	G1	G1
ddr_rasn	DDR SDRAM ROW ADDRESS STROBE OUTPUT (ACTIVE LOW)	0	F2	G4
ddr_resetn	DDR3/DDR3L RESET OUTPUT (ACTIVE LOW)	0	G2	G2
ddr_vref	Voltage Reference Input	A	H4	J4
ddr_vtp	VTP Compensation Resistor	1//	J1	J3
ddr_wen	DDR SDRAM WRITE ENABLE OUTPUT (ACTIVE LOW)	0	A4	B2

External Memory Interfaces/General-Purpose Memory Controller Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
gpmc_a0	GPMC Address	0	U1 /	R1, R13
gpmc_a1	GPMC Address	0	U2, U7	R2, U5, V14
gpmc_a10	GPMC Address	0	W5	T16, V5
gpmc_a11	GPMC Address	0	W7	R6, V17
gpmc_a12	GPMC Address	0	V4	U1
gpmc_a13	GPMC Address	0	W4	U2
gpmc_a14	GPMC Address	0	U5	U3
gpmc_a15	GPMC Address	0	V5	U4
gpmc_a16	GPMC Address	0	V6	R13, V2
gpmc_a17	GPMC Address	0	U6	V14, V3
gpmc_a18	GPMC Address	0	W6	U14, V4
gpmc_a19	GPMC Address	0	V7	T14, T5
gpmc_a2	GPMC Address	0	T7, V1	R3, R5, U14
gpmc_a20	GPMC Address	0	H19	F17, R14
gpmc_a21	GPMC Address	0	H18	F18, V15
gpmc_a22	GPMC Address	0	H17	G15, U15
gpmc_a23	GPMC Address	0	G18	G16, T15
gpmc_a24	GPMC Address	0	G19	G17, V16
gpmc_a25	GPMC Address	0	G17/	G18, U16
gpmc_a26	GPMC Address	0	NA	T16



### External Memory Interfaces/General-Purpose Memory Controller Signals Description (continued)

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
gpmc_a27	GPMC Address	0/0	NA	V17	
gpmc_a3	GPMC Address	0	U17, V2	R4, T13, T14	
gpmc_a4	GPMC Address	0	W2	R14, T1	
gpmc_a5	GPMC Address	0	W3	T2, V15	
gpmc_a6	GPMC Address	0	V3 🗸	T3, U15	
gpmc_a7	GPMC Address	0	U3	T15, T4	
gpmc_a8	GPMC Address	0	U7	U5, V16	
gpmc_a9	GPMC Address	0	T7	R5, U16	
gpmc_ad0	GPMC Address and Data	I/O	W10	U7/	
gpmc_ad1	GPMC Address and Data	I/O	V9	V7	
gpmc_ad10	GPMC Address and Data	I/O	T12	T11	
gpmc_ad11	GPMC Address and Data	I/O	U12	U12	
gpmc_ad12	GPMC Address and Data	I/O	U13	T12	
gpmc_ad13	GPMC Address and Data	I/O	T13	R12	
gpmc_ad14	GPMC Address and Data	I/O	W17	V13	
gpmc_ad15	GPMC Address and Data	I/O	V17	U13	
gpmc_ad2	GPMC Address and Data	I/O	V12	R8	
gpmc_ad3	GPMC Address and Data	I/O	W13	T8	
gpmc_ad4	GPMC Address and Data	I/O	V13	U8	
gpmc_ad5	GPMC Address and Data	I/O	W14	V8	
gpmc_ad6	GPMC Address and Data	1/0	U14	R9	
gpmc_ad7	GPMC Address and Data	1/0	W15	T9	
gpmc_ad8	GPMC Address and Data	1/0	V15	U10	
gpmc_ad9	GPMC Address and Data	1/0	W16	T10	
gpmc_advn_ale	GPMC Address Valid / Address Latch Enable	0	V10	R7	
gpmc_be0n_cle	GPMC Byte Enable 0 / Command Latch Enable	0	V8	T6	
gpmc_be1n	GPMC Byte Enable 1	0	U15, V18	U18, V9	
gpmc_clk	GPMC Clock	I/O	V14, V16	U9, V12	
gpmc_csn0	GPMC Chip Select	0	W8	V6.	
gpmc_csn1	GPMC Chip Select	0	V14	U9/ A	
gpmc_csn2	GPMC Chip Select	0	U15	V9	
gpmc_csn3	GPMC Chip Select	0	U17	T13	
gpmc_csn4	GPMC Chip Select	0	R15	T17	
gpmc_csn5	GPMC Chip Select	0	W18	U17	
01 –	GPMC Chip Select	0	V18	U18	
gpmc_csn6 gpmc_dir	GPMC Data Direction	0	V18	U18	
gpmc_oen_ren	GPMC Output / Read Enable	0	W9	T7	
0. – –	GPMC Wait 0	ı		T17	
gpmc_wait0 gpmc_wait1	GPMC Wait 0	ı	R15 V16	V12	
	* 10 -				
gpmc_wen gpmc_wpn	GPMC Write Enable  GPMC Write Protect	0	U8 W18	U6 U17	
gpmc_wpn   GPMC Write Protect   O   W18   U17    Terminal Configuration and Functions   Copyright © 2011–2015, Texas Instruments Incorporated					
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# General-Purpose IOs

General-Purpose IOs/GPIO0 Signals Description

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SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
gpio0_0	GPIO	I/O	P17	M17
gpio0_1	GPIO	I/O	R19	M18
gpio0_10	GPIO	I/O	W6	V4
gpio0_11	GPIO	I/O	V7	T5
gpio0_12	GPIO	I/O	E17	D18
gpio0_13	GPIO	I/O	D19	Ď17
gpio0_14	GPIO	I/O	D18	D16
gpio0_15	GPIO	I/O	C19	D15
gpio0_16	GPIO	I/O	M17	J18
gpio0_17	GPIO	I/O	N18	K15
gpio0_18	GPIO	I/O	G16	F16
gpio0_19	GPIO	I/O	C15	A15
gpio0_2	GPIO ~	I/O	A18	A17
gpio0_20	GPIO 2	I/O	B15	D14
gpio0_21	GPIO	I/O	M18	K16
gpio0_22	GPIO	I/O	V15	U10
gpio0_23	GPIO 73	I/O	W16	T10
gpio0_26	GPIO	I/O	T12	T11
gpio0_27	GPIO	I/O	U12	U12
gpio0_28	GPIO	1/0	L18	K17
gpio0_29	GPIO	1/0	K18	H18
gpio0_3	GPIO	1/0	B18	B17
gpio0_30	GPIO	I/O	R15	T17
gpio0_31	GPIO	I/O	W18	U17
gpio0_4	GPIO	I/O	B17	B16
gpio0_5	GPIO	I/O	A17	A16
gpio0_6	GPIO	I/O	B16	C15
gpio0_7	GPIO	I/O	E18	C18,
gpio0_8	GPIO	I/O	V6	V2
gpio0_9	GPIO P	I/O	U6	V3

General-Purpose IOs/GPIO1 Signals Description

General-Fulpose 103/0F101 Signals Description						
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]		
gpio1_0	GPIO	I/O	W10	U7		
gpio1_1	GPIO	I/O	V9	V7		
gpio1_10	GPIO	I/O	E19	E15		
gpio1_11	GPIO	I/O	F17	E16		
gpio1_12	GPIO	I/O	U13	T12		
gpio1_13	GPIO	I/O	T13	R12		
gpio1_14	GPIO	1/0	W17	V13		
gpio1_15	GPIO	VO	V17	U13		
gpio1_16	GPIO	I/O	NA	R13		
gpio1_17	GPIO	1/0	NA	V14		
gpio1_18	GPIO	I/O	NA	U14		
gpio1_19	GPIO	I/O	NA	T14		



### General-Purpose IOs/GPIO1 Signals Description (continued)

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	SIGNAL NAME [1]	I-Purpose IOs/GPIO1 Signals Descripti  DESCRIPTION [2]	TYPE	ZCE BALL [4]	ZCZ BALL [4]
	gpio1_2	GPIO	1/0	V12	R8
	gpio1_20	GPIO	1/0	NA	R14
	gpio1_21	GPIO	I/O	NA	V15
	gpio1_22	GPIO	I/O	NA	U15
	gpio1_23	GPIO	I/O	NA 🦪	T15
	gpio1_24	GPIO	I/O	NA	V16
	gpio1_25	GPIO	I/O	NA	U16
	gpio1_26	GPIO	I/O	NA	T16,
	gpio1_27	GPIO	I/O	NA	V17
	gpio1_28	GPIO	I/O	V18	U18
	gpio1_29	GPIO	I/O	W8	V6
	gpio1_3	GPIO	I/O	W13	T8
	gpio1_30	GPIO	I/O	V14	U9
2	gpio1_31	GPIO	I/O	U15	V9
500	gpio1_4	GPIO	I/O	V13	U8
7,2	gpio1_5	GPIO 7,2	I/O	W14	V8
	gpio1_6	GPIO	I/O	U14	R9
1,	gpio1_7	GPIO 1/1-	I/O	W15	T9
	gpio1_8	GPIO	I/O	F19	E18
	gpio1_9	GPIO	I/O	F18	E17

General-Purpose IOs/GPIO2 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
gpio2_0	GPIO	I/O	U17	T13
gpio2_1	GPIO	I/O	V16	V12
gpio2_10	GPIO	I/O	W2 🗸	T1
gpio2_11	GPIO	I/O	W3	T2
gpio2_12	GPIO	I/O	V3	<b>T</b> 3
gpio2_13	GPIO	I/O	U3	<b>T</b> 4
gpio2_14	GPIO	I/O	V4	U1
gpio2_15	GPIO	I/O	W4	U2
gpio2_16	GPIO	I/O	U5	U3
gpio2_17	GPIO	I/O	V5	U4
gpio2_18	GPIO	I/O	N17	L17
gpio2_19	GPIO	I/O	N16	L16
gpio2_2	GPIO O	I/O	V10	R7
gpio2_20	GPIO	I/O	P19	L15
gpio2_21	GPIO	I/O	P18	M16
gpio2_22	GPIO "J	I/O	U7	U5
gpio2_23	GPIO	I/O	T7	R5
gpio2_24	GPIO	I/O	W5	V5
gpio2_25	GPIO	NO.	W7	R6
gpio2_26	GPIO	I/O	H19	F17
gpio2_27	GPIO	1/0	H18	F18
gpio2_28	GPIO	I/O	H17	G15
gpio2_29	GPIO	I/O	G18	G16





### General-Purpose IOs/GPIO2 Signals Description (continued)

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
gpio2_3	GPIO	1/0	W9	T7
gpio2_30	GPIO	1/0	G19	G17
gpio2_31	GPIO	I/O	G17	G18
gpio2_4	GPIO	I/O	U8	U6
gpio2_5	GPIO	I/O	V8 🗸	T6
gpio2_6	GPIO	I/O	U1	R1
gpio2_7	GPIO	I/O	U2	R2
gpio2_8	GPIO	I/O	V1	R3
gpio2_9	GPIO	I/O	V2	R4

General-Purpose IOs/GPIO3 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
gpio3_0	GPIO	I/O	J19	H16
gpio3_1	GPIO	I/O	J18	H17
gpio3_10	GPIO	I/O	M19	L18
gpio3_13	GPIO	I/O	NA	F15
gpio3_14	GPIO	I/O	NA	A13
gpio3_15	GPIO	I/O	NA	B13
gpio3_16	GPIO	I/O	NA	D12
gpio3_17	GPIO	I/O	NA	C12
gpio3_18	GPIO	VO	NA	B12
gpio3_19	GPIO	I/O	NA	C13
gpio3_2	GPIO	1/0	K19	J15
gpio3_20	GPIO	I/O	NA	D13
gpio3_21	GPIO	I/O	NA	A14
gpio3_3	GPIO	I/O	K17	J16
gpio3_4	GPIO	I/O	L19	J17
gpio3_5	GPIO	I/O	C18	C17
gpio3_6	GPIO	I/O	B19	C16
gpio3_7	GPIO	I/O	A15	C14
gpio3_8	GPIO	I/O	D14	B14
gpio3_9	GPIO	I/O	N19	K18

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# Miscellaneous

Miscellaneous/Miscellaneous Signals Description

<i>1</i> //	DESCRIPTION 191	TYPE		707 DALL 541
SIGNAL NAME [1]	DESCRIPTION [2]	[3]	ZCE BALL [4]	ZCZ BALL [4]
clkout1	Clock out1	0	<b>0</b> 15	A15
clkout2	Clock out2	0	B15	D14
ENZ_KALDO_1P8V	Active low enable input for internal CAP_VDD_RTC voltage regulator	I	A7 7	B4
EXT_WAKEUP	EXT_WAKEUP input	I	B5	C5
nNMI	External Interrupt to ARM Cortex-A8 core	I	C17	B18
nRESETIN_OUT	Active low Warm Reset	I/OD	A16	A10
OSC0_IN	High frequency oscillator input	I	W11	V10
OSC0_OUT	High frequency oscillator output	0	W12	U11
OSC1_IN	Low frequency (32.768 kHz) Real Time Clock oscillator input	I	A6	A6
OSC1_OUT	Low frequency (32.768 kHz) Real Time Clock oscillator output	0	A5	A4
PMIC_POWER_EN	PMIC_POWER_EN output	0	C7	C6
porz	Active low Power on Reset	I	E15	B15
RTC_PORz	Active low RTC reset input	I	B7	B5
telkin	Timer Clock In	I	B15	D14
xdma_event_intr0	External DMA Event or Interrupt 0	I	C15	A15
xdma_event_intr1	External DMA Event or Interrupt 1	I	B15	D14
xdma_event_intr2	External DMA Event or Interrupt 2	l,	B16, E18, K18	C15, C18, H18
xdma_event_intr2	TAN .		B16, E18, K18	TAN .

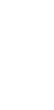
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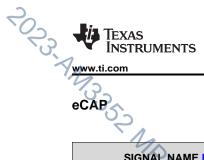
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eCAP/eCAP0 Signals Description

7/A				
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
eCAP0_in_PWM0_out	Enhanced Capture 0 input or Auxiliary PWM0 output	I/O	E18	C18

eCAP/eCAP1 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4] ZCZ BALL [4]
eCAP1_in_PWM1_out	Enhanced Capture 1 input or Auxiliary PWM1 output	I/O	B16, B19, F17 C15, C16, E16

eCAP/eCAP2 Signals Description

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DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
Enhanced Capture 2 input or Auxiliary PWM2 output	I/O	C18, E19	C12, C17, E15
output			
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7,5			
73			
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	10,		
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THE		,	Ty
	DESCRIPTION [2]  Enhanced Capture 2 input or Auxiliary PWM2 output	DESCRIPTION [2] [3]	DESCRIPTION [2] TYPE [3] ZCE BALL [4]

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**eHRPWM** 

eHRPWM/eHRPWM0 Signals Description

Critic Willy Critic William Description				
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
ehrpwm0A	eHRPWM0 A output.	0	A18	A13, A17
ehrpwm0B	eHRPWM0 B output.	0	B18	B13, B17
ehrpwm0_synci	Sync input to eHRPWM0 module from an external pin	1	A17	A16, C12
ehrpwm0_synco	Sync Output from eHRPWM0 module to an external pin	0	U12, V2, W4	R4, U12, U2, V14
ehrpwm0_tripzone_input	eHRPWM0 trip zone input	I	B17	B16, D12

eHRPWM/eHRPWM1 Signals Description

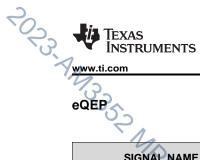
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
ehrpwm1A	eHRPWM1 A output.	0	U5	U14, U3
ehrpwm1B	eHRPWM1 B output.	0	V5	T14, U4
ehrpwm1_tripzone_input	eHRPWM1 trip zone input	I	V4	R13, U1

eHRPWM/eHRPWM2 Signals Description

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SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
ehrpwm2A	eHRPWM2 A output.	0	U1, V15	R1, U10	
ehrpwm2B	eHRPWM2 B output.	0	U2, W16	R2, T10	
ehrpwm2_tripzone_input	eHRPWM2 trip zone input	N	T12, V1	R3, T11	
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eQEP/eQEP0 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
eQEP0A_in	eQEP0A quadrature input	ı	M18	B12, K16	
eQEP0B_in	eQEP0B quadrature input	I	L18	C13, K17	
eQEP0_index	eQEP0 index.	I/O	K17	D13, J16	
eQEP0_strobe	eQEP0 strobe.	I/O	P19	A14, L15	

eQEP/eQEP1 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
eQEP1A_in	eQEP1A quadrature input	I	V6	R14, V2
eQEP1B_in	eQEP1B quadrature input	I	U6	V15, V3
eQEP1_index	eQEP1 index.	I/O	W6	U15, V4
eQEP1_strobe	eQEP1 strobe.	I/O	V7	T15, T5

eQEP/eQEP2 Signals Description

	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
Y,	eQEP2A_in	eQEP2A quadrature input	I	U13, W2	T1, T12
Ť	eQEP2B_in	eQEP2B quadrature input	I	T13, W3	R12, T2
	eQEP2_index	eQEP2 index.	I/O	V3, W17	T3, V13
	eQEP2_strobe	eQEP2 strobe.	I/O	U3, V17	T4, U13
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Terminal Configuration and Functions



Timer/Timer4 Signals Description

// 4		7/ /		
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
timer4	Timer trigger event / PWM out	I/O	©15, C18, K17, V10	A15, C17, J16, R7

**Timer/Timer5 Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4] ZCZ BALL [4]
timer5	Timer trigger event / PWM out	I/O	D19, H19, R19, D47, F17, M18, V8

Timer/Timer6 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
timer6	Timer trigger event / PWM out	I/O	E17, H18, P17, U8	D18, F18, M17, U6

SIGNAL NAME [1]	DESCRIPTION [2]	[3]	ZCE BALL [4]	ZCZ BALL [4]
timer6	Timer trigger event / PWM out	I/O	E17, H18, P17, U8	D18, F18, M17, U6
	Timer/Timer7 Signals Descripti	ion		
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
/timer7	Timer trigger event / PWM out	I/O	B15, B19, F19, W9	C16, D14, E18, T7
35	3	5		
Mp,		1/0,		
1,			1,	
P			P	
7			7	
	4		1	T_
	7			V
	timer6  SIGNAL NAME [1]  timer7	Timer trigger event / PWM out  Timer/Timer7 Signals Descript  SIGNAL NAME [1]  DESCRIPTION [2]  timer7  Timer trigger event / PWM out	timer6  Timer trigger event / PWM out  I/O  Timer/Timer7 Signals Description  SIGNAL NAME [1]  DESCRIPTION [2]  TYPE [3]  timer7  Timer trigger event / PWM out  I/O	timer6  Timer trigger event / PWM out  I/O  E17, H18, P17, U8  Timer/Timer7 Signals Description  SIGNAL NAME [1]  DESCRIPTION [2]  TYPE [3]  ZCE BALL [4]  timer7  Timer trigger event / PWM out  I/O  B15, B19, F19, W9

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# PRU-ICSS

PRU-ICSS/eCAP Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
pr1_ecap0_ecap_capin_apwm_o	Enhanced capture input or Auxiliary PWM out	I/O	£18, V17	C18, U13

**PRU-ICSS/ECAT Signals Description** 

FINO-1033/LCAT Signals Descripti	<u> </u>		1
DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
Data In	I	E17	D18
Data In	1	D19	D17
Data Out	0	F19	E18/
Data Out	0	F18	E17
Data In	I	B17	B16
Data In	I	A17	A16
Data In	1	U7	U5
Data In	1	T7	R5
Data In	I	W5	V5
Data In	I	W7	R6
Data In	I	V14, V3	T3, U9
Data In	I	U15, U3	T4, V9
Data Out	0	B17	B16
Data Out	0	A17	A16
Data Out	9	U7	U5
Data Out	0/0	T7	R5
Data Out	0	W5	V5
Data Out	0	W7	R6
Data Out	0	V14, V3	T3, U9
Data Out	0	U15, U3	T4, V9
Latch In	I	B18	B17
Start of Frame	0	A18	A17
	Description [2]  Data In  Data In  Data Out  Data Out  Data In  Data Out  Data Out	Description   2     Type   3   3	DESCRIPTION [2]   TYPE [3]   ZCE BALL [4]     Data In

pri_edio_sor			Alo	AII	
PRU-ICSS/MDIO Signals Description					
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
pr1_mdio_data	MDIO Data	I/O	U17	T13	
pr1_mdio_mdclk	MDIO CIk	0	V16	V12	

PRU-ICSS/MII0 Signals Description

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SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]		
pr1_mii0_col	MII Collision Detect	I	W16	T10		
pr1_mii0_crs	MII Carrier Sense	I	U17, W5	T13, V5		
pr1_mii0_rxd0	MII Receive Data bit 0	I	V5	U4		
pr1_mii0_rxd1	MII Receive Data bit 1	ı	U5	U3		
pr1_mii0_rxd2	MII Receive Data bit 2	1/2	W4	U2		
pr1_mii0_rxd3	MII Receive Data bit 3	1/1	V4	U1		
pr1_mii0_rxdv	MII Receive Data Valid		V7	T5		
pr1_mii0_rxer	MII Receive Data Error	1	U6	V3		
pr1_mii0_rxlink	MII Receive Link	I	V6/	V2		



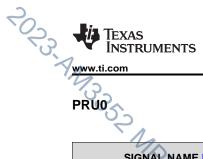
## PRU-ICSS/MII0 Signals Description (continued)

SPRS717I - OCTOBER 2011 - REVISED DEC	I3356, AM3354, AM3352, AM3351 EMBER 2015 PRU-ICSS/MII0 Signals Description (co	ontinued)		TEXAS INSTRUMENTS www.ti.com
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
pr1_mii0_txd0	MII Transmit Data bit 0	0/0/	W17, W3	T2, V13
pr1_mii0_txd1	MII Transmit Data bit 1	0	T13, W2	R12, T1
pr1_mii0_txd2	MII Transmit Data bit 2	0	U13, V2	R4, T12
pr1_mii0_txd3	MII Transmit Data bit 3	0	U12, V1	R3, U12
pr1_mii0_txen	MII Transmit Enable	0	T12, U2	R2, T11
pr1_mii_mr0_clk	MII Receive Clock	I	W6	V4
pr1_mii_mt0_clk	MII Transmit Clock	1	U1, V15	R1, U10

PRU-ICSS/MII1 Signals Description

7 TO-1033/WIIT Signals Description					
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
pr1_mii1_col	MII Collision Detect	I	R15	T17	
pr1_mii1_crs	MII Carrier Sense	1	V16, W7	R6, V12	
pr1_mii1_rxd0	MII Receive Data bit 0	1	NA	V16	
pr1_mii1_rxd1	MII Receive Data bit 1	1	NA	T15	
pr1_mii1_rxd2	MII Receive Data bit 2	1	NA	U15	
pr1_mii1_rxd3	MII Receive Data bit 3	I	NA	V15	
pr1_mii1_rxdv	MII Receive Data Valid	I	NA	T16	
pr1_mii1_rxer	MII Receive Data Error	1	NA	V17	
pr1_mii1_rxlink	MII Receive Link	1	V18	U18	
pr1_mii1_txd0	MII Transmit Data bit 0	0	NA	R14	
pr1_mii1_txd1	MII Transmit Data bit 1	0	NA	T14	
pr1_mii1_txd2	MII Transmit Data bit 2	0	NA	U14	
pr1_mii1_txd3	MII Transmit Data bit 3	0	NA	V14	
pr1_mii1_txen	MII Transmit Enable	0	W18	U17	
pr1_mii_mr1_clk	MII Receive Clock	1	NA	U16	
pr1_mii_mt1_clk	MII Transmit Clock	I	NA 🥠	R13	

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
pr1_uart0_cts_n	UART Clear to Send	I	A18, E17	A17, D18
pr1_uart0_rts_n	UART Request to Send	0	B18, D19	B17, D17
pr1_uart0_rxd	UART Receive Data	I	B17, D18	B16, D16
pr1_uart0_txd	UART Transmit Data	0	A17, C19	A16, D15
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PRU0/General-Purpose Inputs Signals Description

	110	ourgeneral-rurpose imputs signals be	cacripin	J11	
	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
	pr1_pru0_pru_r31_0	PRU0 Data In	ı	NA	A13
	pr1_pru0_pru_r31_1	PRU0 Data In	I	NA	B13
	pr1_pru0_pru_r31_10	PRU0 Data In	I	H17	G15
	pr1_pru0_pru_r31_11	PRU0 Data In	I	G18	G16
	pr1_pru0_pru_r31_12	PRU0 Data In	I	G19	G17
	pr1_pru0_pru_r31_13	PRU0 Data In	I	G17	G18
	pr1_pru0_pru_r31_14	PRU0 Data In	I	W17	V13
	pr1_pru0_pru_r31_15	PRU0 Data In	I	V17	U13
	pr1_pru0_pru_r31_16	PRU0 Data In Capture Enable	I	B15, C19	D14, D15
	pr1_pru0_pru_r31_2	PRU0 Data In	I	NA	D12
	pr1_pru0_pru_r31_3	PRU0 Data In	I	NA	C12
	pr1_pru0_pru_r31_4	PRU0 Data In	I	NA	B12
2	pr1_pru0_pru_r31_5	PRU0 Data In	I	NA	C13
7023	pr1_pru0_pru_r31_6	PRU0 Data In	I	NA	D13
,O,	pr1_pru0_pru_r31_7	PRU0 Data In	I	NA	A14
Y	pr1_pru0_pru_r31_8	PRU0 Data In	I	H19	F17
	pr1_pru0_pru_r31_9	PRU0 Data In	I	H18	F18
	PRI	J0/General-Purpose Outputs Signals D	escript	ion	
	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE	ZCE BALL [4]	ZCZ BALL [4]

		DESCRIPTION 191	TYPE		707 DALL [41
	SIGNAL NAME [1]	DESCRIPTION [2]	[3]	ZCE BALL [4]	ZCZ BALL [4]
	pr1_pru0_pru_r30_0	PRU0 Data Out	0	NA	A13
	pr1_pru0_pru_r30_1	PRU0 Data Out	0	NA	B13
	pr1_pru0_pru_r30_10	PRU0 Data Out	0	H17	G15
	pr1_pru0_pru_r30_11	PRU0 Data Out	0	G18	G16
	pr1_pru0_pru_r30_12	PRU0 Data Out	0	G19	G17
	pr1_pru0_pru_r30_13	PRU0 Data Out	0	G17	G18
	pr1_pru0_pru_r30_14	PRU0 Data Out	0	U13	<b>†</b> 12
	pr1_pru0_pru_r30_15	PRU0 Data Out	0	T13	R12
	pr1_pru0_pru_r30_2	PRU0 Data Out	0	NA	D12
	pr1_pru0_pru_r30_3	PRU0 Data Out	0	NA	C12
	pr1_pru0_pru_r30_4	PRU0 Data Out	0	NA	B12
	pr1_pru0_pru_r30_5	PRU0 Data Out	0	NA	C13
	pr1_pru0_pru_r30_6	PRU0 Data Out	0	NA	D13
2	pr1_pru0_pru_r30_7	PRU0 Data Out	0	NA	A14
2	pr1_pru0_pru_r30_8	PRU0 Data Out	0	H19	F17
,O,	pr1_pru0_pru_r30_9	PRU0 Data Out	0	H18	F18
7	pr1_pru0_pru_r30_9	MAC	MUP		
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PRU1/General-Purpose Inputs Signals Description

	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
	pr1_pru1_pru_r31_0	PRU1 Data In	T ,	Lý1	R1
	pr1_pru1_pru_r31_1	PRU1 Data In	I	U2/	R2
	pr1_pru1_pru_r31_10	PRU1 Data In	I	W5	V5
	pr1_pru1_pru_r31_11	PRU1 Data In	I	W7	R6
	pr1_pru1_pru_r31_12	PRU1 Data In	I	V14	U9
	pr1_pru1_pru_r31_13	PRU1 Data In	I	U15	<i>V</i> 9
	pr1_pru1_pru_r31_14	PRU1 Data In	I	E19	E15
	pr1_pru1_pru_r31_15	PRU1 Data In	I	F17	E16
	pr1_pru1_pru_r31_16	PRU1 Data In Capture Enable	I	C15, D18	A15, D16
	pr1_pru1_pru_r31_2	PRU1 Data In	1	V1	R3
	pr1_pru1_pru_r31_3	PRU1 Data In	I	V2	R4
	pr1_pru1_pru_r31_4	PRU1 Data In	I	W2	T1
2	pr1_pru1_pru_r31_5	PRU1 Data In	I	W3	T2
, C2	pr1_pru1_pru_r31_6	PRU1 Data In	I	V3	T3
,0 <del>,</del>	pr1_pru1_pru_r31_7	PRU1 Data In	1	U3	T4
Y	pr1_pru1_pru_r31_8	PRU1 Data In	I	U7	U5
	pr1_pru1_pru_r31_9	PRU1 Data In	I	T7	R5
PRU1/General-Purpose Outputs Signals Description					
	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]

	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE	ZCE BALL [4]	ZCZ BALL [4]
	pr1_pru1_pru_r30_0	PRU1 Data Out	0	∘U1	R1
	pr1_pru1_pru_r30_1	PRU1 Data Out	0	<b>U</b> 2	R2
	pr1_pru1_pru_r30_10	PRU1 Data Out	0	W5	V5
	pr1_pru1_pru_r30_11	PRU1 Data Out	0	W7	R6
	pr1_pru1_pru_r30_12	PRU1 Data Out	0	V14	U9
	pr1_pru1_pru_r30_13	PRU1 Data Out	0	U15	V9
	pr1_pru1_pru_r30_14	PRU1 Data Out	0	E19	<b>€</b> 15
	pr1_pru1_pru_r30_15	PRUI Data Out	0	F17	E16
	pr1_pru1_pru_r30_2	PRU1 Data Out	0	V1	R3
	pr1_pru1_pru_r30_3	PRU1 Data Out	0	V2	R4
	pr1_pru1_pru_r30_4	PRU1 Data Out	0	W2	T1
	pr1_pru1_pru_r30_5	PRU1 Data Out	0	W3	T2
	pr1_pru1_pru_r30_6	PRU1 Data Out	0	V3	T3
2	pr1_pru1_pru_r30_7	PRU1 Data Out	0	U3	T4
2	pr1_pru1_pru_r30_8	PRU1 Data Out	0	U7	U5
,O,	pr1_pru1_pru_r30_9	PRU1 Data Out	0	T7	R5
	pr1_pru1_pru_r30_9	PRU1 Data Out	MAC	N <sub>O</sub>	
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### Removable Media Interfaces

Removable Media Interfaces/MMC0 Signals Description

Removable Media Interfaces/Minor Signals Description					
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
mmc0_clk	MMC/SD/SDIO Clock	I/O	G19	G17	
mmc0_cmd	MMC/SD/SDIO Command	I/O	G17	G18	
mmc0_dat0	MMC/SD/SDIO Data Bus	I/O	G18	G16	
mmc0_dat1	MMC/SD/SDIO Data Bus	I/O	H17	G15	
mmc0_dat2	MMC/SD/SDIO Data Bus	I/O	H18	F18	
mmc0_dat3	MMC/SD/SDIO Data Bus	I/O	H19	£17	
mmc0_dat4	MMC/SD/SDIO Data Bus	I/O	N16	L16/	
mmc0_dat5	MMC/SD/SDIO Data Bus	I/O	N17	L17	
mmc0_dat6	MMC/SD/SDIO Data Bus	I/O	M19	L18	
mmc0_dat7	MMC/SD/SDIO Data Bus	I/O	N19	K18	
mmc0_pow	MMC/SD Power Switch Control	0	B16, K18	C15, H18	
mmc0_sdcd	SD Card Detect	I	B16, P17	A13, C15, M17	
mmc0_sdwp	SD Write Protect	I	E18, R19	B12, C18, M18	

Removable Media Interfaces/MMC1 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
mmc1_clk	MMC/SD/SDIO Clock	I/O	L18, R19, V14	K17, M18, U9
mmc1 cmd	MMC/SD/SDIO Command	I/O	M18, P17, U15	K16, M17, V9
mmc1_dat0	MMC/SD/SDIO Data Bus	NO	N19, V15, W10	K18, U10, U7
mmc1_dat1	MMC/SD/SDIO Data Bus	1/0	M19, V9, W16	L18, T10, V7
mmc1_dat2	MMC/SD/SDIO Data Bus	1/0	N17, T12, V12	L17, R8, T11
mmc1_dat3	MMC/SD/SDIO Data Bus	I/O	N16, U12, W13	L16, T8, U12
mmc1_dat4	MMC/SD/SDIO Data Bus	I/O	U13, V13	T12, U8
mmc1_dat5	MMC/SD/SDIO Data Bus	I/O	T13, W14	R12, V8
mmc1_dat6	MMC/SD/SDIO Data Bus	I/O	U14, W17	R9, V13
mmc1_dat7	MMC/SD/SDIO Data Bus	I/O	V17, W15	T9, U13
mmc1_sdcd	SD Card Detect	I	R15	B13, T17
mmc1_sdwp	SD Write Protect	I	B17, D18	B16, D16

Removable Media Interfaces/MMC2 Signals Description

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SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]		
mmc2_clk	MMC/SD/SDIO Clock	I/O	P19, R19, V16	L15, M18, V12		
mmc2_cmd	MMC/SD/SDIO Command	I/O	K17, P17, U17	J16, M17, T13		
mmc2_dat0	MMC/SD/SDIO Data Bus	I/O	L19, U13	J17, T12, V14		
mmc2_dat1	MMC/SD/SDIO Data Bus	I/O	M17, T13	J18, R12, U14		
mmc2_dat2	MMC/SD/SDIO Data Bus	I/O	N18, W17	K15, T14, V13		
mmc2_dat3	MMC/SD/SDIO Data Bus	I/O	J19, V17, V18	H16, U13, U18		
mmc2_dat4	MMC/SD/SDIO Data Bus	I/O	V15	U10, U15		
mmc2_dat5	MMC/SD/SDIO Data Bus	I/O	W16	T10, T15		
mmc2_dat6	MMC/SD/SDIO Data Bus	NO	T12	T11, V16		
mmc2_dat7	MMC/SD/SDIO Data Bus	1/0	U12	U12		
mmc2_sdcd	SD Card Detect	1 (	W18	D12, U17		
mmc2_sdwp	SD Write Protect	1	A17, C19	A16, D15		



### Serial Communication Interfaces

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Serial Communication Interfaces					
CAN/DCAN0 Signals Description					
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
dcan0_rx	DCAN0 Receive Data	I	D19, F17, N18	D17, E16, K15	
dcan0_tx	DCAN0 Transmit Data	0	E17, E19, M17	D18, E15, J18	

**CAN/DCAN1 Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
dcan1_rx	DCAN1 Receive Data	I	C19, F18, G17	D15, E17, G18
dcan1_tx	DCAN1 Transmit Data	0	D18, F19, G19	D16, E18, G17

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### GEMAC\_CPSW

**GEMAC\_CPSW/MDIO Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
mdio_clk	MDIO CIk	0	R19	M18
mdio_data	MDIO Data	I/O	P17	M17

**GEMAC\_CPSW/MII1 Signals Description** 

GEMAC_CP3W/MITT Signals Description						
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]		
gmii1_col	MII Colision	I	J19	H16		
gmii1_crs	MII Carrier Sense	I	J18	H17		
gmii1_rxclk	MII Receive Clock	I	M19	L18		
gmii1_rxd0	MII Receive Data bit 0	I	P18	M16		
gmii1_rxd1	MII Receive Data bit 1	I	P19	L15		
gmii1_rxd2	MII Receive Data bit 2	I	N16	L16		
gmii1_rxd3	MII Receive Data bit 3	I	N17	L17		
gmii1_rxdv	MII Receive Data Valid	I	L19	J17		
gmii1_rxer	MII Receive Data Error	I	K19	J15		
gmii1_txclk	MII Transmit Clock	I	N19	K18		
gmii1_txd0	MII Transmit Data bit 0	0	L18	K17		
gmii1_txd1	MII Transmit Data bit 1	0	M18	K16		
gmii1_txd2	MII Transmit Data bit 2	0	N18	K15		
gmii1_txd3	MII Transmit Data bit 3	9	M17	J18		
gmii1_txen	MII Transmit Enable	6/0	K17	J16		

GEMAC\_CPSW/MII2 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCF BALL [4]	ZCZ BALL [4]
gmii2_col	MII Colision	I	V18	U18
gmii2_crs	MII Carrier Sense	I	R15	T17
gmii2_rxclk	MII Receive Clock	I	NA	T15
gmii2_rxd0	MII Receive Data bit 0	I	NA	V17
gmii2_rxd1	MII Receive Data bit 1	I	NA	T16
gmii2_rxd2	MII Receive Data bit 2	I	NA	U16
gmii2_rxd3	MII Receive Data bit 3	I	NA	V16
gmii2_rxdv	MII Receive Data Valid	I	NA	V14
gmii2_rxer	MII Receive Data Error	I	W18	U17
gmii2_txclk	MII Transmit Clock	I	NA	U15
gmii2_txd0	MII Transmit Data bit 0	0	NA	V15
gmii2_txd1	MII Transmit Data bit 1	0	NA	R14
gmii2_txd2	MII Transmit Data bit 2	0	NA	T14
gmii2_txd3	MII Transmit Data bit 3	0	NA	U14
gmii2_txen	MII Transmit Enable	0	NA	R13

**GEMAC\_CPSW/RGMII1 Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
rgmii1_rclk	RGMII Receive Clock	1	M19	L18
rgmii1_rctl	RGMII Receive Control	I	L19	J17



### **GEMAC\_CPSW/RGMII1 Signals Description (continued)**

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SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
rgmii1_rd0	RGMII Receive Data bit 0	1/0/	P18	M16
rgmii1_rd1	RGMII Receive Data bit 1	1	P19	L15
rgmii1_rd2	RGMII Receive Data bit 2	1	N16	L16
rgmii1_rd3	RGMII Receive Data bit 3	I	N17	L17
rgmii1_tclk	RGMII Transmit Clock	0	N19	K18
rgmii1_tctl	RGMII Transmit Control	0	K17	J16
rgmii1_td0	RGMII Transmit Data bit 0	0	L18	K17
rgmii1_td1	RGMII Transmit Data bit 1	0	M18	K16,
rgmii1_td2	RGMII Transmit Data bit 2	0	N18	K15
rgmii1_td3	RGMII Transmit Data bit 3	0	M17	J18

**GEMAC\_CPSW/RGMII2 Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
rgmii2_rclk	RGMII Receive Clock	I	NA	T15
rgmii2_rctl	RGMII Receive Control	I	NA	V14
rgmii2_rd0	RGMII Receive Data bit 0	I	NA	V17
rgmii2_rd1	RGMII Receive Data bit 1	I	NA	T16
rgmii2_rd2	RGMII Receive Data bit 2	I	NA	U16
rgmli2_rd3	RGMII Receive Data bit 3	I	NA	V16
rgmii2_tclk	RGMII Transmit Clock	0	NA	U15
rgmii2_tctl	RGMII Transmit Control	0	NA	R13
rgmii2_td0	RGMII Transmit Data bit 0	0	NA	V15
rgmii2_td1	RGMII Transmit Data bit 1	0	NA	R14
rgmii2_td2	RGMII Transmit Data bit 2	0	NA	T14
rgmii2_td3	RGMII Transmit Data bit 3	0	NA	U14

GEMAC\_CPSW/RMII1 Signals Description

/, <u></u>				
SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
rmii1_crs_dv	RMII Carrier Sense / Data Valid	I	J18	H17
rmii1_refclk	RMII Reference Clock	I/O	K18	H18
rmii1_rxd0	RMII Receive Data bit 0	I	P18	M16
rmii1_rxd1	RMII Receive Data bit 1	I	P19	L15
rmii1_rxer	RMII Receive Data Error	I	K19	J15
rmii1_txd0	RMII Transmit Data bit 0	0	L18	K17
rmii1_txd1	RMII Transmit Data bit 1	0	M18	K16
rmii1_txen	RMII Transmit Enable	0	K17	J16

**GEMAC CPSW/RMII2 Signals Description** 

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SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
rmii2_crs_dv	RMII Carrier Sense / Data Valid	او	R15, U17	T13, T17
rmii2_refclk	RMII Reference Clock	1/0	J19	H16
rmii2_rxd0	RMII Receive Data bit 0	í/O,	NA	V17
rmii2_rxd1	RMII Receive Data bit 1	ı C	NA	T16
rmii2_rxer	RMII Receive Data Error	I	W18	U17
rmii2_txd0	RMII Transmit Data bit 0	0	NA	V15

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GEMAC\_CPSW/RMII2 Signals Description (continued)

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
rmii2_txd1	RMII Transmit Data bit 1	0/0	NA	R14
rmii2_txen	RMII Transmit Enable	0	NA	R13
RMII Transmit Enable			PAY.	TAN .

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I2C/I2C0 Signals Description

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SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
I2C0_SCL	I2C0 Clock	I/OD	B19	C16
I2C0_SDA	I2C0 Data	I/OD	C18	C17

I2C/I2C1 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
I2C1_SCL	12C1 Clock	I/OD	1440	A16, D15, E17, J15
I2C1_SDA	I2C1 Data	I/OD		B16, D16, E18, H17

		I2C/I2	C2 Signals Description			
2	SIGNAL NAME [1]	DE	ESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
500	I2C2_SCL	I2C2 Clock	502	I/OD	B18, D19, F17	B17, D17, E16
7,5	I2C2_SDA	I2C2 Data	7,5	I/OD	A18, E17, E19	A17, D18, E15
	IZC2_SCL IZC2_SDA  Magazia	Styl	To Ansos	MSC	MURAX K	t of

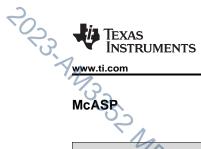
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McASP/MCASP0 Signals Description

	MICASP/MICASPU Signals Description					
	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]	
	mcasp0_aclkr	McASP0 Receive Bit Clock	I/O	119, V18, V6	B12, J17, U18, V2	
	mcasp0_aclkx	McASP0 Transmit Bit Clock	I/O	N19, V4	A13, K18, U1, V16	
	mcasp0_ahclkr	McASP0 Receive Master Clock	I/O	V5	C12, U4	
	mcasp0_ahclkx	McASP0 Transmit Master Clock	I/O	N18, V7	A14, K15, T5	
	mcasp0_axr0	McASP0 Serial Data (IN/OUT)	I/O	N17, U5	D12, L17, T16, U3	
	mcasp0_axr1	McASP0 Serial Data (IN/OUT)	I/O	N16, W6	D13, L16, V17, V4	
	mcasp0_axr2	McASP0 Serial Data (IN/OUT)	I/O	J19, V5, V6	B12, C12, H16, U4, V2	
	mcasp0_axr3	McASP0 Serial Data (IN/OUT)	I/O	P18, U6, V7	A14, C13, M16, T5, V3	
2023	mcasp0_fsr	McASP0 Receive Frame Sync	I/O	M17, U6, V16	C13, J18, V12, V3	
707	mcasp0_fsx	McASP0 Transmit Frame Sync	I/O	M19, W4	B13, L18, U16, U2	
,	1/3	McASP/MCASP1 Signals Descript	ion			
	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE	ZCE BALL [4]	ZCZ BALL [4]	

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
mcasp1_aclkr	McASP1 Receive Bit Clock	1/0	L18, P18	K17, M16
mcasp1_aclkx	McASP1 Transmit Bit Clock	1/0	J18, L19	B12, H17, J17
mcasp1_ahclkr	McASP1 Receive Master Clock	1/0	P18	M16
mcasp1_ahclkx	McASP1 Transmit Master Clock	I/O	K18, P18	H18, M16
mcasp1_axr0	McASP1 Serial Data (IN/OUT)	I/O	K17, N18	D13, J16, K15
mcasp1_axr1	McASP1 Serial Data (IN/OUT)	I/O	M18	A14, K16
mcasp1_axr2	McASP1 Serial Data (IN/OUT)	I/O	J19, L18	H16, K17
mcasp1_axr3	McASP1 Serial Data (IN/OUT)	I/O	K18, P19	H18, L15
mcasp1_fsr	McASP1 Receive Frame Sync	I/O	M18, P19	K16, L15
mcasp1_fsx	McASP1 Transmit Frame Sync	I/O	K19, M17	C13, J15, J18

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4/	SPI/SPI0 Signals Description	TYPE		
SIGNAL NAME [1]	DESCRIPTION [2]	[3]	ZCE BALL [4]	ZCZ BALL [4]
spi0_cs0	SPI Chip Select	I/O	A17	A16
spi0_cs1	SPI Chip Select	I/O	B16	C15
spi0_d0	SPI Data	I/O	B18	B17
spi0_d1	SPI Data	I/O	B17	B16
spi0_sclk	SPI Clock	I/O	A18	A17
	SPI/SPI1 Signals Description	1	17,	<b>T</b> y.
	1/1/	TVDE		1/1/

	SDIU_SCIK	SPI Clock	1/0	A18	A17
		SPI/SPI1 Signals Description			ts.
	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
	spi1_cs0	SPI Chip Select	I/O	E17, E19, F18, K18	C12, D18, E15, E17, H18
	spi1_cs1	SPI Chip Select	I/O	C15, D19, E18, F17	A15, C18, D17, E16
2	spi1_d0	SPI Data	I/O	F19, J18	B13, E18, H17
,02	spi1_d1	SPI Data	I/O	F18, K19	D12, E17, J15
2023,4	spi1_sclk	SPI Clock	I/O	E18, J19	A13, C18, H16
	spi1_sclk  Assistance of the spin and s	SPI Clock  Thistory	MAC	MARAN	TAN .

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UART/UART0 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
uart0_ctsn	UART Clear to Send	1	F19	E18
uart0_rtsn	UART Request to Send	0	F18	E17
uart0_rxd	UART Receive Data		E19	E15
uart0_txd	UART Transmit Data	0	F17	E16

**UART/UART1 Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
uart1_ctsn	UART Clear to Send	ı	E17	D18
uart1_dcdn	UART Data Carrier Detect	I	H19, N19	F17, K18
uart1_dsrn	UART Data Set Ready	I	H18, M19	F18, L18
uart1_dtrn	UART Data Terminal Ready	0	H17, N17	G15, L17
uart1_rin	UART Ring Indicator	I	G18, N16	G16, L16
uart1_rtsn	UART Request to Send	0	D19	D17
uart1_rxd	UART Receive Data	1	D18	D16
uart1_txd	UART Transmit Data	0	C19	D15

**UART/UART2 Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
uart2_ctsn	UART Clear to Send	1/2	C18, V4	C17, U1
uart2_rtsn	UART Request to Send	0	B19, W4	C16, U2
uart2_rxd	UART Receive Data		A18, G19, J18, N19	A17, G17, H17, K18
uart2_txd	UART Transmit Data	0	B18, G17, K19, M19	B17, G18, J15, L18

**UART/UART3 Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
uart3_ctsn	UART Clear to Send	1	G19, P17, U5	G17, M17, U3
uart3_rtsn	UART Request to Send	0	G17, R19, V5	G18, M18, U4
uart3_rxd	UART Receive Data	1	B16, H17, N17	C15, G15, L17
uart3_txd	UART Transmit Data	0	E18, G18, N16	C18, G16, L16

**UART/UART4 Signals Description** 

SIGNAL NAME [1]	DESCRIPTION [2]		ZCE BALL [4]	ZCZ BALL [4]
uart4_ctsn	UART Clear to Send	I	H19, V6	F17, V2
uart4_rtsn	UART Request to Send	0	H18, U6	F18, V3
uart4_rxd	UART Receive Data	I	F19, M17, R15	E18, J18, T17
uart4_txd	UART Transmit Data	0	F18, N18, W18	E17, K15, U17

UART/UART5 Signals Description

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
uart5_ctsn	UART Clear to Send	1	H17, J18, W6	G15, H17, V4
uart5_rtsn	UART Request to Send	0	G18, K19, V7	G16, J15, T5

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### **UART/UART5 Signals Description (continued)**

7	CTOBER 2011-REVISED DEC	M3356, AM3354, AM3352, AM335 DEMBER 2015  UART/UART5 Signals Descripti	, /3	Ų	TEXAS INSTRUMENTS www.ti.com
SI	GNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
uart5_rxd	2	UART Receive Data	170	J19, P17, W4, W6	H16, M17, U2, V4
uart5_txd	M	UART Transmit Data	0	K18, L19, R19, V4	H18, J17, M18, U1
	PA)	Ptyl		77/4	Ty.

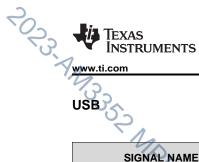
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USB/USB0 Signals Description /

SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]				
USB0_CE	USB0 Active high Charger Enable output	Α	<b>T</b> 18	M15				
USB0_DM	USB0 Data minus	Α	U18	N18				
USB0_DP	USB0 Data plus	Α	U19	N17				
USB0_DRVVBUS	USB0 Active high VBUS control output	0	G16	F16				
USB0_ID	USB0 OTG ID (Micro-A or Micro-B Plug)	Α	V19	P16				
USB0_VBUS	USB0 VBUS	Α	T19	P15				

USB/USB1 Signals Description

	SIGNAL NAME [1]	DESCRIPTION [2]	TYPE [3]	ZCE BALL [4]	ZCZ BALL [4]
	USB1_CE	USB1 Active high Charger Enable output	Α	NA	P18
	USB1_DM	USB1 Data minus	Α	NA	R18
_	USB1_DP	USB1 Data plus	Α	NA	R17
0	USB1_DRVVBUS	USB1 Active high VBUS control output	0	NA	F15
773	USB1_ID	USB1 OTG ID (Micro-A or Micro-B Plug)	Α	NA	P17
\ \ \	USB1_VBUS	USB1 VBUS	Α	NA	T18
	USB1_VBUS  MANUAL  MAN	USB1 VBUS	MAC	MARAN	t <sub>y</sub>

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Terminal Configuration and Functions



#### 5 **Specifications**

### Absolute Maximum Ratings(1)(2)

SPRS717I - OCTOBER 2011	1-REVISED DECEMBER 2015		ww	w.ti.com
1/2	ns  aximum Ratings <sup>(1)(2)</sup> axirure range (unless otherwise noted)			
5 Specification	ns			
<b>2</b>	(4)(0)			
5.1 Absolute M	aximum Ratings <sup>(1)(2)</sup>			
over junction temperat	cure range (unless otherwise noted)			
	,	MIN	MAX	UNIT
VDD_MPU <sup>(3)</sup>	Supply voltage for the MPU core domain	-0.5	1.5	V
VDD_CORE	Supply voltage for the core domain	-0.5	1.5	V
CAP_VDD_RTC <sup>(4)</sup>	Supply voltage for the RTC core domain	-0.5	1.5	V
VPP <sup>(5)</sup>	Supply voltage for the FUSE ROM domain	-0.5	2.2	V
VDDS_RTC	Supply voltage for the RTC domain	-0.5	2.1	V
VDDS_OSC	Supply voltage for the System oscillator	-0.5	2.1	V
VDDS_SRAM_CORE_BG	Supply voltage for the Core SRAM LDOs	-0.5	2.1/	V
VDDS_SRAM_MPU_BB	Supply voltage for the MPU SRAM LDOs	-0.5	2.1	V
VDDS_PLL_DDR	Supply voltage for the DPLL DDR	-0.5	2.1	V
VDDS_PLL_CORE_LCD	Supply voltage for the DPLL Core and LCD	-0.5	2.1	V
VDDS_PLL_MPU	Supply voltage for the DPLL MPU	-0.5	2.1	V
VDDS_DDR	Supply voltage for the DDR IO domain	-0.5	2.1	V
VDDS	Supply voltage for all dual-voltage IO domains	-0.5	2.1	V
VDDA1P8V_USB0	Supply voltage for USBPHY	-0.5	2.1	V
VDDA1P8V_USB1 <sup>(6)</sup>	Supply voltage for USBPHY	-0.5	2.1	V
VDDA_ADC	Supply voltage for ADC	-0.5	2.1	V
VDDSHV1	Supply voltage for the dual-voltage IO domain	-0.5	3.8	V
VDDSHV2 <sup>(6)</sup>	Supply voltage for the dual-voltage IO domain	-0.5	3.8	V
VDDSHV3 <sup>(6)</sup>	Supply voltage for the dual-voltage IO domain	-0.5	3.8	V
VDDSHV4	Supply voltage for the dual-voltage IO domain	-0.5	3.8	V
VDDSHV5	Supply voltage for the dual-voltage IO domain	-0.5	3.8	V
VDDSHV6	Supply voltage for the dual-voltage IO domain	-0.5	3.8	V
VDDA3P3V_USB0	Supply voltage for USBPHY	-0.5	4	V
VDDA3P3V_USB1 <sup>(6)</sup>	Supply voltage for USBPHY	0.5	4	V
USB0_VBUS <sup>(7)</sup>	Supply voltage for USB VBUS comparator input	-0.5	5.25	V
USB1_VBUS <sup>(6)(7)</sup>	Supply voltage for USB VBUS comparator input	-0.5	5.25	V
DDR VREF	Supply voltage for the DDR SSTL and HSTL reference voltage	-0.3	1.1	V
Steady state max voltage at all IO pins <sup>(8)</sup>	/A.	-0.5 V to IO supply v	*	
USB0_ID <sup>(9)</sup>	Steady state maximum voltage for the USB ID input	-0.5	2.1	V
USB1_ID <sup>(6)(9)</sup>	Steady state maximum voltage for the USB ID input	-0.5	2.1	V
Transient overshoot and undershoot specification at IO terminal		25% of correspondi voltage for up to 30 period	ng IO supply 0% of signal	
Latch-up performance <sup>(10)</sup>	Class II (105°C)	45		mA
Storage temperature, $T_{stg}^{(11)}$		<b>-</b> 55	155	°C

- Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to their associated VSS or VSSA\_x.
- (3) Not available on the ZCE package. VDD\_MPU is merged with VDD\_CORE on the ZCE package.
- (4) This supply is sourced from an internal LDO when RTC\_KALDO\_ENn is low. If RTC\_KALDO\_ENn is high, this supply must be sourced from an external power supply.
- (5) During functional operation, this pin is a no connect.
- (6) Not available on the ZCE package.
- (7) This terminal is connected to a fail-safe IO and does not have a dependence on any IO supply voltage.
- This parameter applies to all IO terminals which are not fail-safe and the requirement applies to all values of IO supply voltage. For example, if the voltage applied to a specific IO supply is 0 volts the valid input voltage range for any IO powered by that supply will be -0.5 to +0.3 V. Apply special attention anytime peripheral devices are not powered from the same power sources used to power the respective IO supply. It is important the attached peripheral never sources a voltage outside the valid input voltage range, including

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power supply ramp-up and ramp-down sequences.

- (9) This terminal is connected to analog circuits in the respective USB PHY. The circuit sources a known current while measuring the voltage to determine if the terminal is connected to VSSA\_USB with a resistance less than 10 Ω or greater than 100 kΩ. The terminal should be connected to ground for USB host operation or open-circuit for USB peripheral operation, and should never be connected to any external voltage source.
- (10) Based on JEDEC JESD78D [IC Latch-Up Test].
- (11) For tape and reel the storage temperature range is [-10°C; +50°C] with a maximum relative humidity of 70%. TI recommends returning to ambient room temperature before usage.

Fail-safe IO terminals are designed such they do not have dependencies on the respective IO power supply voltage. This allows external voltage sources to be connected to these IO terminals when the respective IO power supplies are turned off. The USB0 VBUS and USB1 VBUS are the only fail-safe IO terminals. All other IO terminals are not fail-safe and the voltage applied to them should be limited to the value defined by the steady state max. Voltage at all IO pins parameter in Section 5.1.

#### 5.2 **ESD Ratings**

			VALUE	UNIT
V	Electrostatic discharge	Human Body Model (HBM), per ANSI/ESDA/JEDEC JS001 (1)	±2000	V
V <sub>ESD</sub>	(ESD) performance:	Charged Device Model (CDM), per JESD22-C101 (2)	±500	V
(1) JEDEC (2) JEDEC	document JEP155 states tha	at 500-V HBM allows safe manufacturing with a standard ESD control product 250-V CDM allows safe manufacturing with a standard ESD control product.	cess. cess.	

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### 5.3 Power-On Hours (POH)

Table 5-1. Reliability Data(1)(2)(3)(4)

OPERATING	COMME	COMMERCIAL		INDUSTRIAL		EXTENDED		INDUSTRIAL EXTENDED	
CONDITION	JUNCTION TEMP (T <sub>J</sub> )	LIFETIME (POH) <sup>(5)</sup>							
Nitro	0°C to 90°C	100K	-40°C to 90°C	100K	-40°C to 105°C	37K	-40°C to 125°C	-	
Turbo	0°C to 90°C	<b>100K</b>	-40°C to 90°C	100K	-40°C to 105°C	80K	-40°C to 125°C	-	
OPP120	0°C to 90°C	100K	-40°C to 90°C	100K	-40°C to 105°C	100K	-40°C to 125°C	-	
OPP100	0°C to 90°C	100K	-40°C to 90°C	100K	-40°C to 105°C	100K	-40°C to 125°C	35K	
OPP50	0°C to 90°C	100K	–40°C to 90°C	100K	-40°C to 105°C	100K	–40°C to 125°C	95K	

- (1) The power-on hours (POH) information in this table is provided solely for your convenience and does not extend or modify the warranty provided under TI's standard terms and conditions for TI semiconductor products.
- (2) To avoid significant degradation, the device power-on hours (POH) must be limited as described in this table.
- (3) Logic functions and parameter values are not assured out of the range specified in the recommended operating conditions.
- (4) The previous notations cannot be deemed a warranty or deemed to extend or modify the warranty under TI's standard terms and conditions for TI semiconductor products.
- (5) POH = Power-on hours when the device is fully functional.

### 5.4 Operating Performance Points (OPPs)

Device OPPs are defined in Table 5-2 through Table 5-9

# Table 5-2. VDD\_CORE OPPs for ZGZ Package With Device Revision Code "Blank" (1)

VDD_CORE		VDD_CORE			1			
OPP Device Rev. "Blank"	MIN	NOM	MAX	DDR3, DDR3L <sup>(2)</sup>	DDR2 <sup>(2)</sup>	mDDR <sup>(2)</sup>	L3 and L4	
OPP100	1.056 V	1.100 V	1.144 V	400 MHz	266 MHz	200 MHz	200 and 100 MHz	
OPP50	0.912 V	0.950 V	0.988 V	_	125 MHz	90 MHz	100 and 50 MHz	

- (1) Frequencies in this table indicate maximum performance for a given OPP condition.
- (2) This parameter represents the maximum memory clock frequency. Because data is transferred on both edges of the clock, double-data rate (DDR), the maximum data rate is two times the maximum memory clock frequency defined in this table.

# Table 5-3. VDD\_MPU OPPs for ZCZ Package with Device Revision Code "Blank"(1)

VDD_MPU OPP		VDD_MPU		A DM (A 0)
Device Rev. "Blank"	MIN	NOM	MAX	ARM (A8)
Turbo	1.210 V	1.260 V	1.326 V	720 MHz
OPP120	1.152 V	1.200 V	1.248 V	600 MHz
OPP100 <sup>(2)</sup>	1.056 V	1.100 V	1.144 V	500 MHz
OPP100 <sup>(3)</sup>	1.056 V	1.100 V	1.144 V	275 MHz

- (1) Frequencies in this table indicate maximum performance for a given OPP condition.
- (2) Applies to all orderable AM335\_ZCZ\_50 (500-MHz speed grade) or higher devices.
- (3) Applies to all orderable AM335\_ZCZ\_27 (275-MHz speed grade) devices.

V 275 MHz

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#### Table 5-4. Valid Combinations of VDD CORE and VDD\_MPU OPPs for ZCZ Package with Device Revision Code "Blank"

TEXAS INSTRUMENTS	AM3359, A	AM3358, AM3357, AM3356, AI SPRS7171-OCTOBER
Moss Maria	VDD_MPU OPPs for ZCZ Pa	ations of VDD CORE and ackage with Device Revision Blank"
	OPP50	OPP100
12		
	OPP100	OPP100
	OPP100	OPP120
	OPP100	Turbo
	Table 5-5. VDD_CORE	OPPs for ZCE Package

# Table 5-5. VDD\_CORE OPPs for ZCE Package with Device Revision Code "Blank" (1)

VDD_CORE	VDD_MPU <sup>(2)</sup>							1/
OPP Device Rev. "Blank"	MIN	NOM	MAX	ARM (A8)	DDR3, DDR3L <sup>(3)</sup>	DDR2 <sup>(3)</sup>	mDDR <sup>(3)</sup>	L3 and L4
OPP100	1.056 V	1.100 V	1.144 V	500 MHz	400 MHz	266 MHz	200 MHz	200 and 100 MHz
OPP100	1.056 V	1.100 V	1.144 V	275 MHz	400 MHz	266 MHz	200 MHz	200 and 100 MHz

- (1) Frequencies in this table indicate maximum performance for a given OPP condition.
- (2) VDD\_MPU is merged with VDD\_CORE on the ZCE package.
- (3) This parameter represents the maximum memory clock frequency. Because data is transferred on both edges of the clock, double-data rate (DDR), the maximum data rate is two times the maximum memory clock frequency defined in this table.

  Table 5-6. VDD CORE OPPs for ZCZ Package

#### Table 5-6. VDD CORE OPPs for ZCZ Package with Device Revision Code "A" or Newer (1)

VDD_CORE	0	VDD_CORE			170		
OPP Rev "A" or Newer	MIN	NOM	MAX	DDR3, DDR3L <sup>(2)</sup>	DDR2 <sup>(2)</sup>	mDDR <sup>(2)</sup>	L3 and L4
OPP100	1.056 V	1.100 V	1.144 V	400 MHz	266 MHz	200 MHz	200 and 100 MHz
OPP50	0.912 V	0.950 V	0.988 V	_	125 MHz	90 MHz	100 and 50 MHz

- (1) Frequencies in this table indicate maximum performance for a given OPP condition.
- (2) This parameter represents the maximum memory clock frequency. Because data is transferred on both edges of the clock, double-data rate (DDR), the maximum data rate is two times the maximum memory clock frequency defined in this table.

#### Table 5-7. VDD\_MPU OPPs for ZCZ Package with Device Revision Code "A" or Newer

VDD_MPU OPP		VDD_MPU				
Rev "A" or Newer	MIN	NOM	MAX	ARM (A8)		
Nitro	1.272 V	1.325 V	1.378 V	1 GHz		
Turbo	1.210 V	1.260 V	1.326 V	800 MHz		
OPP120	1.152 V	1.200 V	1.248 V	720 MHz		
OPP100 <sup>(2)</sup>	1.056 V	1.100 V	1.144 V	600 MHz		
OPP100 <sup>(3)</sup>	1.056 V	1.100 V	1.144 V	300 MHz		
OPP50	0.912 V	0.950 V	0.988 V	300 MHz		

- (1) Frequencies in this table indicate maximum performance for a given OPP condition
- (2) Applies to all orderable AM335\_\_ZCZ\_60 (600 MHz speed grade) or higher devices.
- (3) Applies to all orderable AM335\_\_ZCZ\_30 (300 MHz speed grade) devices.



# Table 5-8. Valid Combinations of VDD\_CORE and VDD\_MPU OPPs for ZCZ Package With Device Revision Code "A" or Newer

AM3359, AM3358, AM335 SPRS717I – OCTOBER 2011 – REVIS	5 <b>7, AM3356, AM3354, AM335</b> ED DECEMBER 2015	2, AM3351
1000 A	VDD MPU OPPs for ZC	ations of VDD_CORE and Z Package With Device e "A" or Newer
	VDD_CORE	VDD_MPU
	OPP50	OPP50
4	OPP50	OPP100
	OPP100	OPP50
	OPP100	OPP100
	OPP100	OPP120
	OPP100	Turbo
	OPP100	Nitro

#### Table 5-9. VDD\_CORE OPPs for ZCE Package with Device Revision Code "A" or Newer (1)

VDD_CORE		VDD_MPU <sup>(2)</sup>						
OPP Rev "A" or newer	MIN	NOM	MAX	ARM (A8)	DDR3, DDR3L <sup>(3)</sup>	DDR2 <sup>(3)</sup>	mDDR <sup>(3)</sup>	L3 and L4
OPP100	1.056 V	1.100 V	1.144 V	600 MHz	400 MHz	266 MHz	200 MHz	200 and 100 MHz
OPP100	1.056 V	1.100 V	1.144 V	300 MHz	400 MHz	266 MHz	200 MHz	200 and 100 MHz
OPP50	0.912 V	0.950 V	0.988 V	300 MHz	73-	125 MHz	90 MHz	100 and 50 MHz

- (1) Frequencies in this table indicate maximum performance for a given OPP condition.
- (2) VDD\_MPU is merged with VDD\_CORE on the ZCE package.
- (3) This parameter represents the maximum memory clock frequency. Because data is transferred on both edges of the clock, double-data this MURA PARA Maxin.
  Merry Park rate (DDR), the maximum data rate is two times the maximum memory clock frequency defined in this table.

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# 5.5 Recommended Operating Conditions

SUPPLY NAME	range (unless otherwise noted)  DESCRIPTION	MIN /	NOM	MAX	UNIT
JOI I LI MAINE	Supply voltage range for core		<del>′⁄/,</del>		OIALL
VDD_CORE <sup>(1)</sup>	domain; OPP100	1.056	1.100	1.144	V
VDD_CORE	Supply voltage range for core domain; OPP50	0.912	0.950	0.988	V
/	Supply voltage range for MPU domain, Nitro	1.272	1.325	1.378	
	Supply voltage range for MPU domain, Turbo	1.210	1.260	1.326	
VDD_MPU <sup>(1)(2)</sup>	Supply voltage range for MPU domain; OPP120	1.152	1.200	1.248	V
	Supply voltage range for MPU domain; OPP100	1.056	1.100	1.144	
	Supply voltage range for MPU domain; OPP50	0.912	0.950	0.988	
CAP_VDD_RTC(3)	Supply voltage range for RTC domain input	0.900	1.100	1.250	V
VDDS_RTC	Supply voltage range for RTC domain	1.710	1.800	1.890	V
	Supply voltage range for DDR IO domain (DDR2)	1.710	1.800	1.890	
VDDS_DDR	Supply voltage range for DDR IO domain (DDR3)	1.425	1.500	1.575	V
35	Supply voltage range for DDR IO domain (DDR3L)	1.283	1.350	1.418	
VDDS <sup>(4)</sup>	Supply voltage range for all dual-voltage IO domains	1.710	1.800	1.890	V
VDDS_SRAM_CORE_BG	Supply voltage range for Core SRAM LDOs, analog	1.710	1.800	1.890	V
VDDS_SRAM_MPU_BB	Supply voltage range for MPU SRAM LDOs, analog	1.710	1.800	1.890	V
VDDS_PLL_DDR(5)	Supply voltage range for DPLL DDR, analog	1.710	1.800	1.890	V
VDDS_PLL_CORE_LCD(5)	Supply voltage range for DPLL CORE and LCD, analog	1.710	1.800	1.890	V
VDDS_PLL_MPU <sup>(5)</sup>	Supply voltage range for DPLL MPU, analog	1.710	1.800	1,890	V
VDDS_OSC	Supply voltage range for system oscillator IO's, analog	1.710	1.800	1.890	V
VDDA1P8V_USB0 <sup>(5)</sup>	Supply voltage range for USBPHY and PER DPLL, analog, 1.8 V	1.710	1.800	1.890	V
VDDA1P8V_USB1 <sup>(6)</sup>	Supply voltage range for USB PHY, analog, 1.8 V	1.710	1.800	1.890	V
VDDA3P3V_USB0	Supply voltage range for USB PHY, analog, 3.3 V	3.135	3.300	3.465	V
VDDA3P3V_USB1 <sup>(6)</sup>	Supply voltage range for USB PHY, analog, 3.3 V	3.135	3.300	3.465	V
VDDA ADC	Supply voltage range for ADC, analog	1.710	1.800	1.890	V
VDDSHV1	Supply voltage range for dual- voltage IO domain (1.8-V operation)	1.710	1.800	1.890	V
VDDSHV2 <sup>(6)</sup>	Supply voltage range for dual- voltage IO domain (1.8-V operation)	1.710	1.800	1.890	V

### **Recommended Operating Conditions (continued)**

over junction temperature range (unless otherwise noted)

SUPPLY NAME	DESCRIPTION	MIN	NOM	MAX	UNIT
VDDSHV3 <sup>(6)</sup>	Supply voltage range for dual- voltage IO domain (1.8-V operation)	1.710	1,800	1.890	V
VDDSHV4	Supply voltage range for dual- voltage IO domain (1.8-V operation)	1.710	1.800	1.890	V
VDDSHV5	Supply voltage range for dual- voltage 10 domain (1.8-V operation)	1.710	1.800	1.890	V
VDDSHV6	Supply voltage range for dual- voltage IO domain (1.8-V operation)	1.710	1.800	1.890	V
VDDSHV1	Supply voltage range for dual- voltage IO domain (3.3-V operation)	3.135	3.300	3.465	V
VDDSHV2 <sup>(6)</sup>	Supply voltage range for dual- voltage IO domain (3.3-V operation)	3.135	3.300	3.465	V
VDDSHV3 <sup>(6)</sup>	Supply voltage range for dual- voltage IO domain (3.3-V operation)	3.135	3.300	3.465	V
VDDSHV4	Supply voltage range for dual- voltage IO domain (3.3-V operation)	3.135	3.300	3.465	V
VDDSHV5	Supply voltage range for dual- voltage IO domain (3.3-V operation)	3.135	3.300	3.465	V
VDDSHV6	Supply voltage range for dual- voltage IO domain (3.3-V operation)	3.135	3.300	3.465	V
DDR_VREF	Voltage range for DDR SSTL and HSTL reference input (DDR2, DDR3, DDR3L)	0.49 × VDDS_DDR	0.50 × VDDS_DDR	0.51 × VDDS_DDR	V
USB0_VBUS	Voltage range for USB VBUS comparator input	0.000	5.000	5.250	V
USB1_VBUS <sup>(6)</sup>	Voltage range for USB VBUS comparator input	0.000	5.000	5.250	V
USB0_ID	Voltage range for the USB ID input		(7)	"	V
USB1_ID <sup>(6)</sup>	Voltage range for the USB ID input		(7)		V
	Commercial temperature	0		90	
Operating temperature range, T <sub>J</sub>	Industrial temperature	-40		90	°C
90, 1,1	Extended temperature	-40		105	

- (1) The supply voltage defined by OPP100 should be applied to this power domain before the device is released from reset.
- (2) Not available on the ZCE package. VDD\_MPU is merged with VDD\_CORE on the ZCE package.
- (3) This supply is sourced from an internal LDO when RTC\_KALDO\_ENn is low. If RTC\_KALDO\_ENn is high, this supply must be sourced from an external power supply.
- (4) VDDS should be supplied irrespective of 1.8- or 3.3-V mode of operation of the dual-voltage IOs.
- (5) For more details on power supply requirements, see Section 6.1.4.
- (6) Not available on the ZCE package.
- (7) This terminal is connected to analog circuits in the respective USB PHY. The circuit sources a known current while measuring the voltage to determine if the terminal is connected to VSSA\_USB with a resistance less than 10 Ω or greater than 100 kΩ. The terminal should be connected to ground for USB host operation or open-circuit for USB peripheral operation, and should never be connected to any external voltage source.

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### 5.6 Power Consumption Summary

Table 5-10 summarizes the power consumption at the AM335x power terminals.

### Table 5-10. Maximum Current Ratings at AM335x Power Terminals<sup>(1)</sup>

SUPPLY NAME	DESCRIPTION	1/2	MAX	UNIT
7/,	Maximum current rating for the core domain; OPP100	7//	400	mA
VDD_CORE <sup>(2)</sup>	Maximum current rating for the core domain; OPP50	P	250	mA
-	Maximum current rating for the MPU domain; Nitro	at 1 GHz	1000	mA
	Maximum current rating for the MPU domain; Turbo	at 800 MHz	800	mA
	7/	at 720 MHz	720	
	Maximum current rating for the MPU domain; OPP120	at 720 MHz	720	mA
		at 600 MHz	600	
VDD_MPU <sup>(2)</sup>	Maximum current rating for the MPU domain; OPP100	at 600 MHz	600	mA
		at 500 MHz	500	
		at 300 MHz	380	mA
		at 275 MHz	350	
	Maximum current rating for the MPU domain; OPP50	at 300 MHz	330	mA
	2	at 275 MHz	300	
CAP_VDD_RTC <sup>(3)</sup>	Maximum current rating for RTC domain input and LDO outp	ut	2	mA
VDDS_RTC	Maximum current rating for the RTC domain		5	mA
VDDS_DDR	Maximum current rating for DDR IO domain		250	mA
VDDS	Maximum current rating for all dual-voltage IO domains		50	mA
VDDS_SRAM_CORE_BG	Maximum current rating for core SRAM LDOs		10	mA
VDDS_SRAM_MPU_BB	Maximum current rating for MPU SRAM LDOs	4	10	mA
VDDS_PLL_DDR	Maximum current rating for the DPLL DDR	<i>'</i> N <sub>/</sub> .	10	mA
VDDS_PLL_CORE_LCD	Maximum current rating for the DPLL Core and LCD		20	mA
VDDS_PLL_MPU	Maximum current rating for the DPLL MPU	1/1	10	mA
VDDS_OSC	Maximum current rating for the system oscillator IOs	<b>%</b>	5	mA
VDDA1P8V_USB0	Maximum current rating for USBPHY 1.8 V	4	25	mA
VDDA1P8V_USB1 <sup>(4)</sup>	Maximum current rating for USBPHY 1.8 V		25	mA
VDDA3P3V_USB0	Maximum current rating for USBPHY 3.3 V		40	mA
VDDA3P3V_USB1 <sup>(4)</sup>	Maximum current rating for USBPHY 3.3 V		40	mA
VDDA_ADC	Maximum current rating for ADC		10	mA
VDDSHV1 <sup>(5)</sup>	Maximum current rating for dual-voltage IO domain		50	mA
VDDSHV2 <sup>(4)</sup>	Maximum current rating for dual-voltage IO domain		50	mA
VDDSHV3 <sup>(4)</sup>	Maximum current rating for dual-voltage IO domain		50	mA
VDDSHV4	Maximum current rating for dual-voltage IO domain		50	mA
VDDSHV5	Maximum current rating for dual-voltage IO domain		50	mA
VDDSHV6	Maximum current rating for dual-voltage IO domain		100	mA

<sup>(1)</sup> Current ratings specified in this table are worst-case estimates. Actual application power supply estimates could be lower. For more information, see the *AM335x Power Consumption Summary* application report (SPRABN5).

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<sup>(2)</sup> VDD\_MPU is merged with VDD\_CORE and is not available separately on the ZCE package. The maximum current rating for VDD\_CORE on the ZCE package is the sum of VDD\_CORE and VDD\_MPU shown in this table.

<sup>(3)</sup> This supply is sourced from an internal LDO when RTC\_KALDO\_ENn is low. If RTC\_KALDO\_ENn is high, this supply must be sourced from an external power supply.

<sup>(4)</sup> Not available on the ZCE package.

<sup>(5)</sup> VDDSHV1 and VDDSHV2 are merged in the ZCE package. The maximum current rating for VDDSHV1 on the ZCE package is the sum of VDDSHV1 and VDDSHV2 shown in this table.



Table 5-11. AM335x Low-Power Modes Power Consumption Summary

'/	PRS717I – OCTOBE	358, AM3357, AM3356, AM33 ER 2011-REVISED DECEMBER 2015 11 summarizes the power con	sumption of the AM335x low-pov	wer mode:	S.	wv	ww.ti.c
	Th,	Table 5-11. AM335x Low	r-Power Modes Power Consum	ption Sui	mmary		
	POWER MODES	APPLICATION STATE	POWER DOMAINS, CLOCKS, AND VOLTAGE SUPPLY STATES	2	NOM	MAX	UNI
s	Standby	DDR memory is in self-refresh and contents are preserved. Wake up from any GPIO. Cortex-A8 context/register contents are lost and must be saved before entering standby. On exit, context must be restored from DDR. For wake-up, boot ROM executes and branches to system resume.	Power supplies:  All power supplies are ON. VDD_MPU = 0.95 V (nom) VDD_CORE = 0.95 V (non) Main Oscillator (OSC0) = 0 All DPLLs are in bypass. Power domains: PD_PER = ON PD_MPU = OFF PD_GFX = OFF PD_WKUP = ON DDR is in self-refresh.	n)	16.5	22.0	mV
	Deepsleep1	On-chip peripheral registers are preserved. Cortex-A8 context/registers are lost, so the application needs to save them to the L3 OCMC RAM or DDR before entering DeepSleep. DDR is in self-refresh. For wake-up, boot ROM executes and branches to system resume.	Power supplies:  All power supplies are ON.  VDD_MPU = 0.95 V (nom)  VDD_CORE = 0.95 V (nom)  Main Oscillator (OSC0) = 0  All DPLLs are in bypass.  Power domains:  PD_PER = ON  PD_MPU = OFF  PD_GFX = OFF  PD_WKUP = ON  DDR is in self-refresh.	n)	6.0	10.0	mV
	Deepsleep0	PD_PER peripheral and Cortex-A8/MPU register information will be lost. On- chip peripheral register (context) information of PD-PER domain needs to be saved by application to SDRAM before entering this mode. DDR is in self-refresh. For wake-up, boot ROM executes and branches to peripheral context restore followed by system resume.	Power supplies:  • All power supplies are ON.  • VDD_MPU = 0.95 V (nom)  • VDD_CORE = 0.95 V (nom)  • VDD_CORE = 0.95 V (nom)  • All DPLLs are in bypass.  Power domains:  • PD_PER = OFF  • PD_MPU = OFF  • PD_GFX = OFF  • PD_WKUP = ON  DDR is in self-refresh.	n) DFF	3.0	4.3	mV
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### 5.7 DC Electrical Characteristics<sup>(1)</sup>

over recommended ranges of supply voltage and operating temperature (unless otherwise noted)

**PARAMETER** 

2,DDR_A R_D1,DD	SETn,DDR_CSn0,DDR_CKE,DDR_CK,DDR_CKn,DDR_C/ 3,DDR_A4,DDR_A5,DDR_A6,DDR_A7,DDR_A8,DDR_A9, R_D2,DDR_D3,DDR_D4,DDR_D5,DDR_D6,DDR_D7,DDR QM1,DDR_DQS0,DDR_DQSn0,DDR_DQS1,DDR_DQSn1	DDR_A10,DDR_A11 _D8,DDR_D9,DDR_I	,DDR_A12,DDR_A13,DD D10,DDR_D11,DDR_D12,	R_A14,DDR_A15,DDR_ODT,DDR	_D0,DD
$V_{\text{IH}}$	High-level input voltage		0.65 × VDDS_DDR	P	V
$V_{IL}$	Low-level input voltage			0.35 × VDDS_DDR	V
$V_{HYS}$	Hysteresis voltage at an input	Hysteresis voltage at an input		0.25	V
$V_{OH}$	High level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OH</sub> = 8 mA	VDDS_DDR - 0.4	Ty	V
$V_{OL}$	Low level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OL</sub> = 8 mA		0.4	V
	Input leakage current, Receiver disabled, pullup or pull	down inhibited		10	
$I_{l}$	Input leakage current, Receiver disabled, pullup enable	ed	-240	-80	μΑ
	Input leakage current, Receiver disabled, pulldown ena	bled	80	240	
I <sub>OZ</sub>	Total leakage current through the terminal connection combination that may include a pullup or pulldown. The disabled and the pullup or pulldown is inhibited.			10	μA

DDR\_RESETn,DDR\_CSn0,DDR\_CKE,DDR\_CK,DDR\_CKn,DDR\_CASn,DDR\_RASn,DDR\_WEn,DDR\_BA0,DDR\_BA1,DDR\_BA2,DDR\_A0,DDR\_A1,DDR\_A
2,DDR\_A3,DDR\_A4,DDR\_A5,DDR\_A6,DDR\_A7,DDR\_A8,DDR\_A9,DDR\_A10,DDR\_A11,DDR\_A12,DDR\_A13,DDR\_A14,DDR\_A15,DDR\_ODT,DDR\_D0,DD
R\_D1,DDR\_D2,DDR\_D3,DDR\_D4,DDR\_D5,DDR\_D6,DDR\_D7,DDR\_D8,DDR\_D9,DDR\_D10,DDR\_D11,DDR\_D12,DDR\_D13,DDR\_D14,DDR\_D15,DDR\_D4,DDR\_D4,DDR\_D25,DDR\_D

V <sub>H</sub> ⊃	High-level input voltage		DDR_VREF + 0.125		V
V <sub>HYS</sub>	Hysteresis voltage at an input		000	N/A	V
V <sub>OH</sub>	High-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OH</sub> = 8 mA	VDDS_DDR - 0.4		V
V <sub>OL</sub>	Low-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OL</sub> = 8 mA	~~.	0.4	V
	Input leakage current, Receiver disabled, pullup or pull	down inhibited	1	10	
I <sub>I</sub>	Input leakage current, Receiver disabled, pullup enable	ed	-240	-80	μA
	Input leakage current, Receiver disabled, pulldown ena	bled	80	240	
l <sub>oz</sub>	Total leakage current through the terminal connection of combination that may include a pullup or pulldown. The disabled and the pullup or pulldown is inhibited.			10	μA

DDR\_RESETn,DDR\_CSn0,DDR\_CKE,DDR\_CK,DDR\_CKn,DDR\_CASn,DDR\_RASn,DDR\_WEn,DDR\_BA0,DDR\_BA1,DDR\_BA2,DDR\_A0,DDR\_A1,DDR\_A
2,DDR\_A3,DDR\_A4,DDR\_A5,DDR\_A6,DDR\_A7,DDR\_A8,DDR\_A9,DDR\_A10,DDR\_A11,DDR\_A12,DDR\_A13,DDR\_A14,DDR\_A15,DDR\_QDT,DDR\_D0,DD
R\_D1,DDR\_D2,DDR\_D3,DDR\_D4,DDR\_D5,DDR\_D6,DDR\_D7,DDR\_D8,DDR\_D9,DDR\_D10,DDR\_D11,DDR\_D12,DDR\_D13,DDR\_D14,DDR\_D15,DDR\_D0,DDR\_DQM
0,DDR\_DQM1,DDR\_DQS0,DDR\_DQS0,DDR\_DQS1,DDR\_DQS1,DDR\_DQS11,DDR\_DDR3, DDR3L - HSTL Mode)

V <sub>IH</sub>	High-level input voltage	VDDS_DDR = 1.5 V	DDR_VREF + 0.1	Ť	V
		VDDS_DDR = 1.35 V	DDR_VREF + 0.09		
V	Low-level input voltage	VDDS_DDR = 1.5 V		DDR_VREF - 0.1	V
V <sub>IL</sub>	Low-lever input voltage	VDDS_DDR = 1.35 V		DDR_VREF - 0.09	V
V <sub>HYS</sub>	Hysteresis voltage at an input	,O,		N/A	V
Уон	High-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OH</sub> = 8 mA	VDDS_DDR - 0.4		V
Volume	Low-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OL</sub> = 8 mA	000	0.4	V
52	Input leakage current, Receiver disabled, pullup or pulldov	wn inhibited	2	10	
I <sub>I</sub>	Input leakage current, Receiver disabled, pullup enabled		-240	-80	μΑ
	Input leakage current, Receiver disabled, pulldown enable	ed	80	240	

The interfaces or signals described in this table correspond to the interfaces or signals available in multiplexing mode 0. All interfaces or signals multiplexed on the terminals described in this table have the same DC electrical characteristics.

Specifications



## DC Electrical Characteristics<sup>(1)</sup> (continued)

	PARAMETER		MIN	NOM	MAX	UNIT
I <sub>OZ</sub>	Total leakage current through the terminal connection o combination that may include a pullup or pulldown. The				10	μА
	disabled and the pullup or pulldown is inhibited.	•	1	1,		
	PWM0_OUT,UART0_CTSn,UART0_RTSn,UART0_RXD, _EVENT_INTR0,XDMA_EVENT_INTR1,WARMRSTn,EXT					A,I2C0
V <sub>IH</sub>	High-level input voltage		0.65 × VDDSHV6	17		V
$V_{IL}$	Low-level input voltage			0.35 ×	VDDSHV6	V
$V_{HYS}$	Hysteresis voltage at an input	e at an input		<b>(</b> A)	0.305	V
V <sub>OH</sub>	High-level output voltage, driver enabled, pullup or pulldown disabled	led				V
V <sub>OL</sub>	Low-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OL</sub> = 4 mA			0.45	V
	Input leakage current, Receiver disabled, pullup or pullo			8		
4	Input leakage current, Receiver disabled, pullup enable	d	-161	-100	<b>-</b> 52	μΑ
	Input leakage current, Receiver disabled, pulldown enal	bled	52	100	170	
loz	Total leakage current through the terminal connection o combination that may include a pullup or pulldown. The disabled and the pullup or pulldown is inhibited.				8	μA
	PWM0_OUT,UART0_CTSn,UART0_RTSn,UART0_RXD, _EVENT_INTR0,XDMA_EVENT_INTR1,WARMRSTn,EXT					A,I2C
Уін	High-level input voltage	7	2			V
112	Low-level input voltage	1/1	1-		0.8	V
/HYS O	Hysteresis voltage at an input		0.265		0.44	V
/ <sub>ОН</sub>	High-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OH</sub> = 4 mA	VDDSHV6 - 0.45			V
V <sub>OL</sub>	Low-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OL</sub> = 4 mA	1/0.		0.45	V
	Input leakage current, Receiver disabled, pullup or pullo	down inhibited			18	
I	Input leakage current, Receiver disabled, pullup enable	d	-243	-100	-19	μΑ
	Input leakage current, Receiver disabled, pulldown enal	bled	51	110	210	
oz	Total leakage current through the terminal connection o combination that may include a pullup or pulldown. The disabled and the pullup or pulldown is inhibited.			PAX	18	μA
TCK (VDDSI	HV6 = 1.8 V)			//		
V <sub>IH</sub>	High-level input voltage		1.45	·?		V
V <sub>IL</sub>	Low-level input voltage				0.46	V
V <sub>HYS</sub>	Hysteresis voltage at an input		0.4		1//	V
1113	Input leakage current, Receiver disabled, pullup or pullo	down inhibited			8	
ı	Input leakage current, Receiver disabled, pullup enabled		-161	-100	-52	μA
	Input leakage current, Receiver disabled, pulldown enal		52	100	170	
TCK (VDDSI	HV6 = 3.3 V)		1			
V <sub>IH</sub>	High-level input voltage		2.15			V
V <sub>IL</sub>	Low-level input voltage	2	20		0.46	V
V <sub>HYS</sub>	Hysteresis voltage at an input		0.4		0.10	V
*1175	Input leakage current, Receiver disabled, pullup or pullo	lown inhibited	0.1		18	
7	Input leakage current, Receiver disabled, pullup enabled		-243	-100	-19	μA
15	Input leakage current, Receiver disabled, pullup enabled Input leakage current, Receiver disabled, pulldown enabled		51	110	210	μΛ
PWRONEST	In (VDDSHV6 = 1.8 or 3.3 V) <sup>(2)</sup>	0.00	1000	110	210	
<del></del>	High-level input voltage		1.35			V
V <sub>IH</sub>	<i>A</i>		1.33		0.5	V
V <sub>IL</sub>	Low-level input voltage		0.05		0.5	
V <sub>HYS</sub>	Hysteresis voltage at an input	V 46V	0,07		0.4	V
l <sub>l</sub>	Input leakage current	V <sub>I</sub> = 1.8 V		<del>)</del>	0.1	μΑ
	111	$V_1 = 3.3 \text{ V}$		1.	2	-

The input voltage thresholds for this input are not a function of VDDSHV6. (2)

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## DC Electrical Characteristics<sup>(1)</sup> (continued)

over recommended ranges of supply voltage and operating temperature (unless otherwise noted)

	PARAMETER		MIN	NOM	MAX	UNIT
RTC_PWROI	NRSTn /		7/.			
V <sub>IH</sub>	High-level input voltage		0.65 × VDDS_RTC	4,		V
V <sub>IL</sub>	Low-level input voltage			C/D	0.35 × VDDS_RTC	V
V <sub>HYS</sub>	Hysteresis voltage at an input		0.065	'7x		V
l <sub>i</sub>	Input leakage current		-1		1	μA
PMIC_POWE	R EN				Q,	
V <sub>OH</sub>	High-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OH</sub> = 6 mA	VDDS_RTC - 0.45		TA	V
V <sub>OL</sub>	Low-level output voltage, driver enabled pullup or pulldown disabled	I <sub>OL</sub> = 6 mA			0.45	V
h	Input leakage current, Receiver disabled, pullup or pulldo	wn inhibited	-1		1	μA
	Input leakage current, Receiver disabled, pullup enabled		-200	-40		
	Input leakage current, Receiver disabled, pulldown enable	ed	40		200	
l <sub>OZ</sub>	Total leakage current through the terminal connection of a combination that may include a pullup or pulldown. The disabled and the pullup or pulldown is inhibited.	a driver-receiver	-1		1	μА
EXT_WAKE	JP	7,2	I			
Уін	High-level input voltage	A	0.65 × VDDS_RTC			٧
V <sub>I</sub> U <sub>2</sub>	Low-level input voltage		(J)		0.35 × VDDS_RTC	V
V <sub>HYS</sub>	Hysteresis voltage at an input		0.15			V
	Input leakage current, Receiver disabled, pullup or pulldo	wn inhibited	7_1-1		1	μΑ
•	Input leakage current, Receiver disabled, pullup enabled		-200		-40	
	Input leakage current, Receiver disabled, pulldown enable	ed	40		200	
XTALIN (OS	CO) /			1	+	
V <sub>IH</sub>	High-level input voltage		0.65 × VDDS_OSC	700		٧
V <sub>IL</sub>	Low-level input voltage			772	0.35 × VDDS_OSC	V
RTC_XTALIN	(OSC1)		1		<u> </u>	
V <sub>IH</sub>	High-level input voltage		0.65 × VDDS_RTC	1	94	V
V <sub>IL</sub>	Low-level input voltage				0.35 × VDDS_RTC	V
All other LV	CMOS pins (VDDSHVx = 1.8 V; x = 1 to 6)		I			
V <sub>IH</sub>	High-level input voltage		0.65 × VDDSHVx			V
V <sub>IL</sub>	Low-level input voltage			0.3	5 × VDDSHVx	V
V <sub>HYS</sub>	Hysteresis voltage at an input		0.18		0.305	V
V <sub>OH</sub>	High-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OH</sub> = 6 mA	VDDSHVx - 0.45			V
V <sub>OL</sub>	Low-level output voltage, driver enabled, pullup or pulldown disabled	$I_{OL} = 6 \text{ mA}$			0.45	V
	Input leakage current, Receiver disabled, pullup or pulldo	wn inhibited			8	
	Input leakage current, Receiver disabled, pullup enabled	1//	-161	-100	-52	μA
(P)	Input leakage current, Receiver disabled, pulldown enable	ed	52	100	170	
oz OZ	Total leakage current through the terminal connection of a combination that may include a pullup or pulldown. The disabled and the pullup or pulldown is inhibited.	a driver-receiver	35		8	μA
All other LV	CMOS pins (VDDSHVx = 3.3 V; x = 1 to 6)		4//			
V <sub>IH</sub>	High-level input voltage		2			V
V <sub>IL</sub>	Low-level input voltage		-0	1	0.8	V
V <sub>HYS</sub>	Hysteresis voltage at an input		0.265	4,	0.44	V
· H12		1	0.200	- / /	U.77	· ·

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Specifications



DC Electrical Characteristics<sup>(1)</sup> (continued)

over recommended ranges of supply voltage and operating temperature (unless otherwise noted)

	PARAMETER		MIN	NOM	MAX	UNIT
V <sub>OH</sub>	High-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OH</sub> = 6 mA	VDDSHVx - 0.45			V
V <sub>OL</sub>	Low-level output voltage, driver enabled, pullup or pulldown disabled	I <sub>OL</sub> = 6 mA	1,	7(,,	0.45	V
	Input leakage current, Receiver disabled, pullup or pul	ldown inhibited		P	18	
$I_1$	Input leakage current, Receiver disabled, pullup enable	ed	-243	-100	-19	μΑ
	Input leakage current, Receiver disabled, pulldown ena	abled	51	110	210	
I <sub>OZ</sub>	Total leakage current through the terminal connection combination that may include a pullup or pulldown. The disabled and the pullup or pulldown is inhibited.			74	18	μА

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### 5.8 Thermal Resistance Characteristics for ZCE and ZCZ Packages

Failure to maintain a junction temperature within the range specified in Section 5.5 reduces operating lifetime, reliability, and performance—and may cause irreversible damage to the system. Therefore, the product design cycle should include thermal analysis to verify the maximum operating junction temperature of the device. It is important this thermal analysis is performed using specific system use cases and conditions. TI provides an application report to aid users in overcoming some of the existing challenges of producing a good thermal design. For more information, see AM335x Thermal Considerations (SPRABT1).

Table 5-12 provides thermal characteristics for the packages used on this device.

#### NOTE

Table 5-12 provides simulation data and may not represent actual use-case values.

Table 5-12. Thermal Resistance Characteristics (PBGA Package) [ZCE and ZCZ]

		ZCE (°C/W) <sup>(1)</sup>	ZCZ (°C/W) <sup>(1)</sup>	AIR FLOW (m/s) <sup>(3)</sup>
$R_{\Theta JC}$	Junction-to-case	10.3	10.2	N/A
$R_{\Theta JB}$	Junction-to-board	11.6	12.1	N/A
R <sub>⊝JA</sub>	Junction-to-free air	24.7	24.2	0
1	No.	20.5	20.1	1.0
(C)		19.7	19.3	2.0
05		19.2	18.8	3.0
ФЈТ	Junction-to-package top	0.4	0.3	0.0
•	4 <sub>A</sub>	0.6	0.6	1.0
		0.7	0.7	2.0
	1.	0.9	0.8	3.0
ФЈВ	Junction-to-board	11.9	12.7	0.0
	<b>P</b>	11.7	12.3	1.0
	'A'	11.7	12.3	2.0
		11.6	12.2	3.0

These values are based on a JEDEC-defined 2S2P system (with the exception of the theta JC [Relic] value, which is based on a JEDEC-defined 1S0P system) and will change based on environment as well as application. For more information, see these EIA/JEDEC standards:

- JESD51-2, Integrated Circuits Thermal Test Method Environmental Conditions Natural Convection (Still Air
- JESD51-3, Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages
- JESD51-7, High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages
- JESD51-9, Test Boards for Area Array Surface Mount Package Thermal Measurements
- Power dissipation of 2 W and an ambient temperature of 70°C is assumed.
- °C/W = degrees Celsius per watt.



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## 5.9 External Capacitors

To improve module performance, decoupling capacitors are required to suppress the switching noise generated by high frequency and to stabilize the supply voltage. A decoupling capacitor is most effective when it is close to the device, because this minimizes the inductance of the circuit board wiring and interconnects.

### 5.9.1 Voltage Decoupling Capacitors

Table 5-13 summarizes the Core voltage decoupling characteristics.

### 5.9.1.1 Core Voltage Decoupling Capacitors

To improve module performance, decoupling capacitors are required to suppress high-frequency switching noise and to stabilize the supply voltage. A decoupling capacitor is most effective when located close to the AM335x device, because this minimizes the inductance of the circuit board wiring and interconnects.

Table 5-13. Core Voltage Decoupling Characteristics

	PARAMETER	TYP	UNIT
C <sub>VDD_CORE</sub> <sup>(1)</sup>	2	10.08	μF
C <sub>VDD_MPU</sub> <sup>(2)(3)</sup>	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	10.05	μF

- (1) The typical value corresponds to 1 cap of 10  $\mu$ F and 8 caps of 10 nF.
- (2) Not available on the ZCE package. VDD\_MPU is merged with VDD\_CORE on the ZCE package.
- (3) The typical value corresponds to 1 cap of 10 µF and 5 caps of 10 nF.

### 5.9.1.2 IO and Analog Voltage Decoupling Capacitors

Table 5-14 summarizes the power-supply decoupling capacitor recommendations.

Table 5-14. Power-Supply Decoupling Capacitor Characteristics

PARAMETER PARAMETER	1/1, TYP	UNIT
C <sub>VDDA_ADC</sub>	10	nF
C <sub>VDDA1P8V_USB0</sub>	10	nF
C <sub>CVDDA3P3V_USB0</sub>	10	nF
C <sub>VDDA1P8V_USB1</sub> <sup>(1)</sup>	10	nF
C <sub>VDDA3P3V_USB1</sub> <sup>(1)</sup>	10	nF
C <sub>VDDS</sub> <sup>(2)</sup>	10.04	μF
C <sub>VDDS_DDR</sub>	(3)	· V
C <sub>VDDS_OSC</sub>	10	nF
C <sub>VDDS_PLL_DDR</sub>	10	nF
C <sub>VDDS_PLL_CORE_LCD</sub>	10	nF
C <sub>VDDS_SRAM_CORE_BG</sub> <sup>(4)</sup>	10.01	μF
C <sub>VDDS_SRAM_MPU_BB</sub> <sup>(5)</sup>	10.01	μF
C <sub>VDDS_PLL_MPU</sub>	10	nF
C <sub>VDDS_RTC</sub>	10	nF
C <sub>VDDSHV1</sub> <sup>(6)</sup>	10.02	μF
C <sub>VDDSHV2</sub> (1)(6)	10.02	μF
C <sub>VDDSHV3</sub> (1)(6)	10.02	μF
C <sub>VDDSHV4</sub> <sup>(6)</sup>	10.02	μF
C <sub>VDDSHV5</sub> <sup>(6)</sup>	10.02	μF
C <sub>VDDSHV6</sub> <sup>(7)</sup>	10.06	μF

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(1) Not available on the ZCE package.

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- (2) Typical values consist of 1 cap of 10 μF and 4 caps of 10 nF.
- (3) For more details on decoupling capacitor requirements for the mDDR(LPDDR), DDR2, DDR3, DDR3L memory interface, see Section 7.7.2.1.2.6 and Section 7.7.2.1.2.7 when using mDDR(LPDDR) memory devices, Section 7.7.2.2.2.6 and Section 7.7.2.2.2.2.6 when using DDR2 memory devices, or Section 7.7.2.3.3.6 and Section 7.7.2.3.3.7 when using DDR3 or DDR3L memory devices.
- (4) VDDS\_SRAM\_CORE\_BG supply powers an internal LDO for SRAM supplies. Inrush currents could cause voltage drop on the VDDS SRAM CORE BG supplies when the SRAM LDO is enabled after powering up VDDS SRAM CORE BG terminals. A 10 µF is recommended to be placed close to the terminal and routed with widest traces possible to minimize the voltage drop on VDDS\_SRAM\_CORE\_BG terminals.
- (5) VDDS\_SRAM\_MPU\_BB supply powers an internal LDO for SRAM supplies. Inrush currents could cause voltage drop on the VDDS SRAM MPU BB supplies when the SRAM LDO is enabled after powering up VDDS SRAM MPU BB terminals. A 10 µF is recommended to be placed close to the terminal and routed with widest traces possible to minimize the voltage drop on VDDS\_SRAM\_MPU\_BB terminals.
- (6) Typical values consist of 1 cap of 10 µF and 2 caps of 10 nF.
- (7) Typical values consist of 1 cap of 10 μF and 6 caps of 10 nF.

### 5.9.2 Output Capacitors

Internal low dropout output (LDO) regulators require external capacitors to stabilize their outputs. These capacitors should be placed as close as possible to the respective terminals of the AM335x device. Table 5-15 summarizes the LDO output capacitor recommendations.

**Table 5-15. Output Capacitor Characteristics** 

PARAMETER	71	TYP	UNIT
CCAP_VDD_SRAM_CORE (1)	7,5	1	μF
CCAP_VDD_RTC <sup>(1)(2)</sup>		1	μF
C <sub>CAP_VDD_SRAM_MPU</sub> <sup>(1)</sup>	2	1	μF
C <sub>CAP_VBB_MPU</sub> <sup>(1)</sup>	1/2.	1	μF

(1) LDO regulator outputs should not be used as a power source for any external components.

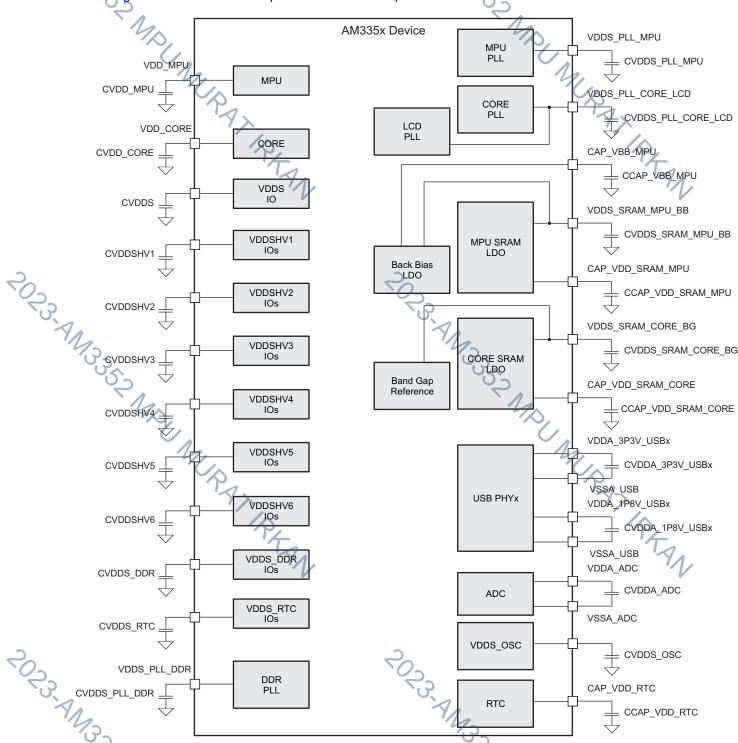
(2) The CAP\_VDD\_RTC terminal operates as an input to the RTC core voltage domain when the RTC\_KLDO\_ENn terminal is high. MURAX PAN UPA) Ptan

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Figure 5-1 shows an example of the external capacitors.



Decoupling capacitors must be placed as closed as possible to the power terminal. Choose the ground located closest to the power pin for each decoupling capacitor. In case of interconnecting powers, first insert the decoupling capacitor and then interconnect the powers.

The decoupling capacitor value depends on the board characteristics.

Figure 5-1. External Capacitors



### 5.10 Touch Screen Controller and Analog-to-Digital Subsystem Electrical Parameters

The touch screen controller (TSC) and analog-to-digital converter (ADC) subsystem (TSC\_ADC) is an 8channel general-purpose ADC with optional support for interleaving TSC conversions for 4-wire, 5-wire, or 8-wire resistive panels. The TSC\_ADC subsystem can be configured for use in one of the following MURAX PERM applications:

- 8 general-purpose ADC channels
- 4-wire TSC with 4 general-purpose ADC channels
- 5-wire TSC with 3 general-purpose ADC channels
- 8-wire TSC.

Table 5-16 summarizes the TSC\_ADC subsystem electrical parameters.

Table 5-16. TSC\_ADC Electrical Parameters

	_	ADO Electrical i arai			
PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
Analog Input					
VREFP <sup>(1)</sup>		(0.5 × VDDA_ADC) + 0.25		VDDA_ADC	V
VREFN <sup>(1)</sup>		0		(0.5 × VDDA_ADC) – 0.25	V
VREFP + VREFN <sup>(1)</sup>		\ <u>\</u> \\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	VDDA_ADC		V
<b>4</b>	Internal voltage reference	<b>4</b> 0		VDDA_ADC	
Full-scale input range	External voltage reference	VREFN		VREFP	V
Differential non-linearity (DNL)	Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP - VREFN = 1.8 V	25	0.5	1	LSB
No.	Source impedance = 50 Ω Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP – VREFN = 1.8 V	-2	M	2	LSB
Integral non-linearity (INL)	Source impedance = 1 kΩ Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP – VREFN = 1.8 V		±1	19) Pty	LSB
Gain error	Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP – VREFN = 1.8 V		±2	As .	LSB
Offset error	Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP – VREFN = 1.8 V		±2		LSB
Input sampling capacitance		2	5.5		pF
Signal-to-noise ratio (SNR)	Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP - VREFN = 1.8 V Input signal: 30-kHz sine wave at -0.5-dB full scale	PSAMS	70		dB
Total harmonic distortion (THD)	Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP - VREFN = 1.8 V Input signal: 30-kHz sine wave at -0.5-dB full scale	ODS, AMOSS.	NO 75		dB

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Y,	SPRS717I – OCTOBER 2011 – RI	EVISED DECEMBER 2015	W	ww.ti.com
		Table 5-16. TSC_ADC E	lectrical Parameters (continued)	
	PARAMETER	TEST CONDITIONS	MIN NOM MAX	UNIT
	Spurious free dynamic range	Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP - VREFN = 1.8 V Input signal: 30-kHz sine wave at -0.5-dB full scale		dB
	Signal-to-noise plus distortion	Internal voltage reference: VDDA_ADC = 1.8 V External voltage reference: VREFP - VREFN = 1.8 V Input signal: 30-kHz sine wave at -0.5-dB full scale	69	dB
	VREFP and VREFN input in	npedance	20	kΩ
	Input impedance of AIN[7:0] <sup>(2)</sup>	f = Input frequency	[1 / ((65.97 × 10 <sup>-12</sup> ) × <i>f</i> )]	Ω
	Sampling Dynamics			
	Conversion time		15	ADC clock cycles
	Acquisition time		2	ADC clock cycles
	Sampling rate	ADC clock = 3 MHz	200	kSPS
Ť	Channel-to-channel isolation	1	100	dB
	Touch Screen Switch Drive	ers		
	Pullup and pulldown switch	ON resistance (Ron)	2	Ω
	Pullup and pulldown switch current leakage lleak	Source impedance = $500 \Omega$	0.5	uA
	Drive current		25	mA
	Touch screen resistance		6	kΩ
	Pen touch detect		2	kΩ
	(1) VREFP and VREFN mu	ust be tied to ground if the internal vo	oltage reference is used.	
	(2) This parameter is valid v	when the respective AIN terminal is	oltage reference is used. configured to operate as a general-purpose ADC input.	

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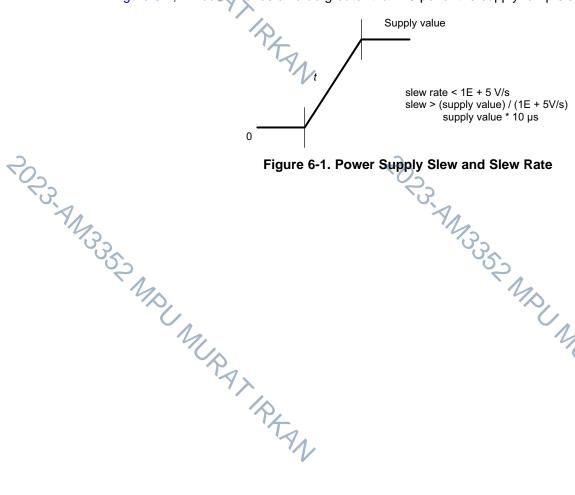
Product Folder Links: AM3359 AM3358 AM3357 AM3356 AM3354 AM3352 AM3351



- **Power and Clocking** 6
- **Power Supplies** 6.1

#### 6.1.1 Power Supply Slew Rate Requirement

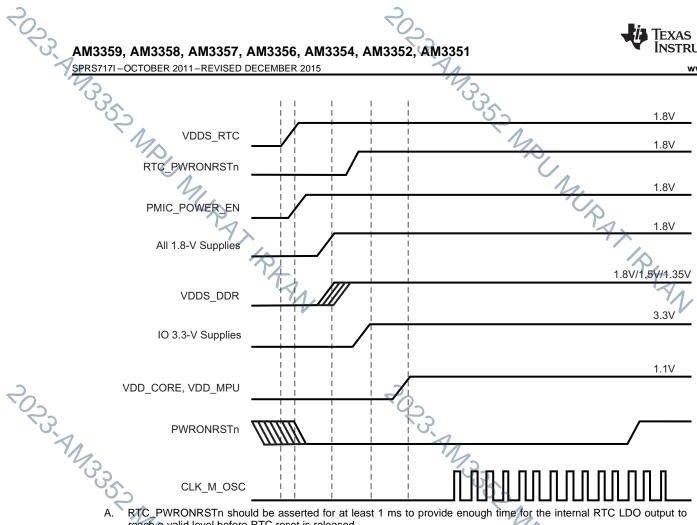
SSS MAL To maintain the safe operating range of the internal ESD protection devices. TI recommends limiting the maximum slew rate for powering on the supplies to be less than 1.0E +5 V/s. For instance, as shown in Figure 6-1, TI recommends a value greater than 18 µs for the supply ramp slew for a 1.8-V supply.



Ally Six Portal Manager Manage Figure 6-1. Power Supply Slew and Slew Rate

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- RTC\_PWRONRSTn should be asserted for at least 1 ms to provide enough time for the internal RTC LDO output to reach a valid level before RTC reset is released.
- When using the ZCZ package option, VDD\_MPU and VDD\_CORE power inputs may be powered from the same source if the application only uses operating performance points (OPPs) that define a common power supply voltage for VDD\_MPU and VDD\_CORE. The ZCE package option has the VDD\_MPU domain merged with the VDD\_CORE domain.
- If a USB port is not used, the respective VDDA1P8V\_USB terminal may be connected to any 1.8-V power supply and the respective VDDA3P3V\_USB terminal may be connected to any 3.3-V power supply. If the system does not have a 3.3-V power supply, the VDDA3P3V\_USB terminal may be connected to ground.
- D. If the system uses mDDR of DDR2 memory devices, VDDS\_DDR can be ramped simultaneously with the other 1.8-V IO power supplies.
- VDDS\_RTC can be ramped independent of other power supplies if PMIC\_POWER\_EN functionality is not required. If VDDS\_RTC is ramped after VDD\_CORE, there might be a small amount of additional leakage current on VDD\_CORE. The power sequence shown provides the lowest leakage option.
- To configure VDDSHVx [1-6] as 1.8 V, power up the respective VDDSHVx [1-6] to 1.8 V following the recommended sequence. To configure VDDSHVx [1-6] as 3.3 V, power up the respective VDDSHVx [1-6] to 3.3 V following the recommended sequence.

POPS: ANDSSE MALMUR Figure 6-2. Preferred Power-Supply Sequencing With Dual-Voltage IOs Configured as 3.3 V

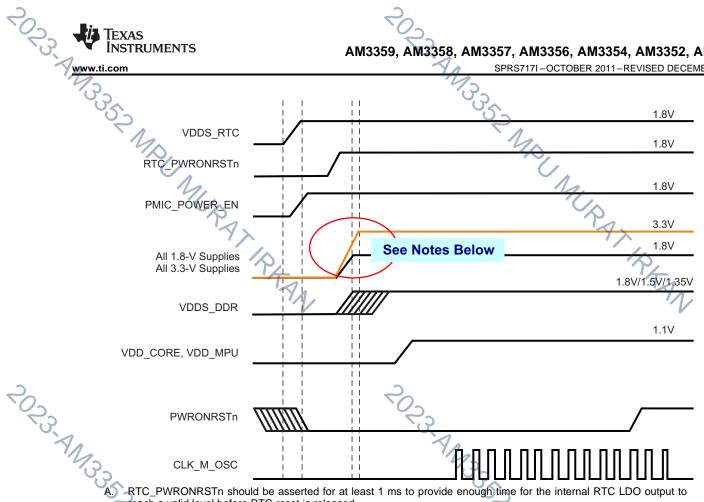
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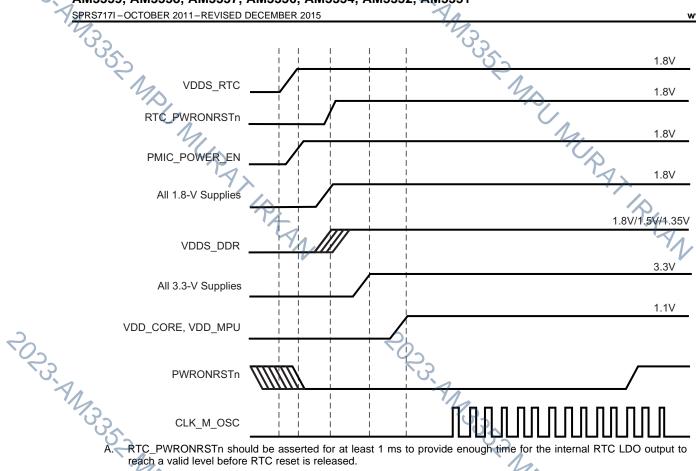




- RTC\_PWRONRSTn should be asserted for at least 1 ms to provide enough time for the internal RTC LDO output to reach a valid level before RTC reset is released.
- The 3.3-V IO power supplies may be ramped simultaneously with the 1.8-V IO power supplies if the voltage sourced by any 3.3-V power supplies does not exceed the voltage sourced by any 1.8-V power supply by more than 2 V. Serious reliability issues may occur if the system power supply design allows any 3.3-V IO power supplies to exceed any 1.8-V IO power supplies by more than 2 V.
- When using the ZCZ package option, VDD\_MPU and VDD\_CORE power inputs may be powered from the same source if the application only uses operating performance points (OPPs) that define a common power supply voltage for VDD\_MPU and VDD\_CORE. The ZCE package option has the VDD\_MPU domain merged with the VDD\_CORE
- If a USB port is not used, the respective VDDA1P8V USB terminal may be connected to any 1.8-V power supply and the respective VDDA3P3V\_USB terminal may be connected to any 3.3-V power supply. If the system does not have a 3.3-V power supply, the VDDA3P3V\_USB terminal may be connected to ground.
- If the system uses mDDR or DDR2 memory devices, VDDS DDR can be ramped simultaneously with the other 1.8-V IO power supplies.
- VDDS\_RTC can be ramped independent of other power supplies if PMIC\_POWER\_EN functionality is not required. If VDDS\_RTC is ramped after VDD\_CORE, there might be a small amount of additional leakage current on VDD\_CORE. The power sequence shown provides the lowest leakage option.
- To configure VDDSHVx [1-6] as 1.8 V, power up the respective VDDSHVx [1-6] to 1.8 V following the recommended sequence. To configure VDDSHVx [1-6] as 3.3 V, power up the respective VDDSHVx [1-6] to 3.3 V following the POPS-AMBSSE MANUAL MUR recommended sequence.

S. AMBUMUR Figure 6-3. Alternate Power-Supply Sequencing with Dual-Voltage IOs Configured as 3.3 V





- RTC\_PWRONRSTn should be asserted for at least 1 ms to provide enough time for the internal RTC LDO output to reach a valid level before RTC reset is released.
- When using the ZCZ package option, VDD\_MPU and VDD\_CORE power inputs may be powered from the same source if the application only uses operating performance points (OPPs) that define a common power supply voltage for VDD\_MPU and VDD\_CORE. The ZCE package option has the VDD\_MPU domain merged with the VDD\_CORE domain.
- If a USB port is not used, the respective VDDA1P8V\_USB terminal may be connected to any 1.8-V power supply and the respective VDDA3P3V USB terminal may be connected to any 3.3-V power supply. If the system does not have a 3.3-V power supply, the VDDA3P3V\_USB terminal may be connected to ground.
- If the system uses mDDR or DDR2 memory devices, VDDS DDR can be ramped simultaneously with the other 1.8-V IO power supplies.
- VDDS\_RTC can be ramped independent of other power supplies if PMIC\_POWER\_EN functionality is not required. If VDDS\_RTC is ramped after VDD\_CORE, there might be a small amount of additional leakage current on VDD\_CORE. The power sequence shown provides the lowest leakage option.
- To configure VDDSHVx [1-6] as 1.8 V, power up the respective VDDSHVx [1-6] to 1.8 V following the recommended sequence. To configure VDDSHVx [1-6] as 3.3 V, power up the respective VDDSHVx [1-6] to 3.3 V following the recommended sequence.

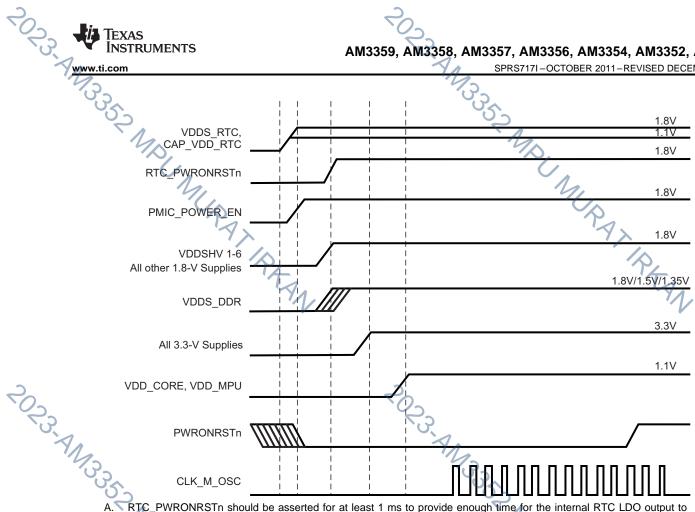
Figure 6-4. Power-Supply Sequencing With Dual-Voltage IOs Configured as 1.8 V

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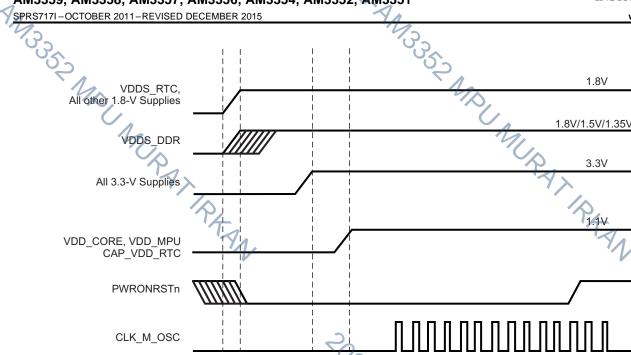
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- RTC\_PWRONRSTn should be asserted for at least 1 ms to provide enough time for the internal RTC LDO output to reach a valid level before RTC reset is released.
- The CAP\_VDD\_RTC terminal operates as an input to the RTC core voltage domain when the internal RTC LDO is disabled by connecting the RTC\_KALDO\_ENn terminal to VDDS\_RTC. If the internal RTC LDO is disabled, CAP\_VDD\_RTC should be sourced from an external 1.1-V power supply.
- When using the ZCZ package option, VDD\_MPU and VDD\_CORE power inputs may be powered from the same source if the application only uses operating performance points (OPPs) that define a common power supply voltage for VDD\_MPU and VDD\_CORE. The ZCE package option has the VDD\_MPU domain merged with the VDD\_CORE
- If a USB port is not used, the respective VDDA1P8V\_USB terminal may be connected to any 1.8-V power supply and the respective VDDA3P3V USB terminal may be connected to any 3.3-V power supply. If the system does not have a 3.3-V power supply, the VDDA3P3V USB terminal may be connected to ground.
- If the system uses mDDR or DDR2 memory devices, VDDS DDR can be ramped simultaneously with the other 1.8-V IO power supplies.
- VDDS\_RTC should be ramped at the same time or before CAP\_VDD\_RTC, but these power inputs can be ramped independent of other power supplies if PMIC\_POWER\_EN functionality is not required. If CAP\_VDD\_RTC is ramped after VDD\_CORE, there might be a small amount of additional leakage current on VDD\_CORE. The power sequence shown provides the lowest leakage option.
- POPS-AMBSSE MAN MAR THE TOTAL POPSITION OF THE POPSITION To configure VDDSHVx [1-6] as 1.8 V, power up the respective VDDSHVx [1-6] to 1.8 V following the recommended sequence. To configure VDDSHVx [1-6] as 3.3 V, power up the respective VDDSHVx [1-6] to 3.3 V following the recommended sequence.

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- CAP\_VDD\_RTC terminal operates as an input to the RTC core voltage domain when the internal RTC LDO is disabled by connecting the RTC\_KALDO\_ENn terminal to VDDS\_RTC. If the internal RTC LDO is disabled, CAP\_VDD\_RTC should be sourced from an external 1.1-V power supply. The PMIC\_POWER\_EN output cannot be used when the RTC is disabled.
- When using the ZCZ package option, VDD\_MPU and VDD\_CORE power inputs may be powered from the same source if the application only uses operating performance points (OPPs) that define a common power supply voltage for VDD\_MPU and VDD\_CORE. The ZCE package option has the VDD\_MPU domain merged with the VDD\_CORE
- If a USB port is not used, the respective VDDA1P8V\_USB terminal may be connected to any 1.8-V power supply and the respective VDDA3P3V\_USB terminal may be connected to any 3.3-V power supply. If the system does not have a 3.3-V power supply, the VDDA3P3V\_USB terminal may be connected to ground.
- If the system uses mDDR or DDR2 memory devices, VDDS\_DDR can be ramped simultaneously with the other 1.8-V IO power supplies.
- VDDS\_RTC should be ramped at the same time or before CAP\_VDD\_RTC, but these power inputs can be ramped independent of other power supplies if PMIC\_POWER\_EN functionality is not required. If CAP\_VDD\_RTC is ramped after VDD\_CORE, there might be a small amount of additional leakage current on VDD\_CORE. The power sequence shown provides the lowest leakage option.
- To configure VDDSHVx [1-6] as 1.8 V, power up the respective VDDSHVx [1-6] to 1.8 V following the recommended sequence. To configure VDDSHVx [1-6] as 3.3 V, power up the respective VDDSHVx [1-6] to 3.3 V following the recommended sequence.

Figure 6-6. Power-Supply Sequencing with RTC Feature Disabled

### 6.1.2 Power-Down Sequencing

PWRONRSTn input terminal should be taken low, which stops all internal clocks before power supplies are turned off. All other external clocks to the device should be shut off.

The preferred way to sequence power down is to have all the power supplies ramped down sequentially in the exact reverse order of the power-up sequencing. In other words, the power supply that has been ramped up first should be the last one that should be ramped down. This ensures there would be no spurious current paths during the power-down sequence. The VDDS power supply must ramp down after all 3.3-V VDDSHVx [1-6] power supplies.

If it is desired to ramp down VDDS and VDDSHVx [1-6] simultaneously, it should always be ensured that the difference between VDDS and VDDSHVx [1-6] during the entire power-down sequence is <2 V. Any violation of this could cause reliability risks for the device. Further it is recommended to maintain VDDS ≥1.5V as all the other supplies fully ramp down to minimize in-rush currents.

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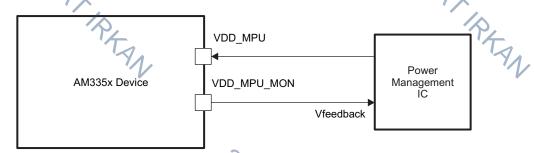
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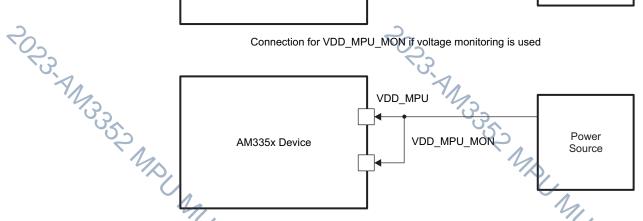
If none of the VDDSHVx [1-6] power supplies are configured as 3.3 V, the VDDS power supply may ramp down along with the VDDSHVx [1-6] supplies or after all the VDDSHVx [1-6] supplies have ramped down. It is recommended to maintain VDDS ≥1.5V as all the other supplies fully ramp down to minimize in-rush currents.

### 6.1.3 VDD MPU MON Connections

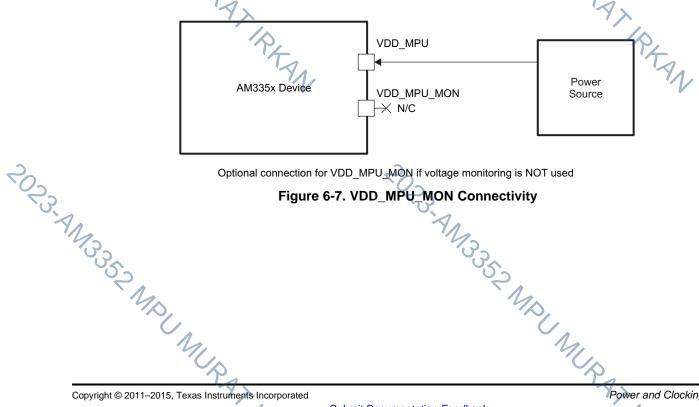
Figure 6-7 shows the VDD\_MPU\_MON connectivity. VDD\_MPU\_MON connectivity is available only on the ZCZ package.



Connection for VDD\_MPU\_MON if voltage monitoring is used



Preferred connection for VDD\_MPU\_MON if voltage monitoring is NOT used



Optional connection for VDD MPU MON if voltage monitoring is NOT used

Figure 6-7. VDD\_MPU\_MON Connectivity

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### 6.1.4 Digital Phase-Locked Loop Power Supply Requirements

The digital phase-locked loop (DPLL) provides all interface clocks and functional clocks to the processor of the AM335x device. The AM335x device integrates 5 different DPLLs-Core DPLL, Per DPLL, Display DPLL, DDR DPLL, MPU DPLL.

Figure 6-8 shows the power supply connectivity implemented in the AM335x device. Table 6-1 provides the power supply requirements for the DPLL.

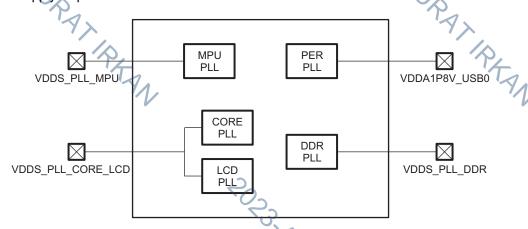


Figure 6-8. DPLL Power Supply Connectivity

Table 6-1. DPLL Power Supply Requirements

VDDS_	Figure 6-8. DPLL Power Supply Connectivity  Table 6-1. DPLL Power Supply Requirements	S_PLL_I	DDR		
SUPPLY NAME	DESCRIPTION	MIN	NOM	MAX	UNIT
VDDA1P8V_USB0	Supply voltage range for USBPHY and PER DPLL, Analog, 1.8 V	1.71	1.8	1.89	V
	Max peak-to-peak supply noise			50	mV (p-p)
VDDS_PLL_MPU	Supply voltage range for DPLL MPU, analog	1.71	1.8	1.89	V
4	Max peak-to-peak supply noise			50	mV (p-p)
VDDS_PLL_CORE_LCD	Supply voltage range for DPLL CORE and LCD, analog	1,71	1.8	1.89	V
	Max peak-to-peak supply noise	17	_	50	mV (p-p)
VDDS_PLL_DDR	Supply voltage range for DPLL DDR, analog	1.71	1.8	1.89	V
	Max peak-to-peak supply noise		10	50	mV (p-p)

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### 6.2 Clock Specifications

### Input Clock Specifications

The AM335x device has two clock inputs. Each clock input passes through an internal oscillator which can be connected to an external crystal circuit (oscillator mode) or external LVCMOS square-wave digital clock source (bypass mode). The oscillators automatically operate in bypass mode when their input is connected to an external LVCMOS square-wave digital clock source. The oscillator associated with a specific clock input must be enabled when the clock input is being used in either oscillator mode or bypass mode.

The OSC1 oscillator provides a 32.768-kHz reference clock to the real-time clock (RTC) and is connected to the RTC XTALIN and RTC XTALOUT terminals. This clock source is referred to as the 32K oscillator (CLK\_32K\_RTC) in the AM335x Sitara Processors Technical Reference Manual (SPRUH73) OSC1 is disabled by default after power is applied. This clock input is optional and may not be required if the RTC is configured to receive a clock from the internal 32k RC oscillator (CLK\_RC32K) or peripheral PLL (CLK 32KHZ) which receives a reference clock from the OSC0 input.

The OSC0 oscillator provides a 19.2-MHz, 24-MHz, 25-MHz, or 26-MHz reference clock which is used to clock all non-RTC functions and is connected to the XTALIN and XTALOUT terminals. This clock source is referred to as the master oscillator (CLK M OSC) in the AM335x Sitara Processors Technical Reference Manual (SPRUH73). OSC0 is enabled by default after power is applied.

For more information related to recommended circuit topologies and crystal oscillator circuit requirements for these clock inputs, see Section 6.2.2.

## 6.2.2 Input Clock Requirements

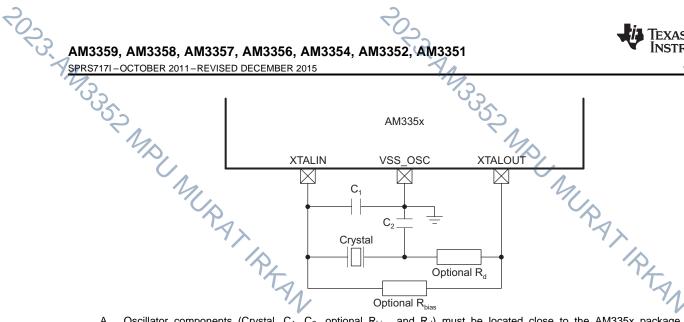
#### **OSCO Internal Oscillator Clock Source** 6.2.2.1

Figure 6-9 shows the recommended crystal circuit. It is recommended that pre-production printed circuit board (PCB) designs include the two optional resistors R<sub>bias</sub> and R<sub>d</sub> in case they are required for proper oscillator operation when combined with production crystal circuit components. In most cases, Rbias is not required and  $R_d$  is a  $0-\Omega$  resistor. These resistors may be removed from production PCB designs after evaluating oscillator performance with production crystal circuit components installed on pre-production PCBs.

The XTALIN terminal has a 15- to 40-k $\Omega$  internal pulldown resistor which is enabled when OSC0 is disabled. This internal resistor prevents the XTALIN terminal from floating to an invalid logic level which may increase leakage current through the oscillator input buffer.

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- Oscillator components (Crystal,  $C_1$ ,  $C_2$ , optional  $R_{\text{bias}}$  and  $R_d$ ) must be located close to the AM335x package. Parasitic capacitance to the VSS\_OSC and respective crystal circuit component grounds should be connected directly to the nearest PCB digital ground (VSS).
- C1 and C2 represent the total capacitance of the respective PCB trace, load capacitor, and other components (excluding the crystal) connected to each crystal terminal. The value of capacitors C1 and C2 should be selected to 2023. AM33 provide the total load capacitance,  $C_L$ , specified by the crystal manufacturer. The total load capacitance is  $C_L = [(C_1 \times C_2)]$  $(C_2) / (C_1 + C_2) + C_{shunt}$ , where  $C_{shunt}$  is the crystal shunt capacitance  $(C_0)$  specified by the crystal manufacturer plus any mutual capacitance (C<sub>pkg</sub> + C<sub>PCB</sub>) seen across the AM335x XTALIN and XTALOUT signals. For recommended values of crystal circuit components, see Table 6-2.

### Figure 6-9. OSC0 Crystal Circuit Schematic

### Table 6-2. OSC0 Crystal Circuit Requirements

$f_{xtal}$	METER		MIN	TYP	MAX	UNIT
J xtal	Crystal parallel resonance frequency	Fundamental mode oscillation only	40	19.2, 24, 25, or 26		MHz
	Crystal frequency stability and tolerance <sup>(1)</sup>		-50	,	50	ppm
C <sub>C1</sub>	C <sub>1</sub> capacitance	C <sub>shunt</sub> ≤ 5 pF	12	11,	24	pF
	o i sapasita	C <sub>shunt</sub> > 5 pF	18	90	24	Γ.
C <sub>C2</sub>	C <sub>2</sub> capacitance	C <sub>shunt</sub> ≤ 5 pF	12	-4>	24	pF
		C <sub>shunt</sub> > 5 pF	18		24	
C <sub>shunt</sub>	Shunt capacitance				7	pF
ESR	Crystal effective series resistance	$f_{\rm xtal}$ = 19.2 MHz, oscillator has nominal negative resistance of 272 $\Omega$ and worst-case negative resistance of 163 $\Omega$			54.4	Ω
		$f_{\text{xtal}}$ = 24 MHz, oscillator has nominal negative resistance of 240 $\Omega$ and worst-case negative resistance of 144 $\Omega$			48.0	Ω
		$f_{\rm xtal}$ = 25 MHz, oscillator has nominal negative resistance of 233 $\Omega$ and worst-case negative resistance of 140 $\Omega$			46.6	Ω
		$f_{\rm xtal}$ = 26 MHz, oscillator has nominal negative resistance of 227 $\Omega$ and worst-case negative resistance of 137 $\Omega$			45.3	Ω
	iai accuracy, temperature unit, an	d aging effects should be combined when eva	Solution a reference	Se clock for this	roquireinei	ιι.
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108	Power and Clocking			011–2015, Texas	Instruments I	ncorpora
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Table 6-3. OSC0 Crystal Circuit Characteristics

NAME	DESCRIPTION		2	MIN	TYP	MAX	UNIT
C <sub>pkg</sub>	Shunt capacitance of	ZCE package	4	<u> </u>	0.01		рF
	package	ZCZ package		7,	0.01		pF
P <sub>xtal</sub>	typical crystal power diss	ESR, $f_{\rm Xtal}$ , and C <sub>L</sub> should be used to yield a ipation value. Using the maximum values and C <sub>L</sub> parameters yields a maximum power		xtal	= 0.5 ESR C <sub>L</sub> VDDS_O	$(2 \pi f_{\text{xtal}})$	
t <sub>sX</sub>	Start-up time				1.5		ms

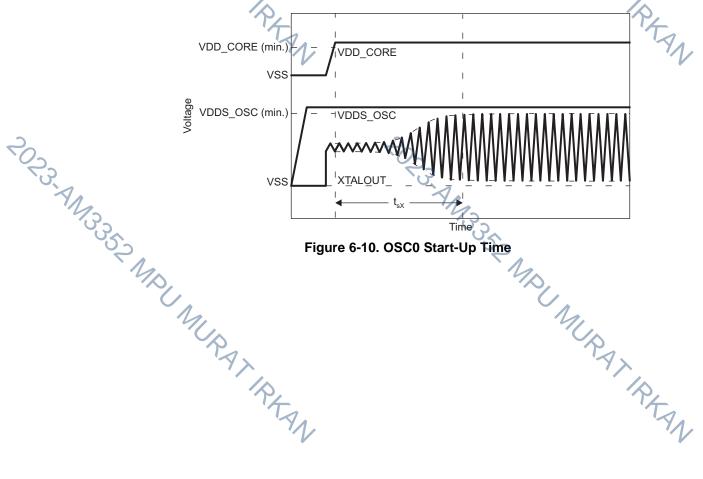


Figure 6-10. OSC0 Start-Up Time

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Power and Clocking

#### 6.2.2.2 OSC0 LVCMOS Digital Clock Source

Figure 6-11 shows the recommended oscillator connections when OSC0 is connected to an LVCMOS square-wave digital clock source. The LVCMOS clock source is connected to the XTALIN terminal. The ground for the LVCMOS clock source and VSS\_OSC should be connected directly to the nearest PCB digital ground (VSS). In this mode of operation, the XTALOUT terminal should not be used to source any external components. The printed circuit board design should provide a mechanism to disconnect the XTALOUT terminal from any external components or signal traces that may couple noise into OSC0 via the XTALOUT terminal.

The XTALIN terminal has a 15- to 40-k $\Omega$  internal pulldown resistor which is enabled when OSC0 is disabled. This internal resistor prevents the XTALIN terminal from floating to an invalid logic level which may increase leakage current through the oscillator input buffer.

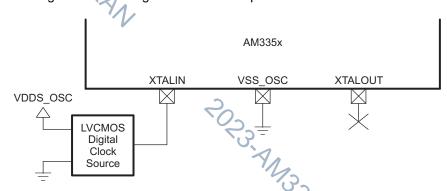


Figure 6-11. OSC0 LVCMOS Circuit Schematic

Table 6-4. OSC0 LVCMOS Reference Clock Requirements

		XTALIN VS	SS_OSC XTALOUT		
2023	VDDS_OSC  LVCMOS Digital	200			
NOS AMBOS.	Clock Source	44 OSCO I VCMO	Angolio Calamatic		
5.	Figure 6	-11. USCU LVCINO	S Circuit Schematic		
	Table 6-4. OSC	CO LVCMOS Refer	ence Clock Requireme	nts	
NAME	DES	SCRIPTION	MIN	TYP MA	X UNIT
$f_{(XTALIN)}$	Frequency, LVCMOS reference clo	ock	1,	19.2, 24, 25, or 26	MHz
	Frequency, LVCMOS reference clo	ock stability and tolerand	e <sup>(1)</sup> –50		50 ppm
t <sub>dc(XTALIN)</sub>	Duty cycle, LVCMOS reference clo	ck period	45%	55	%
t <sub>jpp(XTALIN)</sub>	Jitter peak-to-peak, LVCMOS refer	ence clock period	-1%	1	%
t <sub>R(XTALIN)</sub>	Time, LVCMOS reference clock ris	e		10	5 ns
t <sub>F(XTALIN)</sub>	Time, LVCMOS reference clock fall	I		T	5 ns

Initial accuracy, temperature drift, and aging effects should be combined when evaluating a reference clock for this requirement.

#### 6.2.2.3 OSC1 Internal Oscillator Clock Source

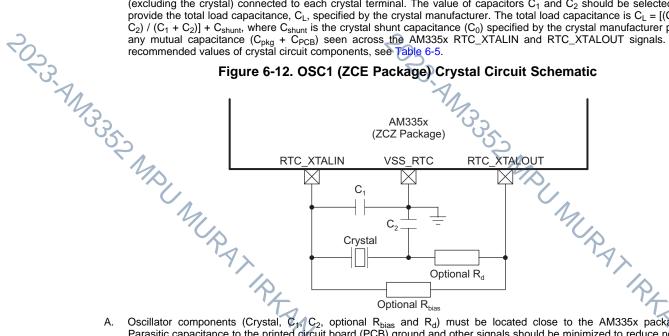
Figure 6-12 shows the recommended crystal circuit for OSC1 of the ZCE package and Figure 6-13 shows the recommended crystal circuit for OSC1 of the ZCZ package. It is recommended that pre-production printed circuit board (PCB) designs include the two optional resistors  $R_{\text{bias}}$  and  $R_{\text{d}}$  in case they are required for proper oscillator operation when combined with production crystal circuit components. In most cases, R<sub>bias</sub> is not required and R<sub>d</sub> is a 0-Ω resistor. These resistors may be removed from production PCB designs after evaluating oscillator performance with production crystal circuit components installed on pre-production PCBs.

The RTC\_XTALIN terminal has a 10- to 40-kΩ internal pullup resistor which is enabled when OSC1 is disabled. This internal resistor prevents the RTC\_XTALIN terminal from floating to an invalid logic level which may increase leakage current through the oscillator input buffer

MARINE L. MARINE L. MARINE TYST. AM335x (ZCE Package) RTC\_XTALOUT RTC XTALIN Optional Rhias Optional R Crystal C,  $C_2$ 

- Oscillator components (Crystal,  $C_1$ ,  $C_2$ , optional  $R_{bias}$  and  $R_d$ ) must be located close to the AM335x package. Parasitic capacitance to the printed circuit board (PCB) ground and other signals should be minimized to reduce noise coupled into the oscillator. VSS\_RTC and respective crystal circuit component grounds should be connected directly to the nearest PCB digital ground (VSS).
- C<sub>1</sub> and C<sub>2</sub> represent the total capacitance of the respective PCB trace, load capacitor, and other components (excluding the crystal) connected to each crystal terminal. The value of capacitors C1 and C2 should be selected to provide the total load capacitance,  $C_L$ , specified by the crystal manufacturer. The total load capacitance is  $C_L = [(C_1 \times C_2)]$ C2) / (C1 + C2)] + Cshunt, where Cshunt is the crystal shunt capacitance (C0) specified by the crystal manufacturer plus any mutual capacitance ( $C_{pkg} + C_{PCB}$ ) seen across the AM335x RTC\_XTALIN and RTC\_XTALOUT signals. For recommended values of crystal circuit components, see Table 6-5.

Figure 6-12. OSC1 (ZCE Package) Crystal Circuit Schematic



- Oscillator components (Crystal,  $C_1$ ,  $C_2$ , optional  $R_{bias}$  and  $R_d$ ) must be located close to the AM335x package. Parasitic capacitance to the printed circuit board (PCB) ground and other signals should be minimized to reduce noise coupled into the oscillator. VSS\_RTC and respective crystal circuit component grounds should be connected directly to the nearest PCB digital ground (VSS).
- C<sub>1</sub> and C<sub>2</sub> represent the total capacitance of the respective PCB trace, load capacitor, and other components (excluding the crystal) connected to each crystal terminal. The value of capacitors C<sub>1</sub> and C<sub>2</sub> should be selected to POR AMBORATOR MANAGER provide the total load capacitance,  $C_L$ , specified by the crystal manufacturer. The total load capacitance is  $C_L = [(C_1 \times C_2)^2]$  $(C_2)$  /  $(C_1 + C_2)$ ] +  $(C_{shunt})$  where  $(C_{shunt})$  is the crystal shunt capacitance  $(C_0)$  specified by the crystal manufacturer plus any mutual capacitance  $(C_{pkg})$  +  $(C_{pcg})$  seen across the AM335x RTC\_XTALIN and RTC\_XTALOUT signals. For recommended values of crystal circuit components, see Table 6-5.

Figure 6-13. OSC1 (ZCZ Package) Crystal Circuit Schematic MOSS MALMUR

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	NAME	DESCRIPTION		MIN	TYP	MAX	UNIT
	$f_{xtal}$	Crystal parallel resonance frequency	Fundamental mode oscillation only	1/0,	32.768		kHz
		Crystal frequency stability and tolerance <sup>(1)</sup>	Maximum RTC error = 10.512 minutes per year	-20.0	7,.	20.0	ppm
		P	Maximum RTC error = 26.28 minutes per year	-50.0	P	50.0	ppm
	C <sub>C1</sub>	C <sub>1</sub> capacitance		12.0	'Y <sub>\(\text{\ti}}\\ \text{\tex{\tex</sub>	24.0	pF
	C <sub>C2</sub>	C <sub>2</sub> capacitance		12.0	//	24.0	pF
	C <sub>shunt</sub>	Shunt capacitance			7	1.5	pF
	ESR	Crystal effective series resistance	$f_{\rm xtal}$ = 32.768 kHz, oscillator has nominal negative resistance of 725 k $\Omega$ and worst-case negative resistance of 250 k $\Omega$		*	80	kΩ

<sup>(1)</sup> Initial accuracy, temperature drift, and aging effects should be combined when evaluating a reference clock for this requirement.

### **Table 6-6. OSC1 Crystal Circuit Characteristics**

NAME	DESCRIPTION	_	MIN	TYP	MAX	UNIT
$C_{pkg}$	Shunt capacitance of	ZCE package		0.17		pF
	package ZCZ package		0.01			pF
P <sub>xtal</sub>	typical crystal power dissipat	R, $f_{\rm xtal}$ , and C <sub>L</sub> should be used to yield a ion value. Using the maximum values C <sub>L</sub> parameters yields a maximum power	P <sub>xtal</sub> = 0.5 VD	ESR (2 $\pi f_{xtal}$ CDS_RTC) <sup>2</sup>	C <sub>L</sub>	
t <sub>sX</sub>	Start-up time	O,	Ŷ-	2		S

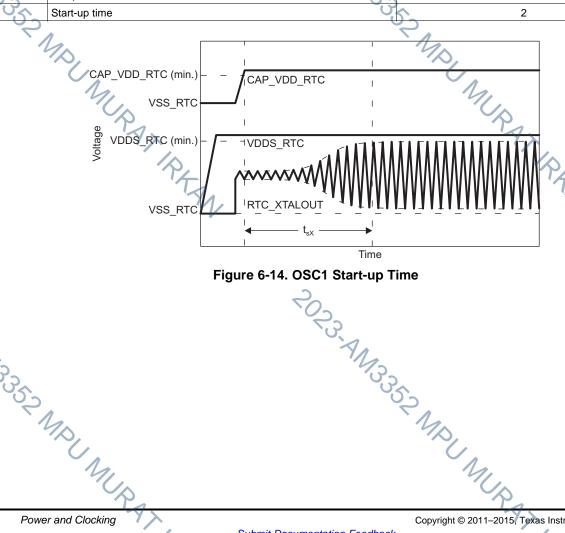
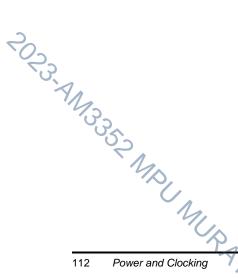


Figure 6-14. OSC1 Start-up Time



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Product Folder Links: AM3359 AM3358 AM3357 AM3356 AM3354 AM3352 AM3351





#### 6.2.2.4 OSC1 LVCMOS Digital Clock Source

Figure 6-15 shows the recommended oscillator connections when OSC1 of the ZCE package is connected to an LVCMOS square-wave digital clock source and Figure 6-16 shows the recommended oscillator connections when OSC1 of the ZCZ package is connected to an LVCMOS square-wave digital clock source. The LVCMOS clock source is connected to the RTC\_XTALIN terminal. The ground for the LVCMOS clock source and VSS RTC of the ZCZ package should be connected directly to the nearest PCB digital ground (VSS). In this mode of operation, the RTC\_XTALOUT terminal should not be used to source any external components. The printed circuit board design should provide a mechanism to disconnect the RTC\_XTALOUT terminal from any external components or signal traces that may couple noise into OSC1 via the RTC\_XTALOUT terminal.

The RTC XTALIN terminal has a 10- to 40-k $\Omega$  internal pullup resistor which is enabled when OSC1 is disabled. This internal resistor prevents the RTC\_XTALIN terminal from floating to an invalid logic level which may increase leakage current through the oscillator input buffer.

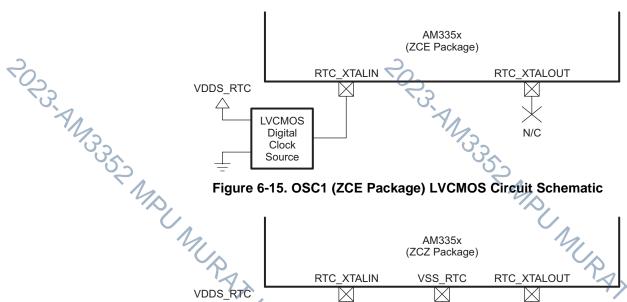


Figure 6-15. OSC1 (ZCE Package) LVCMOS Circuit Schematic

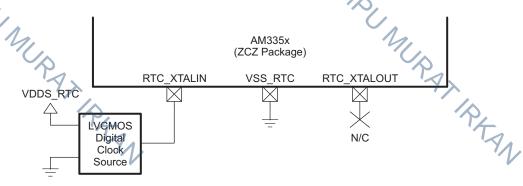


Figure 6-16. OSC1 (ZCZ Package) LVCMOS Circuit Schematic

Table 6-7. OSC1 LVCMOS Reference Clock Requirements

NAME	DESCRIPTION	70-	MIN	TYP MAX	UNIT
$f_{(RTC\_XTALIN)}$	Frequency, LVCMOS reference clock			32.768	kHz
	Frequency, LVCMOS reference clock stability and tolerance <sup>(1)</sup>	Maximum RTC error = 10.512 minutes/year	-20	20	ppm
700		Maximum RTC error = 26.28 minutes/year	-50	50	ppm
t <sub>dc(RTC_XTALIN)</sub>	Duty cycle, LVCMOS reference clock period		45%	55%	
t <sub>jpp(RTC_XTALIN)</sub>	Jitter peak-to-peak, LVCMOS reference cloc	k period	-1%	1%	
t <sub>R(RTC_XTALIN)</sub>	Time, LVCMOS reference clock rise	7	٥,	5	ns
t <sub>F(RTC_XTALIN)</sub>	Time, LVCMOS reference clock fall			5	ns

Initial accuracy, temperature drift, and aging effects should be combined when evaluating a reference clock for this requirement.

#### 6.2.2.5 OSC1 Not Used

Figure 6-17 shows the recommended oscillator connections when OSC1 of the ZCE package is not used and Figure 6-18 shows the recommended oscillator connections when OSC1 of the ZCZ package is not used. An internal 10 kΩ pullup on the RTC\_XTALIN terminal is turned on when OSC1 is disabled to prevent this input from floating to an invalid logic level which may increase leakage current through the oscillator input buffer. OSC1 is disabled by default after power is applied. Therefore, both RTC XTALIN and RTC\_XTALOUT terminals should be a no connect (NC) when OSC1 is not used.

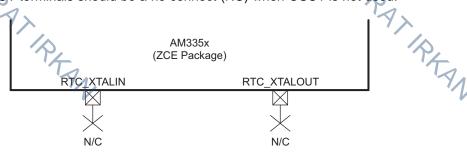


Figure 6-17. OSC1 (ZCE Package) Not Used Schematic

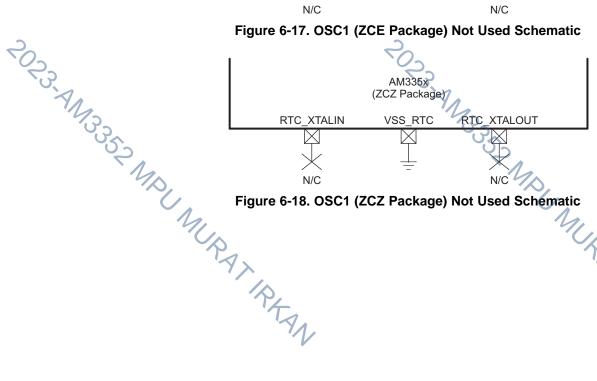


Figure 6-18. OSC1 (ZCZ Package) Not Used Schematic NRA) Rtan



## 6.2.3 Output Clock Specifications

The AM335x device has two clock output signals. The CLKOUT1 signal is always a replica of the OSC0 input clock which is referred to as the master oscillator (CLK\_M\_OSC) in the AM335x Sitara Processors Technical Reference Manual (SPRUH73). The CLKOUT2 signal can be configured to output the OSC1 input clock, which is referred to as the 32K oscillator (CLK\_32K\_RTC) in the AM335x Sitara Processors Technical Reference Manual (SPRUH73), or four other internal clocks. For more information related to configuring these clock output signals, see the CLKOUT Signals section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73).

### 6.2.4 Output Clock Characteristics

#### **NOTE**

The AM335x CLKOUT1 and CLKOUT2 clock outputs should not be used as a synchronous clock for any of the peripheral interfaces because they were not timing closed to any other signals. These clock outputs also were not designed to source any time critical external circuits that require a low jitter reference clock. The jitter performance of these outputs is unpredictable due to complex combinations of many system variables. For example, CLKOUT2 may be sourced from several PLLs with each PLL supporting many configurations that yield different jitter performance. There are also other unpredictable contributors to jitter performance such as application specific noise or crosstalk into the clock circuits. Therefore, there are no plans to specify jitter performance for these outputs.

# 6.2.4.1 **CLKOUT1**

The CLKOUT1 signal can be output on the XDMA\_EVENT\_INTR0 terminal. This terminal connects to one of seven internal signals via configurable multiplexers. The XDMA EVENT INTRO multiplexer must be configured for Mode 3 to connect the CLKOUT1 signal to the XDMA\_EVENT\_INTR0 terminal.

The default reset configuration of the XDMA EVENT INTRO multiplexer is selected by the logic level applied to the LCD\_DATA5 terminal on the rising edge of PWRONRSTn\_The XDMA\_EVENT\_INTR0 multiplexer is configured to Mode 7 if the LCD DATA5 terminal is low on the rising edge of PWRONRSTn or Mode 3 if the LCD DATA5 terminal is high on the rising edge of PWRONRSTn. This allows the CLKOUT1 signal to be output on the XDMA EVENT INTR0 terminal without software intervention. In this mode, the output is held low while PWRONRSTn is active and begins to toggle after PWRONRSTn is released.

#### 6.2.4.2 CLKOUT2

The CLKOUT2 signal can be output on the XDMA\_EVENT\_INTR1 terminal. This terminal connects to one of seven internal signals via configurable multiplexers. The XDMA EVENT INTR1 multiplexer must be configured for Mode 3 to connect the CLKOUT2 signal to the XDMA\_EVENT\_INTR1 terminal.

POPS, AMBOSE MAN, MURA Instr. The default reset configuration of the XDMA\_EVENT\_INTR1 multiplexer is always Mode 7. Software must configure the XDMA\_EVENT\_INTR1 multiplexer to Mode 3 for the CLKOUT2 signal to be output on the 23. AMBUMUR XDMA\_EVENT\_INTR1 terminal.

# Peripheral Information and Timings

The AM335x device contains many peripheral interfaces. In order to reduce package size and lower overall system cost while maintaining maximum functionality, many of the AM335x terminals can multiplex up to eight signal functions. Although there are many combinations of pin multiplexing that are possible, only a certain number of sets, called IO Sets, are valid due to timing limitations. These valid IO Sets were carefully chosen to provide many possible application scenarios for the user.

Texas Instruments has developed a Windows-based application called Pin Mux Utility that helps a system designer select the appropriate pin-multiplexing configuration for their AM335x-based product design. The Pin Mux Utility provides a way to select valid IO Sets of specific peripheral interfaces to ensure the pinmultiplexing configuration selected for a design only uses valid IO Sets supported by the AM335x device.

#### **Parameter Information** 7.1

The data provided in the following Timing Requirements and Switching Characteristics tables assumes the device is operating within the Recommended Operating Conditions defined in Section 5, unless otherwise noted.

#### Timing Parameters and Board Routing Analysis 7.1.1

The timing parameter values specified in this data manual do not include delays by board routings. As a good board design practice, such delays must always be taken into account. Timing values may be adjusted by increasing or decreasing such delays. The recommends using the available IO buffer information specification (IBIS) models to analyze the timing characteristics correctly. If needed, external logic hardware such as buffers may be used to compensate any timing differences.

The timing parameter values specified in this data manual assume the SLEWCTRL bit in each pad control register is configured for fast mode (0b).

For the mDDR(LPDDR), DDR3, DDR3L memory interface, it is not necessary to use the IBIS models to analyze timing characteristics. TI provides a PCB routing rules solution that describes the routing rules to ensure the mDDR(LPDDR), DDR2, DDR3, DDR3L memory interface timings are met.

#### 7.2 Recommended Clock and Control Signal Transition Behavior

All clocks and control signals *must* transition between V<sub>IH</sub> and V<sub>IL</sub> (or between V<sub>IL</sub> and V<sub>IH</sub>) in a monotonic manner.

#### 7.3 **OPP50 Support**

Some peripherals and features have limited support when the device is operating in OPP50. A complete list of these limitations follows.

#### Not supported when operating in OPP50:

- **CPSW**
- DDR3
- **DEBUGSS-Trace**
- **GPMC** Asynchronous Mode
- LCDC LIDD Mode
- **MDIO**
- PRU-ICSS MII

# Reduced performance when operating in

- DDR2
- **DEBUGSS-JTAG**
- **GPMC** Synchronous Mode
- **LCDC** Raster Mode
- LPDDR
- McSPI
- **MMCSD**

OPP50:

Peripheral Information and Timings 116

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## 7.4 Controller Area Network (CAN)

For more information, see the Controller Area Network (CAN) section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73).

# 7.4.1 DCAN Electrical Data and Timing

#### Table 7-1. Timing Requirements for DCANx Receive

#### (see Figure 7-1)

NC		-//_	MIN	MAX	UNIT
	$f_{baud(baud)}$	Maximum programmable baud rate		7_ 1	Mbps
1	t <sub>w(RX)</sub>	Pulse duration, receive data bit	H – 2 <sup>(1)</sup>	$H + 2^{(1)}$	ns

<sup>(1)</sup> H = Period of baud rate, 1 / programmed baud rate

#### Table 7-2. Switching Characteristics for DCANx Transmit

#### (see Figure 7-1)

NO.	PARAMETER	MIN MAX	UNIT
	$f_{baud(baud)}$ Maximum programmable baud rate	1	Mbps
2	t <sub>w(TX)</sub> Pulse duration, transmit data bit	$H - 2^{(1)}$ $H + 2^{(1)}$	ns

(1) H = Period of baud rate, 1 / programmed baud rate

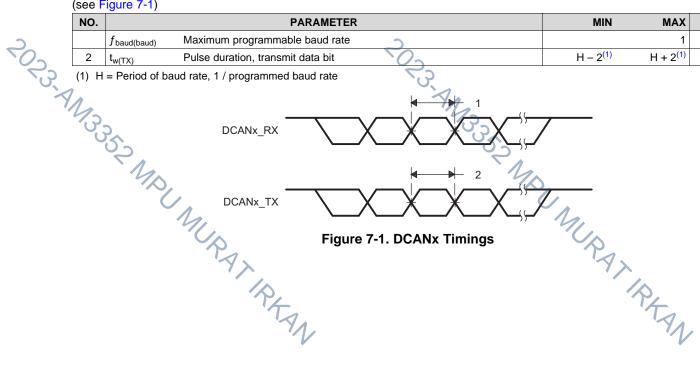


Figure 7-1. DCANx Timings

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## 7.5 DMTimer

## DMTimer Electrical Data and Timing

# Table 7-3. Timing Requirements for DMTimer [1-7]

#### (see Figure 7-2)

NO.	· Os	MIN	MAX	UNIT
1	t <sub>c(TCLKIN)</sub> Cycle time, TCLKIN	4P + 1 <sup>(1)</sup>		ns

(1) P = Period of PICLKOCP (interface clock).

#### Table 7-4. Switching Characteristics for DMTimer [4-7]

#### (see Figure 7-2)

NO.	PARAMETER	MIN MAX	UNIT
2	$t_{w(TIMERxH)}$ Pulse duration, high	$4P - 3^{(1)}$	ns
3	t <sub>w/TIMERYL</sub> ) Pulse duration, low	$4P - 3^{(1)}$	ns

(1) P = Period of PICLKTIMER (functional clock).

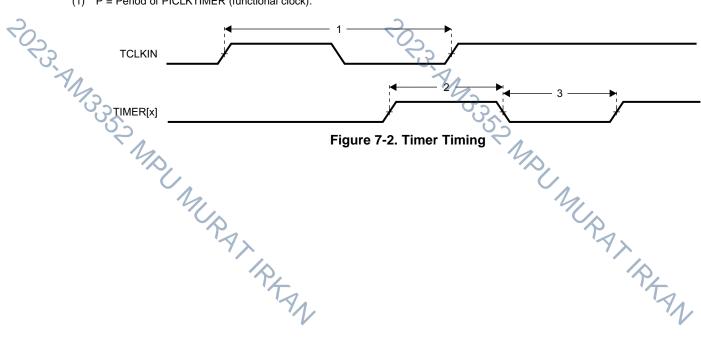


Figure 7-2. Timer Timing

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## 7.6 Ethernet Media Access Controller (EMAC) and Switch

#### EMAC and Switch Electrical Data and Timing

The EMAC and Switch implemented in the AM335x device supports GMII mode, but the AM335x design does not pin out 9 of the 24 GMII signals. This was done to reduce the total number of package terminals. Therefore, the AM335x device does not support GMII mode. MII mode is supported with the remaining GMII signals.

The AM335x Sitara Processors Technical Reference Manual (SPRUH73) and this document may reference internal signal names when discussing peripheral input and output signals because many of the AM335x package terminals can be multiplexed to one of several peripheral signals. For example, the AM335x terminal names for port 1 of the EMAC and switch have been changed from GMII to MII to indicate their Mode 0 function, but the internal signal is named GMII. However, documents that describe the Ethernet switch reference these signals by their internal signal name. For a cross-reference of internal signal names to terminal names, see Table 4-1.

Operation of the EMAC and switch is not supported for OPP50.

Table 7-5. EMAC and Switch Timing Conditions

	PARAMETER	0-	MIN	TYP	MAX	UNIT
Input Cond	itions	7,5			<u> </u>	
t <sub>R</sub>	Input signal rise time	×	1 <sup>(1)</sup>		5 <sup>(1)</sup>	ns
Ip/	Input signal fall time	1/2	1 <sup>(1)</sup>		5 <sup>(1)</sup>	ns
Output Con	dition	775				
C <sub>LOAD</sub>	Output load capacitance	5	3		30	pF

<sup>(1)</sup> Except when specified otherwise.

#### EMAC/Switch MDIO Electrical Data and Timing

#### Table 7-6. Timing Requirements for MDIO\_DAT

(see Figure 7-3)

 9	-1			
NO.	42	MIN	TYP MAX	UNIT
1	t <sub>su(MDIO-MDC)</sub> Setup time, MDIO valid before MDC high	90	//	ns
2	th/MDIO MDC) Hold time, MDIO valid from MDC high	0	7	ns

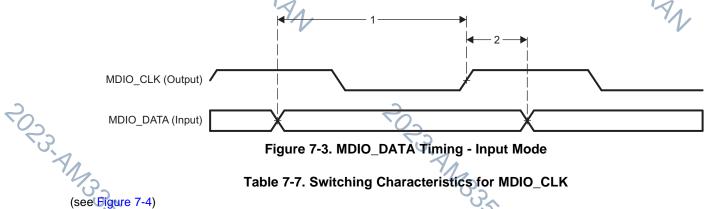


Figure 7-3. MDIO\_DATA Timing - Input Mode

Table 7-7. Switching Characteristics for MDIO\_CLK

(see Figure 7-4)

NO	PARAMETER	MIN TYP	MAX	UNIT
1 1	c <sub>(MDC)</sub> Cycle time, MDC	400		ns
2	t <sub>w(MDCH)</sub> Pulse duration, MDC high	160		ns
3	t <sub>w(MDCL)</sub> Pulse duration, MDC low	160		ns
4	t <sub>t(MDC)</sub> Transition time, MDC	4/.	5	ns

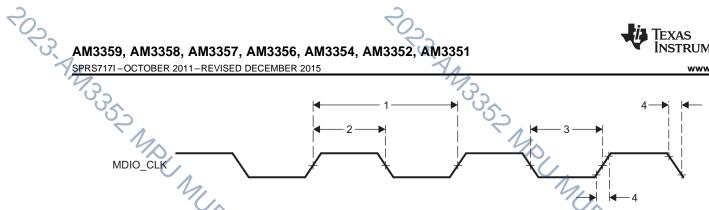


Figure 7-4. MDIO\_CLK Timing

Table 7-8. Switching Characteristics for MDIO\_DATA

#### (see Figure 7-5)

`	,	<b>7</b>				
NO.		PARAMETER	MIN	TYP 🗐	VAX	UNIT
1	t <sub>d(MDC-MDIO)</sub>	Delay time, MDC high to MDIO val	id 10	-	390	ns

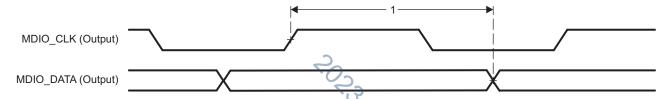


Figure 7-5. MDIO\_DATA Timing - Output Mode

### **EMAC and Switch MII Electrical Data and Timing**

#### Table 7-9. Timing Requirements for GMII[x]\_RXCLK - MII Mode

# (see Figure 7-6)

NO.			10 Mbps			10	UNIT		
NO.		1.	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
1	t <sub>c(RX_CLK)</sub>	Cycle time, RX_CLK	399.96		400.04	39.996	/^	40.004	ns
2	t <sub>w(RX_CLKH)</sub>	Pulse duration, RX_CLK high	140		260	14	7	26	ns
3	t <sub>w(RX_CLKL)</sub>	Pulse duration, RX_CLK low	140		260	14	$\gamma_{\lambda}$	26	ns
4	t <sub>t(RX CLK)</sub>	Transition time, RX_CLK			5			5	ns

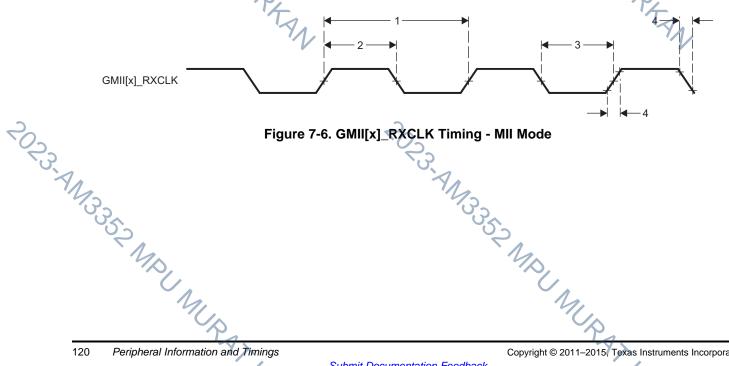


Figure 7-6. GMII[x]\_RXCLK Timing - MII Mode K 3. ANSOSE MALMUR 301

Table 7-10. Timing Requirements for GMII[x]\_TXCLK - MII Mode

(see Fi	gure 7-7)				4	<u> </u>			
NO.	1/1		1	0 Mbps	•	100 Mbps			
4	'~	,	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
1	t <sub>c(TX_CLK)</sub>	Cycle time, TX_CLK	399.96		400.04	39.996		40.004	ns
2	t <sub>w(TX_CLKH)</sub>	Pulse duration, TX_CLK high	140		260	14		26	ns
3	t <sub>w(TX_CLKL)</sub>	Pulse duration, TX_CLK low	140		260	14	A	26	ns
4	t <sub>t(TX_CLK)</sub>	Transition time, TX_CLK			5		4	5	ns

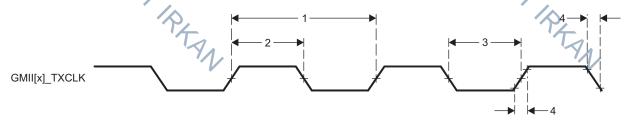


Figure 7-7. GMII[x]\_TXCLK Timing - MII Mode

# Table 7-11. Timing Requirements for GMII[x]\_RXD[3:0], GMII[x]\_RXDV, and GMII[x]\_RXER - MII Mode

(see Figure 7-8)

1	NO			10 Mbps			10		UNIT	
1	1:			MIN	TYP	MAX	MIN	TYP	MAX	UNIT
	0	t <sub>su(RXD-RX_CLK)</sub>	Setup time, RXD[3:0] valid before RX_CLK	8 5						
	1	t <sub>su(RX_DV-RX_CLK)</sub>	Setup time, RX_DV valid before RX_CLK			8			ns	
		t <sub>su(RX_ER-RX_CLK)</sub>	Setup time, RX_ER valid before RX_CLK		1	,				
	2	t <sub>h(RX_CLK-RXD)</sub>	Hold time RXD[3:0] valid after RX_CLK		70,					
		t <sub>h(RX_CLK-RX_DV)</sub>	Hold time RX_DV valid after RX_CLK	8			8			ns
		th(RX CLK-RX ER)	Hold time RX_ER valid after RX_CLK			1	1,			

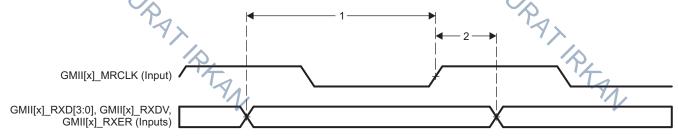


Figure 7-8. GMII[x]\_RXD[3:0], GMII[x]\_RXDV, GMII[x]\_RXER Timing - MII Mode

# Table 7-12. Switching Characteristics for GMII[x]\_TXD[3:0], and GMII[x]\_TXEN - MII Mode

(see Figure 7-9)

NO.	PARAMETER	1	0 Mbps	1	UNIT	
NO.	PARAMETER	MIN	TYP MAX	MIN	TYP MAX	
1	t <sub>d(TX_CLK-TXD)</sub> Delay time, TX_CLK high to TXD[3:0] valid	F	S.F.		25	
	t <sub>d(TX_CLK-TX_EN)</sub> Delay time, TX_CLK to TX_EN valid	5	25	7, 3	25	ns

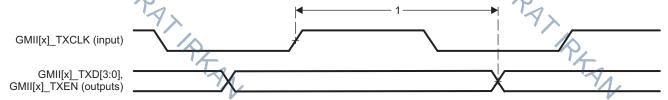


Figure 7-9. GMII[x] TXD[3:0], GMII[x] TXEN Timing - MII Mode

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## **EMAC** and Switch RMII Electrical Data and Timing

#### Table 7-13. Timing Requirements for RMII[x]\_REFCLK - RMII Mode

(see Figure 7-10)

•				
NO.		MIN TYP	MAX	UNIT
1	t <sub>c(REF_CLK)</sub> Cycle time, REF_CLK	19.999	20.001	ns
2	t <sub>w(REF_CLKH)</sub> Pulse duration, REF_CLK high	7	13	ns
3	t <sub>w(REF CLKL)</sub> Pulse duration, REF_CLK low	7	13	ns

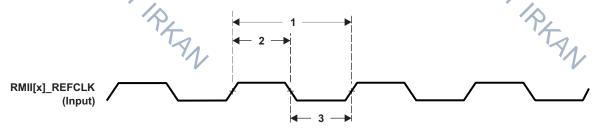


Figure 7-10. RMII[x]\_REFCLK Timing - RMII Mode

# Table 7-14. Timing Requirements for RMII[x]\_RXD[1:0], RMII[x]\_CRS\_DV, and RMII[x]\_RXER - RMII Mode

(see Figure 7-11)

NO.		4	11-	MIN	TYP	MAX	UNIT
(C) (C)	t <sub>su(RXD-REF_CLK)</sub>	Setup time, RXD[1:0] valid before REF_CLK	(V) 3				
1 (	t <sub>su(CRS_DV-REF_CLK)</sub>	Setup time, CRS_DV valid before REF_CLK		4			ns
	t <sub>su(RX_ER-REF_CLK)</sub>	Setup time, RX_ER valid before REF_CLK	7/				
	t <sub>h(REF_CLK-RXD)</sub>	Hold time RXD[1:0] valid after REF_CLK	"	<b>\( \)</b>			
2	t <sub>h(REF_CLK-CRS_DV)</sub>	Hold time, CRS_DV valid after REF_CLK	•	2			ns
	th(REF CLK-RX ER)	Hold time, RX_ER valid after REF_CLK		1/2			

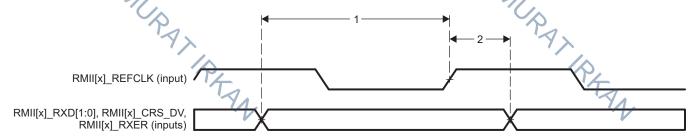


Figure 7-11. RMII[x]\_RXD[1:0], RMII[x]\_CRS\_DV, RMII[x]\_RXER Timing - RMII Mode

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# Table 7-15. Switching Characteristics for RMII[x]\_TXD[1:0], and RMII[x]\_TXEN - RMII Mode

(see Figure 7-12)

NO.	PARAMETER	1/1	MIN	TYP	MAX	UNIT
1	t <sub>d(REF_CLK-TXD)</sub> Delay time, REF_CLK high to TXD[1:0] valid	'~	<b>/</b> 2		13	no
ı	t <sub>d(REF_CLK-TXEN)</sub> Delay time, REF_CLK to TXEN valid		1		13	ns
2	t <sub>r(TXD)</sub> Rise time, TXD outputs		7/		_	no
1 1 1 2 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	t <sub>r(TX_EN)</sub> Rise time, TX_EN output			9	5	ns
2	$t_{f(TXD)}$ Fall time, TXD outputs		1	4	_	no
3	t <sub>f(TX_EN)</sub> Fall time, TX_EN output		'		5	ns

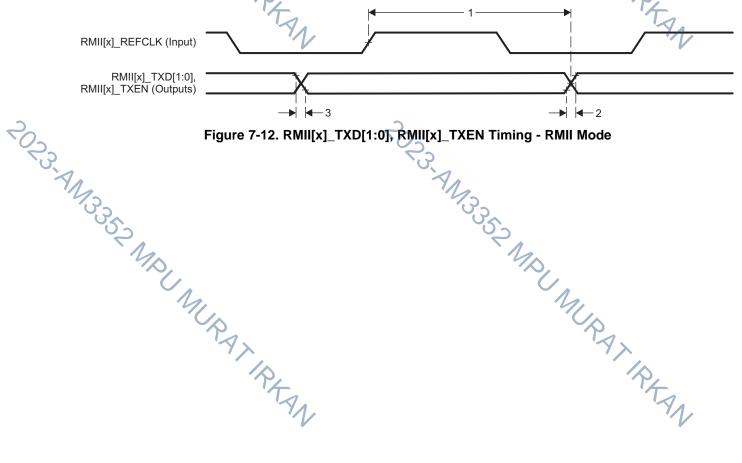


Figure 7-12. RMII[x]\_TXD[1:0], RMII[x]\_TXEN Timing - RMII Mode

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#### 7,7

**EMAC and Switch RGMII Electrical Data and Timing** 

#### Table 7-16. Timing Requirements for RGMII[x]\_RCLK - RGMII Mode

(see Figure 7-13)

NO				10 Mbps	1	00 Mbps	1000 N	lbps	UNIT
NO.		1/1,	MIN	TYP MAX	MIN	TYP MAX	MIN T	YP MAX	UNII
1	t <sub>c(RXC)</sub>	Cycle time, RXC	360	440	36	44	7.2	8.8	ns
2	t <sub>w(RXCH)</sub>	Pulse duration, RXC high	160	240	16	24	3,6	4.4	ns
3	t <sub>w(RXCL)</sub>	Pulse duration, RXC low	160	240	16	24	3.6	4.4	ns
4	t <sub>t(RXC)</sub>	Transition time, RXC	1	0.75		0.75	1	0.75	ns

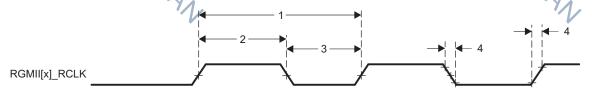
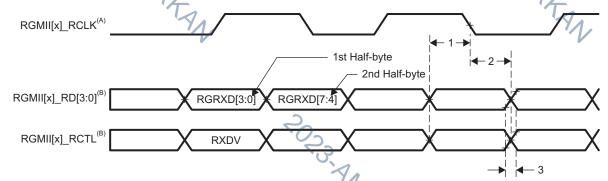


Figure 7-13. RGMII[x] RCLK Timing - RGMII Mode

Table 7-17. Timing Requirements for RGMII[x]\_RD[3:0], and RGMII[x]\_RCTL - RGMII Mode

(see Figure 7-14)

NO.					10 Mbps		100 Mbps		1000 Mbps			UNIT
NO			MIN	TYP	MAX	WIN	TYP	MAX	MIN	TYP	MAX	UNII
1	t <sub>su(RD-RXC)</sub>	Setup time, RD[3:0] valid before RXC high or low	1			T.			1			5
	t <sub>su(RX_CTL-RXC)</sub>	Setup time, RX_CTL valid before RXC high or low	1			1	10/		1			ns
2	t <sub>h(RXC-RD)</sub>	Hold time, RD[3:0] valid after RXC high or low	1			1		1	1			
	t <sub>h(RXC-RX_CTL)</sub>	Hold time, RX_CTL valid after RXC high or low	1			1			P 1			ns
3	t <sub>t(RD)</sub>	Transition time, RD			0.75			0.75	7		0.75	no
	t <sub>t(RX_CTL)</sub>	Transition time, RX_CTL			0.75			0.75	1	<b>A</b> .	0.75	ns



A. RGMII[x]\_RCLK must be externally delayed relative to the RGMII[x]\_RD[3:0] and RGMII[x]\_RCTL signals to meet the respective timing requirements.

Data and control information is received using both edges of the clocks. RGMII[x]\_RD[3:0] carries data bits 3-0 on the rising edge of RGMII[x]\_RCLK. Similarly, RGMII[x]\_RCTL carries RXDV on rising edge of RGMII[x]\_RCLK and RXERR on falling edge of RGMII[x]\_RCLK.

Figure 7-14. RGMII[x]\_RD[3:0], RGMII[x]\_RCTL Timing - RGMII Mode



Table 7-18. Switching Characteristics for RGMII[x]\_TCLK - RGMII Mode

(see Figure 7-15)

NO.	PARAMETER		10 Mbps			10	00 Mbps	10	UNIT	
NO.	'^	PARAWETER	MIN	TYP	MAX	MIN	TYP MAX	MIN	TYP MAX	
1	t <sub>c(TXC)</sub>	Cycle time, TXC	360		440	36	44)	7.2	8.8	ns
2	t <sub>w(TXCH)</sub>	Pulse duration, TXC high	160		240	16	24	3.6	4.4	ns
3	t <sub>w(TXCL)</sub>	Pulse duration, TXC low	160		240	16	24	3.6	4.4	ns
4	t <sub>t(TXC)</sub>	Transition time, TXC			0.75		0.75		0.75	ns

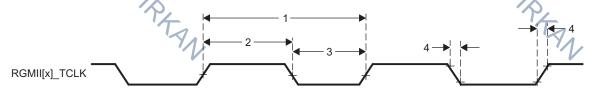
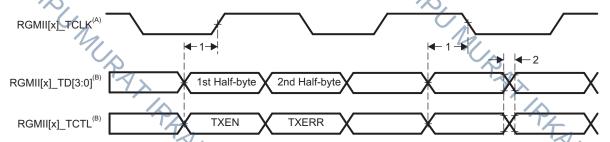


Figure 7-15. RGMII[x]\_TCLK Timing - RGMII Mode

Table 7-19. Switching Characteristics for RGMII[x]\_TD[3:0], and RGMII[x]\_TCTL - RGMII Mode

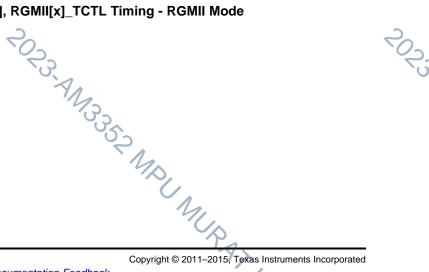
(see Figure 7-16)

	<b>\</b>	9									
	NO.	PARAMETER		10	0 Mbps	10	0 Mbps	10	1000 Mbps		
7	/ NO.	TANAMETER			TYP MAX	MIN	TYP MAX	MIN	TYP MAX	UNIT	
	1/2	t <sub>sk(TD-TXC)</sub>	TD to TXC output skew	-0.5	0.5	-0.5	0.5	-0.5	0.5		
	95	t <sub>sk(TX_CTL-TXC)</sub>	TX_CTL to TXC output skew	-0.5	0.5	<b>9</b> –0.5	0.5	-0.5	0.5	ns	
	,	$t_{t(TD)}$	Transition time, TD		0.75	J	0.75		0.75		
	2	t <sub>t(TX_CTL)</sub>	Transition time, TX_CTL		0.75		0.75		0.75	ns	



- The EMAC and switch implemented in the AM335x device supports internal delay mode, but timing closure was not performed for this mode of operation Therefore, the AM335x device does not support internal delay mode.
- Data and control information is transmitted using both edges of the clocks. RGMII[x]\_TD[3:0] carries data bits 3-0 on the rising edge of RGMII[x]\_TCLK and data bits 7-4 on the falling edge of RGMII[x]\_TCLK. Similarly, RGMII[x]\_TCTL carries TXEN on rising edge of RGMII[x]\_TCLK and TXERR of falling edge of RGMII[x]\_TCLK.

Figure 7-16. RGMII[x]\_TD[3:0], RGMII[x]\_TCTL Timing - RGMII Mode



# 7.7 External Memory Interfaces

The device includes the following external memory interfaces:

- General-purpose memory controller (GPMC)
- mDDR(LPDDR), DDR2, DDR3, DDR3L Memory Interface (EMIF)

### 7.7.1 General-Purpose Memory Controller (GPMC)

#### NOTE

For more information, see the Memory Subsystem and General-Purpose Memory Controller section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73).

The GPMC is the unified memory controller used to interface external memory devices such as:

- Asynchronous SRAM-like memories and ASIC devices
- Asynchronous page mode and synchronous burst NOR flash
- NAND flash

#### **GPMC and NOR Flash—Synchronous Mode**

Table 7-21 and Table 7-22 assume testing over the recommended operating conditions and electrical characteristic conditions shown in Table 7-20 (see Figure 7-17 through Figure 7-21).

Table 7-20. GPMC and NOR Flash Timing Conditions—Synchronous Mode

000	PARAMETER	000	MIN	TYP MAX	UNIT
Input Condi	tions	2			
$t_R$	Input signal rise time	1/2	1	5	ns
t <sub>F</sub>	Input signal fall time		) 1	5	ns
Output Cond	dition	·			
C <sub>LOAD</sub>	Output load capacitance		3,	30	pF

#### Table 7-21, GPMC and NOR Flash Timing Requirements – Synchronous Mode

		<u> </u>	<u> </u>		- 7	
NO				OPP100	OPP50	
NO.		(P)		MIN M	IAX MIN MAX	UNIT
F12	t <sub>su(dV-clkH)</sub>	Setup time, input data gpmc_ad[15:0] gpmc_clk high	valid before output clock	3.2	13.2	ns
F13	t <sub>h(clkH-dV)</sub>	Hold time, input data gpme_ad[15:0] valid after output clock gpmc_clk high	Industrial extended temperature (-40°C to 125°C)	4.74	4.74	ns
			All other temperature ranges	4.74	2.75	
F21	t <sub>su(waitV-clkH)</sub>	Setup time, input wait gpmc_wait[x] <sup>(1)</sup> gpmc_clk high	valid before output clock	3.2	13.2	ns
F22	t <sub>h(clkH-waitV)</sub>	Hold time, input wait gpmc_wait[x] <sup>(1)</sup> valid after output clock gpmc_clk high	Industrial extended temperature (-40°C to 125°C)	4.74	4.74	ns
9,			All other temperature ranges	4.74	2.75	
.0	n gpmc_wait[x]	, x is equal to 0 or 1.		MACIN		
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Table 7-22. GPMC and NOR Flash Switching Characteristics – Synchronous Mode<sup>(2)</sup>

No	2	DADAMETED	OPP	100	OPP50		LINUT
NO.	1/2	PARAMETER	MIN	MAX	MIN	MAX	UNIT
F0	1 / t <sub>c(clk)</sub>	Frequency <sup>(18)</sup> , output clock gpmc_clk	•	100		50	MHz
F1	t <sub>w(clkH)</sub>	Typical pulse duration, output clock gpmc_clk high	0.5P <sup>(15)</sup>	0.5P <sup>(15)</sup>	0.5P <sup>(15)</sup>	0.5P <sup>(15)</sup>	ns
F1	t <sub>w(clkL)</sub>	Typical pulse duration, output clock gpmc_clk low	0.5P <sup>(15)</sup>	0.5P <sup>(15)</sup>	0.5P <sup>(15)</sup>	0.5P <sup>(15)</sup>	ns
	t <sub>dc(clk)</sub>	Duty cycle error, output clock gpmc_clk	-500	500	<b>-</b> 500	500	ps
	t <sub>J(clk)</sub>	Jitter standard deviation <sup>(19)</sup> , output clock gpmc_clk		33.33	7	33.33	ps
	t <sub>R(clk)</sub>	Rise time, output clock gpmc_clk		2		2	ns
	t <sub>F(clk)</sub>	Fall time, output clock gpmc_clk		2		2	ns
	t <sub>R(do)</sub>	Rise time, output data gpmc_ad[15:0]		2		2	ns
	t <sub>F(do)</sub>	Fall time, output data gpmc_ad[15:0]		2		///2	ns
F2	t <sub>d(clkH-csnV)</sub>	Delay time, output clock gpmc_clk rising edge to output chip select gpmc_csn[x] <sup>(14)</sup> transition	F <sup>(6)</sup> - 2.2	F <sup>(6)</sup> + 4.5	F <sup>(6)</sup> - 3.2	F <sup>(6)</sup> + 9.5	ns
F3	t <sub>d(clkH-csnIV)</sub>	Delay time, output clock gpmc_clk rising edge to output chip select gpmc_csn[x] <sup>(14)</sup> invalid	$E^{(5)} - 2.2$	$E^{(5)} + 4.5$	$E^{(5)} - 3.2$	$E^{(5)} + 9.5$	ns
F4	t <sub>d(aV-clk)</sub>	Delay time, output address gpmc_a[27:1] valid to output clock gpmc_clk first edge	$B^{(2)} - 4.5$	$B^{(2)} + 2.3$	$B^{(2)} - 5.5$	B <sup>(2)</sup> + 12.3	ns
F5	t <sub>d(clkH-alV)</sub>	Delay time, output clock gpmc_clk rising edge to output address gpmc_a[27:1] invalid	-2.3	4.5	-3.3	14.5	ns
F6	t <sub>d(be[x]nV-clk)</sub>	Delay time, output lower byte enable and command latch enable gpmc_be0n_cle, output upper byte enable gpmc_be1n valid to output clock gpmc_clk first edge	B <sup>(2)</sup> – 1.9	B <sup>(2)</sup> + 2.3	B <sup>(2)</sup> – 2.9	B <sup>(2)</sup> + 12.3	ns
F7	ta(clkH-be[x]nIV)	Delay time, output clock gpmc_clk rising edge to output lower byte enable and command latch enable gpmc_be0n_cle, output upper byte enable gpmc_be1n invalid <sup>(11)</sup>	D <sup>(4)</sup> + 2,3	D <sup>(4)</sup> + 1.9	D <sup>(4)</sup> – 3.3	$D^{(4)} + 6.9$	ns
F7	t <sub>d(clkL-be[x]nIV)</sub>	Delay time, gpmc_clk falling edge to gpmc_nbe0_cle, gpmc_nbe1 invalid <sup>(12)</sup>	$D^{(4)} - 2.3$	D <sup>(4)</sup> + 1.9	$D^{(4)} - 3.3$	$D^{(4)} + 6.9$	ns
F7	t <sub>d(clkL-be[x]nIV)</sub>	Delay time, gpmc_clk falling edge to gpmc_nbe0_cle, gpmc_nbe1 invalid <sup>(13)</sup>	$D^{(4)} - 2.3$	D <sup>(4)</sup> + 1.9	$D^{(4)} - 3.3$	D <sup>(4)</sup> + 11.9	ns
F8	t <sub>d(clkH-advn)</sub>	Delay time, output clock gpmc_clk rising edge to output address valid and address latch enable gpmc_advn_ale transition	$G^{(7)} - 2.3$	$G^{(7)} + 4.5$	G <sup>(7)</sup> – 3.3	G <sup>(7)</sup> + 9.5	ns
F9	t <sub>d</sub> (clkH-advnIV)	Delay time, output clock gpmc_clk rising edge to output address valid and address latch enable gpmc_advn_ale invalid	$D^{(4)} - 2.3$	D <sup>(4)</sup> + 3.5	D <sup>(4)</sup> – 3.3	$D^{(4)} + 9.5$	ns
F10	t <sub>d(clkH-oen)</sub>	Delay time, output clock gpmc_clk rising edge to output enable gpmc_oen transition	$H^{(8)} - 2.3$	$H^{(8)} + 3.5$	$H^{(8)} - 3.3$	H <sup>(8)</sup> + 8.5	ns
F11	t <sub>d(clkH-oenIV)</sub>	Delay time, output clock gpmc_clk rising edge to output enable gpmc_oen invalid	$E^{(8)} - 2.3$	$E^{(8)} + 3.5$	$E^{(8)} - 3.3$	E <sup>(8)</sup> + 8.5	ns
F14	t <sub>d(clkH-wen)</sub>	Delay time, output clock gpmc_clk rising edge to output write enable gpmc_wen transition	$I^{(9)} - 2.3$	l <sup>(9)</sup> + 4.5	$I^{(9)} - 3.3$	I <sup>(9)</sup> + 9.5	ns
F15	t <sub>d(clkH-do)</sub>	Delay time, output clock gpmc_clk rising edge to output data gpmc_ad[15:0] transition <sup>(11)</sup>	$J^{(10)} - 2.3$	J <sup>(10)</sup> + 1.9	$J^{(10)} - 3.3$	J <sup>(10)</sup> + 6.9	ns
F15	t <sub>d(clkL-do)</sub>	Delay time, gpmc_clk falling edge to gpmc_ad[15:0] data bus transition <sup>(12)</sup>	$J^{(10)} - 2.3$	J <sup>(10)</sup> + 1.9	$J^{(10)} - 3.3$	J <sup>(10)</sup> + 6.9	ns
F15	t <sub>d(clkL-do)</sub>	Delay time, gpmc_clk falling edge to gpmc_ad[15:0] data bus transition <sup>(13)</sup>	$\mathcal{O}_{\mathcal{I}}$	J <sup>(10)</sup> + 1.9	$J^{(10)} - 3.3$	J <sup>(10)</sup> + 11.9	ns
F17	<sup>t</sup> d(clkH-be[x]n)	Delay time, output clock gpmc_clk rising edge to output lower byte enable and command latch enable gpmc_be0n_cle transition <sup>(11)</sup>	J(10) - 2.3	J <sup>(10)</sup> + 1.9	J <sup>(10)</sup> – 3.3	J <sup>(10)</sup> + 6.9	ns
F17	t <sub>d(clkL-be[x]n)</sub>	Delay time, gpmc_clk falling edge to gpmc_nbe0_cle, gpmc_nbe1 transition <sup>(12)</sup>	$J^{(10)} - 2.3$	J <sup>(10)</sup> + 1.9	$J^{(10)} - 3.3$	J <sup>(10)</sup> + 6.9	ns
F17	t <sub>d(clkL-be[x]n)</sub>	Delay time, gpmc_clk falling edge to ppmc_nbe0_cle, gpmc_nbe1 transition (13)	$J^{(10)} - 2.3$	J <sup>(10)</sup> + 1.9	$J^{(10)} - 3.3$	J <sup>(10)</sup> + 11.9	ns

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Table 7-22. GPMC and NOR Flash Switching Characteristics - Synchronous Mode<sup>(2)</sup> (continued)

				•	•
NO.	PARAMETER		OPP100	OPP50	UNIT
NO.	PARAMETER		MIN MAX	MIN MAX	UNII
F18	t <sub>w(csnV)</sub> Pulse duration, output chip select	Read	A <sup>(1)</sup>	A <sup>(1)</sup>	ns
	gpmc_csn[x] <sup>(14)</sup> low	Write	A <sup>(1)</sup>	A <sup>(1)</sup>	ns
F19	t <sub>w(be[x]nV)</sub> Pulse duration, output lower byte enable	Read	C(3)	C <sub>(3)</sub>	ns
	and command latch enable gpmc_be0n_cle, output upper byte enable gpmc_be1n low	Write	C <sup>(3)</sup>	C(3)	ns
F20	t <sub>w(advnV)</sub> Pulse duration, output address valid and	Read	K <sup>(16)</sup>	K <sup>(16)</sup>	ns
	address latch enable gpmc_advn_ale low	Write	K <sup>(16)</sup>	K <sup>(16)</sup>	ns

- (1) For single read: A = (CSRdOffTime CSOnTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17) For burst read: A = (CSRdOffTime - CSOnTime + (n - 1) x PageBurstAccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17) For burst write:  $A = (CSWrOffTime - CSOnTime + (n - 1) \times PageBurstAccessTime) \times (TimeParaGranularity + 1) \times GPMC_FCLK<sup>(17)</sup>$ With n being the page burst access number.
- (2) B = ClkActivationTime × GPMC FCLK<sup>(17)</sup>
- (3) For single read: C = RdCycleTime × (TimeParaGranularity + 1) × GPMC\_FCLK (17) For burst read:  $C = (RdCycleTime + (n - 1) \times PageBurstAccessTime) \times (TimeParaGranularity + 1) \times GPMC_FCLK^{(17)}$ For burst write: C = (WrCycleTime + (n - 1) x PageBurstAccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17) With n being the page burst access number.
- (4) For single read: D = (RdCycleTime AccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17) For burst read: D = (RdCycleTime - AccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17) For burst write: D = (WrCycleTime - AccessTime) × (TimeParaGranularity + 1) × GPMC\_FCLK<sup>(17)</sup>
- (5) For single read: E = (CSRdOffTime AccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17) For burst read: E = (CSRdOffTime - AccessTime) × (TimeParaGranularity +1) × GPMC\_FCLK(17) For burst write: E = (CSWrOffTime - AccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17)
- (6) For csn falling edge (CS activated):
  - Case GpmcFCLKDivider = 0:
    - F = 0.5 × CSExtraDelay × GPMC\_FCLK(17)
  - Case GpmcFCLKDivider = 1:
    - F = 0.5 x CSExtraDelay x GPMC FCLK<sup>(17)</sup> if (ClkActivationTime and CSOnTime are odd) or (ClkActivationTime and CSOnTime are even)
    - $F = (1 + 0.5 \times CSExtraDelay) \times GPMC_FCLK^{(17)}$  otherwise
  - Case GpmcFCLKDivider = 2:

    - F = 0.5 × CSExtraDelay × GPMC\_FCLK<sup>(17)</sup> if ((CSOnTime ClkActivationTime) is a multiple of 3) F =  $(1 + 0.5 \times CSExtraDelay) \times GPMC_FCLK<sup>(17)</sup>$  if ((CSOnTime ClkActivationTime 1) is a multiple of 3) F =  $(2 + 0.5 \times CSExtraDelay) \times GPMC_FCLK<sup>(17)</sup>$  if ((CSOnTime ClkActivationTime 2) is a multiple of 3)
- (7) For ADV falling edge (ADV activated):
  - Case GpmcFCLKDivider = 0:
    - $G = 0.5 \times ADVExtraDelay \times GPMC_FCLK^{(17)}$
  - Case GpmcFCLKDivider = 1:
    - G = 0.5 × ADVExtraDelay × GPMC FCLK<sup>(17)</sup> if (ClkActivationTime and ADVOnTime are odd) or (ClkActivationTime and ADVOnTime are even)
    - $G = (1 + 0.5 \times ADVExtraDelay) \times GPMC_FCLK^{(17)}$  otherwise
  - Case GpmcFCLKDivider = 2:

    - G =  $0.5 \times ADVExtraDelay \times GPMC\_FCLK^{(17)}$  if ((ADVOnTime ClkActivationTime) is a multiple of 3) G =  $(1 + 0.5 \times ADVExtraDelay) \times GPMC\_FCLK^{(17)}$  if ((ADVOnTime ClkActivationTime 1) is a multiple of 3) G =  $(2 + 0.5 \times ADVExtraDelay) \times GPMC\_FCLK^{(17)}$  if ((ADVOnTime ClkActivationTime 2) is a multiple of 3)

For ADV rising edge (ADV deactivated) in Reading mode:

- Case GpmcFCLKDivider = 0:
  - $G = 0.5 \times ADVExtraDelay \times GPMC_FCLK^{(17)}$
  - Case GpmcFCLKDivider = 1:
    - G = 0.5 × ADVExtraDelay × GPMC\_FCLK<sup>(17)</sup> if (ClkActivationTime and ADVRdOffTime are odd) or (ClkActivationTime and ADVRdOffTime are even)
    - $G = (1 + 0.5 \times ADVExtraDelay) \times GPMC_FCLK^{(17)}$  otherwise
  - Case GpmcFCLKDivider = 2:

  - G = 0.5 × ADVExtraDelay × GPMC\_FCLK<sup>(17)</sup> if ((ADVRdOffTime ClkActivationTime) is a multiple of 3)
    G = (1 + 0.5 × ADVExtraDelay) × GPMC\_FCLK<sup>(17)</sup> if ((ADVRdOffTime ClkActivationTime 1) is a multiple of 3)
    G = (2 + 0.5 × ADVExtraDelay) × GPMC\_FCLK<sup>(17)</sup> if ((ADVRdOffTime ClkActivationTime 2) is a multiple of 3)

For ADV rising edge (ADV deactivated) in Writing mode:

- Case GpmcFCLKDivider = 0:
  - $G = 0.5 \times ADVExtraDelay \times GPMC_FCLK^{(17)}$
- Case GpmcFCLKDivider = 1:



G = 0.5 × ADVExtraDelay × GPMC\_FCLK<sup>(17)</sup> if (ClkActivationTime and ADVWrOffTime are odd) or (ClkActivationTime and ADVWrOffTime are even)

G = (1 + 0.5 × ADVExtraDelay) × GPMC\_FCLK<sup>(17)</sup> otherwise

- Case GpmcFCLKDivider = 2:

  - $G = 0.5 \times ADVExtraDelay \times GPMC\_FCLK^{(17)}$  if ((ADVWrOffTime ClkActivationTime) is a multiple of 3)  $G = (1 + 0.5 \times ADVExtraDelay) \times GPMC\_FCLK^{(17)}$  if ((ADVWrOffTime ClkActivationTime 1) is a multiple of 3)  $G = (2 + 0.5 \times ADVExtraDelay) \times GPMC\_FCLK^{(17)}$  if ((ADVWrOffTime ClkActivationTime 2) is a multiple of 3)
- (8) For OE falling edge (OE activated) and IO DIR rising edge (Data Bus input direction):
  - Case GpmcFCLKDivider = 0:
    - $H = 0.5 \times OEExtraDelay \times GPMC_FCLK^{(17)}$
  - Case GpmcFCLKDivider = 1:
    - H = 0.5 x OEExtraDelay x GPMC\_FCLK<sup>(17)</sup> if (ClkActivationTime and OEOnTime are odd) or (ClkActivationTime and OEOnTime are even)
    - $H = (1 + 0.5 \times OEExtraDelay) \times GPMC_FCLK^{(17)}$  otherwise
  - Case GpmcFCLKDivider = 2:

    - H = 0.5 × OEExtraDelay × GPMC\_FCLK<sup>(17)</sup> if ((OEOnTime ClkActivationTime) is a multiple of 3)
      H = (1 + 0.5 × OEExtraDelay) × GPMC\_FCLK<sup>(17)</sup> if ((OEOnTime ClkActivationTime 1) is a multiple of 3)
      H = (2 + 0.5 × OEExtraDelay) × GPMC\_FCLK<sup>(17)</sup> if ((OEOnTime ClkActivationTime 2) is a multiple of 3)

#### For OE rising edge (OE deactivated):

- Case GpmcFCLKDivider = 0:
  - $H = 0.5 \times OEExtraDelay \times GPMC_FCLK^{(17)}$
- Case GpmcFCLKDivider = 1:
  - H = 0.5 x OEExtraDelay x GPMC\_FCLK<sup>(17)</sup> if (ClkActivationTime and OEOffTime are odd) or (ClkActivationTime and OEOffTime are even)
- $H = (1 + 0.5 \times OEExtraDelay) \times GPMC_FCLK^{(17)}$  otherwise
- Case GpmcFCLKDivider = 2:

  - H = 0.5 × OEExtraDelay × GPMC\_FCLK<sup>(17)</sup> if ((OEOffTime ClkActivationTime) is a multiple of 3)
    H = (1 + 0.5 × OEExtraDelay) × GPMC\_FCLK<sup>(17)</sup> if ((OEOffTime ClkActivationTime 1) is a multiple of 3)
    H = (2 + 0.5 × OEExtraDelay) × GPMC\_FCLK<sup>(17)</sup> if ((OEOffTime ClkActivationTime 2) is a multiple of 3)
- (9) For WE falling edge (WE activated):
  - Case GpmcFCLKDivider = 0:
    - J≠ 0.5 x WEExtraDelay x GPMC\_FCLK<sup>(17)</sup>
  - Case GpmcFCLKDivider = 1:
    - I = 0.5 x WEExtraDelay x GPMC\_FCLK(17) if (ClkActivationTime and WEOnTime are odd) or (ClkActivationTime and WEOnTime are even)
    - $I = (1 + 0.5 \times WEExtraDelay) \times GPMC_FCLK^{(17)}$  otherwise
  - Case GpmcFCLKDivider = 2:

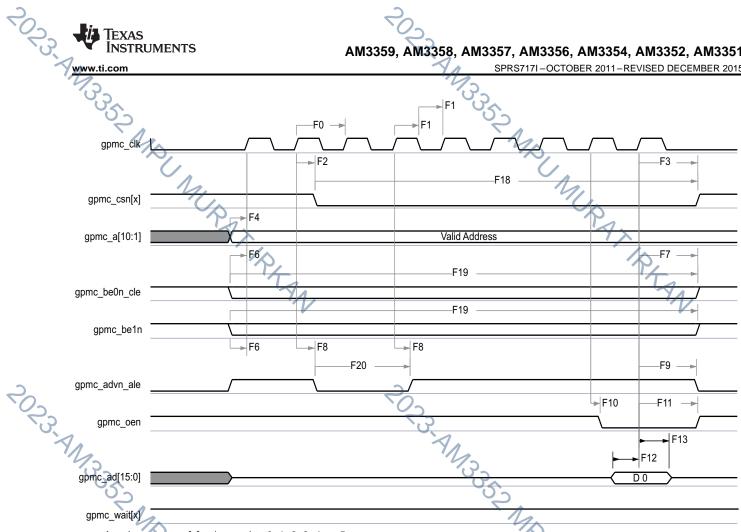
    - $I = 0.5 \times \text{WEExtraDelay} \times \text{GPMC\_FCLK}^{(17)} \text{ if ((WEOnTime ClkActivationTime) is a multiple of 3)}$   $I = (1 + 0.5 \times \text{WEExtraDelay}) \times \text{GPMC\_FCLK}^{(17)} \text{ if ((WEOnTime ClkActivationTime 1) is a multiple of 3)}$
    - $I = (2 + 0.5 \times WEExtraDelay) \times GPMC_FCLK^{(17)}$  if ((WEOnTime ClkActivationTime 2) is a multiple of 3)

#### For WE rising edge (WE deactivated):

- Case GpmcFCLKDivider = 0:
  - $I = 0.5 \times WEExtraDelay \times GPMC_FCLK$  (17)
- Case GpmcFCLKDivider = 1:
  - I = 0.5 x WEExtraDelay x GPMC\_FCLK<sup>(17)</sup> if (ClkActivationTime and WEOffTime are odd) or (ClkActivationTime and WEOffTime are even)
  - $I = (1 + 0.5 \times WEExtraDelay) \times GPMC_FCLK^{(17)}$  otherwise
- Case GpmcFCLKDivider = 2:
- I = 0.5 x WEExtraDelay x GPMC\_FCLK<sup>(17)</sup> if ((WEOffTime ClkActivationTime) is a multiple of 3)
- I = (1 + 0.5 × WEExtraDelay) × GPMC\_FCLK<sup>(17)</sup> if ((WEOffTime ClkActivationTime 1) is a multiple of 3)
  I = (2 + 0.5 × WEExtraDelay) × GPMC\_FCLK<sup>(17)</sup> if ((WEOffTime ClkActivationTime 2) is a multiple of 3)
- (10)  $J = GPMC\_FCLK^{(17)}$
- (11) First transfer only for CLK DIV 1 mode.
- (12) Half cycle; for all data after initial transfer for CLK DIV 1 mode
- (13) Half cycle of GPMC\_CLK\_OUT; for all data for modes other than CLK DIV 1 mode. GPMC\_CLK\_OUT divide down from GPMC\_FCLK.
- (14) In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5. In gpmc\_wait[x], x is equal to 0 or 1.
- (15) P = gpmc\_clk period in ns
- (16) For read: K = (ADVRdOffTime ADVOnTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17) For write: K = (ADVWrOffTime - ADVOnTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(17)
- (17) GPMC FCLK is general-purpose memory controller internal functional clock period in ns.
- (18) Related to the gpmc\_clk output clock maximum and minimum frequencies programmable in the GPMC module by setting the GPMC CONFIG1 CSx configuration register bit field GpmcFCLKDivider.
- (19) The jitter probability density can be approximated by a Gaussian function.

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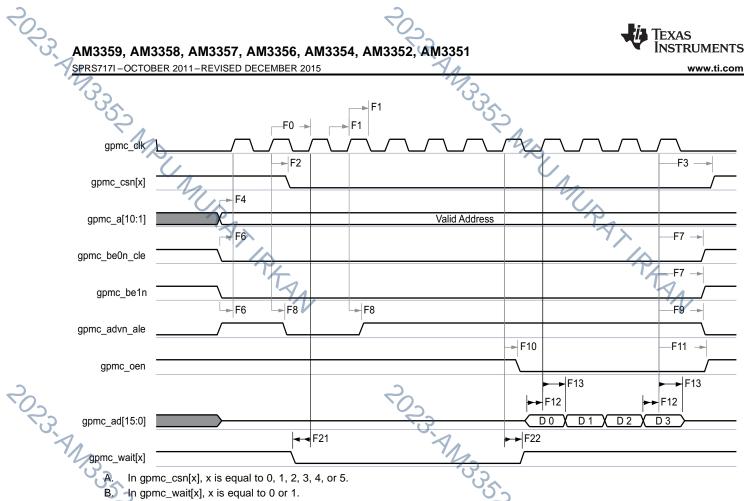


- A. In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5.
- In gpmc\_wait[x], x is equal to 0 or 1.

Figure 7-17, GPMC and NOR Flash—Synchronous Single Read—(GpmcFCLKDivider = 0) PANARAN

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B. In gpmc\_wait[x], x is equal to 0 or 1.

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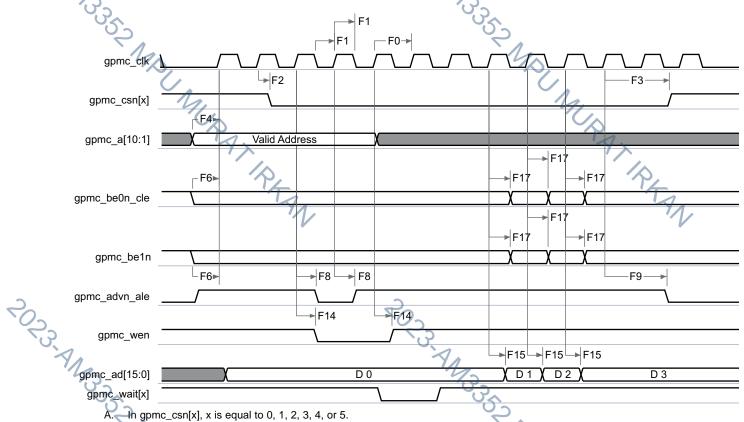
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In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5.

In gpmc\_wait[x], x is equal to 0 or 1.

Figure 7-19. GPMC and NOR Flash—Synchronous Burst Write—(GpmcFCLKDivider > 0) Mers Pts MURANAPAN

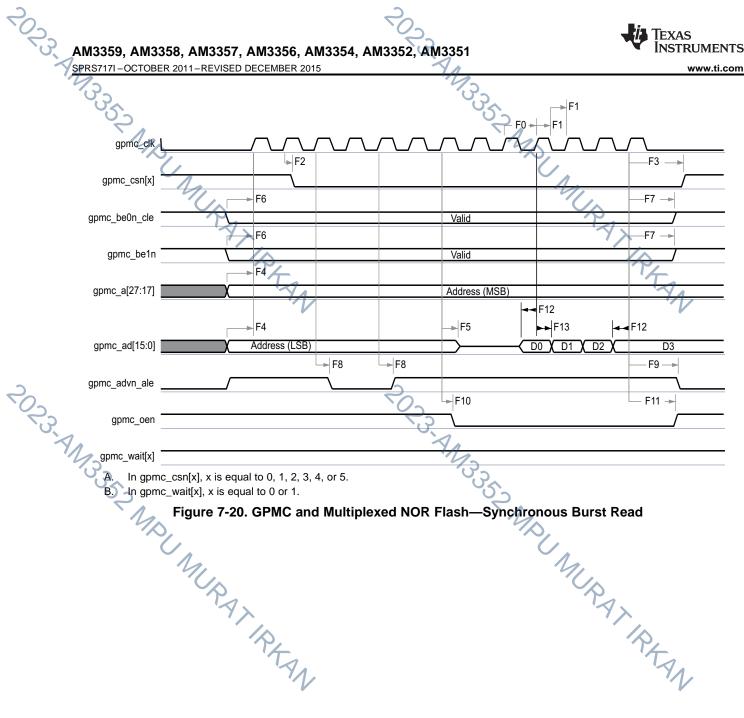
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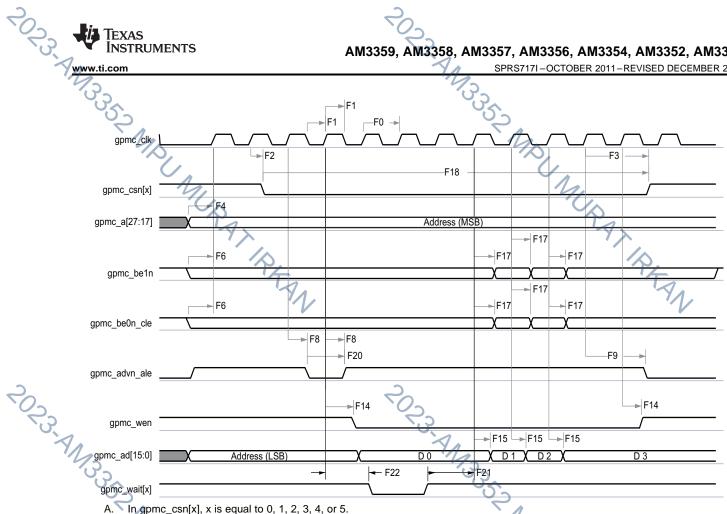
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REAL Figure 7-20. GPMC and Multiplexed NOR Flash—Synchronous Burst Read

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A. In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5.

In gpmc\_wait[x], x is equal to 0 or 1.

Figur Many Report of the Control of MRAX PAN Figure 7-21. GPMC and Multiplexed NOR Flash—Synchronous Burst Write

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# 7.7.1.2 GPMC and NOR Flash—Asynchronous Mode

Table 7-24 and Table 7-25 assume testing over the recommended operating conditions and electrical characteristic conditions shown in Table 7-23 (see Figure 7-22 through Figure 7-27).

Table 7-23. GPMC and NOR Flash Timing Conditions—Asynchronous Mode

	41,	MIN TYP MAX	UNIT
Input Con	ditions		
t <sub>R</sub>	Input signal rise time	1 5	ns
t <sub>F</sub>	Input signal fall time	1 5	ns
Output Condition			
C <sub>LOAD</sub>	Output load capacitance	3 30	pF

# Table 7-24. GPMC and NOR Flash Internal Timing Requirements—Asynchronous Mode<sup>(1)(2)</sup>

NO.		OPP100	OPP50	LINIT
NO.		MIN MAX	MIN MAX	UNIT
FI1	Delay time, output data gpmc_ad[15:0] generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
FI2	Delay time, input data gpmc_ad[15:0] capture from internal functional clock GPMC_FCLK <sup>(3)</sup>	4	4	ns
FI3	Delay time, output chip select gpmc_csn[x] generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
FI4	Delay time, output address gpmc_a[27:1] generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
FI5	Delay time, output address gpmc_a[27:1] valid from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
FI6	Delay time, output lower-byte enable and command latch enable gpmc_be0n_cle, output upper-byte enable gpmc_be1n generation from internal functional clock GPMC_FCLK(3)	6.5	6.5	ns
FI7	Delay time, output enable gpmc_oen generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
FI8	Delay time, output write enable gpmc_wen generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
FI9	Skew, internal functional clock GPMC_FCLK <sup>(3)</sup>	100	100	ps

<sup>(1)</sup> The internal parameters table must be used to calculate data access time stored in the corresponding CS register bit field.

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<sup>(2)</sup> Internal parameters are referred to the GPMC functional internal clock which is not provided externally.

<sup>(3)</sup> GPMC\_FCLK is general-purpose memory controller internal functional clock.



Table 7-25. GPMC and NOR Flash Timing Requirements—Asynchronous Mode

NO.		OPP100	OPP50	UNIT	
	1/2		MIN MAX	MIN MAX	
FA5 <sup>(1)</sup>	t <sub>acc(d)</sub>	Data access time	H <sup>(5)</sup>	H <sup>(5)</sup>	ns
FA20 <sup>(2)</sup>	t <sub>acc1-pgmode(d)</sub>	Page mode successive data access time	P <sup>(4)</sup>	P <sup>(4)</sup>	ns
FA21 <sup>(3)</sup>	t <sub>acc2-pgmode(d)</sub>	Page mode first data access time	H(5)	H <sup>(5)</sup>	ns

- (1) The FA5 parameter shows the amount of time required to internally sample input data. It is expressed in number of GPMC functional clock cycles. From start of read cycle and after FA5 functional clock cycles, input data is internally sampled by active functional clock edge. FA5 value must be stored inside the AccessTime register bit field.
- (2) The FA20 parameter shows amount of time required to internally sample successive input page data. It is expressed in number of GPMC functional clock cycles. After each access to input page data, next input page data is internally sampled by active functional clock edge after FA20 functional clock cycles. The FA20 value must be stored in the PageBurstAccessTime register bit field.
- (3) The FA21 parameter shows amount of time required to internally sample first input page data. It is expressed in number of GPMC functional clock cycles. From start of read cycle and after FA21 functional clock cycles, first input page data is internally sampled by active functional clock edge. FA21 value must be stored inside the AccessTime register bit field.
- (4) P = PageBurstAccessTime × (TimeParaGranularity + 1) × GPMC\_FCLK<sup>(6)</sup>
- (5) H = AccessTime × (TimeParaGranularity + 1) × GPMC\_FCLK<sup>(6)</sup>
- (6) GPMC\_FCLK is general-purpose memory controller internal functional clock period in ns.

#### Table 7-26. GPMC and NOR Flash Switching Characteristics – Asynchronous Mode

NO.		PARAMETER	٠٠,	OPP	100	OPP!	50	UNIT
NO.		PARAMETER	7	MIN	MAX	MIN	MAX	UNII
45	t <sub>R(d)</sub>	Rise time, output data gpmc_ad[15:0]		1/2	2		2	ns
CO	t <sub>F(d)</sub>	Fall time, output data gpmc_ad[15:0]		.O.2	2		2	ns
FA0	t <sub>w(be[x]nV)</sub>	Pulse duration, output lower-byte	Read	305	N <sup>(12)</sup>		N <sup>(12)</sup>	ns
	Ms.	enable and command latch enable gpmc_be0n_cle, output upper-byte enable gpmc_be1n valid time	Write		N <sup>(12)</sup>		N <sup>(12)</sup>	
FA1	t <sub>w(csnV)</sub>	Pulse duration, output chip select	Read		(A <sup>(1)</sup>		A <sup>(1)</sup>	ns
	1,	gpmc_csn[x] <sup>(13)</sup> low	Write		A(1)	7,	A <sup>(1)</sup>	
FA3	t <sub>d(csnV-advnIV)</sub>	Delay time, output chip select	Read	$B^{(2)} - 0.2$	$B^{(2)} + 2.0$	B <sup>(2)</sup> – 5	B <sup>(2)</sup> + 5	ns
		gpmc_csn[x] <sup>(13)</sup> valid to output address valid and address latch enable gpmc_advn_ale invalid	Write	$B^{(2)} - 0.2$	B <sup>(2)</sup> + 2.0	B <sup>(2)</sup> – 5	B <sup>(2)</sup> + 5	
FA4	t <sub>d(csnV-oenIV)</sub>	Delay time, output chip select gpmc_cs valid to output enable gpmc_oen invali read)		$C^{(3)} - 0.2$	$C^{(3)} + 2.0$	C <sup>(3)</sup> – 5	C <sup>(3)</sup> + 5	ns
FA9	t <sub>d(aV-csnV)</sub>	Delay time, output address gpmc_a[27 to output chip select gpmc_csn[x] <sup>(13)</sup> va		$J^{(9)} - 0.2$	J <sup>(9)</sup> + 2.0	$J^{(9)} - 5$	J <sup>(9)</sup> + 5	ns
FA10	t <sub>d(be[x]nV-csnV)</sub>	Delay time, output lower-byte enable a command latch enable gpmc_be0n_cle upper-byte enable gpmc_be1n valid to chip select gpmc_csn[x] <sup>(13)</sup> valid	e, output	J <sup>(9)</sup> – 0.2	J <sup>(9)</sup> + 2.0	J <sup>(9)</sup> – 5	J <sup>(9)</sup> + 5	ns
FA12	t <sub>d(csnV-advnV)</sub>	Delay time, output chip select gpmc_cs valid to output address valid and addre enable gpmc_advn_ale valid		K <sup>(10)</sup> – 0.2	K <sup>(10)</sup> + 2.0	K <sup>(10)</sup> – 5	K <sup>(10)</sup> + 5	ns
FA13	t <sub>d(csnV-oenV)</sub>	Delay time, output chip select gpmc_cs valid to output enable gpmc_oen valid	sn[x] <sup>(13)</sup>	L <sup>(11)</sup> – 0.2	L <sup>(11)</sup> + 2.0	L <sup>(11)</sup> – 5	L <sup>(11)</sup> + 5	ns
FA16	t <sub>w(alV)</sub>	Pulse durationm output address gpmc invalid between 2 successive read and accesses		G <sup>(7)</sup>		G <sup>(7)</sup>		ns
FA18	t <sub>d</sub> (csnV-oenIV)	Delay time, output chip select gpmc_cs valid to output enable gpmc_oen invali read)	sn[x] <sup>(13)</sup> d (Burst	I <sup>(8)</sup> 0.2	l <sup>(8)</sup> + 2.0	I <sup>(8)</sup> – 5	I <sup>(8)</sup> + 5	ns
FA20	t <sub>w(aV)</sub>	Pulse duration, output address gpmc_a valid - 2nd, 3rd, and 4th accesses	a[27:1]	D <sup>(4)</sup>	7/	D <sup>(4)</sup>		ns
FA25	t <sub>d(csnV-wenV)</sub>	Delay time, output chip select gpmc_cs valid to output write enable gpmc_wen		E <sup>(5)</sup> – 0.2	$E^{(5)} + 2.0$	E <sup>(5)</sup> – 5	E <sup>(5)</sup> + 5	ns

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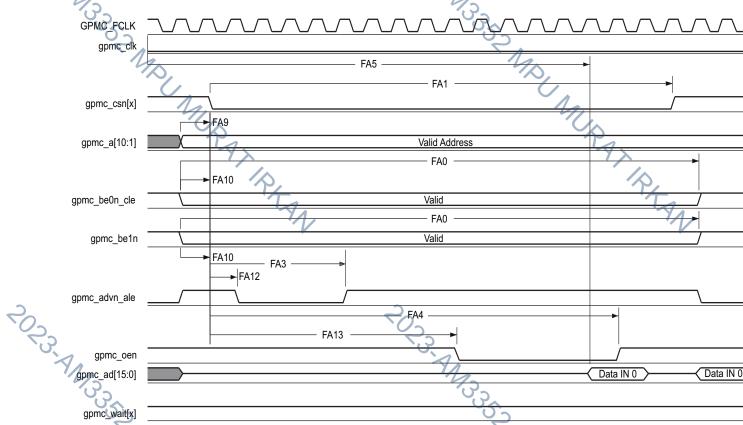
Utable 7-26. GPMC and NOR Flash Switching Characteristics ← Asynchronous Mode (continued)

		•	$\cup$	-	•		•
NO.	PARAMETER		OPP	100	OPP50	)	UNIT
NO.	1/1	PARAMETER	MIN	MAX	MIN	MAX	UNII
FA27	t <sub>d(csnV-wenIV)</sub>	Delay time, output chip select gpmc_csn[x] <sup>(13)</sup> valid to output write enable gpmc_wen invalid	$F^{(6)} - 0.2$	F <sup>(6)</sup> + 2.0	F <sup>(6)</sup> – 5	F <sup>(6)</sup> + 5	ns
FA28	t <sub>d(wenV-dV)</sub>	Delay time, output write enable gpmc_ wen valid to output data gpmc_ad[15:0] valid		2.0		5	ns
FA29	t <sub>d(dV-csnV)</sub>	Delay time, output data gpmc_ad[15:0] valid to output chip select gpmc_csn[x] <sup>(13)</sup> valid	$J^{(9)} - 0.2$	$J^{(9)} + 2.0$	J <sup>(9)</sup> – 5	J <sup>(9)</sup> + 5	ns
FA37	t <sub>d(oenV-alV)</sub>	Delay time, output enable gpmc_oen valid to output address gpmc_ad[15:0] phase end		2.0	4	5	ns

- (1) For single read: A = (CSRdOffTime CSOnTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(14) For single write: A = (CSWrOffTime - CSOnTime) × (TimeParaGranularity + 1) × GPMC\_FCLK<sup>(14)</sup> For burst read: A = (CSRdOffTime - CSOnTime + (n - 1) x PageBurstAccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(14) For burst write: A = (CSWrOffTime - CSOnTime + (n - 1) x PageBurstAccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK<sup>(14)</sup> with n being the page burst access number
- (2) For reading: B = ((ADVRdOffTime CSOnTime)  $\times$  (TimeParaGranularity + 1) + 0.5  $\times$  (ADVExtraDelay CSExtraDelay))  $\times$  GPMC\_FCLK<sup>(14)</sup> For writing: B = ((ADVWrOffTime - CSOnTime)  $\times$  (TimeParaGranularity + 1) + 0.5  $\times$  (ADVExtraDelay - CSExtraDelay))  $\times$  GPMC\_FCLK<sup>(14)</sup>
- (3) C = ((OEOffTime CSOnTime) x (TimeParaGranularity + 1) + 0.5 x (OEExtraDelay CSExtraDelay)) x GPMC\_FCLK<sup>(14)</sup>
- (4) D = PageBurstAccessTime × (TimeParaGranularity + 1) × GPMC\_FCLK<sup>(14)</sup>
- (5) E = ((WEOnTime CSOnTime) x (TimeParaGranularity + 1) + 0.5 x (WEExtraDelay CSExtraDelay)) x GPMC\_FCLK(14)
- (6) F = ((WEOffTime CSOnTime) x (TimeParaGranularity + 1) + 0.5 x (WEExtraDelay CSExtraDelay)) x GPMC\_FCLK(14)
- (7) G = Cycle2CycleDelay × GPMC\_FCLK<sup>(14)</sup>
- (8) I = ((OEOffTime + (n − 1) × PageBurstAccessTime − CSOnTime) × (TimeParaGranularity + 1) + 0.5 × (OEExtraDelay − CSExtraDelay)) × GPMC\_FCLK<sup>(14)</sup>
- (9) J = (CSOnTime × (TimeParaGranularity + 1) + 0.5 × CSExtraDelay) × GPMC\_FCLK(1)
- (10) K = ((ADVOnTime CSOnTime) × (TimeParaGranularity + 1) + 0.5 × (ADVExtraDelay CSExtraDelay)) × GPMC\_FCLK<sup>(14)</sup>
- (11) L = ((OEOnTime CSOnTime) × (TimeParaGranularity + 1) + 0.5 × (OEExtraDelay CSExtraDelay)) × GPMC\_FCLK<sup>(14)</sup>
- (12) For single read: N = RdCycleTime × (TimeParaGranularity + 1) × GPMC\_FCLK<sup>(14)</sup> For single write: N = WrCycleTime × (TimeParaGranularity + 1) × GPMC\_FCLK<sup>(14)</sup> For burst read: N = (RdCycleTime + (n - 1) x PageBurstAccessTime) x (TimeParaGranularity + 1) x GPMC\_FCLK(14) For burst write:  $N = (WrCycleTime + (n - 1) \times PageBurstAccessTime) \times (TimeParaGranularity + 1) \times GPMC_FCLK<sup>(14)</sup>$
- (13) In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5.
- (14) GPMC\_FCLK is general-purpose memory controller internal functional clock period in ns.

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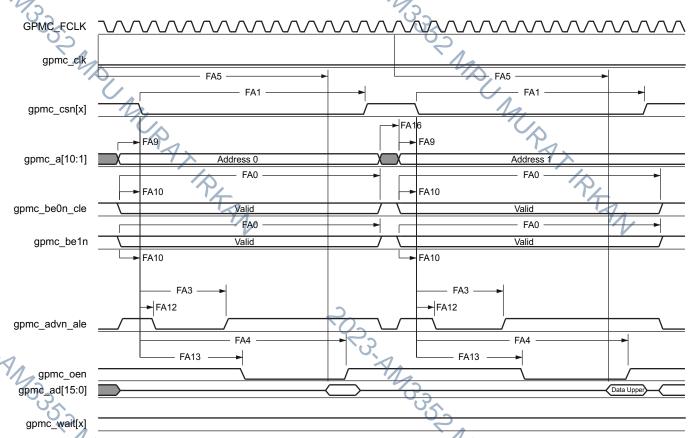


- A. In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5. In gpmc\_wait[x], x is equal to 0 or 1.
- B. FA5 parameter illustrates amount of time required to internally sample input data. It is expressed in number of GPMC functional clock cycles. From start of read cycle and after FA5 functional clock cycles, input data will be internally sampled by active functional clock edge. FA5 value must be stored inside AccessTime register bits field.
- C. GPMC\_FCLK is an internal clock (GPMC functional clock) not provided externally.

Figure 7-22. GPMC and NOR Flash—Asynchronous Read—Single Word

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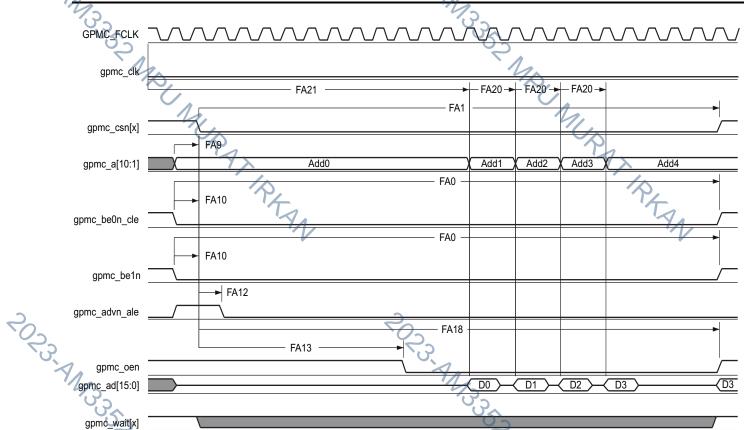
- In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5. In gpmc\_wait[x], x is equal to 0 or 1.
- FA5 parameter illustrates amount of time required to internally sample input data. It is expressed in number of GPMC functional clock cycles. From start of read cycle and after FA5 functional clock cycles, input data will be internally sampled by active functional clock edge. FA5 value must be stored inside AccessTime register bits field.
- GPMC\_FCLK is an internal clock (GPMC functional clock) not provided externally.

Figure 7-23. GPMC and NOR Flash—Asynchronous Read—32-bit Pty.

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gpmc\_wait[x]



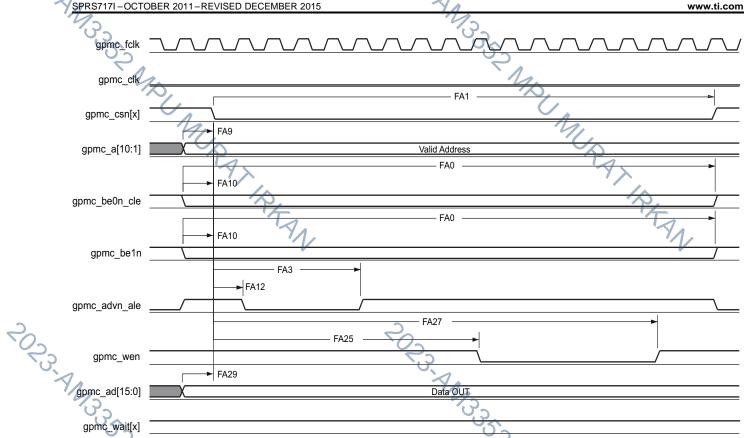
- In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5. In gpmc\_wait[x], x is equal to 0 or 1.
- FA21 parameter illustrates amount of time required to internally sample first input page data. It is expressed in number of GPMC functional clock cycles. From start of read cycle and after FA21 functional clock cycles, first input page data will be internally sampled by active functional clock edge. FA21 calculation must be stored inside AccessTime register bits field.
- FA20 parameter illustrates amount of time required to internally sample successive input page data. It is expressed in number of GPMC functional clock cycles. After each access to input page data, next input page data will be internally sampled by active functional clock edge after FA20 functional clock cycles. FA20 is also the duration of address phases for successive input page data (excluding first input page data). FA20 value must be stored in PageBurstAccessTime register bits field.
- GPMC\_FCLK is an internal clock (GPMC functional clock) not provided externally.

Figure 7-24. GPMC and NOR Flash—Asynchronous Read—Page Mode 4x16-bit

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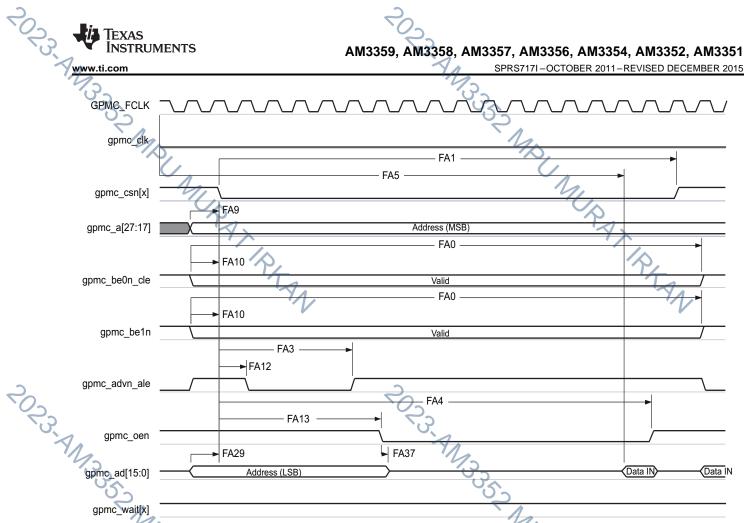
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A. In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5. In gpmc\_wait[x], x is equal to 0 or 1. Pt. MCPA > Pt.

Figure 7-25. GPMC and NOR Flash—Asynchronous Write--Single Word Si.
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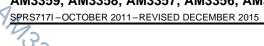


- In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5. In gpmc\_wait[x], x is equal to 0 or 1 A.
- FA5 parameter illustrates amount of time required to internally sample input data. It is expressed in number of GPMC functional clock cycles. From start of read cycle and after FA5 functional clock cycles, input data will be internally sampled by active functional clock edge. FA5 value must be stored inside AccessTime register bits field.
- GPMC\_FCLK is an internal clock (GPMC functional clock) not provided externally.

Figure 7-26. GPMC and Multiplexed NOR Flash—Asynchronous Read--Single Word Pty

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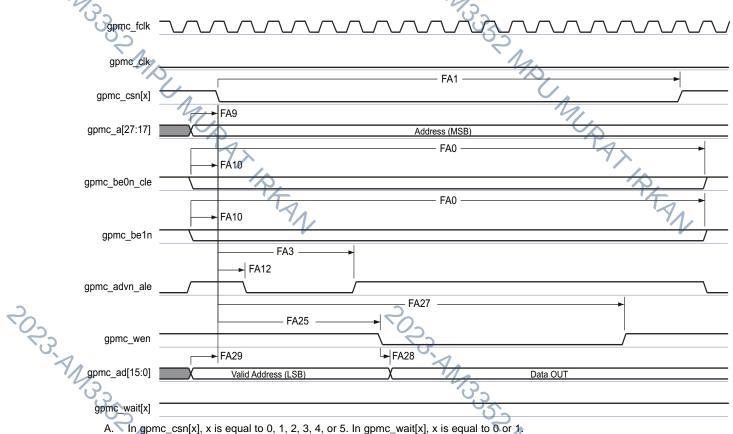


Figure 7-27. GPMC and Multiplexed NOR Flash—Asynchronous Write—Single Word MURAN PAR MERAN

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#### 7.7.1.3 GPMC and NAND Flash—Asynchronous Mode

Table 7-28 and Table 7-29 assume testing over the recommended operating conditions and electrical characteristic conditions shown in Table 7-27 (see Figure 7-28 through Figure 7-31).

Table 7-27. GPMC and NAND Flash Timing Conditions—Asynchronous Mode

	PARAMETER	MIN TYP MAX	UNIT
Input Con	nditions		
t <sub>R</sub>	Input signal rise time	1 5	ns
t <sub>F</sub>	Input signal fall time	1 5	ns
Output Co	Output Condition		
C <sub>LOAD</sub>	Output load capacitance	3 30	pF

#### Table 7-28. GPMC and NAND Flash Internal Timing Requirements—Asynchronous Mode (1)(2)

NO		OPP100	OPP50	LINIT
NO.		MIN MAX	MIN MAX	UNIT
GNFI1	Delay time, output data gpmc_ad[15:0] generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
GNFI2	Delay time, input data gpmc_ad[15:0] capture from internal functional clock GPMC_FCLK <sup>(3)</sup>	4.0	4.0	ns
GNFI3	Delay time, output chip select gpmc_csn[x] generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
GNFI4	Delay time, output address valid and address latch enable gpmc_advn_ale generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
GNFI5	Delay time, output lower-byte enable and command latch enable gpmc_be0n_cle generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
GNFI6	Delay time, output enable gpmc_oen generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
GNFI7	Delay time, output write enable gpmc_wen generation from internal functional clock GPMC_FCLK <sup>(3)</sup>	6.5	6.5	ns
GNFI8	Skew, functional clock GPMC_FCLK <sup>(3)</sup>	100	100	ps

<sup>(1)</sup> Internal parameters table must be used to calculate data access time stored in the corresponding CS register bit field.

## Table 7-29. GPMC and NAND Flash Timing Requirements—Asynchronous Mode

NO.		OPP1	00	OPP	50	UNIT
NO.		MIN	MAX	MIN	MAX	UNII
GNF12 <sup>(1)</sup>	t <sub>acc(d)</sub> Access time, input data gpmc_ad[15:0]		J <sup>(2)</sup>		J <sup>(2)</sup>	ns

<sup>(1)</sup> The GNF12 parameter illustrates the amount of time required to internally sample input data. It is expressed in number of GPMC functional clock cycles. From start of the read cycle and after GNF12 functional clock cycles, input data is internally sampled by the (2) (3) GF. (3) GF. (nstr active functional clock edge. The GNF12 value must be stored inside AccessTime register bit field.

(2) J = AccessTime × (TimeParaGranularity + 1) × GPMC\_FCLK<sup>(3)</sup>

GPMC\_FCLK is general-purpose memory controller internal functional clock period in ns. SSE MAL MU,

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<sup>(2)</sup> Internal parameters are referred to the GPMC functional internal clock which is not provided externally.

<sup>(3)</sup> GPMC\_FCLK is general-purpose memory controller internal functional clock.



## Table 7-30. GPMC and NAND Flash Switching Characteristics—Asynchronous Mode

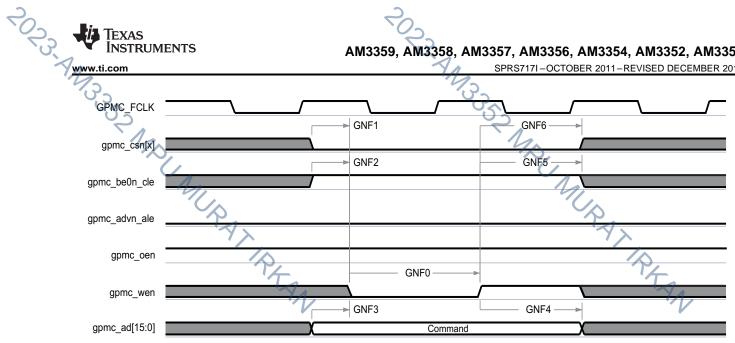
	. ~		- 0 -		
NO.		DADAMETED	OPP100	OPP50	UNIT
NO.	1/2	PARAMETER	MIN / MAX	MIN MAX	UNII
	t <sub>R(d)</sub>	Rise time, output data gpmc_ad[15:0]	2	2	ns
	t <sub>F(d)</sub>	Fall time, output data gpmc_ad[15:0]	/	2	ns
GNF0	t <sub>w(wenV)</sub>	Pulse duration, output write enable gpmc_wen valid	A <sup>(1)</sup>	A <sup>(1)</sup>	ns
GNF1	t <sub>d(csnV-wenV)</sub>	Delay time, output chip select gpmc_csn[x] <sup>(13)</sup> valid to output write enable gpmc_wen valid	$B^{(2)} - 0.2$ $B^{(2)} + 2.0$	7	ns
GNF2	t <sub>w(cleH-wenV)</sub>	Delay time, output lower-byte enable and command latch enable gpmc_be0n_cle high to output write enable gpmc_wen valid	$C^{(3)} - 0.2$ $C^{(3)} + 2.0$	TT	ns
GNF3	t <sub>w(wenV-dV)</sub>	Delay time, output data gpmc_ad[15:0] valid to output write enable gpmc_wen valid	$D^{(4)} - 0.2$ $D^{(4)} + 2.0$	$D^{(4)} - 5$ $D^{(4)} + 5$	ns
GNF4	t <sub>w(wenIV-dIV)</sub>	Delay time, output write enable gpmc_wen invalid to output data gpmc_ad[15:0] invalid	$E^{(5)} - 0.2$ $E^{(5)} + 5$	$E^{(5)} - 5 \qquad E^{(5)} + 5$	ns
GNF5	t <sub>w(wenIV-cleIV)</sub>	Delay time, output write enable gpmc_wen invalid to output lower-byte enable and command latch enable gpmc_be0n_cle invalid	$F^{(6)} - 0.2$ $F^{(6)} + 2.0$	$F^{(6)} - 5$ $F^{(6)} + 5$	ns
GNF6	t <sub>w(wenIV-csnIV)</sub>	Delay time, output write enable gpmc_wen invalid to output chip select gpmc_csn[x] <sup>(13)</sup> invalid	$G^{(7)} - 0.2$ $G^{(7)} + 2.0$	$G^{(7)} - 5 \qquad G^{(7)} + 5$	ns
GNF7	t <sub>w(aleH-wenV)</sub>	Delay time, output address valid and address latch enable gpmc_advn_ale high to output write enable gpmc_wen valid	$C^{(3)} - 0.2$ $C^{(3)} + 2.0$		ns
GNF8	tw(wenIV-aleIV)	Delay time, output write enable gpmc_wen invalid to output address valid and address latch enable gpmc_advn_ale invalid	$F^{(6)} = 0.2$ $F^{(6)} + 2.0$		ns
GNF9	t <sub>c(wen)</sub>	Cycle time, write	H <sup>(8)</sup>		ns
GNF10	t <sub>d(csnV-oenV)</sub>	Delay time, output chip select gpmc_csn[x] <sup>(13)</sup> valid to output enable gpmc_oen valid	$I^{(9)} - 0.2$ $I^{(9)} + 2.0$		ns
GNF13	t <sub>w(oenV)</sub>	Pulse duration, output enable gpmc_oen valid	K <sup>(10)</sup>	K <sup>(10)</sup>	ns
GNF14	t <sub>c(oen)</sub>	Cycle time, read	L <sup>(11)</sup>	L <sup>(11)</sup>	ns
GNF15	t <sub>w(oenIV-csnIV)</sub>	Delay time, output enable gpmc_oen invalid to output chip select gpmc_csn[x] <sup>(13)</sup> invalid	$M^{(12)} - 0.2 M^{(12)} + 2.0$	$M^{(12)} - 5 \qquad M^{(12)} + 5$	ns

- (1) A = (WEOffTime WEOnTime) x (TimeParaGranularity + 1) x GPMC\_FCLK<sup>(14)</sup>
- (2) B = ((WEOnTime CSOnTime) × (TimeParaGranularity + 1) + 0.5 × (WEExtraDelay CSExtraDelay)) × GPMC\_FCLK(14)
- (3) C = ((WEOnTime ADVOnTime) x (TimeParaGranularity + 1) + 0.5 x (WEExtraDelay ADVExtraDelay)) x GPMC\_FCLK
- (4) D = (WEOnTime × (TimeParaGranularity + 1) + 0.5 × WEExtraDelay) × GPMC\_FCLK<sup>(14)</sup>
- (5) E = ((WrCycleTime WEOffTime) x (TimeParaGranularity + 1) 0.5 x WEExtraDelay) x GPMC\_FCLK(14)
- (6) F = ((ADVWrOffTime WEOffTime) x (TimeParaGranularity + 1) + 0.5 x (ADVExtraDelay WEExtraDelay)) x GPMC\_FCLK(14)
- (7) G = ((CSWrOffTime WEOffTime) x (TimeParaGranularity + 1) + 0.5 x (CSExtraDelay WEExtraDelay)) x GPMC\_FCLK<sup>(14)</sup>
- (8) H = WrCycleTime × (1 + TimeParaGranularity) × GPMC\_FCLK<sup>(14)</sup>
- (9) I = ((OEOnTime CSOnTime) × (TimeParaGranularity + 1) + 0.5 × (OEExtraDelay CSExtraDelay)) × GPMC\_FCLK(14)
- (10) K = (OEOffTime OEOnTime) x (1 + TimeParaGranularity) x GPMC\_FCLK(14)
- (11) L = RdCycleTime × (1 + TimeParaGranularity) × GPMC\_FCLK(14)
- 12) M = ((CSRdOffTime OEOffTime) × (TimeParaGranularity + 1) + 0.5 × (CSExtraDelay OEExtraDelay)) × GPMC\_FCLK(14)
- (13) In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5.
- (14) GPMC\_FCLK is general-purpose memory controller internal functional clock period in ns.

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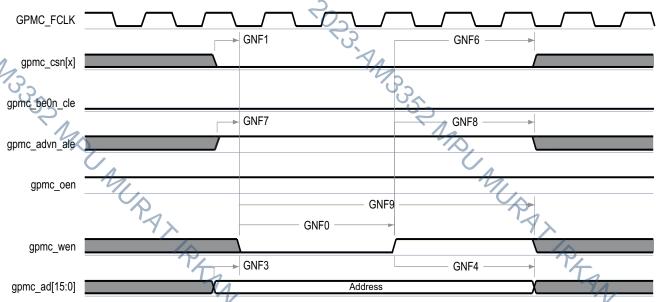
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(1) In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5.

Figure 7-28. GPMC and NAND Flash—Command Latch Cycle



(1) In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5.

Figure 7-29. GPMC and NAND Flash—Address Latch Cycle

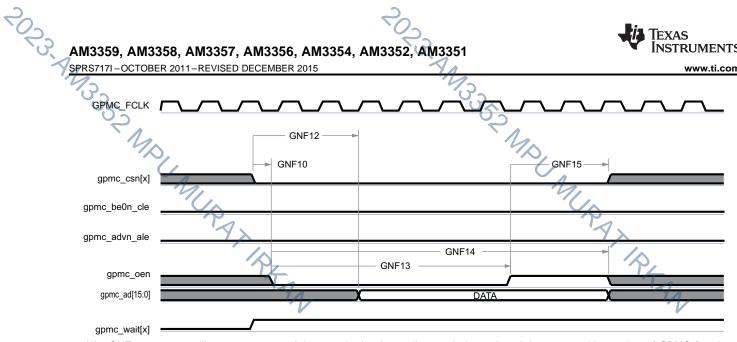
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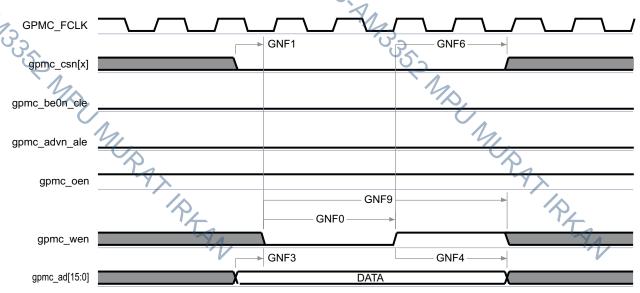
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- GNF12 parameter illustrates amount of time required to internally sample input data. It is expressed in number of GPMC functional clock cycles. From start of read cycle and after GNF12 functional clock cycles, input data will be internally sampled by active functional clock edge. GNF12 value must be stored inside AccessTime register bits field.
- GPMC\_FCLK is an internal clock (GPMC functional clock) not provided externally.
- In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5. In gpmc\_wait[x], x is equal to 0 or 1.

Figure 7-30. GPMC and NAND Flash—Data Read Cycle



(1) In gpmc\_csn[x], x is equal to 0, 1, 2, 3, 4, or 5.

Figure 7-31. GPMC and NAND Flash—Data Write Cycle

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## 7.7.2 mDDR(LPDDR), DDR2, DDR3, DDR3L Memory Interface

The device has a dedicated interface to mDDR(LPDDR), DDR2, DDR3, and DDR3L SDRAM. It supports JEDEC standard compliant mDDR(LPDDR), DDR2, DDR3, and DDR3L SDRAM devices with a 16-bit data path to external SDRAM memory.

For more details on the mDDR(LPDDR), DDR2, DDR3, and DDR3L memory interface, see the EMIF section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73).

#### 7.7.2.1 mDDR (LPDDR) Routing Guidelines

It is common to find industry references to mobile double data rate (mDDR) when discussing JEDEC defined low-power double-data rate (LPDDR) memory devices. The following guidelines use LPDDR when referencing JEDEC defined low-power double-data rate memory devices.

#### 7.7.2.1.1 Board Designs

TI only supports board designs that follow the guidelines outlined in this document. The switching characteristics and the timing diagram for the LPDDR memory interface are shown in Table 7-31 and Figure 7-32.

Table 7-31. Switching Characteristics for LPDDR Memory Interface

NO.	PARAMETER	MIN	MAX	UNIT
23	$t_{c(DDR\_CK)} \ t_{c(DDR\_CKn)}$ Cycle time, DDR_CK and DDR_CKn	5	(1)	ns

(1) The JEDEC JESD209B specification only defines the maximum clock period for LPDDR333 and faster speed bin LPDDR memory devices. To determine the maximum clock period, see the respective LPDDR memory data sheet.

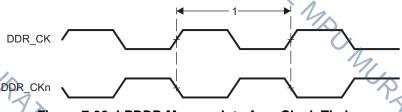


Figure 7-32. LPDDR Memory Interface Clock Timing

#### 7.7.2.1.2 LPDDR Interface

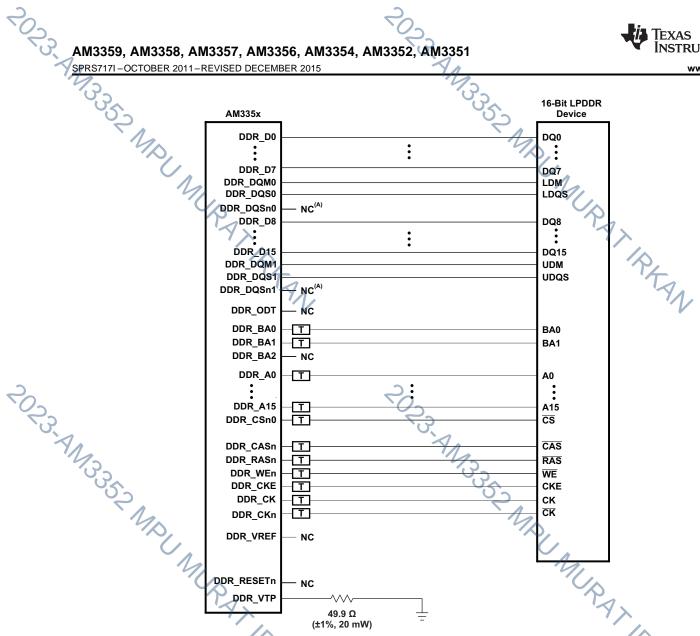
This section provides the timing specification for the LPDDR interface as a PCB design and manufacturing specification. The design rules constrain PCB trace length, PCB trace skew, signal integrity, cross-talk, and signal timing. These rules, when followed, result in a reliable LPDDR memory system without the need for a complex timing closure process. For more information regarding the guidelines for using this LPDDR specification, see the *Understanding TI's PCB Routing Rule-Based DDR Timing Specification* application report (SPRAAVO). This application report provides generic guidelines and approach. All the specifications provided in the data manual take precedence over the generic guidelines and must be adhered to for a reliable LPDDR interface operation.

#### 77.7.2.1.2.1 LPDDR Interface Schematic

Figure 7-33 shows the schematic connections for 16-bit interface on AM335x device using one x16 LPDDR device. The AM335x LPDDR memory interface only supports 16-bit wide mode of operation. The AM335x device can only source one load connected to the DQS[x] and DQ[x] net class signals and one load connected to the CK and ADDR\_CTRL net class signals. For more information related to net classes, see Section 7.7.2.1.2.8.

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- Enable internal weak pulldown on these pins. For details, see the EMIF section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73).
- For all the termination requirements, see Section 7.7.2.1.2.9.

Figure 7-33. 16-Bit LPDDR Interface Using One 16-Bit LPDDR Device

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#### 7.7.2.1.2.2 Compatible JEDEC LPDDR Devices

Table 7-32 shows the parameters of the JEDEC LPDDR devices that are compatible with this interface. Generally, the LPDDR interface is compatible with x16 LPDDR400 speed grade LPDDR devices.

Table 7-32. Compatible JEDEC LPDDR Devices (Per Interface)(1)

NO.	PARAMETER	MIN MAX	UNIT
1	JEDEC LPDDR device speed grade	LPDDR400	
2	JEDEC LPDDR device bit width	x16 x16	Bits
3	JEDEC LPDDR device count	1	Devices
4	JEDEC LPDDR device terminal count	60	Terminals

<sup>(1)</sup> If the LPDDR interface is operated with a clock frequency less than 200 MHz, lower-speed grade LPDDR devices may be used if the minimum clock period specified for the LPDDR device is less than or equal to the minimum clock period selected for the AM335x LPDDR interface.

#### 7.7.2.1.2.3 PCB Stackup

The minimum stackup required for routing the AM335x device is a four-layer stackup as shown in Table 7-POPO AMOSTAMO 33. Additional layers may be added to the PCB stackup to accommodate other circuitry, enhance signal integrity and electromagnetic interference performance, or to reduce the size of the PCB footprint.

Table 7-33. Minimum PCB Stackup(1)

LAYER	TYPE	DESCRIPTION
1	Signal	Top signal routing
2	Plane	Ground
3	Plane	Split Power Plane
4	Signal	Bottom signal routing

(1) All signals that have critical signal integrity requirements should be routed first on layer 1. It may not be possible to route all of these signals on layer 1 which requires some to be routed on layer 4. When this is done, the signal routes on layer 4 should not cross splits in PAY PAY PANALAN the power plane.

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Complete stackup specifications are provided in Table 7-34.

#### Table 7-34. PCB Stackup Specifications<sup>(1)</sup>

NO.	PARAMETER	MIN	TYP	MAX	UNIT
1	PCB routing and plane layers	4			
2	Signal routing layers	2	7/1.		
3	Full ground layers under LPDDR routing region	1	9		
4	Number of ground plane cuts allowed within LPDDR routing region		Yx	0	
5	Full VDDS_DDR power reference layers under LPDDR routing region	1			
6	Number of layers between LPDDR routing layer and reference ground plane		*/	40	
7	PCB routing feature size		4	7/	mils
8	PCB trace width, w		4		mils
9	PCB BGA escape via pad size <sup>(2)</sup>		18	20	mils
10	PCB BGA escape via hole size <sup>(2)</sup>		10		mils
11	Single-ended impedance, Zo <sup>(3)</sup>		50	75	Ω
12	Impedance control <sup>(4)(5)</sup>	Zo-5	Zo	Zo+5	Ω

(1) For the LPDDR device BGA pad size, see the LPDDR device manufacturer documentation.

(2) A 20-10 via may be used if enough power routing resources are available. An 18-10 via allows for more flexible power routing to the AM335x device.

Zo is the nominal singled-ended impedance selected for the PCB.

(4) This parameter specifies the AC characteristic impedance tolerance for each segment of a PCB signal trace relative to the chosen Zo defined by the single-ended impedance parameter.

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Mountain Market And Arthur Market And Art (5) Tighter impedance control is required to ensure flight time skew is minimal.

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#### 7.7.2.1.2.4 Placement

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Figure 7-34 shows the required placement for the LPDDR devices. The dimensions for this figure are defined in Table 7-35. The placement does not restrict the side of the PCB on which the devices are mounted. The ultimate purpose of the placement is to limit the maximum trace lengths and allow for proper routing space. For single-memory LPDDR systems, the second LPDDR device is omitted from the PANATAN placement.

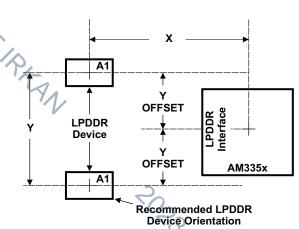


Figure 7-34. AM335x Device and LPDDR Device Placement

#### Table 7-35. Placement Specifications<sup>(1)</sup>

2023. AM3.	Recommended LPDDR Device Orientation  Figure 7-34. AM335x Device and LPDDR Device Plantage Table 7-35. Placement Specifications <sup>(1)</sup>	acement		
NO.	PARAMETER	MIN	MAX	UNIT
1	X <sup>(2)(3)</sup>		1750	mils
2	Y <sup>(2)(3)</sup>		1280	mils
3	Y Offset <sup>(2)(3)(4)</sup>		650	mils
4	Clearance from non-LPDDR signal to LPDDR keepout region <sup>(5)(6)</sup>	4		W

- (1) LPDDR keepout region to encompass entire LPDDR routing area.
- (2) For dimension definitions, see Figure 7-34.
- (3) Measurements from center of AM335x device to center of LPDDR device.
- (4) For single-memory systems, TI recommends that Y offset be as small as possible.
- (5) w is defined as the signal trace width.
- (6) Non-LPDDR signals allowed within LPDDR keepout region provided they are separated from LPDDR routing layers by a ground plane.

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#### 7.7.2.1.2.5 LPDDR Keepout Region

The region of the PCB used for the LPDDR circuitry must be isolated from other signals. The LPDDR keepout region is defined for this purpose and is shown in Figure 7.35. This region should encompass all LPDDR circuitry and the region size varies with component placement and LPDDR routing. Additional clearances required for the keepout region are shown in Table 7-35. Non-LPDDR signals should not be routed on the same signal layer as LPDDR signals within the LPDDR keepout region. Non-LPDDR signals may be routed in the region provided they are routed on layers separated from LRDDR signal layers by a ground layer. No breaks should be allowed in the reference ground or VDDS DDR power plane in this region. In addition, the VDDS\_DDR power plane should cover the entire keepout region.

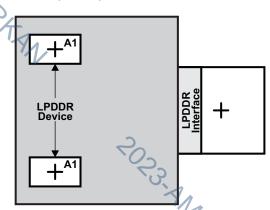


Figure 7-35. LPDDR Keepout Region

# 2023. AM33. Bulk Bypass Capacitors

Bulk bypass capacitors are required for moderate speed bypassing of the LPDDR and other circuitry. Table 7-36 contains the minimum numbers and capacitance required for the bulk bypass capacitors. Note that this table only covers the bypass needs of the AM335x LPDDR interface and LPDDR devices. Additional bulk bypass capacitance may be needed for other circuitry.

Table 7-36. Bulk Bypass Capacitors (1)

NO.	PARAMETER	MIN	MAX	UNIT
1	AM335x VDDS_DDR bulk bypass capacitor count	1	74	Devices
2	AM335x VDDS_DDR bulk bypass total capacitance	10	1	μF
3	LPDDR#1 bulk bypass capacitor count	1	1/	Devices
4	LPDDR#1 bulk bypass total capacitance	10		μF
5	LPDDR#2 bulk bypass capacitor count <sup>(2)</sup>	1		Devices
6	LPDDR#2 bulk bypass total capacitance <sup>(2)</sup>	10		μF

POPS AMSSE MALML POPS, AMBOUNDAM FOR E (1) These devices should be placed near the device they are bypassing, but preference should be given to the placement of the high-speed

(2) Only used when two LPDDR devices are used.



#### 7.7.2.1.2.7 High-Speed Bypass Capacitors

High-speed (HS) bypass capacitors are critical for proper LPDDR interface operation. It is particularly important to minimize the parasitic series inductance of the HS bypass capacitors, AM335x device LPDDR power, and AM335x device LPDDR ground connections. Table 7-37 contains the specification for the HS bypass capacitors as well as for the power connections on the PCB.

Table 7-37. High-Speed Bypass Capacitors

		70	
NO.	PARAMETER	MIN MAX	UNIT
1	HS bypass capacitor package size <sup>(1)</sup>	0402	10 mils
2	Distance from HS bypass capacitor to device being bypassed	250	mils
3	Number of connection vias for each HS bypass capacitor <sup>(2)</sup>	2	Vias
4	Trace length from bypass capacitor contact to connection via	30	mils
5	Number of connection vias for each AM335x VDDS_DDR and VSS terminal	1	Vias
6	Trace length from AM335x VDDS_DDR and VSS terminal to connection via	35	mils
7	Number of connection vias for each LPDDR device power and ground terminal	1	Vias
8	Trace length from LPDDR device power and ground terminal to connection via	35	mils
9	AM335x VDDS_DDR HS bypass capacitor count <sup>(3)</sup>	10	Devices
10	AM335x VDDS_DDR HS bypass capacitor total capacitance	0.6	μF
11	LPDDR device HS bypass capacitor count <sup>(3)(4)</sup>	8	Devices
12	LPDDR device HS bypass capacitor total capacitance <sup>(4)</sup>	0.4	μF
/			

<sup>(1)</sup> LxW, 10-mil units; for example, a 0402 is a 40x20-mil surface-mount capacitor.

#### 7.7.2.1.2.8 Net Classes

Table 7-38 lists the clock net classes for the LPDDR interface. Table 7-39 lists the signal net classes, and associated clock net classes, for the signals in the LPDDR interface. These net classes are used for the termination and routing rules that follow.

Table 7-38. Clock Net Class Definitions

CLOCK NET CLASS	AM335x PIN NAMES
CK	DDR_CK and DDR_CKn
DQS0	DDR_DQS0
DQS1	DDR_DQS1

Table 7-39. Signal Net Class Definitions

j			
SIGNAL NET CLASS	ASSOCIATED CLOCK NET CLASS	AM335x PIN NAMES	
ADDR_CTRL	CK	DDR_BA[1:0], DDR_A[15:0], DDR_CSn0, DDR_CASn, DDR_RASn, DDR_WEn, DDR_CKE	
DQ0	DQS0	DDR_D[7:0], DDR_DQM0	
DQ1	DQS1	DDR_D[15:8], DDR_DQM1	
MACNUS		MACMUP	
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<sup>(2)</sup> An additional HS bypass capacitor can share the connection vias only if it is mounted on the opposite side of the board.

<sup>(3)</sup> These devices should be placed as close as possible to the device being bypassed.

<sup>(4)</sup> Per LPDDR device.

#### 7.7.2.1.2.9 LPDDR Signal Termination

There is no specific need for adding terminations on the LPDDR interface. However, system designers may evaluate the need for serial terminators for EMI and overshoot reduction. Placement of serial terminations for DQS[x] and DQ[x] net class signals should be determined based on PCB analysis. Placement of serial terminations for ADDR\_CTRL net class signals should be close to the AM335x device. Table 7-40 shows the specifications for the serial terminators in such cases.

#### **Table 7-40. LPDDR Signal Terminations**

NO.	PARAMETER	MIN	TYP	MAX	UNIT
1	CK net class <sup>(1)</sup>	0	22	Zo <sup>(2)</sup>	Ω
2	ADDR_CTRL net class <sup>(1)(3)(4)</sup>	0	22	Zo <sup>(2)</sup>	Ω
3	DQS0, DQS1, DQ0, and DQ1 net classes	0	22	Zo <sup>(2)</sup>	Ω

- (1) Only series termination is permitted.
- (2) Zo is the LPDDR PCB trace characteristic impedance.
- PORS. AMSSSS MANUARAN IRAM (3) Series termination values larger than typical only recommended to address EMI issues.
  - (4) Series termination values should be uniform across net class.

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#### 7.7.2.1.3 LPDDR CK and ADDR\_CTRL Routing

Figure 7-36 shows the topology of the routing for the CK and ADDR\_CTRL net classes. The length of signal path AB and AC should be minimized with emphasis to minimize lengths C and D such that length A is the majority of the total length of signal path AB and AC.

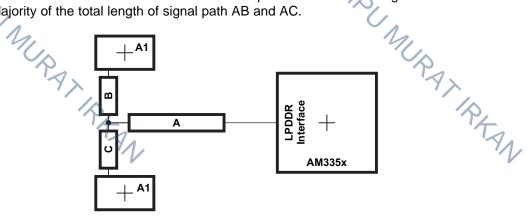


Figure 7-36. CK and ADDR\_CTRL Routing and Topology

Table 7-41. CK and ADDR\_CTRL Routing Specification<sup>(1)(2)</sup>

NO.	PARAMETER	7	MIN	TYP	MAX	UNIT
11	Center-to-center CK spacing	1			2w	
2)	CK differential pair skew length mismatch <sup>(2)(3)</sup>	7	2		25	mils
3	CK B-to-CK C skew length mismatch		00		25	mils
4	Center-to-center CK to other LPDDR trace spacing <sup>(4)</sup>		4w			
5	CK and ADDR_CTRL nominal trace length <sup>(5)</sup>		CACLM-50	CACLM	CACLM+50	mils
6	ADDR_CTRL-to-CK skew length mismatch			•	100	mils
7	ADDR_CTRL-to-ADDR_CTRL skew length mismatch			/ _	100	mils
8	Center-to-center ADDR_CTRL to other LPDDR trace spacing <sup>(4)</sup>		4w	1,		
9	Center-to-center ADDR_CTRL to other ADDR_CTRL trace spacing <sup>(4)</sup>		3w	, OV		
10	ADDR_CTRL A-to-B and ADDR_CTRL A-to-C skew length mismatch <sup>(2)</sup>			7,	100	mils
11	ADDR_CTRL B-to-C skew length mismatch			-7)	100	mils

- (1) CK represents the clock net class, and ADDR\_CTRL represents the address and control signal net class.
- (2) Series terminator, if used, should be located closest to the AM335x device.
- (3) Differential impedance should be Zo x 2, where Zo is the single-ended impedance defined in Table 7-34.
- (4) Center-to-center spacing is allowed to fall to minimum (w) for up to 500 mils of routed length to accommodate BGA escape and routing congestion.
- (5) CACLM is the longest Manhattan distance of the CK and ADDR\_CTRL net classes.

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Figure 7-37 shows the topology and routing for the DQS[x] and DQ[x] net classes; the routes are point to point. Skew matching across bytes is not needed nor recommended.

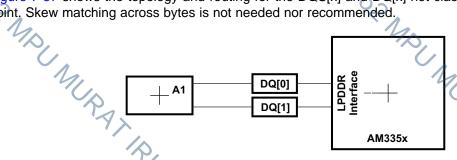


Figure 7-37. DQS[x] and DQ[x] Routing and Topology

Table 7-42. DQS[x] and DQ[x] Routing Specification(1)

NO.	PARAMETER	MIN	TYP	MAX	UNIT
1	Center-to-center DQS[x] spacing			2w	
2	Center-to-center DDR_DQS[x] to other LPDDR trace spacing <sup>(2)</sup>	4w			
3	DQS[x] and DQ[x] nominal trace length <sup>(3)</sup>	DQLM-50	DQLM	DQLM+50	mils
4	DQ[x]-to-DQS[x] skew length mismatch <sup>(3)</sup>			100	mils
5	DQ[x]-to-DQ[x] skew length mismatch <sup>(3)</sup>			100	mils
6	Center-to-center DQ[x] to other LPDDR trace spacing <sup>(2)(4)</sup>	4w			
1/2	Center-to-center DQ[x] to other DQ[x] trace spacing <sup>(2)(5)</sup>	3w			

- (1) DQS[x] represents the DQS0 and DQS1 clock net classes, and DQ[x] represents the DQ0 and DQ1 signal net classes.
- (2) Center-to-center spacing is allowed to fall to minimum (w) for up to 500 mils of routed length to accommodate BGA escape and routing congestion.
- (3) There is no requirement for skew matching between data bytes; that is, from net classes DQS0 and DQ0 to net classes DQS1 and DQ1. MURAY PAN
- (4) Signals from one DQ net class should be considered other LPDDR traces to another DQ net class.
- (5) DQLM is the longest Manhattan distance of each of the DQS[x] and DQ[x] net classes. CPA) Ptan

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#### 7.7.2.2 DDR2 Routing Guidelines

#### 7.7.2.2.1 Board Designs

TI only supports board designs that follow the guidelines outlined in this document. Table 7-43 and Figure 7-38 show the switching characteristics and timing diagram for the DDR2 memory interface.

Table 7-43. Switching Characteristics for DDR2 Memory Interface

NO	).	PARAMETER	MIN	MAX	UNIT
1	t <sub>c(DDR_CK)</sub>	Cycle time, DDR_CK and DDR_CKn	3.75	8 <sup>(1)</sup>	ns

(1) The JEDEC JESD79-2F specification defines the maximum clock period of 8 ns for all standard-speed bin DDR2 memory devices. Therefore, all standard-speed bin DDR2 memory devices are required to operate at 125 MHz.

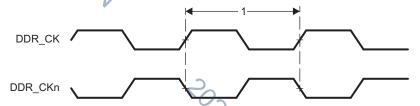


Figure 7-38. DDR2 Memory Interface Clock Timing

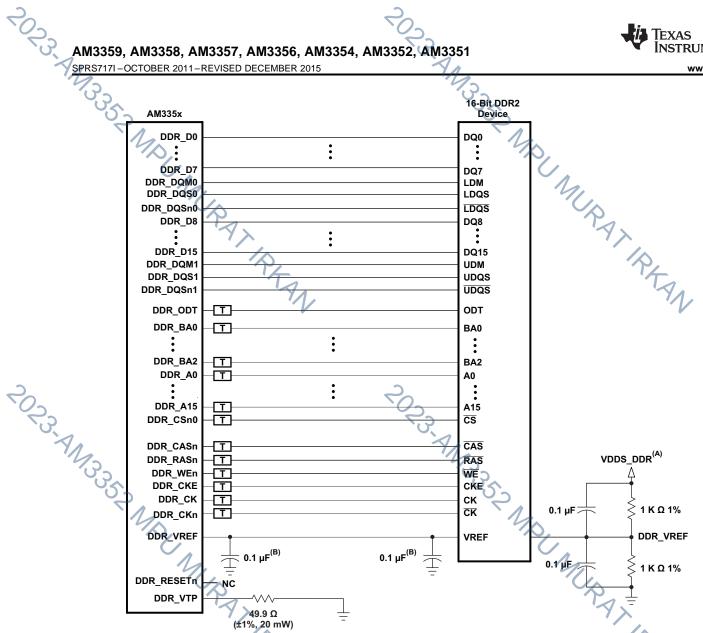
This section provide This section provides the timing specification for the DDR2 interface as a PCB design and manufacturing specification. The design rules constrain PCB trace length, PCB trace skew, signal integrity, cross-talk, and signal timing. These rules, when followed, result in a reliable DDR2 memory system without the need for a complex timing closure process. For more information regarding the guidelines for using this DDR2 specification, see the Understanding TI's PCB Routing Rule-Based DDR Timing Specification application report (SPRAAV0). This application report provides generic guidelines and approach. All the specifications provided in the data manual take precedence over the generic guidelines and must be adhered to for a reliable DDR2 interface operation.

#### 7.7.2.2.2.1 DDR2 Interface Schematic

Figure 7-39 shows the schematic connections for 16-bit interface on AM335x device using one x16 DDR2 device and Figure 7-40 shows the schematic connections for 16-bit interface on AM335x using two x8 DDR2 devices. The AM335x DDR2 memory interface only supports 16-bit wide mode of operation. The AM335x device can only source one load connected to the DQS[x] and DQ[x] net class signals and two loads connected to the CK and ADDR CTRL net class signals. For more information related to net classes, see Section 7.7.2.2.2.8.

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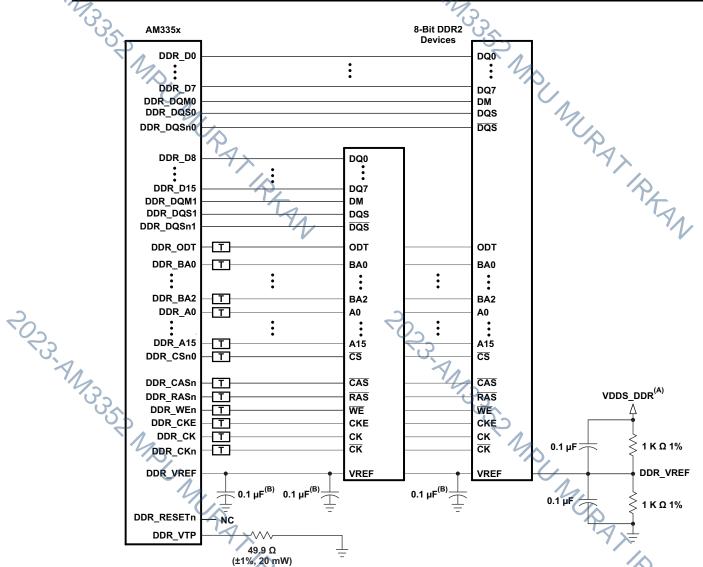


- VDDS\_DDR is the power supply for the DDR2 memories and the AM335x DDR2 interface. A.
- One of these capacitors can be eliminated if the divider and its capacitors are placed near a DDR\_VREF pir B.
- For all the termination requirements, see Section 7.7.2.2.2.9.

Figure 7-39. 16-Bit DDR2 Interface Using One 16-Bit DDR2 Device

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- VDDS\_DDR is the power supply for the DDR2 memories and the AM335x DDR2 interface.
- One of these capacitors can be eliminated if the divider and its capacitors are placed near a DDR\_VREF pin
- For all the termination requirements, see Section 7.7.2.2.2.9.

Figure 7-40. 16-Bit DDR2 Interface Using Two 8-Bit DDR2 Devices

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#### 7.7.2.2.2.2 Compatible JEDEC DDR2 Devices

Table 7-44 shows the parameters of the JEDEC DDR2 devices that are compatible with this interface. Generally, the DDR2 interface is compatible with x16 or x8 DDR2-533 speed grade DDR2 devices.

Table 7-44. Compatible JEDEC DDR2 Devices (Per Interface)(1)

NO.	PARAMETER	MIN MAX	UNIT
1	JEDEC DDR2 device speed grade <sup>(2)</sup>	DDR2-533	
2	JEDEC DDR2 device bit width	x8 x16	bits
3	JEDEC DDR2 device count	1 2	devices
4	JEDEC DDR2 device terminal count <sup>(3)</sup>	60 84	terminals

<sup>(1)</sup> If the DDR2 interface is operated with a clock frequency less than 266 MHz, lower-speed grade DDR2 devices may be used if the minimum clock period specified for the DDR2 device is less than or equal to the minimum clock period selected for the AM335x DDR2 interface.

#### 7.7.2.2.2.3 PCB Stackup

The minimum stackup required for routing the AM335x device is a four-layer stackup as shown in Table 7-45. Additional layers may be added to the PCB stackup to accommodate other circuitry, enhance signal integrity and electromagnetic interference performance, or to reduce the size of the PCB footprint.

Table 7-45. Minimum PCB Stackup(1)

LAYER	TYPE	DESCRIPTION
1	Signal	Top signal routing
2	Plane	Ground
3	Plane	Split power plane
4	Signal	Bottom signal routing

(1) All signals that have critical signal integrity requirements should be routed first on layer 1. It may not be possible to route all of these signals on layer 1 which requires some to be routed on layer 4. When this is done, the signal routes on layer 4 should not cross splits in the power plane.

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<sup>(2)</sup> Higher DDR2 speed grades are supported due to inherent JEDEC DDR2 backwards compatibility.

<sup>(3) 92-</sup>terminal devices are also supported for legacy reasons. New designs will migrate to 84-terminal DDR2 devices. Electrically, the 92and 84-terminal DDR2 devices are the same.

#### Table 7-46. PCB Stackup Specifications(1)

POS. Aww.t	TEXAS INSTRUMENTS AM3359, AM3358, A i.com  Complete stackup specifications are provided in Table 7-46.	•	<b>5, AM3354, A</b> OBER 2011–REV	-	
	Table 7-46. PCB Stackup Spec	ifications <sup>(1)</sup>			
NO.	PARAMETER	MIN	TYP	MAX	UNIT
1	PCB routing and plane layers	4	7		
2	Signal routing layers	2	11,		
3	Full ground layers under DDR2 routing region	1	P		
4	Number of ground plane cuts allowed within DDR2 routing region		'7x	0	
5	Full VDDS_DDR power reference layers under DDR2 routing region	1		_	
6	Number of layers between DDR2 routing layer and reference ground plane	1		0	
7	PCB routing feature size		4	1/2.	mils
8	PCB trace width, w		4	<b>ル</b>	mils
9	PCB BGA escape via pad size <sup>(2)</sup>		18	20	mils
10	PCB BGA escape via hole size <sup>(2)</sup>		10		mils
11	Single-ended impedance, Zo <sup>(3)</sup>		50	75	Ω
12	Impedance control <sup>(4)(5)</sup>	Zo-5	Zo	Zo+5	Ω

- (1) For the DDR2 device BGA pad size, see the DDR2 device manufacturer documentation.
- (2) A 20-10 via may be used if enough power routing resources are available. An 18-10 via allows for more flexible power routing to the AM335x device.
- (3) Zo is the nominal singled-ended impedance selected for the PCB.
- JMEI.

  POSTONIAL MURA / IRAN (4) This parameter specifies the AC characteristic impedance tolerance for each segment of a PCB signal trace relative to the chosen Zo defined by the single-ended impedance parameter. eq ster imp.

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- (5) Tighter impedance control is required to ensure flight time skew is minimal.

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#### 7.7.2.2.2.4 Placement

Figure 7-41 shows the required placement for the DDR2 devices. The dimensions for this figure are defined in Table 7-47. The placement does not restrict the side of the PCB on which the devices are mounted. The ultimate purpose of the placement is to limit the maximum trace lengths and allow for proper routing space. For single-memory DDR2 systems, the second DDR2 device is omitted from the PANAPTAN placement.

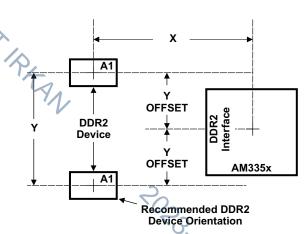


Figure 7-41. AM335x Device and DDR2 Device Placement

Table 7-47. Placement Specifications<sup>(1)</sup>

2023. AM3.	Recommended DDR2 Device Orientation  Figure 7-41. AM335x Device and DDR2 Device Pla  Table 7-47. Placement Specifications <sup>(1)</sup>	] acement		
NO.	PARAMETER	MIN	MAX	UNIT
1	X <sup>(2)(3)</sup>		1750	mils
2	γ(2)(3)		1280	mils
3	Y Offset <sup>(2)(3)(4)</sup>		650	mils
4	Clearance from non-DDR2 signal to DDR2 keepout region <sup>(5)(6)</sup>	4		W

- (1) DDR2 keepout region to encompass entire DDR2 routing area.
- (2) For dimension definitions, see Figure 7-41.
- (3) Measurements from center of AM335x device to center of DDR2 device.
- (4) For single-memory systems, it is recommended that Y offset be as small as possible.
- (5) w is defined as the signal trace width.
- (6) Non-DDR2 signals allowed within DDR2 keepout region provided they are separated from DDR2 routing layers by a ground plane.

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#### 7.7.2.2.2.5 DDR2 Keepout Region

The region of the PCB used for the DDR2 circuitry must be isolated from other signals. The DDR2 keepout region is defined for this purpose and is shown in Figure 7-42. This region should encompass all DDR2 circuitry and the region size varies with component placement and DDR2 routing. Additional clearances required for the keepout region are shown in Table 7-47. Non-DDR2 signals should not be routed on the same signal layer as DDR2 signals within the DDR2 keepout region. Non-DDR2 signals may be routed in the region provided they are routed on layers separated from DDR2 signal layers by a ground layer. No breaks should be allowed in the reference ground or VDDS DDR power plane in this region. In addition, the VDDS\_DDR power plane should cover the entire keepout region.

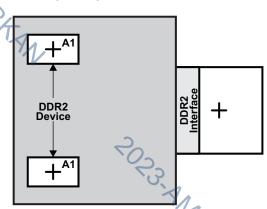


Figure 7-42. DDR2 Keepout Region

# 2023. AM33. Bulk Bypass Capacitors

Bulk bypass capacitors are required for moderate speed bypassing of the DDR2 and other circuitry. Table 7-48 contains the minimum numbers and capacitance required for the bulk bypass capacitors. Note that this table only covers the bypass needs of the AM335x DDR2 interface and DDR2 devices. Additional bulk bypass capacitance may be needed for other circuitry.

Table 7-48. Bulk Bypass Capacitors (1)

NO.	PARAMETER	MIN	MAX	UNIT
1	AM335x VDDS_DDR bulk bypass capacitor count	1	74	devices
2	AM335x VDDS_DDR bulk bypass total capacitance	10	N	μF
3	DDR2 number 1 bulk bypass capacitor count	1	1/	devices
4	DDR2 number 1 bulk bypass total capacitance	10		μF
5	DDR2 number 2 bulk bypass capacitor count <sup>(2)</sup>	1		devices
6	DDR2 number 2 bulk bypass total capacitance <sup>(2)</sup>	10		μF

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(2) Only used when two DDR2 devices are used.





#### 7.7.2.2.2.7 High-Speed (HS) Bypass Capacitors

HS bypass capacitors are critical for proper DDR2 interface operation. It is particularly important to minimize the parasitic series inductance of the HS bypass capacitors, AM335x device DDR2 power, and AM335x device DDR2 ground connections. Table 7-49 contains the specification for the HS bypass capacitors as well as for the power connections on the PCB.

Table 7-49. HS Bypass Capacitors

		/ P	
NO.	PARAMETER	MIN MAX	UNIT
1	HS bypass capacitor package size <sup>(1)</sup>	0402	10 mils
2	Distance from HS bypass capacitor to device being bypassed		mils
3	Number of connection vias for each HS bypass capacitor <sup>(2)</sup>		vias
4	Trace length from bypass capacitor contact to connection via		mils
5	Number of connection vias for each AM335x VDDS_DDR and VSS terminal		vias
6	Trace length from AM335x VDDS_DDR and VSS terminal to connection via 35		mils
7	Number of connection vias for each DDR2 device power and ground terminal		vias
8	Trace length from DDR2 device power and ground terminal to connection via	35	mils
9	AM335x VDDS_DDR HS bypass capacitor count <sup>(3)</sup>		devices
10	AM335x VDDS_DDR HS bypass capacitor total capacitance 0.6		μF
11	DDR2 device HS bypass capacitor count <sup>(3)(4)</sup>		devices
12	DDR2 device HS bypass capacitor total capacitance <sup>(4)</sup>	0.4	μF
7.4.			

<sup>(1)</sup> LxW, 10-mil units; for example, a 0402 is a 40x20-mil surface-mount capacitor.

#### 7.7.2.2.2.8 Net Classes

Table 7-50 lists the clock net classes for the DDR2 interface. Table 7-51 lists the signal net classes, and associated clock net classes, for the signals in the DDR2 interface. These net classes are used for the termination and routing rules that follow.

Table 7-50. Clock Net Class Definitions

CLOCK NET CLASS	AM335x PIN NAMES
CK	DDR_CK and DDR_CKn
DQS0	DDR_DQS0 and DDR_DQSn0
DQS1	DDR_DQS1 and DDR_DQSn1

Table 7-51. Signal Net Class Definitions

SIGNAL NET CLASS	ASSOCIATED CLOCK NET CLASS	AM335x PIN NAMES		
ADDR_CTRL	CK	DDR_BA[2:0], DDR_A[15:0], DDR_CSn0, DDR_CASn, DDR_RASn, DDR_WEn, DDR_CKE, DDR_ODT		
DQ0	DQS0	DDR_D[7:0], DDR_DQM0		
DQ1	DQS1	DDR_D[15:8], DDR_DQM1		
MACNUS		MACMUA		
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<sup>(2)</sup> An additional HS bypass capacitor can share the connection vias only if it is mounted on the opposite side of the board.

<sup>(3)</sup> These devices should be placed as close as possible to the device being bypassed.

<sup>(4)</sup> Per DDR2 device.



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#### 7.7.2.2.2.9 DDR2 Signal Termination

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Signal terminations are required on the CK and ADDR\_CTRL net class signals. Serial terminations should be used on the CK and ADDR\_CTRL lines and is the preferred termination scheme. On-device terminations (ODTs) are required on the DQS[x] and DQ[x] net class signals. They should be enabled to ensure signal integrity. Table 7-52 shows the specifications for the series terminators. Placement of serial terminations for ADDR CTRL net class signals should be close to the AM335x device.

Table 7-52. DDR2 Signal Terminations

NO.	PARAMETER	MIN	TYP MA	X UNIT
1	CK net class <sup>(1)</sup>	0	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	0 Ω
2	ADDR_CTRL net class <sup>(1)(2)(3)</sup>	0	22 Zo	4) Ω
3	DQS0, DQS1, DQ0, and DQ1 net classes <sup>(5)</sup>	N/A	N	Α Ω

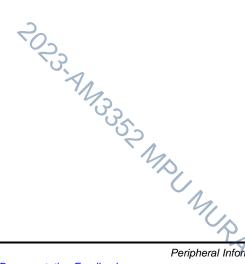
- (1) Only series termination is permitted.
- (2) Series termination values larger than typical only recommended to address EMI issues.
- (3) Series termination values should be uniform across net class.
- (4) Zo is the DDR2 PCB trace characteristic impedance.
- (5) No external termination resistors are allowed and ODT must be used for these net classes.

If the DDR2 interface is operated at a lower frequency (<200-MHz clock rate), on-device terminations are not specifically required for the DQS[x] and DQ[x] net class signals and serial terminations for the CK and ADDR CTRL net class signals are not mandatory. System designers may evaluate the need for serial terminators for EMI and overshoot reduction. Placement of serial terminations for DQS[x] and DQ[x] net class signals should be determined based on PCB analysis. Placement of serial terminations for ADDR CTRL net class signals should be close to the AM335x device. Table 7-53 shows the specifications for the serial terminators in such cases.

Table 7-53. Lower-Frequency DDR2 Signal Terminations

NO.	PARAMETER	MIN	TYP	MAX	UNIT
1	CK net class <sup>(1)</sup>	0	22	Zo <sup>(2)</sup>	Ω
2	ADDR_CTRL net class <sup>(1)(3)(4)</sup>	0	22	Zo <sup>(2)</sup>	Ω
3	DQS0, DQS1, DQ0, and DQ1 net classes	0	22	Zo <sup>(2)</sup>	Ω

- (1) Only series termination is permitted.
- (2) Zo is the DDR2 PCB trace characteristic impedance.
- (3) Series termination values larger than typical only recommended to address EMI issues.
- (4) Series termination values should be uniform across net class.



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#### 7.7.2.2.2.10 DDR VREF Routing

DDR\_VREF is used as a reference by the input buffers of the DDR2 memories as well as the AM335x device, DDR\_VREF is intended to be half the DDR2 power supply voltage and should be created using a resistive divider as shown in Figure 7-39 and Figure 7-40. TI does not recommend other methods of creating DDR\_VREF. Figure 7-43 shows the layout guidelines for DDR\_VREF.

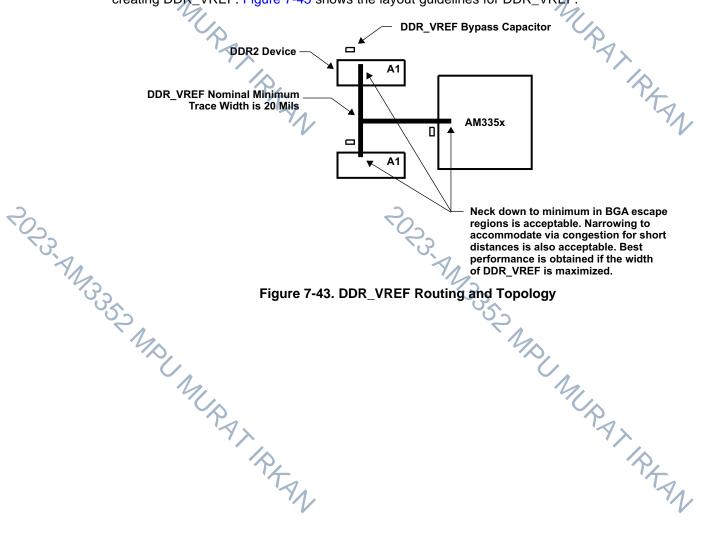


Figure 7-43. DDR\_VREF Routing and Topology

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#### 7.7.2.2.3 DDR2 CK and ADDR CTRL Routing

Figure 7-44 shows the topology of the routing for the CK and ADDR\_CTRL net classes. The length of signal path AB and AC should be minimized with emphasis to minimize lengths C and D such that length A is the majority of the total length of signal path AB and AC.

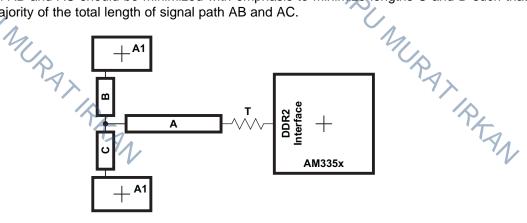


Figure 7-44. CK and ADDR\_CTRL Routing and Topology

Table 7-54. CK and ADDR\_CTRL Routing Specification(1)(2)

NO.	PARAMETER	3	MIN	TYP	MAX	UNIT
113	Center-to-center CK spacing	1/			2w	
2)	CK differential pair skew length mismatch <sup>(2)(3)</sup>	7	2		25	mils
3	CK B-to-CK C skew length mismatch		55		25	mils
4	Center-to-center CK to other DDR2 trace spacing <sup>(4)</sup>		4w			
5	CK and ADDR_CTRL nominal trace length <sup>(5)</sup>		CACLM-50	CACLM	CACLM+50	mils
6	ADDR_CTRL-to-CK skew length mismatch		10,		100	mils
7	ADDR_CTRL-to-ADDR_CTRL skew length mismatch			•	100	mils
8	Center-to-center ADDR_CTRL to other DDR2 trace spacing <sup>(4)</sup>		4w	4,		
9	Center-to-center ADDR_CTRL to other ADDR_CTRL trace spacing <sup>(4)</sup>		3w			
10	ADDR_CTRL A-to-B and ADDR_CTRL A-to-C skew length mismatch <sup>(2)</sup>			71	100	mils
11	ADDR_CTRL B-to-C skew length mismatch			-Y)	100	mils

- (1) CK represents the clock net class, and ADDR\_CTRL represents the address and control signal net class.
- (2) Series terminator, if used, should be located closest to the AM335x device.
- (3) Differential impedance should be Zo x 2, where Zo is the single-ended impedance defined in Table 7-46.
- (4) Center-to-center spacing is allowed to fall to minimum (w) for up to 500 mils of routed length to accommodate BGA escape and routing congestion.
- (5) CACLM is the longest Manhattan distance of the CK and ADDR\_CTRL net classes.

Figure 7-45 shows the topology and routing for the DQS[x] and DQ[x] net classes; the routes are point to POPS-AMSSSE MADU MUR point. Skew matching across bytes is not needed nor recommended.

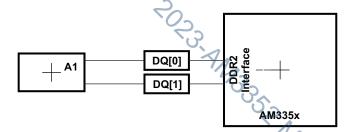


Figure 7-45. DQS[x] and DQ[x] Routing and Topology

#### Table 7-55. DQS[x] and DQ[x] Routing Specification(1)

AM3359, AM3358, AM3357, AM3356, AM3354, AM3352, AM3351 SPRS717I – OCTOBER 2011 – REVISED DECEMBER 2015  Table 7-55. DQS[x] and DQ[x] Routing Specification(1)					
NO.	PARAMETER	MIN	TYP MAX	UNIT	
1	Center-to-center DQS[x] spacing	1/2	2w		
2	DQS[x] differential pair skew length mismatch <sup>(2)</sup>		25	mils	
3	Center-to-center DDR_DQS[x] to other DDR2 trace spacing <sup>(3)</sup>	4w			
4	DQS[x] and DQ[x] nominal trace length <sup>(4)</sup>	DQLM-50	DQLM DQLM+50	mils	
5	DQ[x]-to-DQS[x] skew length mismatch <sup>(4)</sup>		100	mils	
6	DQ[x]-to-DQ[x] skew length mismatch <sup>(4)</sup>		100	mils	
7	Center-to-center DQ[x] to other DDR2 trace spacing <sup>(3)(5)</sup>	4w	//		
8	Center-to-center DQ[x] to other DQ[x] trace spacing <sup>(3)(6)</sup>	3w	74		

- (1) DQS[x] represents the DQS0 and DQS1 clock net classes, and DQ[x] represents the DQ0 and DQ1 signal net classes.
- (2) Differential impedance should be Zo x 2, where Zo is the single-ended impedance defined in Table 7-46.
- Center-to-center spacing is allowed to fall to minimum (w) for up to 500 mils of routed length to accommodate BGA escape and routing congestion.
- PORS. AMBUMURAN IRAM (4) There is no requirement for skew matching between data bytes; that is, from net classes DQS0 and DQ0 to net classes DQS1 and DQ1.
  - (5) Signals from one DQ net class should be considered other DDR2 traces to another DQ net class.
  - (6) DQLM is the longest Manhattan distance of each of the DQS[x] and DQ[x] net classes.

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#### DDR3 and DDR3L Routing Guidelines

#### **NOTE**

All references to DDR3 in this section apply to DDR3 and DDR3L devices, unless otherwise noted.

#### 7.7.2.3.1 Board Designs

TI only supports board designs using DDR3 memory that follow the guidelines in this document. The switching characteristics and timing diagram for the DDR3 memory interface are shown in Table 7-56 and Figure 7-46.

Table 7-56. Switching Characteristics for DDR3 Memory Interface

NO.	PARAMETER	MIN	MAX	UNIT
1	$t_{c(DDR\_CK)} \ t_{c(DDR\_CKn)}$ Cycle time, DDR_CK and DDR_CKn	2.5	3.3 <sup>(1)</sup>	ns

PORS. AMBOSTAMB (1) The JEDEC JESD79-3F Standard defines the maximum clock period of 3.3 ns for all standard-speed bin DDR3 and DDR3L memory devices. Therefore, all standard-speed bin DDR3 and DDR3L memory devices are required to operate at 303 MHz.

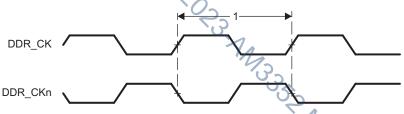


Figure 7-46. DDR3 Memory Interface Clock Timing

#### 7.7.2.3.1.1 DDR3 yersus DDR2

This specification only covers AM335x PCB designs that use DDR3 memory. Designs using DDR2 memory should use the DDR2 routing guidleines described in Section 7.7.2.2 While similar, the two memory systems have different requirements. It is currently not possible to design one PCB that meets the requirements of both DDR2 and DDR3.

#### 7.7.2.3.2 DDR3 Device Combinations

Because there are several possible combinations of device counts and single-side or dual-side mounting, Table 7-57 summarizes the supported device configurations.

Table 7-57. Supported DDR3 Device Combinations

	NUMBER OF DDR3 DEVICES	DDR3 DEVICE WIDTH (BITS)	MIRRORED?	DDR3 EMIF WIDTH (BITS)
_	1	16	N	16
502	2	8	Y <sup>(1)</sup>	16
73,7	(1) Two DDR3 devices are mirrore the board.	ed when one device is placed on the	e top of the board and the second of	device is placed on the bottom of
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<sup>(1)</sup> Two DDR3 devices are mirrored when one device is placed on the top of the board and the second device is placed on the bottom of 

#### 7.7.2.3.3 DDR3 Interface

This section provides the timing specification for the DDR3 interface as a PCB design and manufacturing specification. The design rules constrain PCB trace length, PCB trace skew, signal integrity, cross-talk, and signal timing. These rules, when followed, result in a reliable DDR3 memory system without the need for a complex timing closure process. For more information regarding the guidelines for using this DDR3 specification, see the Understanding TI's PCB Routing Rule-Based DDR Timing Specification application report (SPRAAVO). This application report provides generic guidelines and approach. All the specifications provided in the data manual take precedence over the generic guidelines and must be adhered to for a reliable DDR3 interface operation.

#### 7.7.2.3.3.1 DDR3 Interface Schematic

The DDR3 interface schematic varies, depending upon the width of the DDR3 devices used, Figure 7-47 shows the schematic connections for 16-bit interface on AM335x device using one x16 DDR3 device and Figure 7-49 shows the schematic connections for 16-bit interface on AM335x device using two x8 DDR3 devices. The AM335x DDR3 memory interface only supports 16-bit wide mode of operation. The AM335x to ass sig. POPS-AMSSSS MANUARAN IRAN device can only source one load connected to the DQS[x] and DQ[x] net class signals and two loads connected to the CK and ADDR\_CTRL net class signals. For more information related to net classes, see

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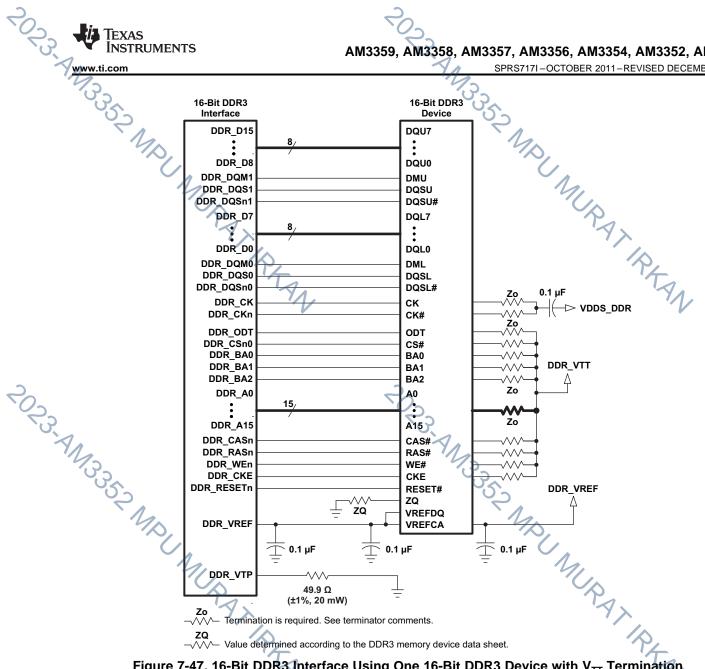
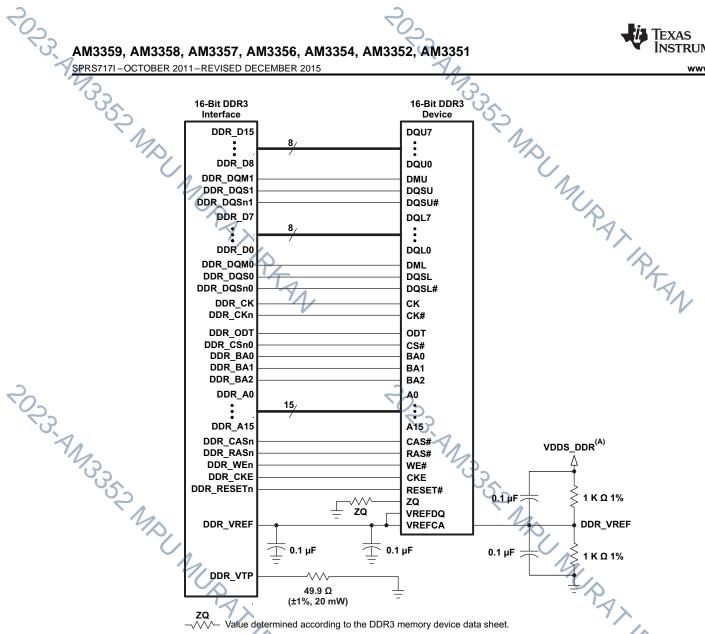


Figure 7-47. 16-Bit DDR3 Interface Using One 16-Bit DDR3 Device with V<sub>TT</sub> Termination

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VDDS\_DDR is the power supply for the DDR3 memories and the AM335x DDR3 interface.

Figure 7-48. 16-Bit DDR3 Interface Using One 16-Bit DDR3 Device without V<sub>TT</sub> Termination

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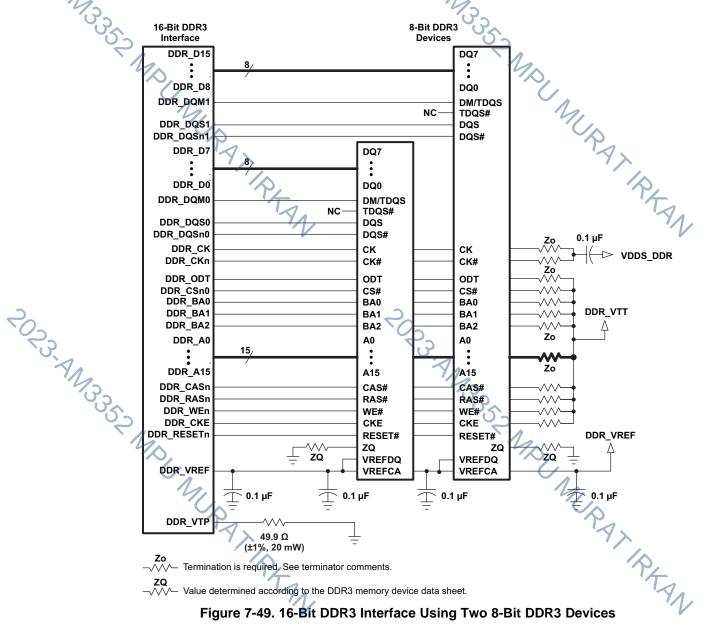


Figure 7-49. 16-Bit DDR3 Interface Using Two 8-Bit DDR3 Devices

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#### 7.7.2.3.3.2 Compatible JEDEC DDR3 Devices

Table 7-58 shows the parameters of the JEDEC DDR3 devices that are compatible with this interface.

#### Table 7-58. Compatible JEDEC DDR3 Devices (Per Interface)

NO.	PARAMETER	TEST CONDITIONS	MIN MAX	UNIT
4	JEDEC DDD2 do ijed speed grade	$t_{C(DDR\_CK)}$ and $t_{C(DDR\_CKn)}$ = 3.3 ns	DDR3-800	
1 JEDEC DDR3 device speed grade	JEDEC DDR3 device speed grade	$t_{C(DDR\_CK)}$ and $t_{C(DDR\_CKn)}$ = 2.5 ns	DDR3-1600	
2	JEDEC DDR3 device bit width		x8 🔷 x16	bits
3	JEDEC DDR3 device count <sup>(1)</sup>		1 72	devices

<sup>(1)</sup> For valid DDR3 device configurations and device counts, see Section 7.7.2.3.3.1, Figure 7-47, and Figure 7-49.

#### 7.7.2.3.3.3 PCB Stackup

The minimum stackup for routing the DDR3 interface is a four-layer stack up as shown in Table 7-59. Additional layers may be added to the PCB stackup to accommodate other circuitry, enhance signal integrity and electromagnetic interference performance, or to reduce the size of the PCB footprint.

#### Table 7-59. Minimum PCB Stackup<sup>(1)</sup>

LAYER	TYPE	DESCRIPTION
1	Signal	Top signal routing
2	Plane	Ground
3	Plane	Split Power Plane
4	Signal	Bottom signal routing

<sup>(1)</sup> All signals that have critical signal integrity requirements should be routed first on layer 1. It may not be possible to route all of these signals on layer 1 which requires some to be routed on layer 4. When this is done, the signal routes on layer 4 should not cross splits in NUPA A PAN MURATIRE the power plane.

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Table 7-60. PCB Stackup Specifications(1)

	<u> </u>			
PARAMETER	MIN	TYP	MAX	UNIT
PCB routing and plane layers	1/4			
Signal routing layers	2			
Full ground reference layers under DDR3 routing region <sup>(2)</sup>	1	12		
Full VDDS_DDR power reference layers under the DDR3 routing region <sup>(2)</sup>	1			
Number of reference plane cuts allowed within DDR3 routing region <sup>(3)</sup>		P	0	
Number of layers between DDR3 routing layer and reference plane <sup>(4)</sup>		7	0	
PCB routing feature size		4	^	mils
PCB trace width, w		4	7	mils
PCB BGA escape via pad size <sup>(5)</sup>		18	20	mils
PCB BGA escape via hole size		10	1	mils
Single-ended impedance, Zo <sup>(6)</sup>		50	75	Ω
Impedance control <sup>(7)(8)</sup>	Zo-5	Zo	Zo+5	Ω
	PCB routing and plane layers  Signal routing layers  Full ground reference layers under DDR3 routing region <sup>(2)</sup> Full VDDS_DDR power reference layers under the DDR3 routing region <sup>(2)</sup> Number of reference plane cuts allowed within DDR3 routing region <sup>(3)</sup> Number of layers between DDR3 routing layer and reference plane <sup>(4)</sup> PCB routing feature size  PCB trace width, w  PCB BGA escape via pad size <sup>(5)</sup> PCB BGA escape via hole size  Single-ended impedance, Zo <sup>(6)</sup>	PCB routing and plane layers  Signal routing layers  2  Full ground reference layers under DDR3 routing region <sup>(2)</sup> 1  Full VDDS_DDR power reference layers under the DDR3 routing region <sup>(2)</sup> 1  Number of reference plane cuts allowed within DDR3 routing region <sup>(3)</sup> Number of layers between DDR3 routing layer and reference plane <sup>(4)</sup> PCB routing feature size  PCB trace width, w  PCB BGA escape via pad size <sup>(5)</sup> PCB BGA escape via hole size  Single-ended impedance, Zo <sup>(6)</sup>	PCB routing and plane layers  Signal routing layers  2  Full ground reference layers under DDR3 routing region <sup>(2)</sup> 1  Full VDDS_DDR power reference layers under the DDR3 routing region <sup>(2)</sup> Number of reference plane cuts allowed within DDR3 routing region <sup>(3)</sup> Number of layers between DDR3 routing layer and reference plane <sup>(4)</sup> PCB routing feature size  4  PCB trace width, w  4  PCB BGA escape via pad size <sup>(5)</sup> 18  PCB BGA escape via hole size  50  Single-ended impedance, Zo <sup>(6)</sup>	PCB routing and plane layers  Signal routing layers  Full ground reference layers under DDR3 routing region <sup>(2)</sup> Full VDDS_DDR power reference layers under the DDR3 routing region <sup>(2)</sup> Number of reference plane cuts allowed within DDR3 routing region <sup>(3)</sup> Number of layers between DDR3 routing layer and reference plane <sup>(4)</sup> PCB routing feature size  PCB trace width, w  PCB BGA escape via pad size <sup>(5)</sup> PCB BGA escape via hole size  Single-ended impedance, Zo <sup>(6)</sup> A   A   A   Single-ended impedance, Zo <sup>(6)</sup> Single-ended impedance, Zo <sup>(6)</sup>

- (1) For the DDR3 device BGA pad size, see the DDR3 device manufacturer documentation.
- (2) Ground reference layers are preferred over power reference layers. Be sure to include bypass caps to accommodate reference layer return current as the trace routes switch routing layers.
- No traces should cross reference plane cuts within the DDR3 routing region. High-speed signal traces crossing reference plane cuts create large return current paths which can lead to excessive crosstalk and EMI radiation.
- Reference planes are to be directly adjacent to the signal plane to minimize the size of the return current loop.
- An 18-mil pad assumes Via Channel is the most economical BGA escape. A 20-mil pad may be used if additional layers are available for power routing. An 18-mil pad is required for minimum layer count escape.
- (6) Zo is the nominal singled-ended impedance selected for the PCB.
- (7) This parameter specifies the AC characteristic impedance tolerance for each segment of a PCB signal trace relative to the chosen Zo defined by the single-ended impedance parameter.
- (8) Tighter impedance control is required to ensure flight time skew is minimal. MURAX PAR

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#### 7.7.2.3.3.4 Placement

Figure 7-50 shows the required placement for the AM335x device as well as the DDR3 devices. The dimensions for this figure are defined in Table 7-61. The placement does not restrict the side of the PCB on which the devices are mounted. The ultimate purpose of the placement is to limit the maximum trace MRAX Ptan lengths and allow for proper routing space.

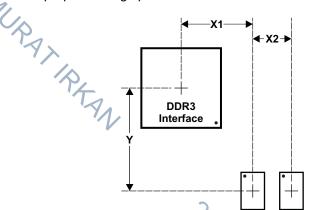


Figure 7-50. Placement Specifications

Table 7-61. Placement Specifications<sup>(1)</sup>

NO.	PARAMETER	132	MIN MAX	UNIT
10	X1 <sup>(2)(3)(4)</sup>	05	1000	mils
2	X2 <sup>(2)(3)</sup>	2	600	mils
3	Y Offset <sup>(2)(3)(4)</sup>	4/	1500	mils
4	Clearance from non-DDR3 signal to DDR3 keepout region <sup>(5)(6)</sup>		4	W

- (1) DDR3 keepout region to encompass entire DDR3 routing area.
- (2) For dimension definitions, see Figure 7-50.
- (3) Measurements from center of AM335x device to center of DDR3 device.
- (4) Minimizing X1 and Y improves timing margins.
- (5) w is defined as the signal trace width.
- (6) Non-DDR3 signals allowed within DDR3 keepout region provided they are separated from DDR3 routing layers by a ground plane.

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#### 7.7.2.3.3.5 DDR3 Keepout Region

The region of the PCB used for DDR3 circuitry must be isolated from other signals. The DDR3 keepout region is defined for this purpose and is shown in Figure 7-51. This region should encompass all DDR3 circuitry and the region size varies with component placement and DDR3 routing. Additional clearances required for the keepout region are shown in Table 7-61. Non-DDR3 signals should not be routed on the same signal layer as DDR3 signals within the DDR3 keepout region. Non-DDR3 signals may be routed in the region provided they are routed on layers separated from DDR3 signal layers by a ground layer. No breaks should be allowed in the reference ground or VDDS\_DDR power plane in this region. In addition, the VDDS\_DDR power plane should cover the entire keepout region.

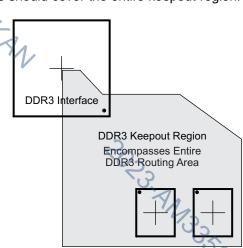


Figure 7-51. DDR3 Keepout Region

# POPS, AMSSSS M. 7.7.2.3.3.6 Bulk Bypass Capacitors

Bulk bypass capacitors are required for moderate speed bypassing of the DDR3 and other circuitry. Table 7-62 contains the minimum numbers and capacitance required for the bulk bypass capacitors. Note that this table only covers the bypass needs of the AM335x DDR3 interface and DDR3 devices. Additional bulk bypass capacitance may be needed for other circuitry.

	Table	7-62.	Bulk	<b>Bypass</b>	Capacitors <sup>(1</sup>	)	
--	-------	-------	------	---------------	--------------------------	---	--

NO.	PARAMETER	MIN	MAX	UNIT
1	AM335x VDDS_DDR bulk bypass capacitor count	2	V	devices
2	AM335x VDDS_DDR bulk bypass total capacitance	20		μF
3	DDR3 number 1 bulk bypass capacitor count	2		devices
4	DDR3 number 1 bulk bypass total capacitance	20		μF
5	DDR3 number 2 bulk bypass capacitor count <sup>(2)</sup>	2		devices
6	DDR3 number 2 bulk bypass total capacitance <sup>(2)</sup>	20		μF

<sup>(1)</sup> These devices should be pieces speed (HS) bypass capacitors and DDR3 sign (2) Only used when two DDR3 devices are used. (1) These devices should be placed near the devices they are bypassing, but preference should be given to the placement of the highspeed (HS) bypass capacitors and DDR3 signal routing.

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#### 7.7.2.3.3.7 High-Speed Bypass Capacitors

High-speed (HS) bypass capacitors are critical for proper DDR3 interface operation. It is particularly important to minimize the parasitic series inductance of the HS bypass capacitors, AM335x device DDR3 power, and AM335x device DDR3 ground connections. Table 7-63 contains the specification for the HS bypass capacitors as well as for the power connections on the PCB. Generally speaking, it is good to:

- Fit as many HS bypass capacitors as possible.
- Minimize the distance from the bypass cap to the power terminals being bypassed.
- Use the smallest physical sized capacitors possible with the highest capacitance readily available.
- Connect the bypass capacitor pads to their vias using the widest traces possible and using the largest hole size via possible.
- Minimize via sharing. Note the limits on via sharing shown in Table 7-63.

#### Table 7-63. High-Speed Bypass Capacitors

NO.	PARAMETER	MIN	TYP	MAX	UNIT
1	HS bypass capacitor package size <sup>(1)</sup>		0201	0402	10 mils
2	Distance, HS bypass capacitor to AM335x VDDS_DDR and VSS terminal being bypassed (2)(3)(4)			400	mils
3	AM335x VDDS_DDR HS bypass capacitor count	20			devices
4	AM335x VDDS_DDR HS bypass capacitor total capacitance	1			μF
5	Trace length from AM335x VDDS_DDR and VSS terminal to connection via (2)		35	70	mils
6	Distance, HS bypass capacitor to DDR3 device being bypassed <sup>(5)</sup>	?.5		150	mils
7	DDR3 device HS bypass capacitor count <sup>(6)</sup>	12			devices
8	DDR3 device HS bypass capacitor total capacitance <sup>(6)</sup>	0.85			μF
9	Number of connection vias for each HS bypass capacitor <sup>(7)(8)</sup>	2			vias
10	Trace length from bypass capacitor connect to connection via <sup>(2)(8)</sup>		35	100	mils
11	Number of connection vias for each DDR3 device power and ground terminal (9)	1 1	7.		vias
12	Trace length from DDR3 device power and ground terminal to connection via (2)(7)		35	60	mils

- (1) LxW, 10-mil units; for example, a 0402 is a 40x20-mil surface-mount capacitor.
- (2) Closer and shorter is better.
- (3) Measured from the nearest AM335x √DDS\_DDR and ground terminal to the center of the capacitor package.
- (4) Three of these capacitors should be located underneath the AM335x device, between the cluster of VDDS\_DDR and ground terminals, between the DDR3 interfaces on the package.
- (5) Measured from the DDR3 device power and ground terminal to the center of the capacitor package.
- (6) Per DDR3 device.
- (7) An additional HS bypass capacitor can share the connection vias only if it is mounted on the opposite side of the board. No sharing of vias is permitted on the same side of the board.
- (8) An HS bypass capacitor may share a via with a DDR3 device mounted on the same side of the PCB. A wide trace should be used for the connection and the length from the capacitor pad to the DDR3 device pad should be less than 150 mils.
- (9) Up to a total of two pairs of DDR3 power and ground terminals may share a via.

#### 7,7.2.3.3.7.1 Return Current Bypass Capacitors

Use additional bypass capacitors if the return current reference plane changes due to DDR3 signals hopping from one signal layer to another. The bypass capacitor here provides a path for the return current to hop planes along with the signal. As many of these return current bypass capacitors should be used as possible. Because these are returns for signal current, the signal via size may be used for these capacitors.

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## 7.7.2.3.3.8 Net Classes

Table 7-64 lists the clock net classes for the DDR3 interface. Table 7-65 lists the signal net classes, and associated clock net classes, for signals in the DDR3 interface. These net classes are used for the termination and routing rules that follow.

**Table 7-64. Clock Net Class Definitions** 

CLOCK NET CLASS	AM335x PIN NAMES
CK	DDR_CK and DDR_CKn
DQS0	DDR_DQS0 and DDR_DQSn0
DQS1	DDR_DQS1 and DDR_DQSn1

Table 7-65. Signal Net Class Definitions

	SIGNAL NET CLASS	ASSOCIATED CLOCK NET CLASS	AM335x PIN NAMES
2	ADDR_CTRL	СК	DDR_BA[2:0], DDR_A[15:0], DDR_CSn0, DDR_CASn, DDR_RASn, DDR_WEn, DDR_CKE, DDR_ODT
70-	DQ0	DQS0	DDR_D[7:0], DDR_DQM0
7,5	DQ1	DQS1	DDR_D[15:8], DDR_DQM1
A	(ODTs) are requir	s are required for the C	K and ADDR_CTRL net class signals. On-device terminations DQ[x] net class signals. Detailed termination specifications are sections.

Signal terminations are required for the CK and ADDR\_CTRD net class signals. On-device terminations (ODTs) are required on the DQS[x] and DQ[x] net class signals. Detailed termination specifications are covered in the routing rules in the following sections.

Figure 7-48 provides an example DDR3 schematic with a single 16-bit DDR3 memory device that does not have V<sub>TT</sub> termination on the address and control signals. A typical DDR3 point-to-point topology may provide acceptable signal integrity without V<sub>TT</sub> termination. System performance should be verified by performing signal integrity analysis using specific PCB design details before implementing this topology.

#### 7.7.2.3.3.10 DDR VREF Routing

DDR VREF is used as a reference by the input buffers of the DDR3 memories as well as the AM335x device. DDR VREF is intended to be half the DDR3 power supply voltage and is typically generated with a voltage divider connected to the VDDS DDR power supply. It should be routed as a nominal 20-mil wide trace with 0.1 µF bypass capacitors near each device connection. Narrowing of DDR\_VREF is allowed to accommodate routing congestion.

#### 7.7.2.3.3.11 VTT

Like DDR VREF, the nominal value of the VTT supply is half the DDR3 supply voltage. Unlike DDR VREF, VTT is expected to source and sink current, specifically the termination current for the ADDR\_CTRL net class Thevinen terminators. VIT is needed at the end of the address bus and it should be routed as a power sub-plane. VTT should be bypassed near the terminator resistors.

## 7.7,2.3.4 DDR3 CK and ADDR\_CTRL Topologies and Routing Definition

The CK and ADDR\_CTRL net classes are routed similarly and are length matched to minimize skew between them. CK is a bit more complicated because it runs at a higher transition rate and is differential. The following subsections show the topology and routing for various DDR3 configurations for CK and ADDR CTRL. The figures in the following subsections define the terms for the routing specification detailed in Table 7-66.

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## 7.7.2.3.4.1 Two DDR3 Devices

Two DDR3 devices are supported on the DDR3 interface consisting of two x8 DDR3 devices arranged as one 16-bit bank. These two devices may be mounted on a single side of the PCB, or may be mirrored in a pair to save board space at a cost of increased routing complexity and parts on the backside of the PCB.

#### 7.7.2.3.4.1.1 CK and ADDR\_CTRL Topologies, Two DDR3 Devices

Figure 7-52 shows the topology of the CK net classes and Figure 7-53 shows the topology for the corresponding ADDR\_CTRL net classes.

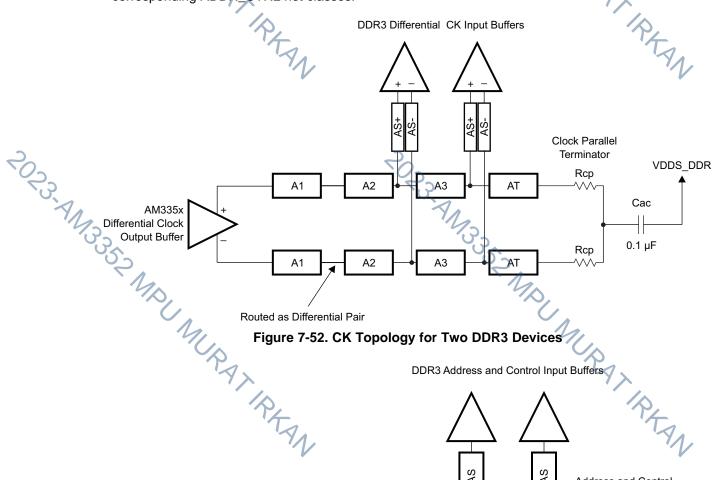


Figure 7-52. CK Topology for Two DDR3 Devices

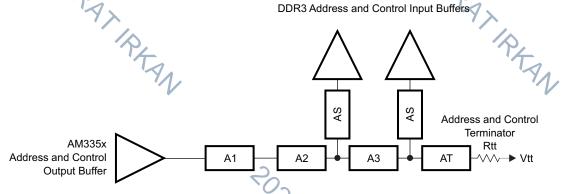


Figure 7-53. ADDR\_CTRL Topology for Two DDR3 Devices

# 7.7,2.3.4.1.2 CK and ADDR\_CTRL Routing, Two DDR3 Devices

Figure 7-54 shows the CK routing for two DDR3 devices placed on the same side of the PCB. Figure 7-55 EMPL MUS shows the corresponding ADDR\_CTRL routing. MAC MUSE



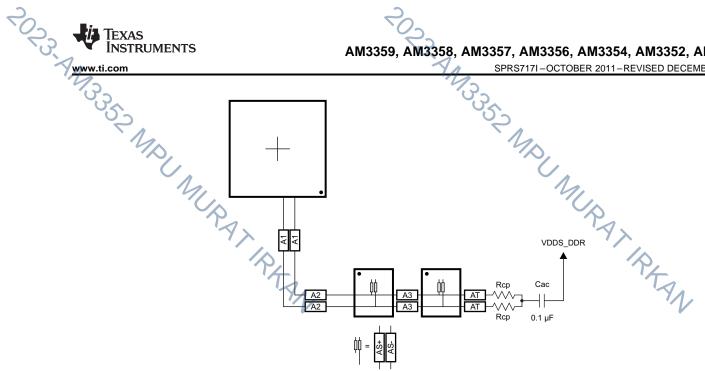


Figure 7-54. CK Routing for Two Single-Side DDR3 Devices

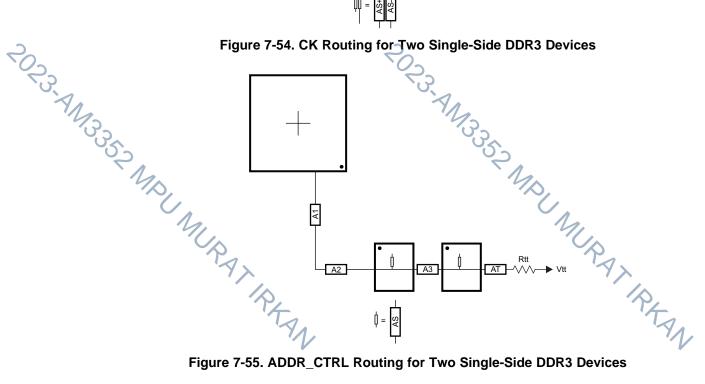


Figure 7-55. ADDR\_CTRL Routing for Two Single-Side DDR3 Devices

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To save PCB space, the two DDR3 memories may be mounted as a mirrored pair at a cost of increased routing and assembly complexity. Figure 7-56 and Figure 7-57 show the routing for CK and ADDR\_CTRL, respectively, for two DDR3 devices mirrored in a single-pair configuration.

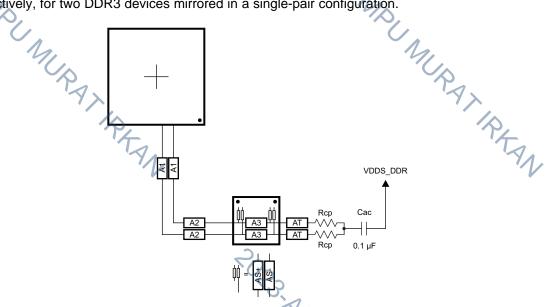
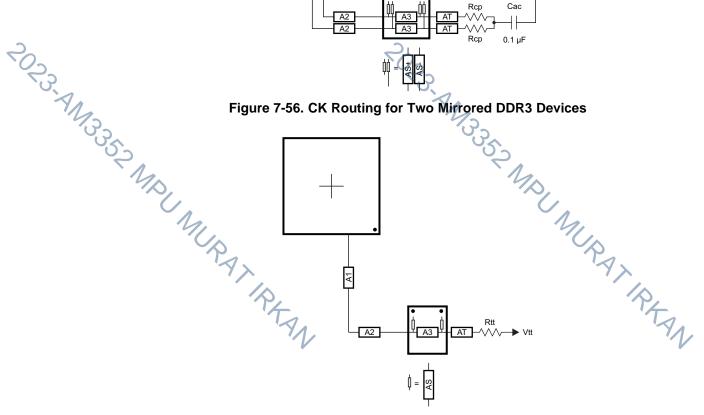


Figure 7-56. CK Routing for Two Mirrored DDR3 Devices



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23. AMBOST MADU MUR
301 Figure 7-57. ADDR\_CTRL Routing for Two Mirrored DDR3 Devices



#### 7.7.2.3.4.2 One DDR3 Device

A single DDR3 device is supported on the DDR3 interface consisting of one x16 DDR3 device arranged as one 16-bit bank.

#### 7.7.2.3.4.2.1 CK and ADDR\_CTRL Topologies, One DDR3 Device

Figure 7-58 shows the topology of the CK net classes and Figure 7-59 shows the topology for the corresponding ADDR\_CTRL net classes.

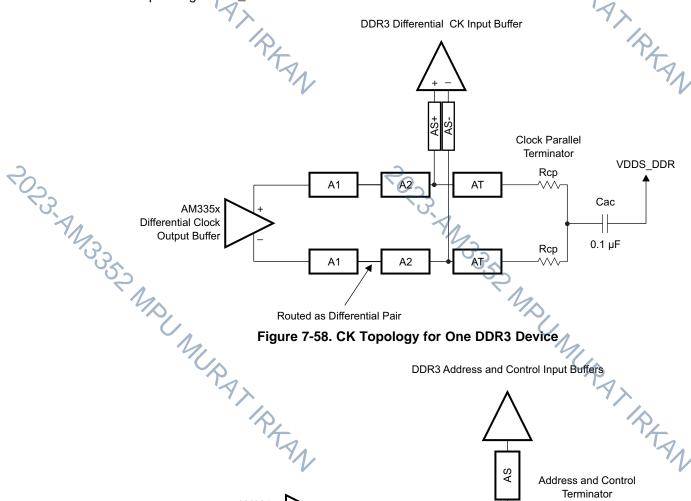


Figure 7-58. CK Topology for One DDR3 Device

DDR3 Address and Control Input Buffers AS Address and Control Terminator AM335x Rtt POPS, AMBUMUR Instr Address and Control Α1 A2 √ Vtt **Output Buffer** 

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In Figure 7-59. ADDR\_CTRL Topology for One DDR3 Device

## 7.7.2.3.4.2.2 CK and ADDR CTRL Routing, One DDR3 Device

Figure 7-60 shows the CK routing for one DDR3 device. Figure 7-61 shows the corresponding ADDR\_CTRL routing.

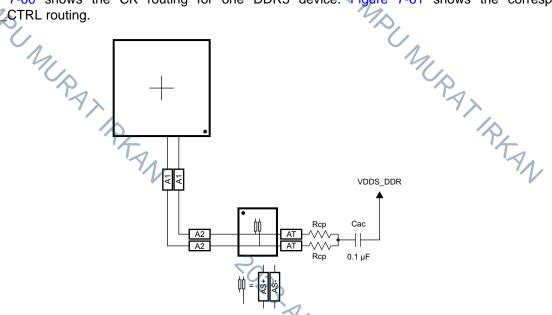


Figure 7-60. CK Routing for One DDR3 Device

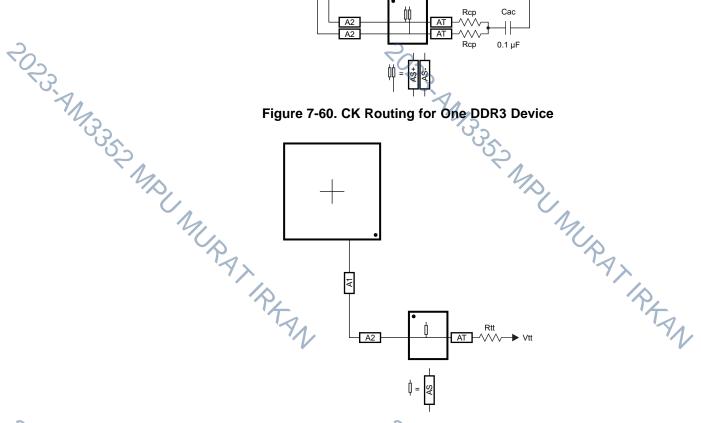


Figure 7-61. ADDR\_CTRL Routing for One DDR3 Device

## 7.7.2.3.5 Data Topologies and Routing Definition

No matter the number of DDR3 devices used, the data line topology is always point to point, so its definition is simple.

## 7.7.2.3.5.1 DQS[x] and DQ[x] Topologies, Any Number of Allowed DDR3 Devices

DQS[x] lines are point-to-point differential, and DQ[x] lines are point-to-point singled ended. Figure 7-62 and Figure 7-63 show these topologies.



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No. 1 DDR3 AM335x DQS[x]+ DQS[x] DQS[x] DQS[x]-IO Buffer IO Buffer Routed Differentially Figure 7-62. DQS[x] Topology AM335x DDR3 DQ[x] IO Buffer DQ[x] DQ[x] IO Buffer x = 0.1Figure 7-63. DQ[x] Topology

#### 7.7.2.3.5.2 DQS[x] and DQ[x] Routing, Any Number of Allowed DDR3 Devices

Figure 7-64 and Figure 7-65 show the DQS[x] and DQ[x] routing.



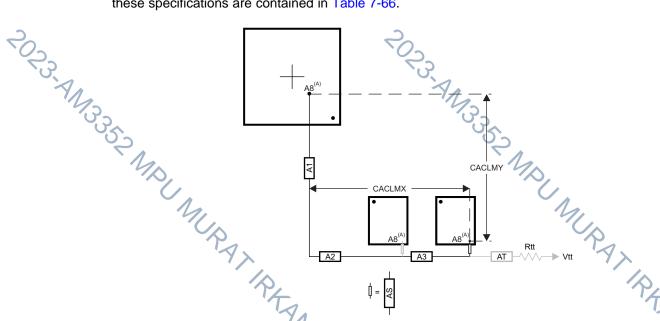


## 7.7.2.3.6 Routing Specification

## 7.7.2.3.6.1/ CK and ADDR\_CTRL Routing Specification

Skew within the CK and ADDR CTRL net classes directly reduces setup and hold margin and, thus, this skew must be controlled. The only way to practically match lengths on a PCB is to lengthen the shorter traces up to the length of the longest net in the net class and its associated clock. A metric to establish this maximum length is Manhattan distance. The Manhattan distance between two points on a PCB is the length between the points when connecting them only with horizontal or vertical segments. A reasonable trace route length is to within a percentage of its Manhattan distance. CACLM is defined as Clock Address Control Longest Manhattan distance.

Given the clock and address pin locations on the AM335x device and the DDR3 memories, the maximum possible Manhattan distance can be determined given the placement. Figure 7-66 shows this distance for two loads. It is from this distance that the specifications on the lengths of the transmission lines for the address bus are determined. CACLM is determined similarly for other address bus configurations; that is, it is based on the longest net of the CK and ADDR\_CTRL net class. For CK and ADDR\_CTRL routing, these specifications are contained in Table 7-66.



It is very likely that the longest CK and ADDR\_CTRL Manhattan distance will be for Address Input 8 (A8) on the DDR3 memories. CACLM is based on the longest Manhattan distance due to the device placement. Verify the net class that satisfies this criteria and use as the baseline for CK and ADDR\_CTRL skew matching and length control.

The length of shorter CK and ADDR\_CTRL stubs as well as the length of the terminator stub are not included in this length calculation. Non-included lengths are grayed out in the figure.

Figure 7-66. CACLM for Two Address Loads on One Side of PCB

Table 7-66. CK and ADDR\_CTRL Routing Specification(1)(2)(3)

		3	3	9							
205		Assuming A8 is the longest, CALM = CACLMY + CACLMX + 300 mils.  The extra 300 mils allows for routing down lower than the DDR3 memories and returning up to reach A8.									
73		Figure 7-66. CACLM for Two Address Loads on One Side of PCB									
4,	Table 7-66. CK and ADDR_CTRL Routing Specification <sup>(1)(2)(3)</sup>										
	NO.	2	PARAMETER	() <sub>\(\times\)</sub>	MIN	TYP	MAX	UNIT			
	1	A1 + A2 length		02	)		2500	mils			
	2	A1 + A2 skew			1.		25	mils			
	3	A3 length			10,		660	mils			
	4	A3 skew <sup>(4)</sup>				•	25	mils			
	5	A3 skew <sup>(5)</sup>			1	1,	125	mils			
	6	AS length					100	mils			

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Table 7-66, CK and ADDR CTRL Routing Specification (1)(2)(3) (continued)

NO.	PARAMETER	MIN	TYP	MAX	UNIT
7	AS skew	1/1		25	mils
8	AS+ and AS- length	17/	,	70	mils
9	AS+ and AS- skew		1-	5	mils
10	AT length <sup>(6)</sup>		500		mils
11	AT skew <sup>(7)</sup>		100		mils
12	AT skew <sup>(8)</sup>		<b>'</b> 4';	5	mils
13	CK and ADDR_CTRL nominal trace length <sup>(9)</sup>	CACLM-50	CACLM	CACLM+50	mils
14	Center-to-center CK to other DDR3 trace spacing <sup>(10)</sup>	4w		7	
15	Center-to-center ADDR_CTRL to other DDR3 trace spacing <sup>(10)(11)</sup>	4w		12.	
16	Center-to-center ADDR_CTRL to other ADDR_CTRL trace spacing <sup>(10)</sup>	3w		1	
17	CK center-to-center spacing <sup>(12)</sup>			•	
18	CK spacing to other net <sup>(10)</sup>	4w			
19	Rcp <sup>(13)</sup>	Zo-1	Zo	Zo+1	Ω
20	Rtt <sup>(13)(14)</sup>	Zo-5	Zo	Zo+5	Ω

- (1) CK represents the clock net class, and ADDR\_CTRL represents the address and control signal net class.
- (2) The use of vias should be minimized.
- (3) Additional bypass capacitors are required when using the VDDS\_DDR plane as the reference plane to allow the return current to jump between the VDDS\_DDR plane and the ground plane when the net class switches layers at a via.
- (4) Mirrored configuration (one DDR3 device on top of the board and one DDR3 device on the bottom).
- (5) Non-mirrored configuration (all DDR3 memories on same side of PCB).
- (6) While this length can be increased for convenience, its length should be minimized.
- (7) ADDR\_CTRL net class only (not CK net class). Minimizing this skew is recommended, but not required.
- (8) CK net class only.
- (9) CACLM is the longest Manhattan distance of the CK and ADDR\_CTRL net classes + 300 mils. For definition, see Section 7.7.2.3.6.1 and Figure 7-66.
- (10) Center-to-center spacing is allowed to fall to minimum (w) for up to 1250 mils of routed length.
- (11) Signals from one DQ net class should be considered other DDR3 traces to another DQ net class.
- (12) CK spacing set to ensure proper differential impedance. Differential impedance should be Z<sub>0</sub> x 2, where Z<sub>0</sub> is the single-ended impedance defined in Table 7-60.
- (13) Source termination (series resistor at driver) is specifically not allowed.
- (14) Termination values should be uniform across the net class.

#### 7.7.2.3.6.2 DQS[x] and DQ[x] Routing Specification

Skew within the DQS[x] and DQ[x] net classes directly reduces setup and hold margin and, thus, this skew must be controlled. The only way to practically match lengths on a PCB is to lengthen the shorter traces up to the length of the longest net in the net class and its associated clock. DQLMn is defined as DQ Longest Manhattan distance n, where n is the byte number. For a 16-bit interface, there are two DQLMs, DQLM0-DQLM1.

### NOTE

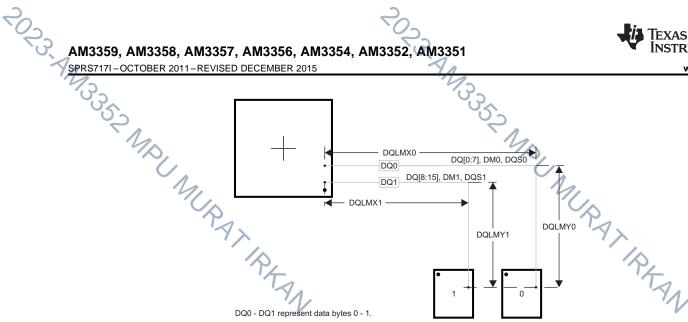
It is not required, nor is it recommended, to match the lengths across all bytes. Length matching is only required within each byte.

Given the DQS[x] and DQ[x] pin locations on the AM335x device and the DDR3 memories, the maximum possible Manhattan distance can be determined given the placement. Figure 7-67 shows this distance for a two-load case. It is from this distance that the specifications on the lengths of the transmission lines for the data bus are determined. For DQS[x] and DQ[x] routing, these specifications are contained in Table 7-67.

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There are two DQLMs, one for each byte (16-bit interface). Each DQLM is the longest Manhattan distance of the byte; therefore:

DQLM0 = DQLMX0 + DQLMY0DQLM1 = DQLMX1 + DQLMY1

#### Figure 7-67. DQLM for Any Number of Allowed DDR3 Devices

## Table 7-67. DQS[x] and DQ[x] Routing Specification(1)(2)

NO.	PARAMETER	An	MIN	TYP	MAX	UNIT
1/1	DQ0 nominal length <sup>(3)(4)</sup>	"			DQLM0	mils
2	DQ1 nominal length <sup>(3)(5)</sup>	, (	()		DQLM1	mils
3	DQ[x] skew <sup>(6)</sup>		05		25	mils
4	DQS[x] skew		10		5	mils
5	DQS[x]-to-DQ[x] skew <sup>(6)(7)</sup>		<b>1</b> 0,		25	mils
6	Center-to-center DQ[x] to other DDR3 trace spacing <sup>(8)(9)</sup>		4w			
7	Center-to-center DQ[x] to other DQ[x] trace spacing <sup>(8)(10)</sup>		3w /	1,		
8	DQS[x] center-to-center spacing <sup>(11)</sup>					
9	DQS[x] center-to-center spacing to other net <sup>(8)</sup>		4w	Ta.		

- (1) DQS[x] represents the DQS0 and DQS1 clock net classes, and DQ[x] represents the DQ0 and DQ1 signal net classes.
- (2) External termination disallowed. Data termination should use built-in ODT functionality.
- (3) DQLMn is the longest Manhattan distance of a byte. For definition, see Section 7.7.2.3.6.2 and Figure 7-67.
- (4) DQLM0 is the longest Manhattan length for the DQ0 net class.
- (5) DQLM1 is the longest Manhattan length for the DQ1 net class.
- (6) Length matching is only done within a byte. Length matching across bytes is not required.
- (7) Each DQS clock net class is length matched to its associated DQ signal net class.
- (8) Center-to-center spacing is allowed to fall to minimum for up to 1250 mils of routed length.
- (9) Other DDR3 trace spacing means signals that are not part of the same DQ[x] signal net class.
- (10) This applies to spacing within same DQ[x] signal net class.
- POPS, AMBUMUP, in E (11) DQS[x] pair spacing is set to ensure proper differential impedance. Differential impedance should be  $Z_0 \times 2$ , where  $Z_0$  is the singleended impedance defined in Table 7-60.



7.8 12C

For more information, see the Inter-Integrated Circuit (I2C) section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73).

## 7.8.1 PC Electrical Data and Timing

#### Table 7-68. I<sup>2</sup>C Timing Conditions – Slave Mode

		STANDARD MODE FAST MODE					
	MIN	MAX	MIN	MAX	UNIT		
<b>Output Condition</b>			· 7/_				
C <sub>b</sub> Capacitive loa	nd for each bus line			400	1	400	pF

## Table 7-69. Timing Requirements for I<sup>2</sup>C Input Timings

#### (see Figure 7-68)

NO			STANDARI	MODE	FAST MODE		LINIT
NO.			MIN	MAX	MIN	MAX	UNIT
1	t <sub>c(SCL)</sub>	Cycle time, SCL	10		2.5		μs
2	t <sub>su(SCLH-SDAL)</sub>	Setup time, SCL high before SDA low (for a repeated START condition)	4.7		0.6		μs
13	t <sub>h(SDAL-SCLL)</sub>	Hold time, SCL low after SDA low (for a START and a repeated START condition)	4		0.6		μs
4	tw(SCLL)	Pulse duration, SCL low	4.7		1.3		μs
5	tw(SCLH)	Pulse duration, SCL high	4		0.6		μs
6	t <sub>su(SDAV-SCLH)</sub>	Setup time, SDA valid before SCL high	250		100 <sup>(1)</sup>		ns
7	t <sub>h(SCLL-SDAV)</sub>	Hold time, SDA valid after SCL low	0(2)	3.45 <sup>(3)</sup>	0 <sup>(2)</sup>	0.9(3)	μs
8	t <sub>w(SDAH)</sub>	Pulse duration, SDA high between STOP and START conditions	4.7		1.3		μs
9	t <sub>r(SDA)</sub>	Rise time, SDA		1000	•	300	ns
10	t <sub>r(SCL)</sub>	Rise time, SCL		1000		300	ns
11	t <sub>f(SDA)</sub>	Fall time, SDA		300	N.	300	ns
12	t <sub>f(SCL)</sub>	Fall time, SCL		300		300	ns
13	t <sub>su(SCLH-SDAH)</sub>	Setup time, high before SDA high (for STOP condition)	4		0.6		μs
14	t <sub>w(SP)</sub>	Pulse duration, spike (must be suppressed)	0	50	4	50	ns

<sup>(1)</sup> A fast-mode  $I^2C$ -bus device can be used in a standard-mode  $I^2C$ -bus system, but the requirement  $t_{su(SDA-SCLH)} \ge 250$  ns must then be met. This is automatically the case if the device does not stretch the LOW period of the SCL signal. If such a device stretches the LOW period of the SCL signal, it must output the next data bit to the SDA line  $t_{r max} + t_{su(SDA-SCLH)} = 1000 + 250 = 1250$  ns (according to the standard-mode I<sup>2</sup>C-Bus Specification) before the SCL line is released.

Not selected and the se (3) The maximum th(SDA-SCLL) has only to be met if the device does not stretch the low period [tw(SCLL)] of the SCL signal.



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<sup>(2)</sup> A device must internally provide a hold time of at least 300 ns for the SDA signal (referred to the V<sub>IHmin</sub> of the SCL signal) to bridge the POPS-AMSSSE MADU MUR undefined region of the falling edge of SCL.



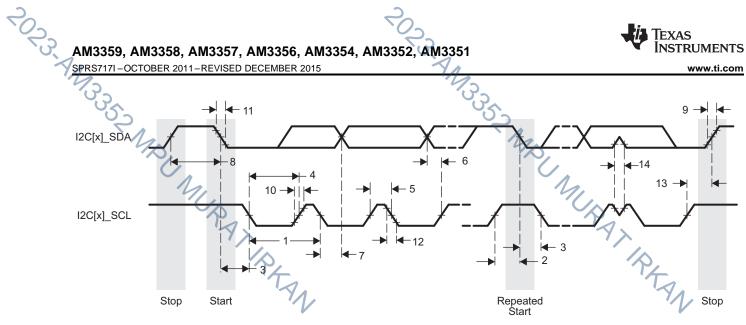


Figure 7-68. I<sup>2</sup>C Receive Timing

### Table 7-70. Switching Characteristics for I<sup>2</sup>C Output Timings

			Table 7-70. Switching Characteristics for	i-c Outp	ut Hillin	igs		
	(see F	igure 7-69)						
500	NO		DADAMETER	STANDAR	D MODE	FAST MODE		LINIT
2023	NO.		PARAMETER	MIN	MAX	MIN	MAX	UNIT
~	15	t <sub>c(SCL)</sub>	Cycle time, SCL	10		2.5		μs
4	16	t <sub>su</sub> (SCLH-SDAL)	Setup time, SCL high before SDA low (for a repeated START condition)	4.7		0.6		μs
	17	th(SDAL-SCLL)	Hold time, SCL low after SDA low (for a START and a repeated START condition)	ر ان ان ان ان		0.6		μs
	18	t <sub>w(SCLL)</sub>	Pulse duration, SCL low	4.7		1.3		μs
	19	t <sub>w(SCLH)</sub>	Pulse duration, SCL high	4	S,	0.6		μs
	20	t <sub>su(SDAV-SCLH)</sub>	Setup time, SDA valid before SCL high	250		100		ns
	21	t <sub>h(SCLL-SDAV)</sub>	Hold time, SDA valid after SCL low	0	3.45	0	0.9	μs
	22	t <sub>w(SDAH)</sub>	Pulse duration, SDA high between STOP and START conditions	4.7		1.3		μs
	23	t <sub>r(SDA)</sub>	Rise time, SDA		1000	7	300	ns
	24	t <sub>r(SCL)</sub>	Rise time, SCL		1000		300	ns
	25	t <sub>f(SDA)</sub>	Fall time, SDA		300	7	300	ns
	26	t <sub>f(SCL)</sub>	Fall time, SCL		300	4	300	ns
	27	t <sub>su(SCLH-SDAH)</sub>	Setup time, high before SDA high (for STOP condition)	4		0.6		μs

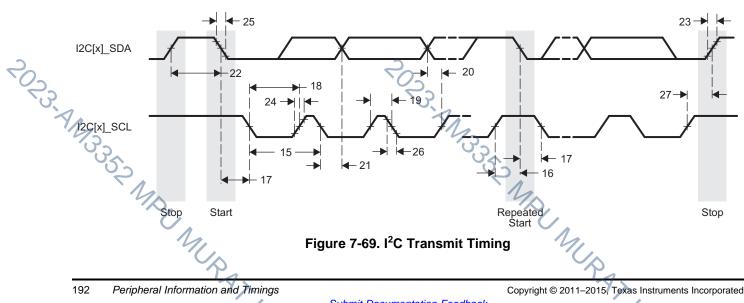


Figure 7-69. I<sup>2</sup>C Transmit Timing



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## 7.9 JTAG Electrical Data and Timing

## Table 7-71. Timing Requirements for JTAG

(see Figure 7-70)

NO.		1.	OPP100		OPP50	UNIT
NO.	'11,		MIN	MAX	MIN MAX	CONTI
1	t <sub>c(TCK)</sub>	Cycle time, TCK	81.5		104.5	ns
1a	t <sub>w(TCKH)</sub>	Pulse duration, TCK high (40% of t <sub>c</sub> )	32.6		41,8	ns
1b	t <sub>w(TCKL)</sub>	Pulse duration, TCK low (40% of t <sub>c</sub> )	32.6		41.8	ns
3	t <sub>su(TDI-TCKH)</sub>	Input setup time, TDI valid to TCK high	3		3	ns
3	t <sub>su(TMS-TCKH)</sub>	Input setup time, TMS valid to TCK high	3		3	ns
4	t <sub>h(TCKH-TDI)</sub>	Input hold time, TDI valid from TCK high	8.05		8.05	ns
4	t <sub>h(TCKH-TMS)</sub>	Input hold time, TMS valid from TCK high	8.05		8.05	ns

Table 7-72. Switching Characteristics for JTAG

NO.	PARAMETER	2		OPP10	0	OPP50		UNIT
NO.	FARAMETER	10.	<b>D</b> _	MIN	MAX	MIN	MAX	UNII
2	t <sub>d(TCKL-TDO)</sub> Delay time, TCK low to TDO valid		ري ا	3	27.6	4	36.8	ns

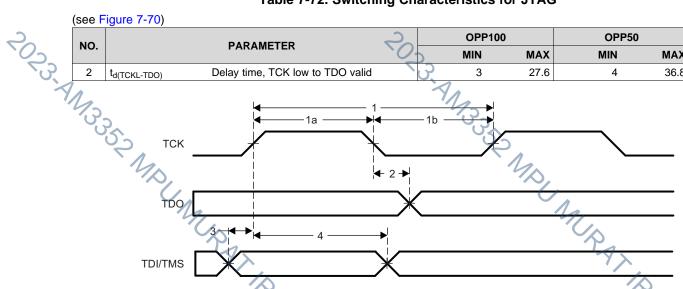


Figure 7-70. JTAG Timing

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The LCDC consists of two independent controllers, the raster controller and the LCD interface display driver (LIDD) controller. Each controller operates independently from the other and only one of them is active at any given time.

- The raster controller handles the synchronous LCD interface. It provides timing and data for constant graphics refresh to a passive display. It supports a wide variety of monochrome and full-color display types and sizes by use of programmable timing controls, a built-in palette, and a gray-scale and serializer. Graphics data is processed and stored in frame buffers. A frame buffer is a contiguous memory block in the system. A built-in DMA engine supplies the graphics data to the raster engine which, in turn, outputs to the external LCD device.
- The LIDD controller supports the asynchronous LCD interface. It provides full-timing programmability of control signals (CS, WE, OE, ALE) and output data.

The maximum resolution for the LCD controller is 2048 x 2048 pixels. The maximum frame rate is determined by the image size in combination with the pixel clock rate.

Table 7-73. LCD Controller Timing Conditions

	PARAMETER	ے.		MIN	TYP MAX	UNIT
<b>Output Condi</b>	tion	0				
C	Output load conscitores	73 L	IDD mode	5	60	۲
C <sub>LOAD</sub>	Output load capacitance	R	Raster mode	3	30	p⊦

## LCD Interface Display Driver (LIDD Mode)

#### Table 7-74. Timing Requirements for LCD LIDD Mode

(see Figure 7-72 through Figure 7-80)

NO.			OPP100	UNIT
NO.	M.		MIN MAX	ONII
16	t <sub>su(LCD_DATA-LCD_MEMORY_CLK)</sub>	Setup time, LCD_DATA[15:0] valid before LCD_MEMORY_CLK high	18	ns
17	t <sub>h(LCD_MEMORY_CLK-LCD_DATA)</sub>	Hold time, LCD_DATA[15:0] valid after LCD_MEMORY_CLK high	0	ns
18	t <sub>t(LCD_DATA)</sub>	Transition time, LCD_DATA[15:0]	1 3	ns

## Table 7-75, Switching Characteristics for LCD LIDD Mode

(see Figure 7-72 through Figure 7-80)

NO	PARAMETER		OPP10		
NO.			MIN	MAX	UNIT
1	t <sub>c(LCD_MEMORY_CLK)</sub>	Cycle time, LCD_MEMORY_CLK	23.7		ns
2	t <sub>w(LCD_MEMORY_CLKH)</sub>	Pulse duration, LCD_MEMORY_CLK high	0.45t <sub>c</sub>	$0.55t_{c}$	ns
3	t <sub>w(LCD_MEMORY_CLKL)</sub>	Pulse duration, LCD_MEMORY_CLK low	0.45t <sub>c</sub>	$0.55t_{c}$	ns
4	t <sub>d</sub> (LCD_MEMORY_CLK-LCD_DATAV)	Delay time, LCD_MEMORY_CLK high to LCD_DATA[15:0] valid (write)		7	ns
1/5	t <sub>d</sub> (LCD_MEMORY_CLK-LCD_DATAI)	Delay time, LCD_MEMORY_CLK high to LCD_DATA[15:0] invalid (write)	0		ns
673	td(LCD_MEMORY_CLK-LCD_AC_BIAS_EN)	Delay time, LCD_MEMORY_CLK high to LCD_AC_BIAS_EN	0	6.8	ns
7	t <sub>t</sub> (LCD_AC_BIAS_EN)	Transition time, LCD_AC_BIAS_EN	1	10	ns
8	t <sub>d</sub> (LCD_MEMORY_CLK-LCD_VSYNC)	Delay time, LCD_MEMORY_CLK high to LCD_VSYNC	0	7	ns
9	t <sub>t(LCD_VSYNC)</sub>	Transition time, LCD_VSYNC	1	10	ns
10	t <sub>d</sub> (LCD_MEMORY_CLK-LCD_HYSNC)	Delay time, LCD_MEMORY_CLK high to LCD_HSYNC		7	ns

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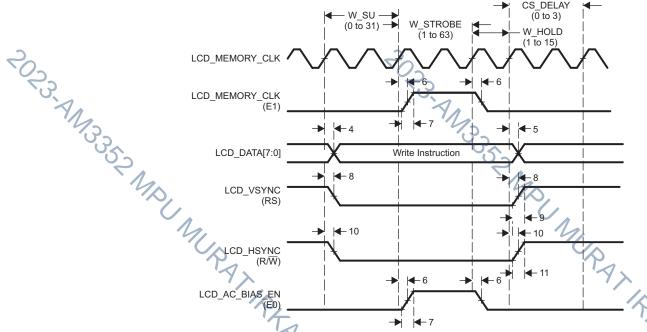




Table 7-75. Switching Characteristics for LCD LIDD Mode (continued)

(see Figure 7-72 through Figure 7-80)

NO.	40	PARAMETER	OPP100	UNIT
NO.	()	PARAMETER	MIN N	MAX
11	t <sub>t</sub> (LCD_HSYNC)	Transition time, LCD_HYSNC	1	10 ns
12	t <sub>d</sub> (LCD_MEMORY_CLK-LCD_PCLK)	Delay time, LCD_MEMORY_CLK high to LCD_PCLK	0	7 ns
13	t <sub>t(LCD_PCLK)</sub>	Transition time, LCD_PCLK	1	10 ns
14	t <sub>d</sub> (LCD_MEMORY_CLK-LCD_DATAZ)	Delay time, LCD_MEMORY_CLK high to LCD_DATA[15:0] high-Z	0	7 ns
15	t <sub>d</sub> (LCD_MEMORY_CLK-LCD_DATA)	Delay time, LCD_MEMORY_CLK high to LCD_DATA[15:0] driven	0 7	7 ns
19	t <sub>t</sub> (LCD_MEMORY_CLK)	Transition time, LCD_MEMORY_CLK	1	2.5 ns
20	t <sub>t(LCD_DATA)</sub>	Transition time, LCD_DATA	1	10 ns

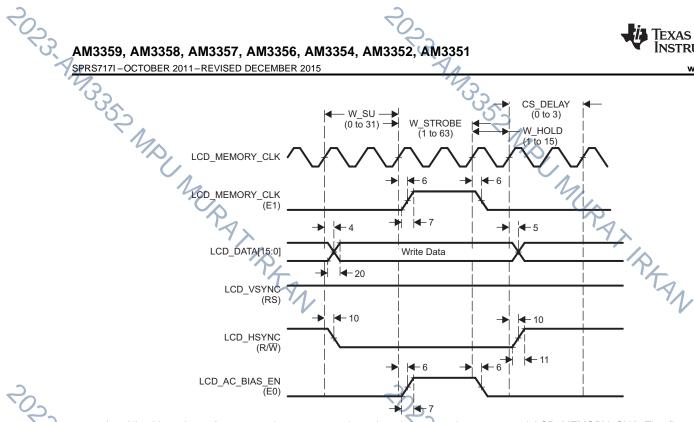


Hitachi mode performs asynchronous operations that do not require an external LCD\_MEMORY\_CLK. The first LCD\_MEMORY\_CLK waveform is only shown as a reference of the internal clock that sequences the other signals. The second LCD\_MEMORY\_CLK waveform is shown as E1 because the LCD\_MEMORY\_CLK signal is used to implement the E1 function in Hitachi mode.

Figure 7-71. Command Write in Hitachi Mode

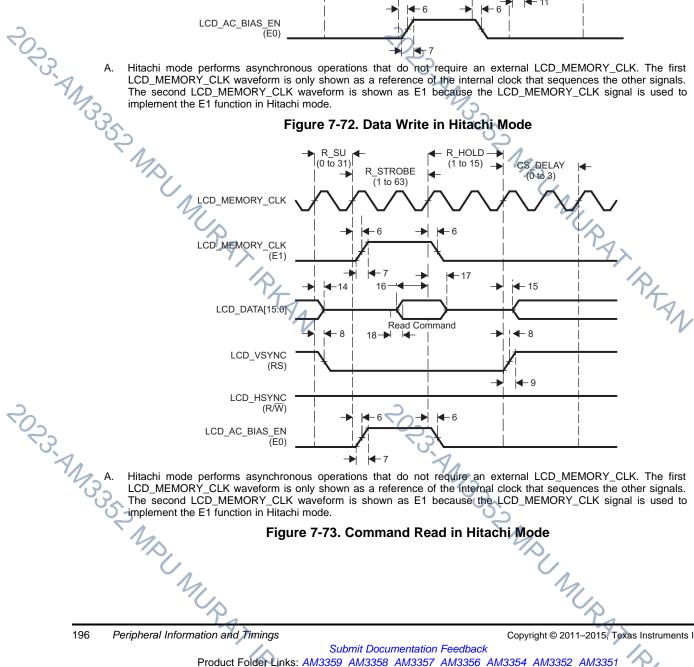
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Hitachi mode performs asynchronous operations that do not require an external LCD\_MEMORY\_CLK. The first LCD\_MEMORY\_CLK waveform is only shown as a reference of the internal clock that sequences the other signals. The second LCD\_MEMORY\_CLK waveform is shown as E1 because the LCD\_MEMORY\_CLK signal is used to implement the E1 function in Hitachi mode.

Figure 7-72. Data Write in Hitachi Mode



Hitachi mode performs asynchronous operations that do not require an external LCD\_MEMORY\_CLK. The first LCD\_MEMORY\_CLK waveform is only shown as a reference of the internal clock that sequences the other signals. The second LCD\_MEMORY\_CLK waveform is shown as E1 because the LCD\_MEMORY\_CLK signal is used to

Figure 7-73. Command Read in Hitachi Mode

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LCD\_MEMOR

LCD\_MEMORY\_CLK
(E1) R\_HOLD R\_SU (0 to 31) (1 to 15) CS\_DELAY R\_STROBE  $(\overline{0} \text{ to } 3)$ (1 to 63) - 6 6 **◄** 17 16 **4**−14 **I** 15 LCD\_DATA[15:0] Read Data 18-LCD\_VSYNC (RS) LCD HSYNC (R/W) **4**−6 **◄** 6

PORS. AMOS STANDE MARKAN MARKAN Hitachi mode performs asynchronous operations that do not require an external LCD\_MEMORY\_CLK. The first LCD\_MEMORY\_CLK waveform is only shown as a reference of the internal clock that sequences the other signals. The second LCD\_MEMORY\_CLK waveform is shown as E1 because the LCD\_MEMORY\_CLK signal is used to implement the E1 function in Hitachi mode. Mode

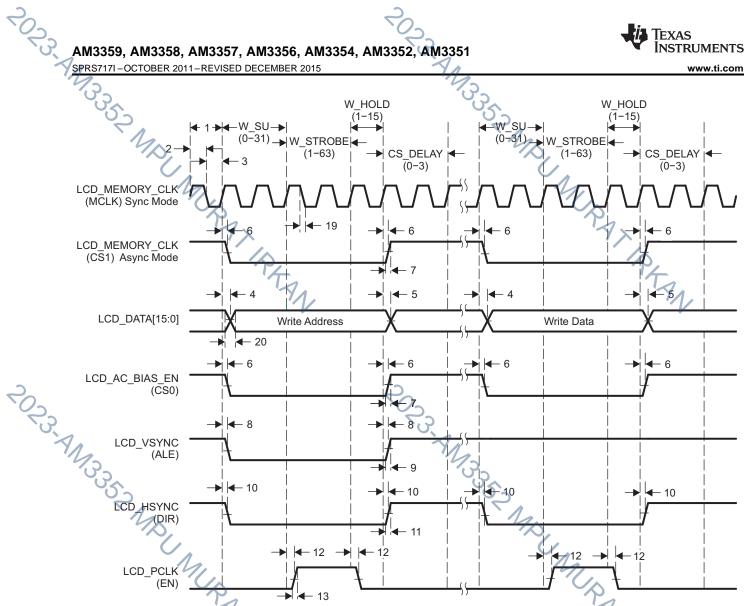
Figure 7-74. Data Read in Hitachi Mode

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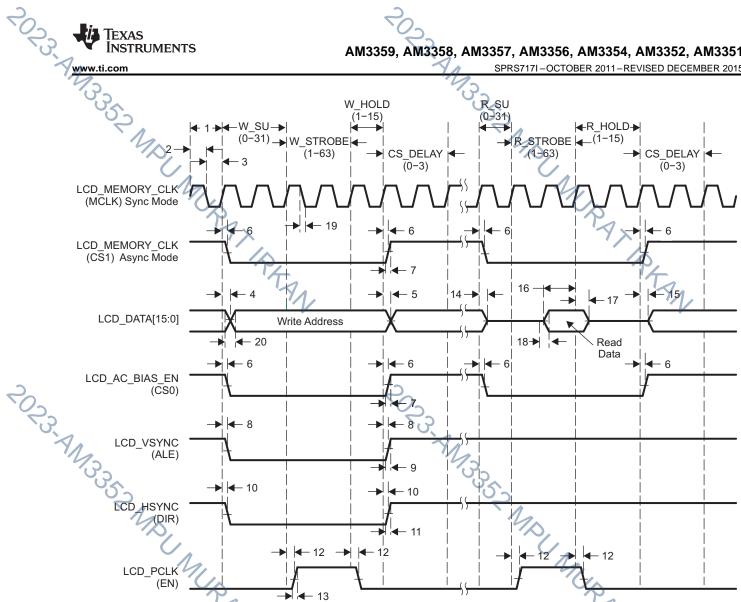
Motorola mode can be configured to perform asynchronous operations or synchronous operations. When configured in asynchronous mode, LCD\_MEMORY\_CLK is not required, so it performs the CS1 function. When configured in synchronous mode, LCD\_MEMORY\_CLK performs the MCLK function. LCD\_MEMORY\_CLK is also shown as a reference of the internal clock that sequences the other signals.

Figure 7-75/Micro-Interface Graphic Display Motorola Write

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Motorola mode can be configured to perform asynchronous operations or synchronous operations. When configured in asynchronous mode, LCD\_MEMORY\_CLK is not required, so it performs the CS1 function. When configured in synchronous mode, LCD\_MEMORY\_CLK performs the MCLK function. LCD\_MEMORY\_CLK is also shown as a reference of the internal clock that sequences the other signals.

Figure 7-76, Micro-Interface Graphic Display Motorola Read

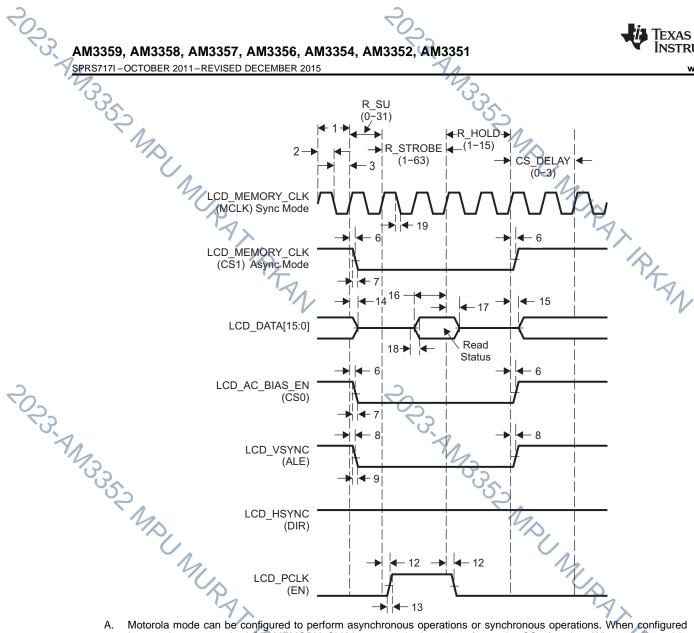
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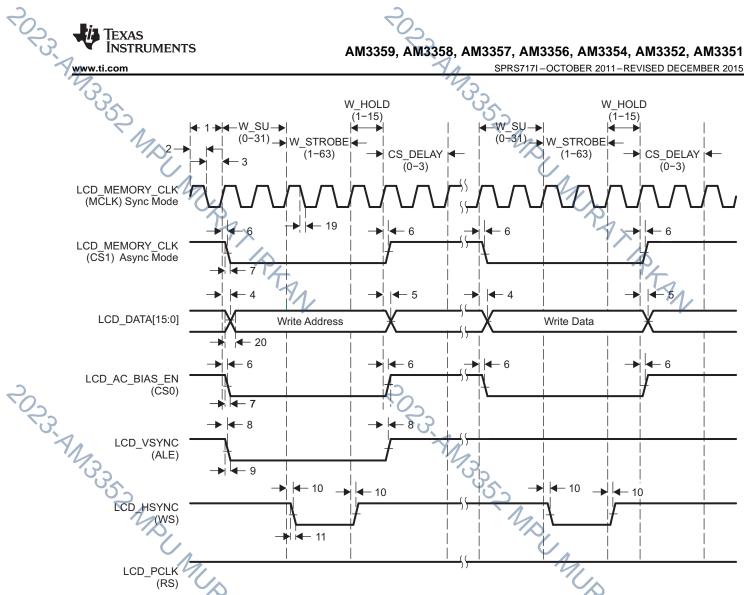
Motorola mode can be configured to perform asynchronous operations or synchronous operations. When configured in asynchronous mode, LCD MEMORY\_CLK is not required, so it performs the CS1 function. When configured in synchronous mode, LCD\_MEMORY\_CLK performs the MCLK function. LCD\_MEMORY\_CLK is also shown as a reference of the internal clock that sequences the other signals.

Figure 7-77. Micro-Interface Graphic Display Motorola Status

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Product Folder Links: AM3359 AM3358 AM3357 AM3356 AM3354 AM3352 AM3351





Intel mode can be configured to perform asynchronous operations or synchronous operations. When configured in asynchronous mode, LCD\_MEMORY\_CLK is not required, so it performs the CS1 function. When configured in synchronous mode, LCD\_MEMORY\_CLK performs the MCLK function. LCD\_MEMORY\_CLK is also shown as a reference of the internal clock that sequences the other signals.

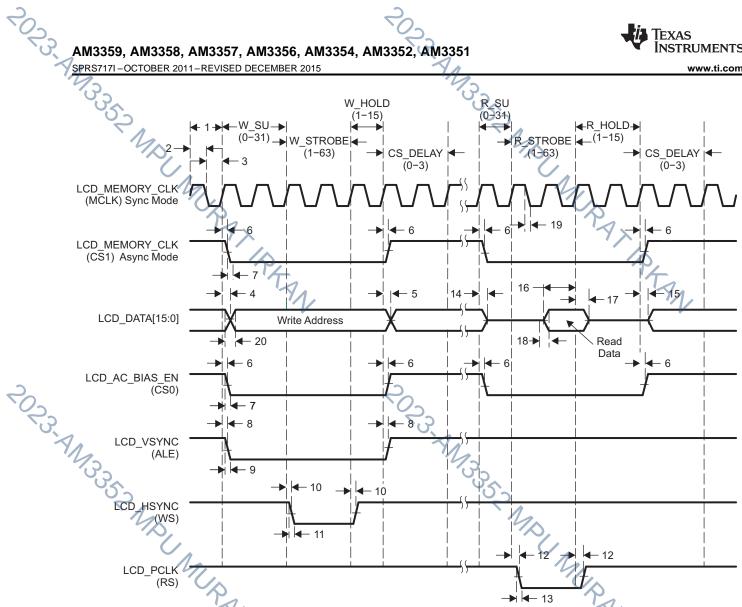
Figure 7-78. Micro-Interface Graphic Display Intel Write

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Intel mode can be configured to perform asynchronous operations or synchronous operations. When configured in asynchronous mode, LCD\_MEMORY\_CLK is not required, so it performs the CS1 function. When configured in synchronous mode, LCD\_MEMORY\_CLK performs the MCLK function. LCD\_MEMORY\_CLK is also shown as a reference of the internal clock that sequences the other signals.

Figure 7-79. Micro-Interface Graphic Display Intel Read

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LCD\_MEMORY\_CLK
(MCLK) Sync Mode

TMORY\_CLF
THIC Mod R\_SU (0-31)R\_HOLD→ ▶| R\_STROBE |**←** (1-15) (1-63) CS DELAY (0-3)- 15 LCD\_DATA[15:0] Read 18→ Status - 6 - 6 LCD\_AC\_BIAS\_EN (CS0) LCD\_VSYNC (ALE) LCD\_HSYNC (WS) - 12 LCD PCLK (RS) - 13

Intel mode can be configured to perform asynchronous operations or synchronous operations. When configured in asynchronous mode, LCD\_MEMORY\_CLK is not required, so it performs the CS1 function. When configured in synchronous mode, LCD\_MEMORY\_CLK performs the MCLK function. LCD\_MEMORY\_CLK is also shown as a reference of the internal clock that sequences the other signals.

Figure 7-80 Micro-Interface Graphic Display Intel Status

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#### 7.10.2 LCD Raster Mode

## Table 7-76. Switching Characteristics for LCD Raster Mode

(see Figure 7-82 through Figure 7-85)

	NO	DADAMETER		OPP	OPP50		00		
NO.		PARAMETER		MIN	MAX	MIN	MAX	UNIT	
	1	t <sub>c(LCD_PCLK)</sub>	Cycle time, pixel clock	15.8		7.9		ns	
	2	t <sub>w(LCD_PCLKH)</sub>	Pulse duration, pixel clock high	0.45t <sub>c</sub>	0.55t <sub>c</sub>	0.45t <sub>c</sub>	$0.55t_{c}$	ns	
	3	t <sub>w(LCD_PCLKL)</sub>	Pulse duration, pixel clock low	0.45t <sub>c</sub>	$0.55t_{c}$	0.45t <sub>c</sub>	$0.55t_{c}$	ns	
	4	t <sub>d(LCD_PCLK-LCD_DATAV)</sub>	Delay time, LCD_PCLK to LCD_DATA[23:0] valid (write)		3.0	P	1.9	ns	
	5	t <sub>d(LCD_PCLK-LCD_DATAI)</sub>	Delay time, LCD_PCLK to LCD_DATA[23:0] invalid (write)	-3.0		-1.7	N	ns	
	6	t <sub>d</sub> (LCD_PCLK-LCD_AC_BIAS_EN)	Delay time, LCD_PCLK to LCD_AC_BIAS_EN	-3.0	3.0	-1.7	1.9	ns	
	7	t <sub>t(LCD_AC_BIAS_EN)</sub>	Transition time, LCD_AC_BIAS_EN	0.5	2.4	0.5	2.4	ns	
	8	t <sub>d(LCD_PCLK-LCD_VSYNC)</sub>	Delay time, LCD_PCLK to LCD_VSYNC	-3.0	3.0	-1.7	1.9	ns	
	9	t <sub>t(LCD_VSYNC)</sub>	Transition time, LCD_VSYNC	0.5	2.4	0.5	2.4	ns	
	10	t <sub>d(LCD_PCLK-LCD_HSYNC)</sub>	Delay time, LCD_PCLK to LCD_HSYNC	-3.0	3.0	-1.7	1.9	ns	
	11	t <sub>t(LCD_HSYNC)</sub>	Transition time, LCD_HSYNC	0.5	2.4	0.5	2.4	ns	
	12	t <sub>t(LCD_PCLK)</sub>	Transition time, LCD_PCLK	0.5	2.4	0.5	2.4	ns	
4	13	t <sub>t(LCD_DATA)</sub>	Transition time, LCD_DATA	0.5	2.4	0.5	2.4	ns	
•	1/3	Frame-to-frame timing is derived through the following parameters in the LCD (RASTER_TIMING register:  Vertical front porch (VFP)							
		<ul> <li>Vertical sync pulse</li> </ul>	e width (VSW)	10.					
		<ul> <li>Vertical back porc</li> </ul>	h (VBP)						
		<ul> <li>Lines per panel (L</li> </ul>	PP B10 + LPP)		1,				

- Lines per panel (LPP\_B10 + LPP)

Line-to-line timing is derived through the following parameters in the LCD (RASTER TIMING 0) register:

- Horizontal front porch (HFP)
- Horizontal sync pulse width (HSW)
- Horizontal back porch (HBP)
- Pixels per panel (PPLMSB + PPLLSB)

LCD\_AC\_BIAS\_EN timing is derived through the following parameter in the LCD (RASTER\_TIMING\_2) register:

AC bias frequency (ACB)

PORS. AMBUMUR. Jani The display format produced in raster mode is shown in Figure 7-81. An entire frame is delivered one line at a time. The first line delivered starts at data pixel (1, 1) and ends at data pixel (P, 1). The last line delivered starts at data pixel (1, L) and ends at data pixel (P, L). The beginning of each new frame is denoted by the activation of IO signal LCD\_VSYNC. The beginning of each new line is denoted by the M. AMBOSENBUM activation of IO signal LCD HSYNC.

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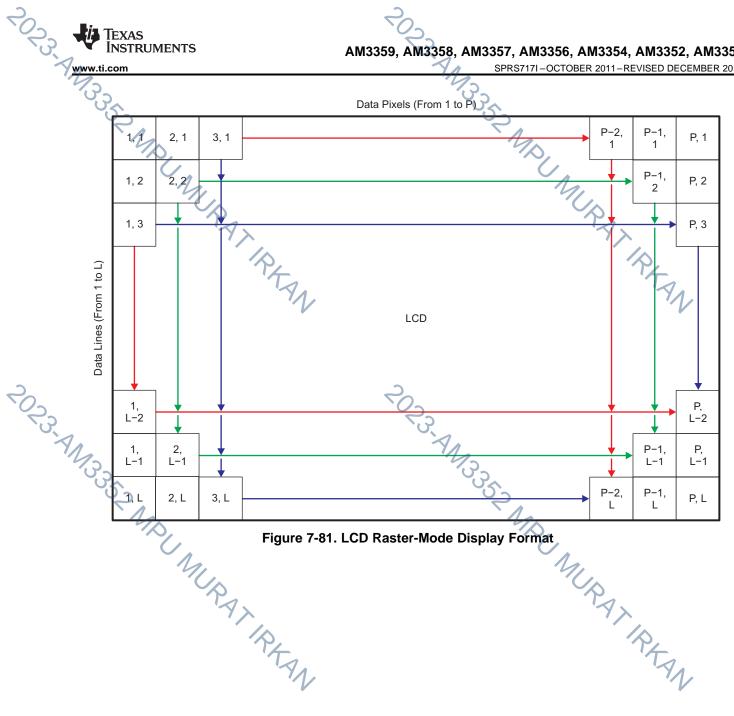
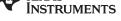


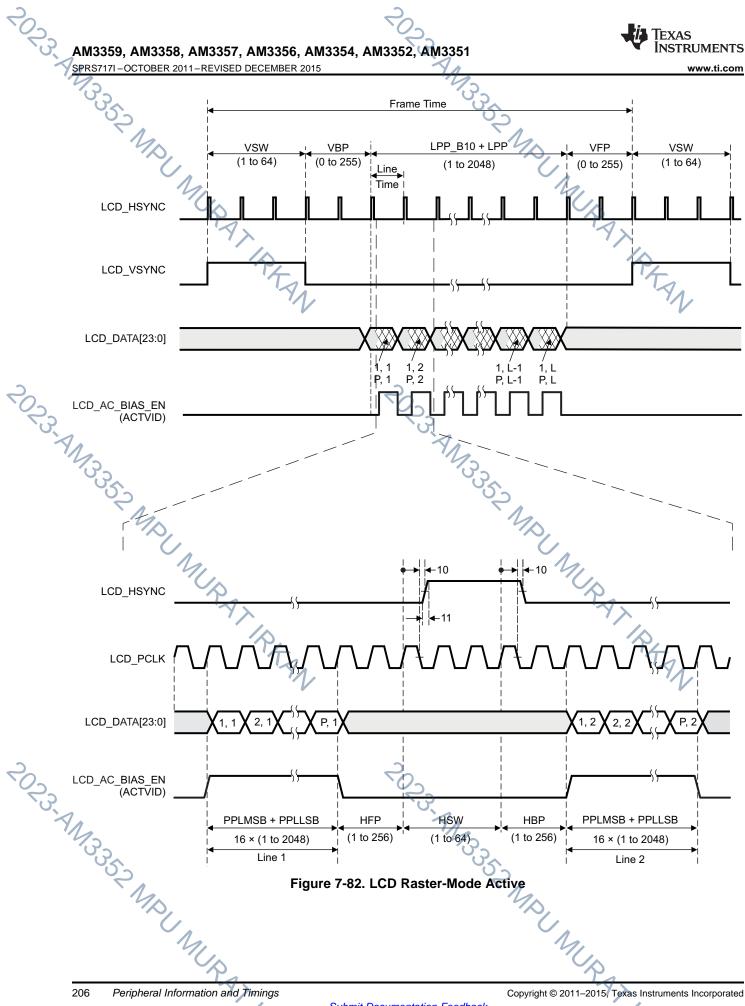
Figure 7-81. LCD Raster-Mode Display Format

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No. 1 No. Frame Time VBP = 0 VFP = 0 LPP\_B10 + LPP (1 to 2048) Line Time LCD\_HSYNC LCD\_VSYNC Data LCD\_DATA[7:0] PORS. AMSSS MANNEY 1, L-3 P, L-3 1, L-2 P, L-2 1, L-4 P, L-4 **ACB** ACB (0 to 255) (0 to 255) **←** 10 LCD\_PCLK LCD\_DATA[7:0] POR AMOSE AMOUNTED INSTRICT HFP PPLMSB + PPLLSB **HSW** HBP PPLMSB + PPLLSB 16 x (1 to 2048) (1 to 256) (1 to 64) (1 to 256) 16 x (1 to 2048)

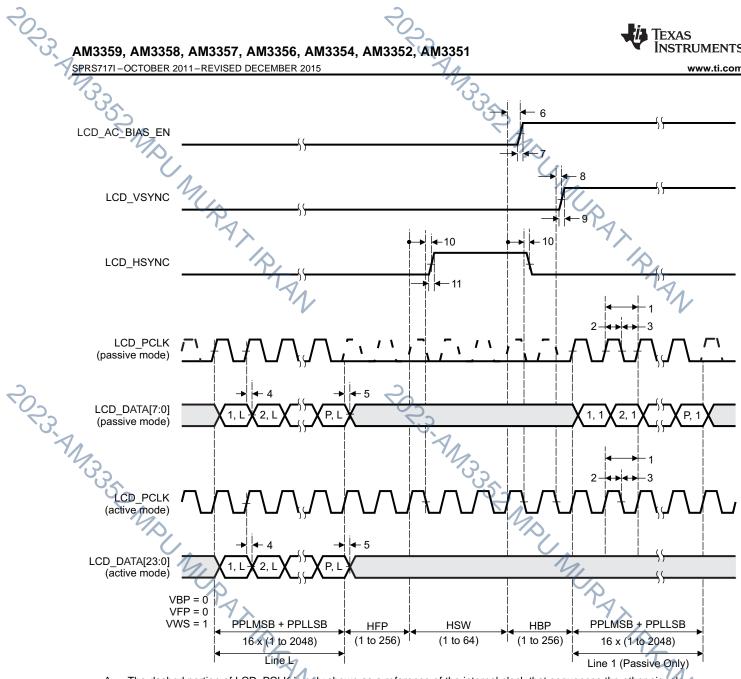
The dashed portion of LCD\_PCLK is only shown as a reference of the internal clock that sequences the other signals. EMBUMUR.

Figure 7-83. LCD Raster-Mode Passive

Line 5

Line 6

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The dashed portion of LCD\_PCLK is only shown as a reference of the internal clock that sequences the other signals.

Figure 7-84. LCD Raster-Mode Control Signal Activation

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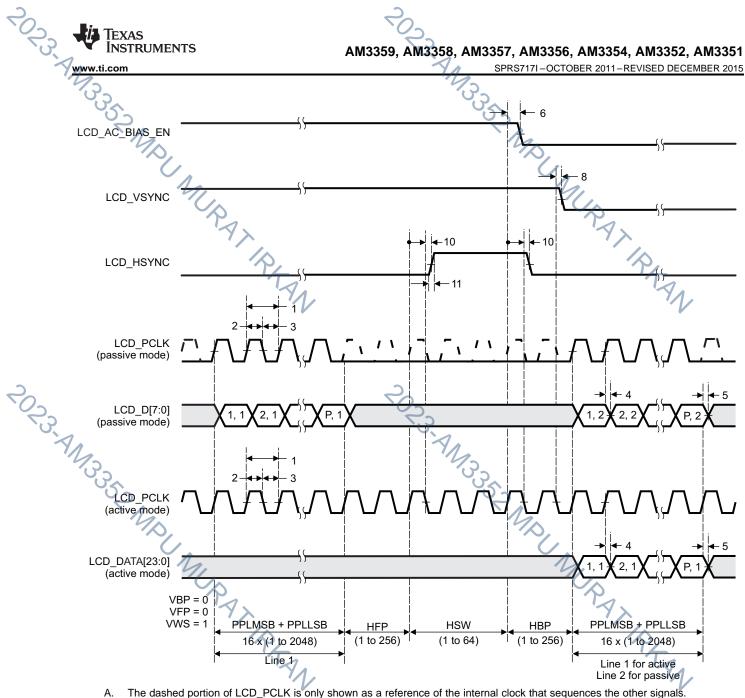


Figure 7-85. LCD Raster-Mode Control Signal Deactivation

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## 7.11 Multichannel Audio Serial Port (McASP)

The multichannel audio serial port (McASP) functions as a general-purpose audio serial port optimized for the needs of multichannel audio applications. The McASP is useful for time-division multiplexed (TDM) stream, Inter-Integrated Sound (I2S) protocols, and inter-component digital audio interface transmission (DIT).

## 7.11.1 McASP Device-Specific Information

The device includes two multichannel audio serial port (McASP) interface peripherals (McASP0 and McASP1). The McASP module consists of a transmit and receive section. These sections can operate completely independently with different data formats, separate master clocks, bit clocks, and frame syncs or, alternatively, the transmit and receive sections may be synchronized. The McASP module also includes shift registers that may be configured to operate as either transmit data or receive data.

The transmit section of the McASP can transmit data in either a time-division-multiplexed (TDM) synchronous serial format or in a digital audio interface (DIT) format where the bit stream is encoded for SPDIF, AES-3, IEC-60958, CP-430 transmission. The receive section of the McASP peripheral supports the TDM synchronous serial format.

The McAST ....
receive format at a time. All transmit and receive round.
the same format; however, the transmit and receive round.
receive sections of the McASP also support burst mode, which is useful round.
passing control information between two devices).

The McASP peripheral has additional capability for flexible clock generation and error detection/handling, as well as error management.

\*\*\*ASP1 modules have up to four serial data pins each. The McASP FIFO size are supported. Buffers are used transparently to

For more detailed information on and the functionality of the McASP peripheral, see the Multichannel Audio Serial Port (McASP) section of the AM335x Sitara Processors Technical Reference Manual A) Ptan (SPRUH73).

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## 7.11.2 McASP Electrical Data and Timing

## **Table 7-77. McASP Timing Conditions**

PARAMETER	MIN	TYP	MAX	UNIT
Input Conditions	1.			
t <sub>R</sub> Input signal rise time	1977		4 <sup>(1)</sup>	ns
t <sub>F</sub> Input signal fall time	1(1)		4 <sup>(1)</sup>	ns
Output Condition	'3	/ <sub>\(\)</sub>	•	
C <sub>LOAD</sub> Output load capacitance	15	///	30	pF

<sup>(1)</sup> Except when specified otherwise.

## Table 7-78. Timing Requirements for McASP<sup>(1)</sup>

#### (see Figure 7-86)

NO.				OPP100		OPP50	
NO.				MIN	MAX	MIN MAX	UNIT
1	t <sub>c(AHCLKRX)</sub>	Cycle time, McASP[x]_AHCLKR and McASP[x]_AHCLKX	2	20		40	ns
2	t <sub>w(AHCLKRX)</sub>	Pulse duration, McASP[x]_AHCLKR a McASP[x]_AHCLKX high or low	and Co	0.5P - 2.5 <sup>(2)</sup>		0.5P - 2.5 <sup>(2)</sup>	ns
3	t <sub>c(ACLKRX)</sub>	Cycle time, McASP[x]_ACLKR and McASP[x]_ACLKX	\ \frac{1}{2}	20		40	ns
4	t <sub>w(ACLKRX)</sub>	Pulse duration, McASP[x]_ACLKR and McASP[x]_ACLKX high or low		0.5R - 2.5 <sup>(3)</sup>		0.5R - 2.5 <sup>(3)</sup>	ns
`	(2)	Setup time, McASP[x]_AFSR and	ACLKR and ACLKX int	11.5		15.5	
5	t <sub>su(AFSRX-</sub> ACLKRX)	McASP[x]_AFSX input valid before McASP[x]_ACLKR and McASP[x]_ACLKX	ACLKR and ACLKX ext in	4/		6	ns
			ACLKR and ACLKX ext out	4	1	6	
	t <sub>h(ACLKRX-</sub> AFSRX)	Hold time, McASP[x]_AFSR and McASP[x]_AFSX input valid after McASP[x]_ACLKR and McASP[x]_ACLKX	ACLKR and ACLKX int	-1		<b>%</b> -1	
6			ACLKR and ACLKX ext in	0.4		0.4	ns
			ACLKR and ACLKX ext out	0.4		0.4	
	t <sub>su(AXR-ACLKRX)</sub>	Setup time, McASP[x]_AXR input valid before McASP[x]_ACLKR and McASP[x]_ACLKX	ACLKR and ACLKX int	11.5		15.5	•
7			ACLKR and ACLKX ext in	4		6	ns
			ACLKR and ACLKX ext out	4		6	
		Hold time, McASP[x]_AXR input valid after McASP[x]_ACLKR and McASP[x]_ACLKX  ACLKX ACLKX ACLKX ACLKX	ACLKR and ACLKX int	-1		-1	
8	t <sub>h(ACLKRX-AXR)</sub>		ACLKR and ACLKX ext in	0.4		0.4	ns
9/1			ACLKR and ACLKX ext out	0.4		0.4	
,	ACLKR external i ACLKR external o ACLKX internal: A ACLKX external i	ACLKRCTL.CLKRM = 1, PDIR.ACLKR nput: ACLKRCTL.CLKRM = 0, PDIR.AC butput: ACLKRCTL.CLKRM = 0, PDIR.AC ACLKXCTL.CLKXM = 1, PDIR.ACLKX = nput: ACLKXCTL.CLKXM = 0, PDIR.AC butput: ACLKXCTL.CLKXM = 0, PDIR.AC butput: ACLKXCTL.CLKXM = 0, PDIR.AC	CLKR = 0 ACLKR = 1 = 1 CLKX = 0	(ns).	),		

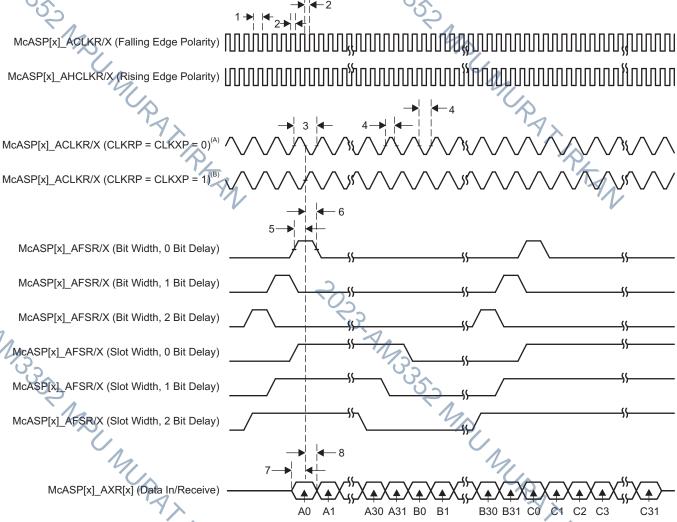
ACLKR external input: ACLKRCTL.CLKRM = 0, PDIR.ACLKR = 0 ACLKR external output: ACLKRCTL.CLKRM = 0, PDIR.ACLKR = 1 ACLKX external input: ACLKXCTL.CLKXM = 0, PDIR.ACLKX = 0 ACLKX external output: ACLKXCTL.CLKXM = 0, PDIR.ACLKX = 1

- (2) P = McASP[x]\_AHCLKR and McASP[x]\_AHCLKX period in nanoseconds (ns).
- (3) R = McASP[x]\_ACLKR and McASP[x]\_ACLKX period in ns.

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- For CLKRP = CLKXP = 0, the McASP transmitter is configured for rising edge (to shift data out) and the McASP receiver is configured for falling edge (to shift data in).
- For CLKRP = CLKXP = 1, the McASP transmitter is configured for falling edge (to shift data out) and the McASP receiver is configured for rising edge (to shift data in).

Figure 7-86. McASP Input Timing

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Table 7-79. Switching Characteristics for McASP<sup>(1)</sup>

(see Figure 7-87)

(300	igure 7-87)								
NO.	1/2	PARAMETER				OPP50		UNIT	
NO.	PARAMETER			MIN	MAX	MIN	MAX	UNIT	
9	t <sub>c(AHCLKRX)</sub>	Cycle time, McASP[x]_AHCLKR and McASP[x]_AHCLKX		20 <sup>(2)</sup>	1,	40		ns	
10	t <sub>w(AHCLKRX)</sub>	Pulse duration, McASP[x]_AHCLKR McASP[x]_AHCLKX high or low	and	$0.5P - 2.5^{(3)}$		0.5P - 2.5 <sup>(3)</sup>		ns	
11	t <sub>c(ACLKRX)</sub>	Cycle time, McASP[x]_ACLKR and McASP[x]_ACLKX		20		40		ns	
12	t <sub>w(ACLKRX)</sub>	Pulse duration, McASP[x]_ACLKR ar McASP[x]_ACLKX high or low	nd	0.5P – 2.5 <sup>(3)</sup>		0.5P – 2.5 <sup>(3)</sup>	_	ns	
	<sup>t</sup> d(ACLKRX-AFSRX)		Delay time, McASP[x]_ACLKR and McASP[x]_ACLKX transmit edge to	ACLKR and ACLKX int	0	6	0	16	
		McASP[x]_AFSR and McASP[x]_AFSX output valid	ACLKR and ACLKX ext in	2	13.5	2	18		
13		Delay time, McASP[x]_ACLKR and McASP[x]_ACLKX transmit edge to McASP[x]_AFSR and McASP[x]_AFSX output valid with Pad Loopback	ACLKR and ACLKX ext	2	13.5	2	18	ns	
		Delay time, McASP[x]_ACLKX	ACLKX int	0	6	0	6		
111		transmit edge to McASP[x]_AXR output valid	ACLKX ext in	2	13.5	2	18	ns	
13	t <sub>d(ACLKX-AXR)</sub>	Delay time, McASP[x]_ACLKX transmit edge to McASP[x]_AXR output valid with Pad Loopback	ACLKX ext out	2	13.5	2	18	115	
	t <sub>dis(ACLKX-AXR)</sub>	Disable time, McASP[x]_ACLKX	ACLKX int	2	6	0	6		
15		transmit edge to McASP[x]_AXR output high impedance	ACLKX ext in	2/	13.5	2	18		
		Disable time, McASP[x]_ACLKX transmit edge to McASP[x]_AXR output high impedance with pad loopback	ACLKX ext out	2	13.5	2	18	ns	

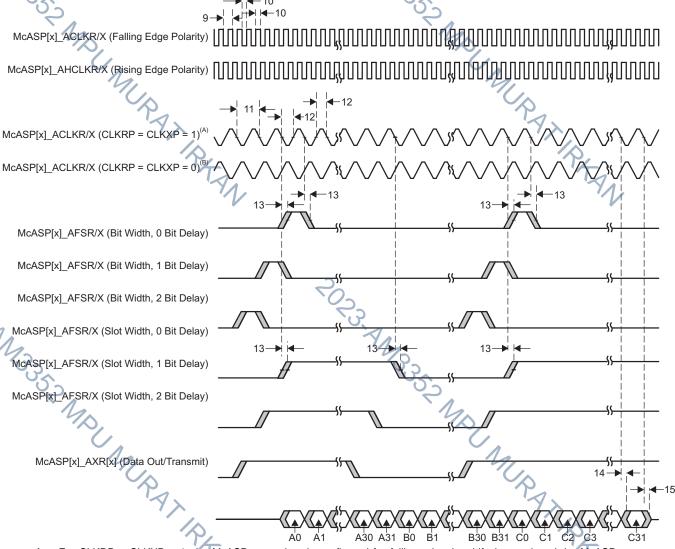
<sup>(1)</sup> ACLKR internal: ACLKRCTL.CLKRM = 1, PDIR.ACLKR = 1 ACLKR external input: ACLKRCTL.CLKRM = 0, PDIR.ACLKR = 0 ACLKR external output: ACLKRCTL.CLKRM = 0, PDIR.ACLKR = 1 ACLKX internal: ACLKXCTL.CLKXM = 1, PDIR.ACLKX = 1
ACLKX external input: ACLKXCTL.CLKXM = 0, PDIR.ACLKX = 0 ACLKX external output: ACLKXCTL.CLKXM = 0, PDIR.ACLKX = 1

- (2) 50 MHz
- (3) P = AHCLKR and AHCLKX period.

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- For CLKRP = CLKXP = 1, the McASP transmitter is configured for falling edge (to shift data out) and the McASP receiver is configured for rising edge (to shift data in).
- For CLKRP = CLKXP = 0, the McASP transmitter is configured for rising edge (to shift data out) and the McASP receiver is configured for falling edge (to shift data in).

Figure 7-87. McASP Output Timing

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## 7.12 Multichannel Serial Port Interface (McSPI)

For more information, see the Multichannel Serial Port Interface (McSPI) section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73).

## 7.12.1 McSPI Electrical Data and Timing

The following timings are applicable to the different configurations of McSPI in master or slave mode for any McSPI and any channel (n).

#### 7.12.1.1 McSPI—Slave Mode

Table 7-80. McSPI Timing Conditions - Slave Mode

			_					
	PARAME	MIN A	IAX UNIT					
Input Cond	ditions							
t <sub>r</sub>	Input signal rise time			5 ns				
t <sub>f</sub>	Input signal fall time			5 ns				
Output Condition								
C <sub>load</sub>	Output load capacitance	2		20 pF				

#### Table 7-81. Timing Requirements for McSPI Input Timings—Slave Mode

(see Figure 7-88)

Y -	_	,		/				
NO.				OPP10	00	OPP50		
16.	S.	^		MIN	MAX	MIN	MAX	UNIT
•	1	t <sub>c(SPICLK)</sub>	Cycle time, SPI_CLK	62.5		124.8		ns
2	2	tw(SPICLKL)	Typical pulse duration, SPI_CLK low	0.5P 3.12 <sup>(1)</sup>	0.5P + 3.12 <sup>(1)</sup>	0.5P – 3.12 <sup>(1)</sup>	0.5P + 3.12 <sup>(1)</sup>	ns
3	3	t <sub>w(SPICLKH)</sub>	Typical pulse duration, SPI_CLK high	0.5P - 3.12 <sup>(1)</sup>	0.5P + 3.12 <sup>(1)</sup>	0.5P – 3.12 <sup>(1)</sup>	0.5P + 3.12 <sup>(1)</sup>	ns
4	4	t <sub>su(SIMO-SPICLK)</sub>	Setup time, SPI_D[x] (SIMO) valid before SPI_CLK active edge <sup>(2)(3)</sup>	12.92	.7	12.92		ns
Ę	Ö	t <sub>h(SPICLK-SIMO)</sub>	Hold time, SPI_D[x] (SIMO) valid after SPI_CLK active edge <sup>(2)(3)</sup>	12.92		12.92		ns
8	3	t <sub>su(CS-SPICLK)</sub>	Setup time, SPI_CS valid before SPI_CLK first edge <sup>(2)</sup>	12.92		12.92		ns
9	9	t <sub>h(SPICLK-CS)</sub>	Hold time, SPI_CS valid after SPI_CLK last edge <sup>(2)</sup>	12.92		12.92	7.	ns
9	9	t <sub>h(SPICLK-CS)</sub>	Hold time, SPI_CS valid after SPI_CLK last edge <sup>(2)</sup>	12.92		12.92	7	ns

<sup>(1)</sup> P = SPI\_CLK period.

#### Table 7-82. Switching Characteristics for McSPI Output Timings—Slave Mode

(see Figure 7-89)

NO.		PARAMETER	OPP100		OPP50		LINUT
NO.		PARAMETER	MIN	MAX	MIN	MAX	UNIT
16	t <sub>d(SPICLK-SOMI)</sub>	Delay time, SPI_CLK active edge to SPI_D[x] (SOMI) transition <sup>(1)(2)</sup>	4.00	17.12	-4.00	17.12	ns
73	t <sub>d</sub> (CS-SOMI)	Delay time, SPI_CS active edge to SPI_D[x] (SOMI) transition <sup>(1)(2)</sup>	00	17.12		17.12	ns

<sup>(1)</sup> This timing applies to all configurations regardless of MCSPIX\_CLK polarity and which clock edges are used to drive output data and capture input data.

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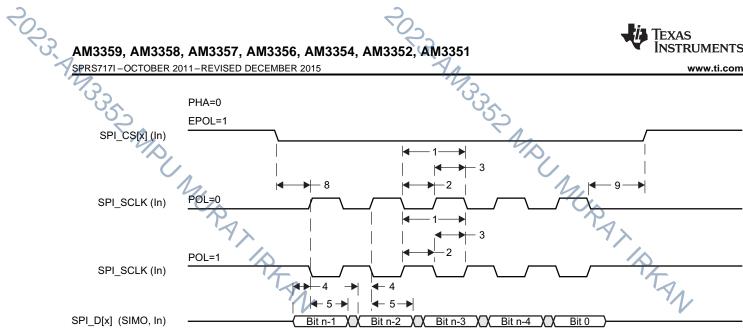
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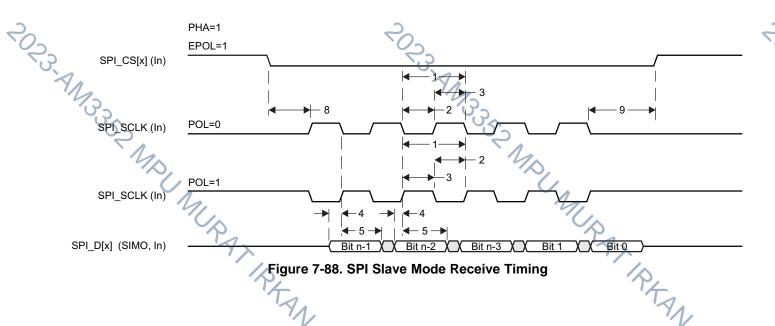
<sup>(2)</sup> This timing applies to all configurations regardless of MCSPIX\_CLK polarity and which clock edges are used to drive output data and capture input data.

<sup>(3)</sup> Pins SPIx\_D0 and SPIx\_D1 can function as SIMO or SOMI.

<sup>(2)</sup> Pins SPIx\_D0 and SPIx\_D1 can function as SIMO or SOMI.

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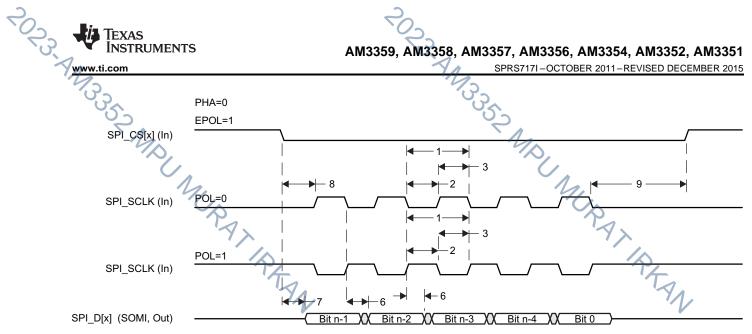


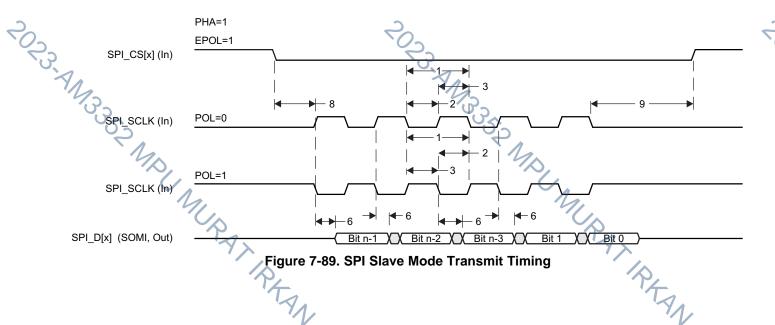
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#### McSPI—Master Mode

#### Table 7-83. McSPI Timing Conditions - Master Mode

	PARAMETER	LOW LOAD	2/	HIGH LOAD		UNIT
	PARAMETER	MIN	MAX	7 MIN	MAX	UNIT
Input Condit	tions		1	11,		
t <sub>r</sub>	Input signal rise time		8	S	8	ns
t <sub>f</sub>	Input signal fall time		8	'Ax	8	ns
Output Cond	dition			//		
C <sub>load</sub>	Output load capacitance		5	7/2	25	рF

## Table 7-84. Timing Requirements for McSPI Input Timings – Master Mode

#### (see Figure 7-90)

					OPP	100			OPI	P50		
NO.				LOW LO	DAD	HIGH L	OAD	LOW L	OAD	HIGH L	OAD	UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
4	t <sub>su(SOMI-</sub> SPICLKH)	Setup time, SPI_D[x] (SON SPI_CLK active edge <sup>(1)</sup>	II) valid before	2.29		3.02		2.29		3.02		ns
5	t <sub>h(SPICLKH-</sub>	Hold time, SPI_D[x] (SOMI) valid after	Industrial extended temperature (-40°C to 125°C)	710		7.1		7.1		7.1		ns
45	SOMI)	SPI_CLK active edge <sup>(1)</sup>	All other temperature ranges	4.7	1	4.7		4.7		4.7		

(1) Pins SPIx\_D0 and SPIx\_D1 can function as SIMO or SOMI.

## Table 7-85. Switching Characteristics for McSPI Output Timings - Master Mode

#### (see Figure 7-91)

(300	iguic 1731)							<b>'</b> ( <b>(</b> ).				
					OP	P100			OP	P50		
NO.		PARAMETER		LOW LO	DAD	HIGH LO	AD	LOW LO	AD	HIGH LO	AD	UNIT
		9//		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
1	t <sub>c(SPICLK)</sub>	Cycle time, SPI_	CLK	20.8		20.8		41.6	40	41.6		ns
2	t <sub>w(SPICLKL)</sub>	Typical pulse du SPI_CLK low	ration,	0.5P – 1.04 <sup>(1)</sup>	0.5P + 1.04 <sup>(1)</sup>	0.5P – 2.08 <sup>(1)</sup>	0.5P + 2.08 <sup>(1)</sup>	0.5P - 1.04 <sup>(1)</sup>	0.5P + 1.04 <sup>(1)</sup>	0.5P – 2.08 <sup>(1)</sup>	0.5P + 2.08 <sup>(1)</sup>	ns
	t <sub>w(SPICLKH)</sub>	Typical pulse du SPI_CLK high	ration,	0.5P – 1.04 <sup>(1)</sup>	0.5P + 1.04 <sup>(1)</sup>	0.5P - 2.08 <sup>(1)</sup>	0.5P + 2.08 <sup>(1)</sup>	0.5P – 1.04 <sup>(1)</sup>	0.5P + 1.04 <sup>(1)</sup>	0.5P - 2.08 <sup>(1)</sup>	0.5P + 2.08 <sup>(1)</sup>	ns
3	t <sub>r(SPICLK)</sub>	Rising time, SPI	_CLK	7.	3.82		3.82		3.82		3.82	ns
	t <sub>f(SPICLK)</sub>	Falling time, SPI	_CLK	1	3.44		3.44		3.44	1	3.44	ns
6	t <sub>d(SPICLK-SIMO)</sub>	Delay time, SPI_ active edge to S (SIMO) transition	PI_D[x]	-3.57	3.57	-4.62	4.62	-3.57	3.57	-4.62	4.62	ns
7	t <sub>d(CS-SIMO)</sub>	Delay time, SPI_edge to SPI_D[x transition <sup>(2)</sup>			3.57		4.62		3.57		4.62	ns
8		Delay time, SPI_CS active	Mode 1 and 3 <sup>(3)</sup>	A - 4.2 <sup>(4)</sup>	7	A – 2.54 <sup>(4)</sup>		A - 4.2 <sup>(4)</sup>		A – 2.54 <sup>(4)</sup>		ns
0	t <sub>d</sub> (CS-SPICLK)	to SPI_CLK first edge	Mode 0 and 2 <sup>(3)</sup>	B – 4.2 <sup>(5)</sup>		B + 2.54 <sup>(5)</sup>		B - 4.2 <sup>(5)</sup>		B – 2.54 <sup>(5)</sup>		ns
4		Delay time, SPI_CLK last	Mode 1 and 3 <sup>(3)</sup>	B – 4.2 <sup>(5)</sup>		B – 2.54 <sup>(5)</sup>	1-	B - 4.2 <sup>(5)</sup>		B – 2.54 <sup>(5)</sup>		ns
97	t <sub>d</sub> (SPICLK-CS)	edge to SPI_CS inactive	Mode 0 and 2 <sup>(3)</sup>	A - 4.2 <sup>(4)</sup>		A – 2.54 <sup>(4)</sup>	5	A - 4.2 <sup>(4)</sup>		A - 2.54 <sup>(4)</sup>		ns

(1) P = SPI\_CLK period.

(2) Pins SPIx\_D0 and SPIx\_D1 can function as SIMO or SOMI.

(3) The polarity of SPIx\_CLK and the active edge (rising or falling) on which mcspix\_simo is driven and mcspix\_somi is latched is all software configurable:

SPIx\_CLK(1) phase programmable with the bit PHA of MCSPI\_CH(i)CONF register: PHA = 1 (Modes 1 and 3).

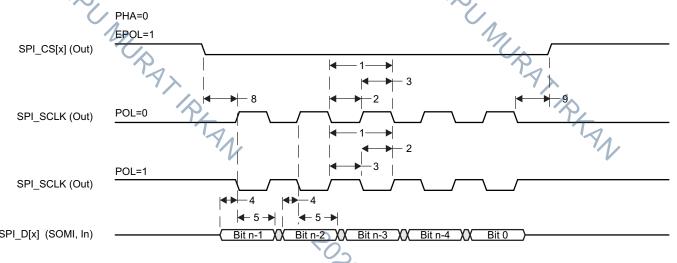
SPIx\_CLK(1) phase programmable with the bit PHA of MCSPI\_CH(i)CONF register: PHA = 0 (Modes 0 and 2).

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- (4) Case P = 20.8 ns, A = (TCS + 1) × TSPICLKREF (TCS is a bit field of MCSPI\_CH(i)CONF register).

  Case P > 20.8 ns, A = (TCS + 0.5) × Fratio × TSPICLKREF (TCS is a bit field of MCSPI\_CH(i)CONF register). Note: P = SPI\_CLK clock period.
- (5) B = (TCS + 0.5) × TSPICLKREF × Fratio (TCS is a bit field of MCSPI\_CH(i)CONF register, Fratio: Even ≥ 2).



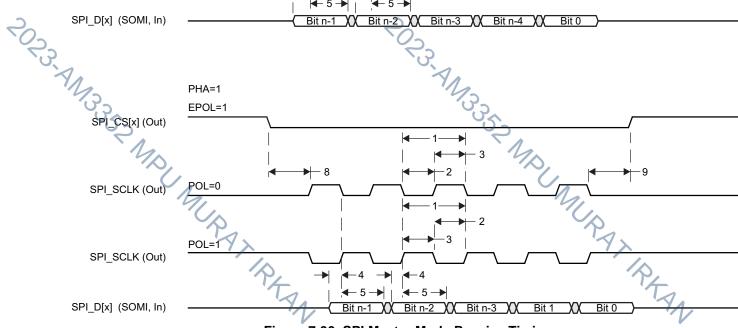
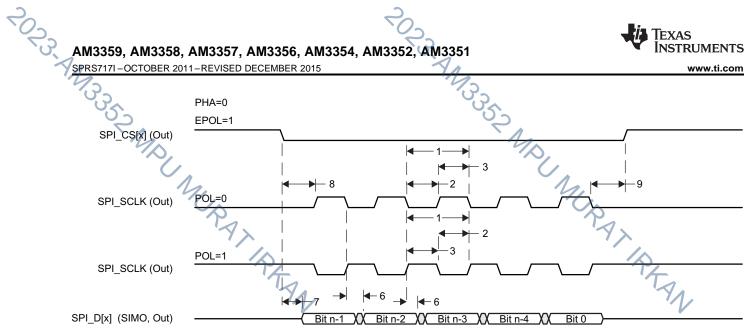
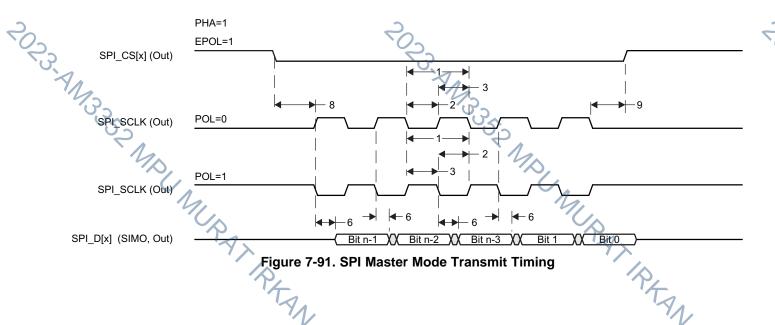


Figure 7-90. SPI Master Mode Receive Timing

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#### 7.13 Multimedia Card (MMC) Interface

For more information, see the Multimedia Card (MMC) section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73).

### 7.13.1 MMC Electrical Data and Timing

**Table 7-86. MMC Timing Conditions** 

	Table 1 of mine 1 mine 2	79		
	PARAMETER	MIN TY	P MAX	UNIT
Input Cor	nditions		/^	
t <sub>r</sub>	Input signal rise time	1	5	ns
t <sub>f</sub>	Input signal fall time	1	5	ns
Output Co	condition	·	1	
C <sub>load</sub>	Output load capacitance	3	30	pF

#### Table 7-87. Timing Requirements for MMC[x] CMD and MMC[x] DAT[7:0]

(see Figure 7-92)

(300	igule 1-32)										
NO.			ا کی		1.8	-V MOD	E	3.3	-V MOD	ÞΕ	UNIT
NO.			102		MIN	TYP	MAX	MIN	TYP	MAX	UNII
1	t <sub>su(CMDV-CLKH)</sub>	Setup time, MMC_CMD valid before MMC_	CLK rising clock edge		4.1			4.1			ns
1/3		Hold time MMC CMD valid after	Industrial extended temperature (-40°C to 125°C)	MMC0-2	3.76			3.76			
2	h(CLKH-CMDV)	Hold time, MMC_CMD valid after MMC_CLK rising clock edge		MMC0	3.76			2.52			ns
	5	_	All other temperature ranges	MMC1	3.76			3.03			
			temperature ranges	MMC2	3.76			3.0			
3	t <sub>su(DATV-CLKH)</sub>	Setup time, MMC_DATx valid before MMC_	CLK rising clock edge		4,1	5		4.1			ns
		LANGE MANO DATIVISIDA etras	Industrial extended temperature (-40°C to 125°C)	MMC0-2	3.76	0/	7,	3.76			
4	$t_{h(CLKH-DATV)}$	Hold time, MMC_DATx valid after MMC_CLK rising clock edge		MMC0	3.76		(()	2.52			ns
		P	All other temperature ranges	MMC1	3.76		1	3.03			
		7>	toporataro rangoo	MMC2	3.76		*	3.0			

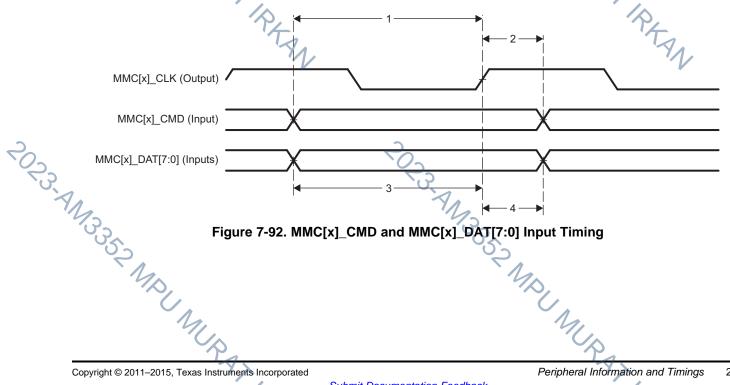


Figure 7-92. MMC[x]\_CMD and MMC[x]\_DAT[7:0] Input Timing

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## Table 7-88. Switching Characteristics for MMC[x]\_CLK

(see Figure 7-93)

NO.	1/2	PARAMETER	STANDARD	MODE	HIGH-SPEED MODE	UNIT
NO.	'~/	PARAMETER	MIN	TYP MAX	MIN TYP MA	
	$f_{op(CLK)}$	Operating frequency, MMC_CLK		24	1	8 MHz
5	t <sub>cop(CLK)</sub>	Operating period: MMC_CLK	41.7		20.8	ns
5	f <sub>id(CLK)</sub>	Identification mode frequency, MMC_CLK		400	40	0 kHz
	t <sub>cid(CLK)</sub>	Identification mode period: MMC_CLK	2500		2500	ns
6	t <sub>w(CLKL)</sub>	Pulse duration, MMC_CLK low	$ (0.5 \times P) - t_{f(CLK)}(1) $		$(0.5 \times P) - t_{f(CLK)}$	ns
7	t <sub>w(CLKH)</sub>	Pulse duration, MMC CLK high	$(0.5 \times P) - t_{r(CLK)}^{(1)}$		$(0.5 \times P) - t_{r(CLK)}(1)$	ns
8	t <sub>r(CLK)</sub>	Rise time, all signals (10% to 90%)	·	2.2	2	2 ns
9	t <sub>f(CLK)</sub>	Fall time, all signals (10% to 90%)		2.2	2.	2 ns

(1) P = MMC\_CLK period

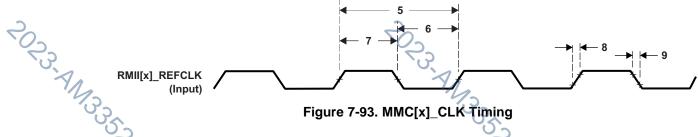


Figure 7-93. MMC[x]\_CLK Timing

Table 7-89. Switching Characteristics for MMC[x]\_CMD and MMC[x]\_DAT[7:0] - Standard Mode

(see Figure 7-94)

•						
NO.	PARAMETER	OPP100		OPP50		UNIT
NO.	PARAMETER	MIN TYP	MAX	MIN TYP	MAX	UNII
10	t <sub>d(CLKL-CMD)</sub> Delay time, MMC_CLK falling clock edge to MMC_CMD transition	-4	14	4/2	17.5	ns
11	t <sub>d(CLKL-DAT)</sub> Delay time, MMC_CLK falling clock edge to MMC_DATx transition	-4	14	-4	17.5	ns

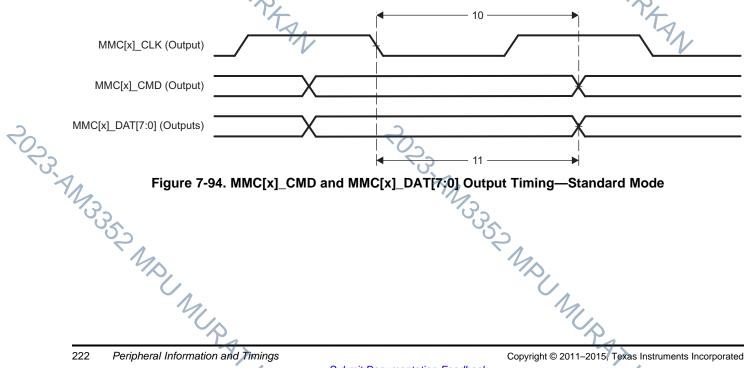


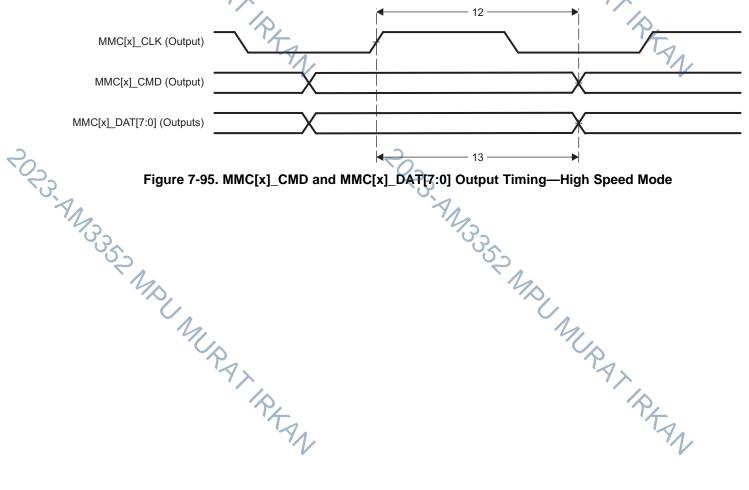
Figure 7-94. MMC[x]\_CMD and MMC[x]\_DAT[7:0] Output Timing—Standard Mode



## Table 7-90. Switching Characteristics for MMC[x]\_CMD and MMC[x]\_DAT[7:0]—High-Speed Mode

(see Figure 7-95)

NO	NO. PARAMETER		PP100	OPP50	UNIT	
NO.	PARAMETER	MIN	TYP MAX	MIN TYP	MAX	UNII
12	t <sub>d(CLKL-CMD)</sub> Delay time, MMC_CLK rising clock edge to MMC_CMD transition	3	14	1 <sub>1</sub> , 3	17.5	ns
13	Delay time, MMC_CLK rising clock edge to MMC_DATx transition	3	14	3	17.5	ns



MAN MAN PARAM Figure 7-95. MMC[x]\_CMD and MMC[x]\_DAT[7:0] Output Timing—High Speed Mode

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#### 7.14 Programmable Real-Time Unit Subsystem and Industrial Communication Subsystem (PRU-ICSS)

For more information, see the Programmable Real-Time Unit Subsystem and Industrial Communication Subsystem Interface (PRU-ICSS) section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73),

#### 7.14.1 Programmable Real-Time Unit (PRU-ICSS PRU)

## Table 7-91. PRU-ICSS PRU Timing Conditions

	PARAMETER	MIN MAX	UNIT
Output Con	dition	T	
C <sub>load</sub>	Capacitive load for each bus line	30	<b>1</b> pF

#### 7.14.1.1 PRU-ICSS PRU Direct Input/Output Mode Electrical Data and Timing

#### Table 7-92. PRU-ICSS PRU Timing Requirements - Direct Input Mode

(see Figure 7-96)

NO.		0,		MIN	MAX	UNIT
1	t <sub>w(GPI)</sub>	Pulse width, GPI	5	$2 \times P^{(1)}$		ns
2	t <sub>r(GPI)</sub>	Rise time, GPI	<b>A</b> .	1.00	3.00	ns
1/1-	t <sub>f(GPI)</sub>	Fall time, GPI	1/2	1.00	3.00	ns
3	t <sub>sk(GPI)</sub>	Internal skew between GPI[n:0] signals <sup>(2)</sup>	PRU0		1.00	ns
	5		PRU1		3.00	

P = L3 CLK (PRU-ICSS ocp clock) period.

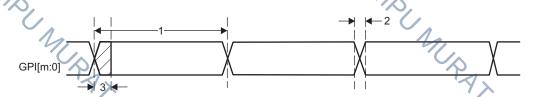


Figure 7-96. PRU-ICSS PRU Direct Input Timing

#### Table 7-93. PRU-ICSS PRU Switching Requirements – Direct Output Mode

(see Figure 7-60)

(300 1	guie 1-03)	· · · · · · · · · · · · · · · · · · ·				
NO.		PARAMETER		MIN	MAX	UNIT
1	t <sub>w(GPO)</sub>	Pulse width, GPO		2 x P <sup>(1)</sup>		ns
2	t <sub>r(GPO)</sub>	Rise time, GPO		1.00	3.00	ns
	t <sub>f(GPO)</sub>	Fall time, GPO		1.00	3.00	ns
3	t <sub>sk(GPO)</sub>	Internal skew between GPO[n:0] signals <sup>(2)</sup>	PRU0		1.00	ns
		2	PRU1		5.00	

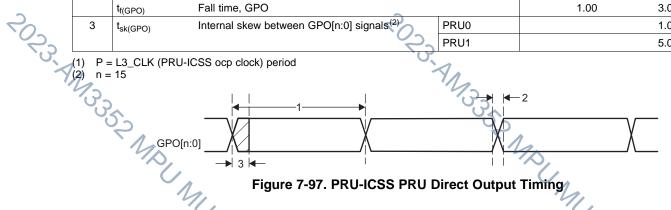


Figure 7-97. PRU-ICSS PRU Direct Output Timing



### PRU-ICSS PRU Parallel Capture Mode Electrical Data and Timing

#### Table 7-94. PRU-ICSS PRU Timing Requirements - Parallel Capture Mode

(see Figure 7-98 and Figure 7-99)

NO.			MIN MAX	UNIT
1	t <sub>c(CLOCKIN)</sub>	Cycle time, CLOCKIN	20.00	ns
2	t <sub>w(CLOCKIN_L)</sub>	Pulse duration, CLOCKIN low	10.00	ns
3	tw(CLOCKIN_H)	Pulse duration, CLOCKIN high	10.00	ns
4	t <sub>r(CLOCKIN)</sub>	Rising time, CLOCKIN	1.00 3.00	ns
5	t <sub>f(CLOCKIN)</sub>	Falling time, CLOCKIN	1.00 3.00	ns
6	t <sub>su(DATAIN-CLOCKIN)</sub>	Setup time, DATAIN valid before CLOCKIN	5.00	ns
7	t <sub>h(CLOCKIN-DATAIN)</sub>	Hold time, DATAIN valid after CLOCKIN	0.00	ns
8	t <sub>r(DATAIN)</sub>	Rising time, DATAIN	1.00 3.00	ns
	t <sub>f(DATAIN)</sub>	Falling time, DATAIN	1.00 3.00	ns

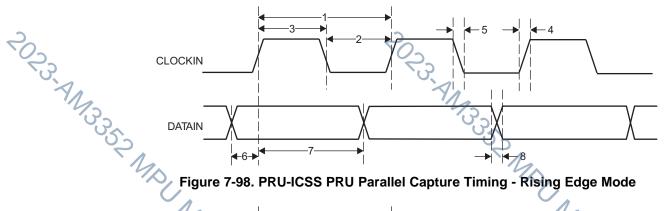


Figure 7-98. PRU-ICSS PRU Parallel Capture Timing - Rising Edge Mode

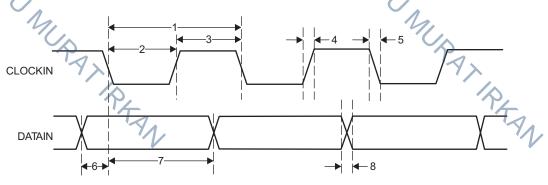


Figure 7-99. PRU-ICSS PRU Parallel Capture Timing - Falling Edge Mode

### 7.14.1.3 PRU-ICSS PRU Shift Mode Electrical Data and Timing

### Table 7-95. PRU-ICSS PRU Timing Requirements - Shift In Mode

(see Figure 7-100)

NO.		7,5	MIN	MAX	UNIT
1 t <sub>c(DATAIN)</sub>	Cycle time, DATAIN		10.00		ns
2 t <sub>w(DATAIN)</sub>	Pulse width, DATAIN	52	$0.45 \times P^{(1)}$	$0.55 \times P^{(1)}$	ns
3 t <sub>r(DATAIN)</sub>	Rising time, DATAIN		1.00	3.00	ns
4 t <sub>f(DATAIN)</sub>	Falling time, DATAIN		1.00	3.00	ns

<sup>(1)</sup> P = L3\_CLK (PRU-ICSS ocp clock) period.



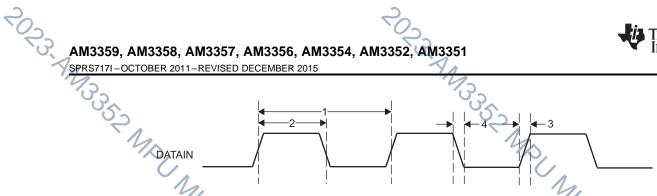


Figure 7-100. PRU-ICSS PRU Shift In Timing

#### Table 7-96. PRU-ICSS PRU Switching Requirements - Shift Out Mode

#### (see Figure 7-101)

NO.		4	MIN	MAX UNIT
1	t <sub>c(CLOCKOUT)</sub>	Cycle time, CLOCKOUT	10.00	ns
2	t <sub>w(CLOCKOUT)</sub>	Pulse width, CLOCKOUT	$0.45 \times P^{(1)}$	0.55 × P <sup>(1)</sup> ns
3	t <sub>r(CLOCKOUT)</sub>	Rising time, CLOCKOUT	1.00	3.00 ns
4	t <sub>f(CLOCKOUT)</sub>	Falling time, CLOCKOUT	1.00	3.00 ns
5	t <sub>d</sub> (CLOCKOUT-DATAOUT)	Delay time, CLOCKOUT to DATAOUT valid	0.00	3.00 ns
6	t <sub>r(DATAOUT)</sub>	Rising time, DATAOUT	1.00	3.00 ns
	t <sub>f(DATAOUT)</sub>	Falling time, DATAOUT	1.00	3.00 ns

#### (1) P = L3\_CLK (PRU-ICSS ocp clock) period.

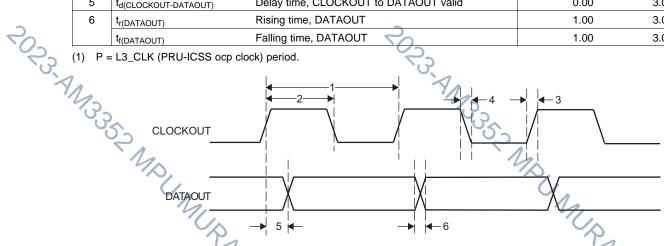


Figure 7-101. PRU-ICSS PRU Shift Out Timing

# 7.14.2 PRU-ICSS EtherCAT (PRU-ICSS ECAT)

#### Table 7-97. PRU-ICSS ECAT Timing Conditions

	PARAMETER	MIN MAX	UNIT	
Output Condition				
C <sub>load</sub>	Capacitive load for each bus line	30	pF	

### 7.14.2.1 PRU-ICSS ECAT Electrical Data and Timing

#### Table 7-98. PRU-ICSS ECAT Timing Requirements – Input Validated with LATCH\_IN

# (see Figure 7-102)

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NO.			.7,2	MIN	MAX	UNIT
10	tw(EDIO_LATCH_IN)	Pulse width, EDIO_LATCH_IN		100.00		ns
2	t <sub>r(EDIO_LATCH_IN)</sub>	Rising time, EDIO_LATCH_IN	5	1.00	3.00	ns
3	t <sub>f(EDIO_LATCH_IN)</sub>	Falling time, EDIO_LATCH_IN	1	1.00	3.00	ns
4	t <sub>su(EDIO_DATA_IN-</sub> EDIO_LATCH_IN)	Setup time, EDIO_DATA_IN valid be active edge	efore EDIO_LATCH_IN	20.00		ns
5	th(EDIO_LATCH_IN- EDIO_DATA_IN)	Hold time, EDIO_DATA_IN valid after edge	er EDIO_LATCH_IN active	20.00		ns

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#### Table 7-98. PRU-ICSS ECAT Timing Requirements – Input Validated with LATCH\_IN (continued)

(see Figure 7-102)

NO.	4/2		1/2	MIN	MAX	UNIT
6	t <sub>r(EDIO_DATA_IN)</sub>	Rising time, EDIO_DATA_IN		1.00	3.00	ns
	t <sub>f(EDIO_DATA_IN)</sub>	Falling time, EDIO_DATA_IN	1,	1.00	3.00	ns

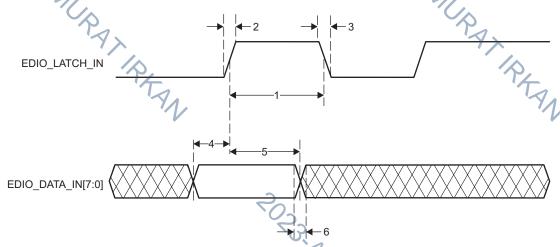


Figure 7-102. PRU-ICSS ECAT Input Validated with LATCH\_IN Timing

#### Table 7-99. PRU-ICSS ECAT Timing Requirements Input Validated with SYNCx

2023, AM33. (see Figure 7-103)

`	,			
NO.	1/2	4	MIN MA	X UNIT
1	t <sub>w(EDC_SYNCx_OUT)</sub>	Pulse width, EDC_SYNCx_OUT	100.00	ns
2	t <sub>r(EDC_SYNCx_OUT)</sub>	Rising time, EDC_SYNCx_OUT	1.00 3.0	00 ns
3	t <sub>f(EDC_SYNCx_OUT)</sub>	Falling time, EDC_SYNCx_OUT	1.00 3.0	00 ns
4	t <sub>su(EDIO_DATA_IN-</sub> EDC_SYNCx_OUT)	Setup time, EDIO_DATA_IN valid before EDC_SYNCx_OUT active edge	20.00	ns
5	t <sub>h</sub> (EDC_SYNCx_OUT- EDIO_DATA_IN)	Hold time, EDIO_DATA_IN valid after EDC_SYNCx_OUT active edge	20.00	ns
6	t <sub>r(EDIO_DATA_IN)</sub>	Rising time, EDIO_DATA_IN	1.00	00 ns
	t <sub>f(EDIO_DATA_IN)</sub>	Falling time, EDIO_DATA_IN	1.00	00 ns

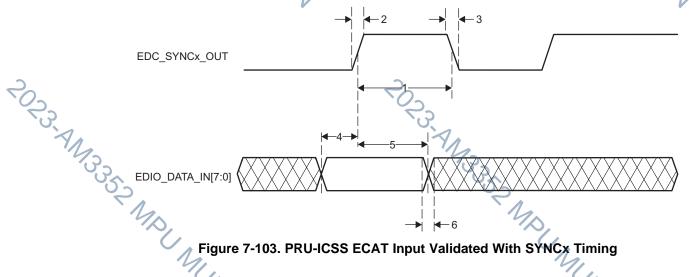


Figure 7-103. PRU-ICSS ECAT Input Validated With SYNCx Timing



### Table 7-100. PRU-ICSS ECAT Timing Requirements – Input Validated with Start of Frame (SOF)

(see Figure 7-104)

NO.	4	1	MIN	MAX	UNIT
1	t <sub>w(EDIO_SOF)</sub>	Pulse duration, EDIO_SOF	4 × P <sup>(1)</sup>	$5 \times P^{(1)}$	ns
2	t <sub>r(EDIO_SOF)</sub>	Rising time, EDIO_SOF	1.00	3.00	ns
3	t <sub>f(EDIO_SOF)</sub>	Falling time, EDIO_SOF	1.00	3.00	ns
4	t <sub>su(EDIO_DATA_IN-</sub> EDIO_SOF)	Setup time, EDIO_DATA_IN valid before EDIO_SOF active edge	20.00		ns
5	th(EDIO_SOF-EDIO_DATA_IN)	Hold time, EDIO_DATA_IN valid after EDIO_SOF active edge	20.00	<u> </u>	ns
6	t <sub>r(EDIO_DATA_IN)</sub>	Rising time, EDIO_DATA_IN	1.00	3.00	ns
	t <sub>f(EDIO_DATA_IN)</sub>	Falling time, EDIO_DATA_IN	1.00	3.00	ns

(1) P = PRU-ICSS IEP clock source period.

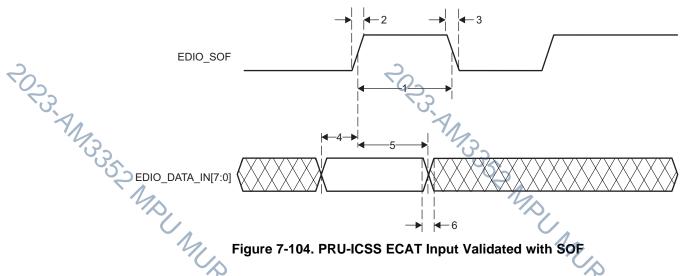


Figure 7-104. PRU-ICSS ECAT Input Validated with SOF

# Table 7-101. PRU-ICSS ECAT Timing Requirements - LATCHX\_IN

(see Figure 7-105)

	<b>3 7</b>				
NO.		<b>1</b>	MIN	MAX	UNIT
1	t <sub>w(EDC_LATCHx_IN)</sub>	Pulse duration, EDC_LATCHx_IN	$3 \times P^{(1)}$	'T	ns
2	t <sub>r(EDC_LATCHx_IN)</sub>	Rising time, EDC_LATCHx_IN	1.00	3.00	ns
3	t <sub>f(EDC_LATCHx_IN)</sub>	Falling time, EDC_LATCHx_IN	1.00	3.00	ns

(1) P = PRU-ICSS IEP clock source period.

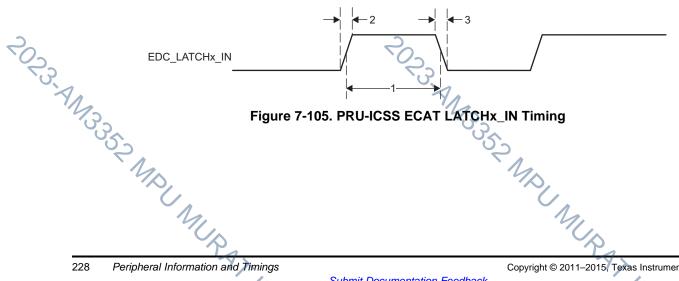


Figure 7-105. PRU-ICSS ECAT LATCHx\_IN Timing SEMBUMUS.



Table 7-102. PRU-ICSS ECAT Switching Requirements - Digital IOs

NO.	2,	PARAMETER	MIN	MAX	UNIT
1	tw(EDIO_OUTVALID)	Pulse duration, EDIO_OUTVALID	14 × P <sup>(1)</sup>	$32 \times P^{(1)}$	ns
2	t <sub>r(EDIO_OUTVALID)</sub>	Rising time, EDIO_OUTVALID	1.00	3.00	ns
3	t <sub>f</sub> (EDIO_OUTVALID)	Falling time, EDIO_OUTVALID	1.00	3.00	ns
4	t <sub>d</sub> (EDIO_OUTVALID- EDIO DATA OUT)	Delay time, EDIO_OUTVALID to EDIO_DATA_OUT	0.00	18 × P <sup>(1)</sup>	ns
	EDIO_DATA_OUT)	<u> </u>	7		
5	t <sub>r(EDIO_DATA_OUT)</sub>	Rising time, EDIO_DATA_OUT	1.00	3.00	ns
6	t <sub>f(EDIO_DATA_OUT)</sub>	Falling time, EDIO_DATA_OUT	1.00	3.00	ns
7	t <sub>sk(EDIO_DATA_OUT)</sub>	EDIO_DATA_OUT skew		8.00	ns

<sup>(1)</sup> P = PRU-ICSS IEP clock source period.

## 7.14.3 PRU-ICSS MII\_RT and Switch

#### Table 7-103. PRU-ICSS MII\_RT Switch Timing Conditions

	PARAMETE	MIN TYP	MAX UNIT	
Input Con	ditions	2		
$t_R$	Input signal rise time	700	1 <sup>(1)</sup>	3 <sup>(1)</sup> ns
t <sub>F</sub>	Input signal fall time	7,3	1 <sup>(1)</sup>	3 <sup>(1)</sup> ns
Output Co	ondition	<b>X</b> .		·
C <sub>LOAD</sub>	Output load capacitance	1/2-	3	20 pF

<sup>(1)</sup> Except when specified otherwise.

### 7.14.3.1 PRU-ICSS MDIO Electrical Data and Timing

## Table 7-104. PRU-ICSS MDIO Timing Requirements - MDIO DATA

(see Figure 7-106)

NO.	91,	MIN TYP MAX	UNIT
1	t <sub>su(MDIO-MDC)</sub> Setup time, MDIO valid before MDC high	90	ns
2	t <sub>h(MDIO-MDC)</sub> Hold time, MDIO valid from MDC high	0	ns

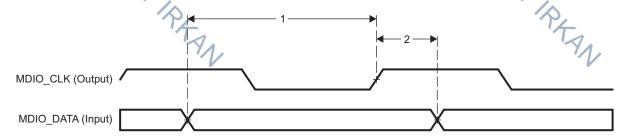


Figure 7-106. PRU-ICSS MDIO\_DATA Timing - Input Mode

#### Table 7-105. PRU-ICSS MDIO Switching Characteristics - MDIO\_CLK

(see Figure 7-107)

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NO.		PARAMETER	132	MIN	TYP	MAX	UNIT
10	t <sub>c(MDC)</sub>	Cycle time, MDC	0,4	400			ns
2	t <sub>w(MDCH)</sub>	Pulse duration, MDC high	7	160			ns
3	t <sub>w(MDCL)</sub>	Pulse duration, MDC low	•	160			ns
4	t <sub>t(MDC)</sub>	Transition time, MDC		10/		5	ns

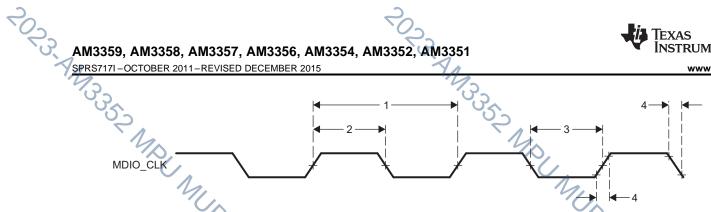


Figure 7-107. PRU-ICSS MDIO\_CLK Timing

#### Table 7-106. PRU-ICSS MDIO Switching Characteristics - MDIO\_DATA

#### (see Figure 7-108)

`	•				7 1	
NO.		41	MIN	TYP	MAX	UNIT
1	t <sub>d(MDC-MDIO)</sub>	Delay time, MDC high to MDIO valid	10		390	ns

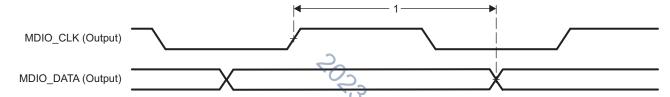


Figure 7-108. PRU-ICSS MDIO\_DATA Timing - Output Mode

## PRU-ICSS MII\_RT Electrical Data and Timing

#### Table 7-107. PRU-ICSS MII\_RT Timing Requirements - MII\_RXCLK

# (see Figure 7-109)

NO.			1	0 Mbps		10	00 Mbps		UNIT
NO.		1.	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
1	t <sub>c(RX_CLK)</sub>	Cycle time, RX_CLK	399.96		400.04	39.996	/_	40.004	ns
2	t <sub>w(RX_CLKH)</sub>	Pulse duration, RX_CLK high	140		260	14	7	26	ns
3	t <sub>w(RX_CLKL)</sub>	Pulse duration, RX_CLK low	140		260	14	$\gamma_{\lambda}$	26	ns
4	t <sub>t(RX CLK)</sub>	Transition time, RX_CLK			3			3	ns

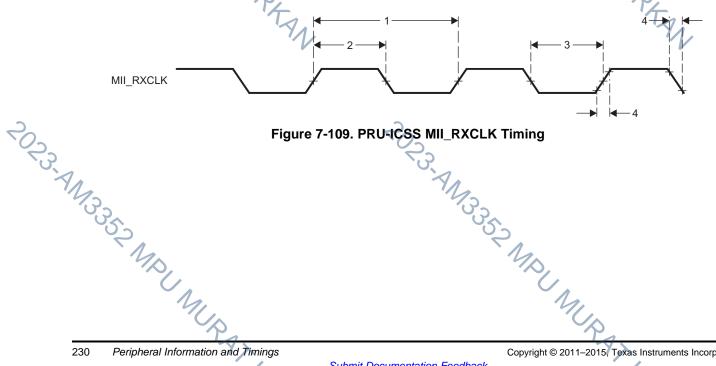


Figure 7-109. PRU-ICSS MII\_RXCLK Timing MANDOSE MANUAL TO THE TOTAL TO

#### Table 7-108. PRU-ICSS MII\_RT Timing Requirements - MII[x]\_TXCLK

(see Figure 7-110)

NO.	4		10 Mbps		10	0 Mbps		UNIT
NO.	·~/,	MIN	TYP	MAX	MIN	TYP	MAX	UNII
1	t <sub>c(TX_CLK)</sub> Cycle time, TX_CLK	399.96		400.04	39.996		40.004	ns
2	t <sub>w(TX_CLKH)</sub> Pulse duration, TX_CLK high	140		260	14		26	ns
3	t <sub>w(TX_CLKL)</sub> Pulse duration, TX_CLK low	140		260	14		26	ns
4	t <sub>t(TX_CLK)</sub> Transition time, TX_CLK			3		4	3	ns

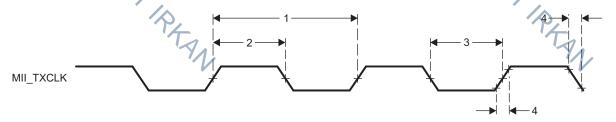


Figure 7-110. PRU-ICSS MII\_TXCLK Timing

### Table 7-109. PRU-ICSS MII\_RT Timing Requirements - MII\_RXD[3:0], MII\_RXDV, and MII\_RXER

(see Figure 7-111)

NO			7 <sub>1</sub> 1	0 Mbps		10	0 Mbps		UNIT
INC			MIN	TYP	MAX	MIN	TYP	MAX	UNII
0	t <sub>su(RXD-RX_CLK)</sub>	Setup time, RXD[3:0] valid before RX_CLK	9						
1	t <sub>su(RX_DV-RX_CLK)</sub>	Setup time, RX_DV valid before RX_CLK	8	25		8			ns
	t <sub>su(RX_ER-RX_CLK)</sub>	Setup time, RX_ER valid before RX_CLK		1					
	t <sub>h(RX_CLK-RXD)</sub>	Hold time RXD[3:0] valid after RX_CLK		1/					
2	t <sub>h(RX_CLK-RX_DV)</sub>	Hold time RX_DV valid after RX_CLK	8			8			ns
	th(RX CLK-RX ER)	Hold time RX_ER valid after RX_CLK			1	7,			

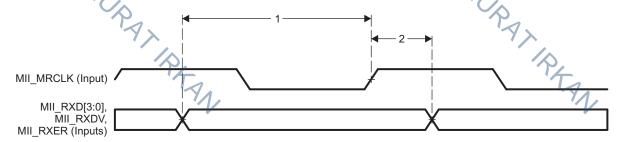


Figure 7-111. PRU-ICSS MII\_RXD[3:0], MII\_RXDV, and MII\_RXER Timing PORS AMBUMUR VIIII

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## Table 7-110. PRU-ICSS MII\_RT Switching Characteristics - MII\_TXD[3:0] and MII\_TXEN

(see Figure 7-112)

NO	4,	1	0 Mbps	1	00 Mbps	UNIT
	~/,	MIN	TYP MAX	MIN	TYP MAX	
4	t <sub>d(TX_CLK-TXD)</sub> Delay time, TX_CLK high to TXD[3:0] valid	F	2/2		25	20
'	t <sub>d(TX_CLK-TX_EN)</sub> Delay time, TX_CLK to TX_EN valid	5	25	7, 3	25	ns

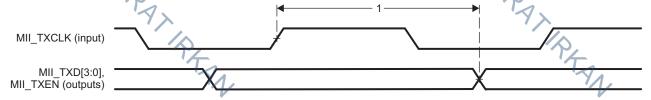


Figure 7-112. PRU-ICSS MII\_TXD[3:0], MII\_TXEN Timing

#### 7.14.4 PRU-ICSS Universal Asynchronous Receiver Transmitter (PRU-ICSS UART)

#### Table 7-111. Timing Requirements for PRU-ICSS UART Receive

(see Figure 7-113)

NO.	, O, ,	MIN	MAX	UNIT
3	t <sub>w(RX)</sub> Pulse duration, receive start, stop, data bit	0.96U <sup>(1)</sup>	1.05U <sup>(1)</sup>	ns

(1) U = UART baud time = 1/programmed baud rate.

#### Table 7-112. Switching Characteristics Over Recommended Operating Conditions for PRU-ICSS UART **Transmit**

(see Figure 7-113)

NO.	PARAMETER	/ .	MIN	MAX	UNIT
1	$f_{baud(baud)}$ Maximum programmable baud rate	1	0	12	MHz
2	t <sub>w(TX)</sub> Pulse duration, transmit start, stop, data bit	U <del>(</del>	- 2 <sup>(1)</sup>	$U + 2^{(1)}$	ns

U = UART baud time = 1/programmed baud rate.

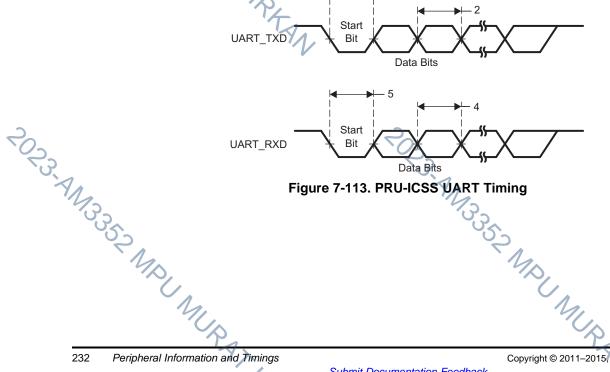


Figure 7-113. PRU-ICSS VART Timing 3352 MACMUR



## 7.15 Universal Asynchronous Receiver Transmitter (UART)

For more information, see the Universal Asynchronous Receiver Transmitter (UART) section of the AM335x Sitara Processors Technical Reference Manual (SPRUH73)

#### 7.15.1 UART Electrical Data and Timing

### Table 7-113. Timing Requirements for UARTx Receive

#### (see Figure 7-114)

NO.	1/2	MIN	/ MAX	UNIT
3	t <sub>w(RX)</sub> Pulse duration, receive start, stop, data bit	0.96U <sup>(1)</sup>	1.05U <sup>(1)</sup>	ns

<sup>(1)</sup> U = UART baud time = 1/programmed baud rate.

#### Table 7-114. Switching Characteristics for UARTx Transmit

#### (see Figure 7-114)

NO.	PARAMETER	MIN	MAX	UNIT
1	$f_{baud(baud)}$ Maximum programmable baud rate		3.6864	MHz
2	t <sub>w(TX)</sub> Pulse duration, transmit start, stop, data bit	U – 2 <sup>(1)</sup>	U + 2 <sup>(1)</sup>	ns

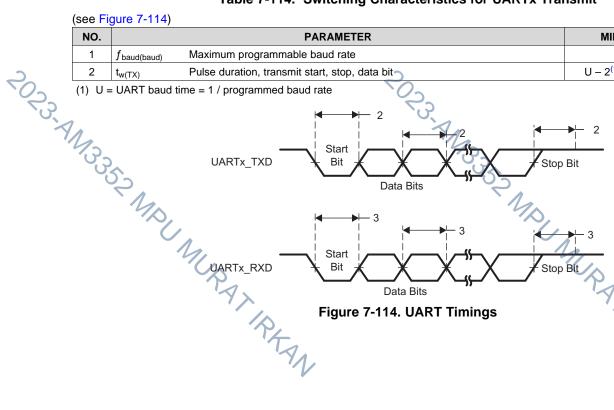


Figure 7-114. UART Timings

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Peripheral Information and Timings

#### 7.15.2 UART IrDA Interface

2 UART IrDA Interface

The IrDA module operates in three different modes:

• Slow infrared (SIR) (≤115.2 kbps)

• Medium infrared (MIR) (0.576 Mbps and 1.152 Mbps)

• Fast infrared (FIR) (4 Mbps).

Figure 7-115 illustrates the UART IrDA pulse parameters. Table 7-115 and Table 7-116 list the signaling rates and pulse durations for UART IrDA receive and transmit modes rates and pulse durations for UART IrDA receive and transmit modes.

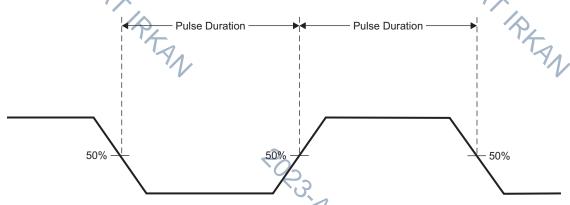


Figure 7-115. UART IrDA Pulse Parameters

Table 7-115. UART IrDA—Signaling Rate and Pulse Duration—Receive Mode

Figure 7-115. UART Table 7-115. UART IrDA—Signaling R	ELECTRICAL PULSE DU		
SIGNALING RATE	MIN	MAX	UN
SIR	7/,		
2.4 kbps	1.41	88.55	μ
9.6 kbps	1.41	22.13	μ
19.2 kbps	1.41	11.07	μ
38.4 kbps	1.41	5.96	μ
57.6 kbps	1.41	4.34	μ
115.2 kbps	1.41	2.23	μ
MIR		1/2	
0.576 Mbps	297.2	518.8	ns
1.152 Mbps	149.6	258.4	ns
FIR			
4 Mbps (single pulse)	67	164	ns
4 Mbps (double pulse)	190	289	ns
4 Mbps (double pulse)  234 Peripheral Information and Timings	190  23. All 190  Copyright © 2011-		

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Table 7-116. UART IrDA—Signaling Rate and Pulse Duration—Transmit Mode

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SIGNALING RATE	ELECTRICAL PULSE DUR	ATION	UNIT			
SIGNALING RATE	MIN	MAX	Olviii			
SIR						
2.4 kbps	78.1	78.1	μs			
9.6 kbps	19.5	19.5	μs			
19.2 kbps	9.75	9.75	μs			
38.4 kbps	4.87	4.87	μs			
57.6 kbps	3.25	3.25	μs			
115.2 kbps	1.62	1.62	μs			
MIR		1	71			
0.576 Mbps	414	419	ns			
1.152 Mbps	206	211	ns			
FIR						
4 Mbps (single pulse)	123	128	ns			
4 Mbps (double pulse)	248	253	ns			
7.5	ANS					
18352 MALMURAN RAN	123 248 7073 AM335 AM30 MACAMANA	PAN				

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Peripheral Information and Timings

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### 8 Device and Documentation Support

#### 8.1 Device Support

#### 8.1.1 Development Support

TI offers an extensive line of development tools, including tools to evaluate the performance of the processors, generate code, develop algorithm implementations, and fully integrate and debug software and hardware modules. The tool's support documentation is electronically available within the Code Composer Studio<sup>TM</sup> Integrated Development Environment (IDE).

The following products support development of AM335x device applications:

**Software Development Tools:** Code Composer Studio<sup>™</sup> Integrated Development Environment (IDE): including Editor C/C++/Assembly Code Generation, and Debug plus additional development tools Scalable, Real-Time Foundation Software (DSP/BIOS<sup>™</sup>), which provides the basic run-time target software needed to support any AM335x device application.

Hardware Development Tools: Extended Development System (XDS™) Emulator

For a complete listing of development-support tools for the AM335x microprocessor platform, visit the Texas Instruments website at <a href="https://www.ti.com">www.ti.com</a>. For information on pricing and availability, contact the nearest TI field sales office or authorized distributor.

#### 81.1.1 Tools, Starter Kits, and Reference Designs

AM335x Evaluation Module: The AM335x Evaluation Module (EVM) enables developers to immediately start evaluating the AM335x processor family (AM3352, AM3354, AM3356, AM3358) and begin building applications such as portable navigation, portable gaming, home/building automation and others.

AM335x Starter Kit: The AM335x Starter Kit (EVM-SK) provides a stable and affordable platform to quickly start evaluation of Sitara ARM Cortex-A8 AM335x processors (AM3352, AM3354, AM3356, AM3358) and accelerate development for smart appliance, industrial and networking applications. It is a low-cost development platform based on the ARM Cortex-A8 processor that is integrated with options such as Dual Gigabit Ethernet, DDR3 and LCD touch screen.

AM3359 Industrial Communications Engine: The AM3359 Industrial Communications Engine (ICE) is a development platform targeted for systems that specifically focus on the industrial communications capabilities of the Sitara AM335x ARM Cortex-A8 processors. The ICE hardware and included software is designed to help integrate the industrial communications interfaces in a broad range of industrial systems.

Enterprise Tablet Reference Design Kit: Powered by the Sitara ARM Cortex-A8 processor family, AM335x, the Enterprise Tablet solution provides high-performance, seamless graphics and the right peripheral support with a bill of materials of less than an estimated \$70 at 100Ku. Target markets include, but are not limited to, shipping and logistics, field service, retail, healthcare, home and building automation, hospitality, education and many others.

#### 8.1.2 Device Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all microprocessors (MPUs) and support tools. Each device has one of three prefixes: X, P, or null (no prefix) (for example, XAM3358AZCE). Texas Instruments recommends two of three possible prefix designators for its support tools: TMDX and TMDS. These prefixes represent evolutionary stages of product development from engineering prototypes (TMDX) through fully qualified production devices and tools (TMDS).

Device development evolutionary flow:

X Experimental device that is not necessarily representative of the final device's electrical specifications and may not use production assembly flow.

Device and Documentation Support

Prototype device that is not necessarily the final silicon die and may not necessarily meet final electrical specifications.

Production version of the silicon die that is fully qualified.

Support tool development evolutionary flow:

**TMDX** 

Development-support product that has not yet completed Texas Instruments internal qualification testing.

**TMDS** 

Fully-qualified development-support product.

X and P devices and TMDX development-support tools are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

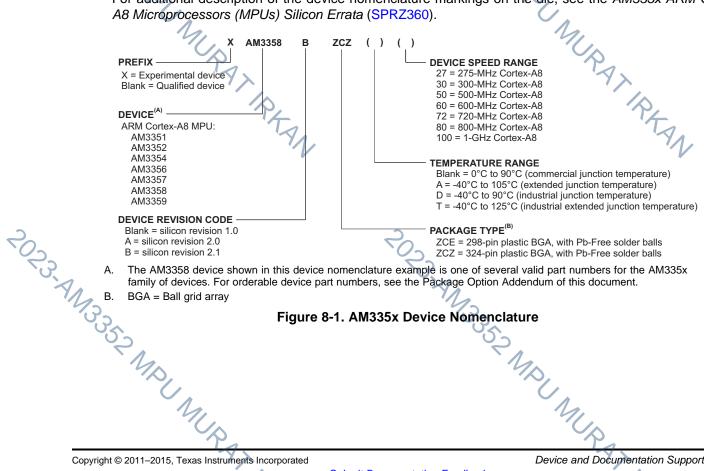
Production devices and TMDS development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (X or P) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the package type (for example, ZCE), the temperature range (for example, blank is the default commercial temperature range), and the device speed range, in megahertz (for example, 27 is 275 MHz). Figure 8-1 provides a legend for reading the complete device name for any AM335x device.

For orderable part numbers of AM335x devices in the ZCE and ZCZ package types, see the Package Option Addendum of this document, the TI website (www.ti.com), or contact your TI sales representative.

For additional description of the device nomenclature markings on the die, see the AM335x ARM Cortex-A8 Microprocessors (MPUs) Silicon Errata (SPRZ360).



The AM3358 device shown in this device nomenclature example is one of several valid part numbers for the AM335x family of devices. For orderable device part numbers, see the Package Option Addendum of this document.

TO MALMI Figure 8-1. AM335x Device Nomenclature

Device and Documentation Support



#### 8.2.1 Related Documentation

The following documents describe the AM335x MPU. Copies of these documents are available on the Internet at www.ti.com.

The current documentation that describes the AM335x MPU, related peripherals, and other technical collateral, is available in the product folder at: www.ti.com.

SPRUH73 AM335x Sitara Processors Technical Reference Manual. Collection of documents providing detailed information on the AM335x device including power, reset, and clock control, interrupts, memory map, and switch fabric interconnect. Detailed information on the microprocessor unit (MPU) subsystem as well as a functional description of the peripherals supported on AM335x devices is also included.

SPRZ360 AM335x Sitara Processors Silicon Errata. Describes the known exceptions to the functional specifications for the AM335x ARM Cortex-A8 Microprocessors.

The following documents are related to the MPU. Copies of these documents can be obtained directly from the internet or from your Texas Instruments representative. To determine the revision of the Cortex-A8 core used on your device, see the AM335x Sitara Processors Silicon Errata (SPRZ360).

Cortex-A8 Technical Reference Manual: This is the technical reference manual for the Cortex-A8 processor. A copy of this document can be obtained via the internet at http://infocenter.arm.com or from your Texas Instruments representative.

ARM Core Cortex-A8 (AT400/AT401) Errata Notice: Provides a list of advisories for the different revisions of the Cortex-A8 processor. Contact your TI representative for a copy of this document.

#### 8.3 **Receiving Notification of Documentation Updates**

To receive notification of documentation updates—including silicon errata—go to the product folder for your device on ti.com (AM3359, AM3358, AM3357, AM3356, AM3354, AM3352, AM3351). In the upper right-hand corner, click the "Alert me" button. This registers you to receive a weekly digest of product information that has changed (if any). For change details, check the revision history of any revised document.

#### 8.4 **Related Links**

Table 8-1 lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 8-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
AM3359	Click here	Click here	Click here	Click here	Click here
AM3358	Click here	Click here	Click here	Click here	Click here
AM3357	Click here	Click here	Click here	Click here	Click here
AM3356	Click here	Click here	Click here	Click here	Click here
AM3354	Click here	Click here	Click here	Click here	Click here
AM3352	Click here	Click here	Click here	Click here	Click here
AM3351	Click here	Click here	Click here	Click here	Click here
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#### 8.5 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

TI Embedded Processors Wiki Texas Instruments Embedded Processors Wiki. Established to help developers get started with Embedded Processors from Texas Instruments and to foster innovation and growth of general knowledge about the hardware and software surrounding these devices.

#### 8.6 **Trademarks**

Sitara, SmartReflex, Code Composer Studio, DSP/BIOS, XDS, E2E are trademarks of Texas Instruments. NEON is a trademark of ARM Ltd or its subsidiaries.

ARM, Cortex are registered trademarks of ARM Ltd or its subsidiaries.

EtherCAT is a registered trademark of EtherCAT Technology Group.

Android is a trademark of Google Inc.

PowerVR SGX is a trademark of Imagination Technologies Limited.

Linux is a registered trademark of Linus Torvalds.

All other trademarks are the property of their respective owners.

## Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 8.8 Glossary //

TI Glossary This glossary lists and explains terms, acronyms, and definitions. A) PLAN

POPS, AMSSS MAUMU,

Device and Documentation Support

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#### 9 Mechanical, Packaging, and Orderable Information

#### Via Channel 9.1

The ZCE package has been specially engineered with Via Channel technology. This allows larger than normal PCB via and trace sizes and reduced PCB signal layers to be used in a PCB design with the 0.65mm pitch package, and substantially reduces PCB costs. It allows PCB routing in only two signal layers (four layers total) due to the increased layer efficiency of the Via Channel BGA technology.

Via Channel technology implemented on the ZCE package makes it possible to build an AM335x-based product with a 4-layer PCB, but a 4-layer PCB may not meet system performance goals. Therefore, system performance using a 4-layer PCB design must be evaluated during product design.

#### **Packaging Information** 9.2

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and PORS, AMSSSS MANUARA, IRAN revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PORSAMBOSE MANUAL MURAN IRAM

POPS, AMSSS MALMAL,

POPS AMSSE MADU MUR Mechanical, Packaging, and Orderable Information

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Product Folder Links: AM3359 AM3358 AM3357 AM3356 AM3354 AM3352 AM3351

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# PACKAGING INFORMATION

							3,7				
Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Sample
AM3351BZCE30	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3351BZCE30	Sample
AM3351BZCE60	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3351BZCE60	Sample
AM3352BZCE30	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3352BZCE30	Sample
AM3352BZCE30R	ACTIVE	NFBGA	ZCE	298	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	Pa.	AM3352BZCE30	Sample
AM3352BZCE60	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3352BZCE60	Sample
AM3352BZCEA30	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3352BZCEA30	Sample
AM3352BZCEA30R	ACTIVE	NFBGA	ZCE	298	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3352BZCEA30	Sample
AM3352BZCEA60	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3352BZCEA60	Sample
AM3352BZCEA60R	ACTIVE	NFBGA	ZCE	298	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3352BZCEA60	Sample
AM3352BZCED30	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3352BZCED30	Sample
AM3352BZCED60	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3352BZCED60	Sample
AM3352BZCZ100	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3352BZCZ100	Sample
AM3352BZCZ30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3352BZCZ30	Sample
AM3352BZCZ60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3352BZCZ60	Sample
AM3352BZCZ80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3352BZCZ80	Sample
AM3352BZCZA100	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3352BZCZA100	Sample
AM3352BZCZA30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3352BZCZA30	Sample

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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking	Samp
AM3352BZCZA60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3352BZCZA60	Samp
AM3352BZCZA80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3352BZCZA80	Samp
AM3352BZCZD30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3352BZCZD30	Samp
AM3352BZCZD60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3352BZCZD60	Samp
AM3352BZCZD80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3352BZCZD80	Samp
AM3352BZCZT60	PREVIEW	NFBGA	ZCZ	324		Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 125	AM3352BZCZT60	
AM3352BZCZT60R	PREVIEW	NFBGA	ZCZ	324		Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 125	AM3352BZCZT60	
AM3354BZCE60	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3354BZCE60	Samp
AM3354BZCEA60	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3354BZCEA60	Samp
AM3354BZCED60	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3354BZCED60	Samp
AM3354BZCZ100	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3354BZCZ100	Samp
AM3354BZCZ30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3354BZCZ30	Samp
AM3354BZCZ60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3354BZCZ60	Samp
AM3354BZCZ80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3354BZCZ80	Samp
AM3354BZCZA100	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3354BZCZA100	Samp
AM3354BZCZA60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3354BZCZA60	Samj
AM3354BZCZA80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3354BZCZA80	Samp
AM3354BZCZA80R	ACTIVE	NFBGA	ZCZ	324	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR		AM3354BZCZA80	Samp

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	Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(5)	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	-
	AM3354BZCZD60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3354BZCZD60	Samples
	AM3354BZCZD80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3354BZCZD80	Samples
	AM3356BZCEA60	ACTIVE	NFBGA	ZCE	298	160	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR		AM3356BZCEA60	Samples
	AM3356BZCZ30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3356BZCZ30	Samples
	AM3356BZCZ60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3356BZCZ60	Samples
	AM3356BZCZ80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3356BZCZ80	Samples
	AM3356BZCZA30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3356BZCZA30	Samples
	AM3356BZCZA60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3356BZCZA60	Samples
	AM3356BZCZA80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3356BZCZA80	Samples
	AM3356BZCZD30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3356BZCZD30	Samples
	AM3356BZCZD60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3356BZCZD60	Samples
	AM3357BZCZA30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3357BZCZA30	Samples
<u>ر</u>	AM3357BZCZA60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3357BZCZA60	Samples
	AM3357BZCZA80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3357BZCZA80	Samples
	AM3357BZCZD30	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3357BZCZD30	Samples
	AM3357BZCZD60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 90	AM3357BZCZD60	Samples
	AM3358BZCZ100	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3358BZCZ100	Samples
	AM3358BZCZ60	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3358BZCZ60	Samples



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Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
0,5	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
AM3358BZCZ80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	0 to 90	AM3358BZCZ80	Samples
AM3358BZCZA100	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3358BZCZA100	Samples
AM3358BZCZA80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3358BZCZA80	Samples
AM3359BZCZA80	ACTIVE	NFBGA	ZCZ	324	126	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 105	AM3359BZCZA80	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF AM3358:

● Enhanced Product: AM3358-EP

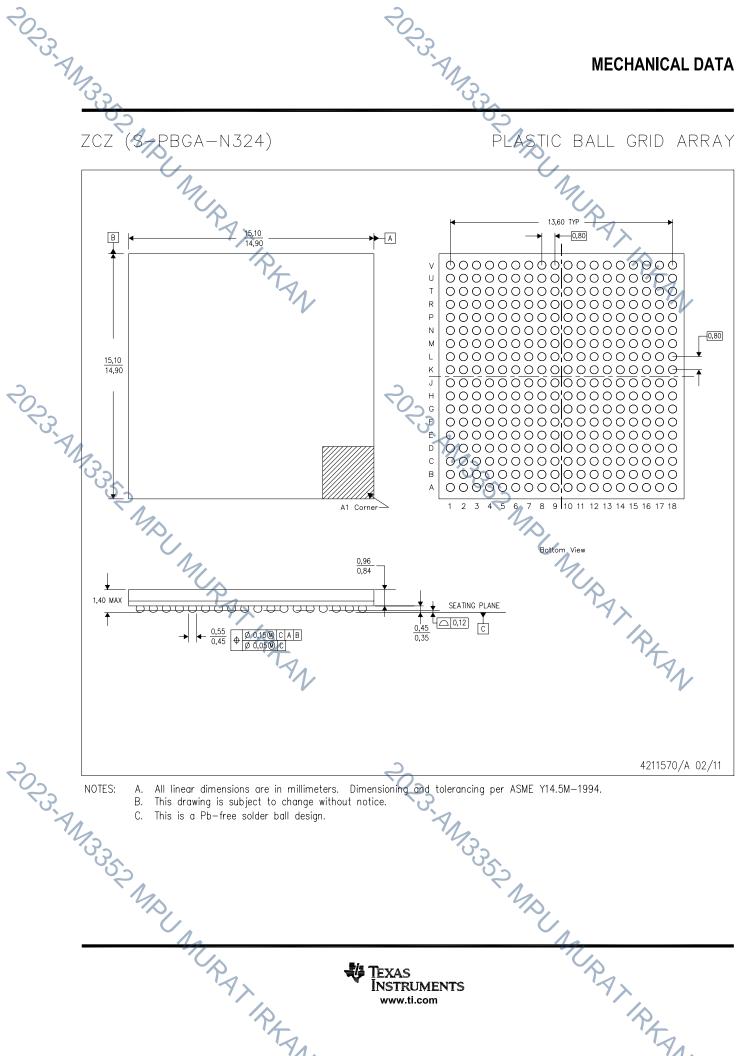
NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

Addendum-Page 5

2023

BALL GRID ARRAY



All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

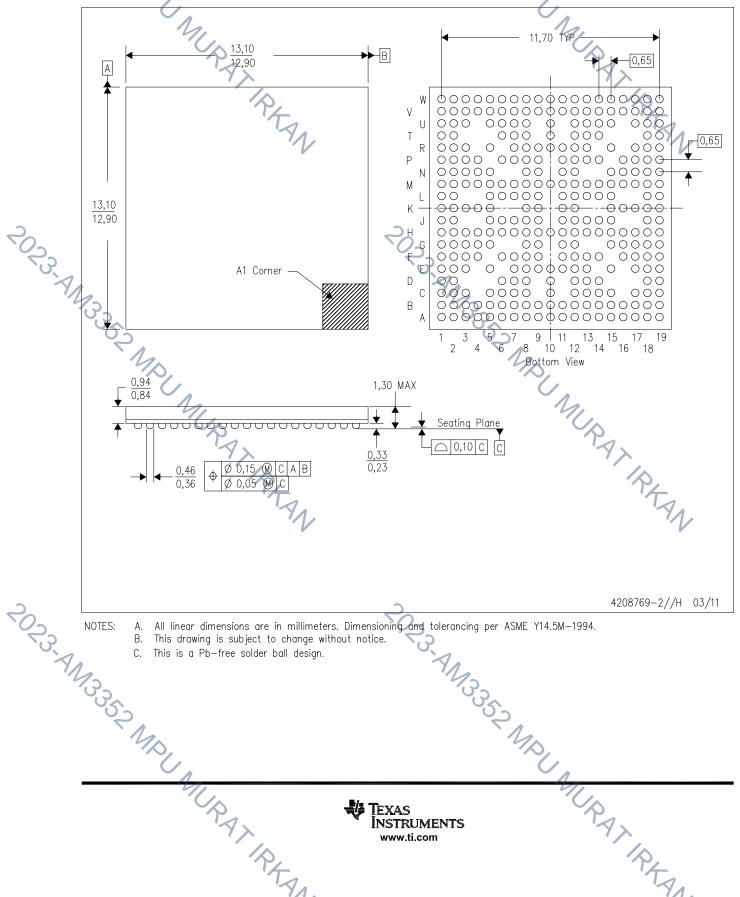
This drawing is subject to change without notice.

This is a Pb-free solder ball design.

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POPS, AMSS. ZCE (SPBGA-N298) 2023, AM333 PLASTIC BALL GRID ARRAY



All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

This drawing is subject to change without notice.

C. This is a Pb-free solder ball design.

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